

L9680

Automotive advanced airbag for mid/high end applications and cut-off battery IC



Features



- AEC-Q100 qualified
- Boost regulator for energy reserve
 - 1.882 MHz operation, I_{load} = 70 mA max
 - Output voltage user selectable, 23 V/ 33 V ±5%
 - Capacitor value & ESR diagnostics
 - Boost regulator for PSI-5 SYNC pulse
 - 1.882 MHz operation,
 - Output voltage, 12 V/14.75 V, user configurable
- Buck regulator for remote sensor
 - 1.882 MHz operation
 - Output voltage, 7.2 V/9 V ±4%, user configurable
- Buck regulator for micro controller unit
 - 1.882 MHz operation
 - Output voltage user selectable, 3.3 V or 5.0 V ±3%
- Integrated energy reserve crossover switch
 - 3 Ω 912 mA max
 - Switch active output indicator
- Battery voltage monitor & shutdown control with Wake-up control

- Datasheet production data
- System voltage diagnostics with integrated ADC
- Squib/pyroswitch deployment drivers
 - 12 channel HSD/LSD
 - 25 V max deployment voltage
 - Various deployment profiles
 - Current monitoring
 - R_{measure}, STB, STG & Leakage diagnostics
 - High & low side driver FET tests
- High side safing switch regulator and enable control
- Four channel remote sensor interface
 - PSI-5 satellite sensors
 - Active wheel speed sensors
- Three channel GPO, HSD or LSD configurable, with PWM 0-100% control
- Nine channel hall-effect, resistive or switch sensor interface
- User customizable safing logic
- Specific disarm signal for passenger airbag
- Temporal and algorithmic Watchdog timers
- End of life disposal interface
- Temperature sensor
- 32 bit SPI communications
- 5.5 V minimum operating voltage at device battery pin
- Operating temperature, -40 to 95 °C
- Packaging 100 pin

Applications

- Mid/High end airbag systems
- Cut-off battery systems
- Pyro Fuse/Pyroswitch management

This is information on a product in full production.

Contents

1	Desc	ription		13
2	Abso	lute ma	ximum ratings	14
3	Opera	ative m	aximum ratings	18
4	Pin o	ut		22
5	Over	view an	d block diagram	23
	5.1	Power	supply	24
	5.2	Deploy	ment drivers	24
	5.3	Remote	e sensor interfaces (4)	25
	5.4	DC sen	sor interfaces (9)	25
	5.5	Genera	Il purpose outputs (3)	25
	5.6	Arming	logic	25
	5.7	Other for	eatures	26
6	Start	-up and	power control	27
	6.1	Power	supply overview	27
	6.2	Power	mode control	29
		6.2.1	POWER OFF mode	30
		6.2.2	SLEEP mode	30
		6.2.3	ACTIVE mode	30
		6.2.4	PASSIVE mode	30
		6.2.5	Power-up and power-down sequences	33
		6.2.6	IC operating states	38
	6.3	ERBOO	DST switching regulator	39
	6.4	Energy	reserve capacitor charging and discharging circuits	41
	6.5	ER CA	P diagnostic	42
		6.5.1	ER CAP measurement	42
		6.5.2	ER CAP ESR measurement	44
	6.6	ER swi	tch and COVRACT pin	45
	6.7	SYNCE	300ST boost regulator	46



6.8	SATBU	JCK regulator
6.9	VCC bi	uck regulator
6.10	VCOR	EMON external core voltage monitor
6.11	VSF re	equiator and control
6.12	Oscillat	tors
6.13	Reset	control 51
0.10	Reserv	
SPI i	nterface	əs
7.1	SPI pro	btocol
7.2	Global	SPI register map
7.3	Global	SPI tables
	Global S	SPI read/write register
	7.3.1	Fault status register (FLTSR)
	7.3.2	System configuration register (SYS_CFG)73
	7.3.3	System control register (SYS_CTL)76
	7.3.4	SPI Sleep command register (SPI_SLEEP)
	7.3.5	System status register (SYS_STATE)78
	7.3.6	Power state register (POWER_STATE)
	7.3.7	Deployment configuration registers (DCR_x)83
	7.3.8	Deployment command (DEPCOM)85
	7.3.9	Deployment status registers (DSR_x)86
	7.3.10	Deployment current monitor registers (DCMTSxy)
	7.3.11	Deploy enable register (SPIDEPEN)
	7.3.12	Deployment ground loss register (LP_GNDLOSS)
	7.3.13	Device version register (VERSION_ID)
	7.3.14	Watchdog retry configuration register (WD_RETRY_CONF)91
	7.3.15	Microcontroller fault test register (MCU_FLT_TEST)
	7.3.16	Watchdog timer configuration register (WDTCR)92
	7.3.17	WD1 timer control register (WD1T)93
	7.3.18	WD state register (WDSTATE)94
	7.3.19	Clock configuration register (CLK_CONF)95
	7.3.20	Scrap seed read command register (SCRAP_SEED)96
	7.3.21	Scrap key write command register (SCRAP_KEY)97
	7.3.22	Scrap state entry command register (SCRAP_STATE)
	7.3.23	Safing state entry command register (SAFING_STATE)
	7.3.24	WD2 recover write command register (WD2_RECOVER)



7

7.3.25	WD2 seed read command register (WD2_SEED)
7.3.26	WD2 key write command register (WD2_KEY)
7.3.27	WD test command register (WD_TEST)100
7.3.28	System diagnostic register (SYSDIAGREQ)101
7.3.29	Diagnostic result register for deployment loops (LPDIAGSTAT) 102
7.3.30	Loops diagnostic configuration command register for low level diagnostic (LPDIAGREQ)
7.3.31	Loops diagnostic configuration command register for high level diagnostic (LPDIAGREQ)
7.3.32	DC sensor diagnostic configuration command register (SWCTRL) 109
7.3.33	ADC request and data registers (DIAGCTRL_x)
7.3.34	Configuration register for switching regulators (SW_REGS_CONF) 114
7.3.35	Global configuration register for GPO driver function (GPOCR) 116
7.3.36	GPOx control register (GPOCTRLx) 117
7.3.37	GPO fault status register (GPOFLTSR)
7.3.38	Wheel speed sensor test request register (WSS_TEST)121
7.3.39	PSI5/WSS configuration register for channel x (RSCRx)122
7.3.40	Remote sensor control register (RSCTRL)
7.3.41	WSS Threshold configuration register 1 (RS_AUX_CONF1)127
7.3.42	WSS Threshold configuration register 2 (RS_AUX_CONF2)127
7.3.43	Safing algorithm configuration register (SAF_ALGO_CONF) 128
7.3.44	Arming signals register (ARM_STATE)129
7.3.45	ARMx assignment registers to specific Loops
	(LOOP_MATRIX_ARMx)
7.3.46	ARMx enable pulse stretch timer status (AEPSTS_ARMx)131
7.3.47	Passenger inhibit upper threshold for DC sensor 0
	(PADTHRESH_HI)
7.3.48	Passenger inhibit lower threshold for DC sensor 0
	(PADTHRESH_LO)
7.3.49	Assignment of PSINH signal to specific Loop(s)
	(LOOP_MATRIX_PSINH)
7.3.50	Safing records enable register (SAF_ENABLE)
7.3.51	Safing records request mask registers (SAF_REQ_MASK_x)134
7.3.52	Safing records request target registers (SAF_REQ_TARGET_x) 136
7.3.53	Safing records response mask registers (SAF_RESP_MASK_x) 138
7.3.54	Safing records response mask registers (SAF_RESP_TARGET_x) 140
7.3.55	Safing records data mask registers (SAF_DATA_MASK_x)
7.3.56	Safing record threshold registers (SAF_THRESHOLD_x)144

DS11615 Rev 3



		7.3.57	Safing control x registers (SAF_CONTROL_x)	146
		7.3.58	Safing record compare complete register (SAF_CC)	149
	7.4	Remote	sensor SPI register map	150
	7.5	Remote	sensor SPI tables	151
		7.5.1	Remote sensor SPI global status word	151
	7.6	Remote	sensor SPI read/write registers	152
		7.6.1	Remote sensor data/fault registers (RSDRx @FLT = 0)	152
		7.6.2	Remote sensor data/fault registers w/o fault (RSDRx @ FLT=1)	155
		7.6.3	Remote sensor x current registers y (RSTHRx_y)	159
		7.6.4	Arming signals register (ARM_STATE)	160
		7.6.5	Safing record compare complete register (SAF_CC)	161
8	Deplo	yment o	drivers	162
	8.1	Control	logic	162
		8.1.1	Deployment current selection	164
		8.1.2	Deploy command expiration timer	164
		8.1.3	Deployment control flow	165
		8.1.4	Deployment current monitoring	166
		8.1.5	Deployment success	166
	8.2	Energy	reserve - deployment voltage	166
	8.3	Deployn	nent ground return	166
	8.4	Deployn	nent driver protections	167
		8.4.1	Delayed low-side deactivation	167
		8.4.2	Low-side voltage clamp	167
		8.4.3	Short to battery	167
		8.4.4	Short to ground	167
		8.4.5	Intermittent open squib/pyroswitch	167
	8.5	Diagnos	tics	168
		8.5.1	Low level diagnostic approach	169
		8.5.2	High level diagnostic approach	176
9	Remo	te sens	or interface	178
	9.1	PSI5 mo	ode	179
		9.1.1	Functional description	179
		9.1.2	Sensor data integrity: LCID and CRC	182
		9.1.3	Detailed description	182



	0.0	Asthered as a descent descent
	9.2	Active wheel speed sensor
		9.2.1 Wheel speed data register formats
		9.2.2 Test mode
	9.3	Remote sensor interface fault protection
		9.3.1 Short to ground, current limit
		9.3.2 Short to battery
		9.3.3 Cross link
		9.3.4 Leakage to battery, sensor open
		9.3.5 Leakage to ground
		9.3.6 Thermal shutdown
10	Watc	hdog timers
	10.1	Temporal watchdog (WD1)
		10.1.1 Watchdog timer configuration
		10.1.2 Watchdog timer operation
	10.2	Algorithmic watchdog (WD2) 192
	10.3	Watchdog reset assertion timer 194
	10.4	Watchdog timer disable input (WDT/TM) 194
11	DC s	ensor interface
	11.1	Passenger inhibit interface
12	Safin	ıg logic
	12.1	Safing logic overview
	12.2	SPI sensor data decoding
	12.3	In-frame and out-of-frame responses
	12.4	Safing state machine operation
		12.4.1 Simple threshold comparison operation
	12.5	Safing engine output logic (ARMxINT)
	-	12.5.1 Arming pulse stretch
	12.6	Additional communication line
	•	
13	Gene	eral purpose output (GPO) drivers
14	Syste	em voltage diagnostics 219
	14.1	Analog to digital algorithmic converter



15	Temp	erature sensor
16	Applie	cations
	16.1	Application circuit
	16.2	BOM (Bill Of Materials) 228
17	Electr	rical characteristics
	17.1	Configuration and control 230
	17.2	Internal analog reference 235
	17.3	Internal regulators
	17.4	Watchdog 237
	17.5	Oscillators
	17.6	Reset
	17.7	SPI interface
	17.8	ERBoost regulator
	17.9	ER CAP current generators and diagnostic 245
	17.10	ER switch
	17.11	COVRACT
	17.12	SYNCBOOST converter
	17.13	SATBUCK converter
	17.14	VCC regulator
	17.15	VSF regulator
	17.16	Deployment drivers
	17.17	Deployment driver diagnostic 259
		17.17.1 Squib/pyroswitch resistance measurement
		17.17.2 Squib/pyroswitch leakage test (VRCM)
		17.17.3 High/low side FET test
		17.17.4 Deployment timer test
	17.18	Remote sensor interface
		17.18.1 PSI-5 interface
	47.40	17.18.2 WSS interface
	17.19	DC sensor interface
	17.20	Sating engine
	17.21	General purpose output drivers 273



	17.22 Analog to digital converter 276
	17.23 Voltage diagnostics (Analog MUX) 278
	17.24 Temperature sensor
18	Quality information
	18.1 OTP memory
19	Errata sheet
20	Package information
	20.1 TQFP100 (14x14x1.4 mm exp. pad down) package information 281
21	Order codes
22	Revision history



List of tables

Table 1.	Absolute maximum ratings	14
Table 2.	Operative maximum ratings	18
Table 3.	Functions disabling by state	31
Table 4.	SPI MOSI and MISO frames layout	54
Table 5.	Global SPI register map	56
Table 6.	Global SPI Global Status Word	68
Table 7.	Remote sensor SPI register map	. 150
Table 8.	GSW - Remote sensor SPI global status word	. 151
Table 9.	Short between loops diagnostics decoding	. 171
Table 10.	HS FET TEST	. 173
Table 11.	LS FET TEST	. 173
Table 12.	Watchdog timer status description	. 190
Table 13.	WD2 states and signals	. 193
Table 14.	Example of combine function operation	. 207
Table 15.	Short to ground fault in LS mode	. 217
Table 16.	Short to battery fault in HS mode	. 218
Table 17.	Diagnostics control register (DIAGCTRLx)	. 221
Table 18.	Diagnostics divider ratios	. 223
Table 19.	Bill Of Materials	. 228
Table 20.	Configuration and control DC specifications.	. 230
Table 21.	Configuration and control AC specifications	. 233
Table 22.	Open ground detection DC specifications	. 235
Table 23.	GND OPEN AC - Open ground detection DC specifications	. 235
Table 24.	Internal analog reference	. 235
Table 25.	Internal regulator DC specifications	. 236
Table 26.	Internal regulators AC specifications	. 236
Table 27.	Temporal watchdog timer AC specifications (WD1)	. 237
Table 28.	Algorithmic watchdog timer DC specifications (WD2).	. 237
Table 29.	Algorithmic watchdog timer AC specifications (WD2).	. 237
Table 30.	Oscillators specifications	. 238
Table 31.	Reset DC specifications	. 239
Table 32.	Reset AC specifications	. 239
Table 33.	Global and remote sensor SPI DC specifications	. 240
Table 34.	SPI AC specifications	. 241
Table 35.	ERBoost regulator DC specifications	. 242
Table 36.	ERBoost regulator AC specifications	. 243
Table 37.	ERBOOST Converter external components design info.	. 244
Table 38.	ER CAP current generators and diagnostic DC specifications	. 245
Table 39.	ER CAP current generators and diagnostic AC specifications	. 246
Table 40.	ER Switch DC specifications	. 246
Table 41.	ER Switch AC specifications.	. 246
Table 42.	COVRACT DC specifications	. 247
Table 43.	COVRACT AC specifications	. 247
Table 44.	SYNCBOOST converter DC specifications.	. 247
Table 45.	SYNCBOOST converter AC specifications.	. 249
Table 46.	SYNCBOOST converter external components design info.	. 249
Table 47.	SATBUCK converter DC specifications	. 250
Table 48.	SATBUCK converter AC specifications	. 251



Table 49.	SATBUCK converter external components design info	. 251
Table 50.	VCC converter DC specifications	. 251
Table 51.	VCC converter AC specifications	253
Table 52.	VCC converter external components design info	. 253
Table 53.	VSF regulator DC specifications	253
Table 54.	VSF regulator AC specifications	254
Table 55.	Deployment drivers – DC specifications	. 254
Table 56.	Deployment drivers – AC specifications	. 258
Table 57.	Deployment drivers diagnostics - Squib/pyroswitch resistance measurement	259
Table 58.	Squib/pyroswitch Leakage Test (VRCM)	. 261
Table 59.	High/low side FET test	262
Table 60.	Deployment timer test - AC specifications	. 263
Table 61.	PSI-5 satellite transceiver - DC specifications	. 263
Table 62.	PSI-5 satellite transceiver - AC specifications	. 265
Table 63.	WSS sensor - DC specifications	. 268
Table 64.	WSS sensor - AC specifications	. 269
Table 65.	DC Sensor interface specifications	. 270
Table 66.	Arming Interface – DC specifications	. 271
Table 67.	Arming interface – AC specifications	. 272
Table 68.	GPO interface DC specifications	. 273
Table 69.	GPO driver interface – AC specifications	. 275
Table 70.	Analog to digital converter	. 276
Table 71.	Voltage diagnostics (Analog MUX)	. 278
Table 72.	Temperature sensor specifications	. 278
Table 73.	Errata sheet	. 280
Table 74.	TQFP100 (14x14x1.4 mm exp. pad down) package mechanical data	. 282
Table 75.	Device summary	. 283
Table 76.	Document revision history	. 284



List of figures

Figure 1.	Pin connection diagram (top view)	. 22
Figure 2.	Device function block diagram	. 23
Figure 3.	Power supply block diagram	. 28
Figure 4.	Power control state flow diagram	. 29
Figure 5.	Wake-up input signal behaviour	. 31
Figure 6.	Normal power-up sequence with VCOREMON function disabled	. 33
Figure 7.	Normal power-up sequence with VCOREMON function enabled	. 34
Figure 8.	Normal power down sequence through POWERMODE SHUTDOWN state - no ER cap	
.9	active discharge	35
Figure 9	Normal power down sequence through Powermode Shutdown state - FR cap	
r igure e.	active discharge	36
Figure 10	Normal power down sequence through FR state	. 00
Figure 11	IC operating state diagram	30
Figure 12	ERBOOST regulator block diagram	. 00
Figure 12.	ERBOOST regulator state diagram	. 40
Figure 14	ER charge state diagram	. 4 1
Figure 14.	ER discharge state diagram	. 41
Figure 15.	ER UIScharge state utagram	. 42
Figure 10.	ER CAP measurement timing diagram	. 42
		. 43
Figure 18.		. 44
Figure 19.		. 45
Figure 20.		. 46
Figure 21.		. 47
Figure 22.		. 47
Figure 23.		. 48
Figure 24.		. 49
Figure 25.	VSF control logic.	. 51
Figure 26.	Internal voltage monitors	. 52
Figure 27.	Reset control logic	. 53
Figure 28.	Deployment driver control blocks	162
Figure 29.	Deployment driver control logic - Enable signal	163
Figure 30.	Deployment driver control logic - Turn-on signals.	163
Figure 31.	Deployment driver block	164
Figure 32.	Global SPI deployment enable state diagram	165
Figure 33.	Current monitor counter behavior	166
Figure 34.	Deployment loop diagnostics	169
Figure 35.	SRx pull-down enable logic	170
Figure 36.	Deployment timer diagnostic sequence	175
Figure 37.	High level loop diagnostic flow1	176
Figure 38.	High level loop diagnostic flow2	177
Figure 39.	Remote sensor interface logic blocks	178
Figure 40.	PSI-5 remote sensor protocol (10-bit, 1-bit parity	179
Figure 41.	Manchester bit encoding.	180
Figure 42.	Remote sensor synchronization pulses	181
Figure 43.	PSI5 slot timing control	181
Figure 44.	Manchester decoder state diagram	183
Figure 45.	Wheel speed sensor protocols	186
Figure 46.	WD1 Temporal watchdog state diagram	189
-		



Figure 47.	Watchdog timer refresh diagram	191
Figure 48.	Algorithmic watchdog timer flow diagram	192
Figure 49.	DC sensor interface block diagram.	195
Figure 50.	Passenger inhibit logic diagram	197
Figure 51.	Top level safing engine flow chart	199
Figure 52.	Safing engine – 32-bit message decoding flow chart	200
Figure 53.	Safing engine – 16-bit Message decoding flow chart	201
Figure 54.	Safing engine - Validate data flow chart	202
Figure 55.	Safing engine - Combine function flow chart	203
Figure 56.	Safing engine threshold comparison	204
Figure 57.	Safing engine - Compare complete	205
Figure 58.	In-frame example	208
Figure 59.	Out-of-frame example	208
Figure 60.	Safing engine arming flow diagram	210
Figure 61.	Safing engine diagnostic logic	211
Figure 62.	ARMx input/output control logic	212
Figure 63.	Pulse stretch timer example	213
Figure 64.	Scrap SEED-KEY state diagram	214
Figure 65.	Scrap ACL state diagram	214
Figure 66.	Disposal PWM signal	215
Figure 67.	GPO driver and diagnostic block diagram	216
Figure 68.	GPO Over temperature logic	217
Figure 69.	ADC MUX	219
Figure 70.	ADC conversion time	225
Figure 71.	Application circuit	227
Figure 72.	SPI timing diagram	241
Figure 73.	Deployment drivers diagram	258
Figure 74.	TQFP100 (14x14x1.4 mm exp. pad down) package outline	281



1 Description

The L9680 is a chip that can be used in advanced airbag systems for mature airbag markets or in cut-off battery systems for integrated safety markets. This device is family compatible with the L9678 and L9679 devices. Safety system integration is enabled through higher power supply currents and integrated active wheel speed sensor interface. The active wheel speed interface is shared with the PSI-5 satellite interface to create a generic remote safety sensor interface compliant to both systems.

High frequency power supply design allows further cost reduction by using smaller and less expensive external components. All switching regulators operate at 1.882 MHz while buck converters have integrated synchronous rectifiers.

Additional attention is given to system integrity and diagnostics. The reserve capacitor is electrically isolated from the boost regulator by a 65 mA nominal fixed current source, controlling in-rush an additional capacitor discharge fixed current source is integrated to diagnose the reserve capacitor value and ESR. The same current sources can be used to discharge the capacitor at shutdown.

Thanks to low quiescent current, the device can be directly connected to battery. In this way, the device start-up and shutdown are controlled through the wake-up input function. The power supply and crossover function are controlled automatically through the internal state machine.

The user can select both ECU logic voltage (V_{CC} at 3.3 V or 5.0 V) and energy reserve output voltage (at either 23 V or 33 V). Deployment voltage is set to a maximum of 25 V for all profiles and can be controlled through external safing switch circuit using the high side safing switch reference enabled through the system SPI interface or the arming logic.



2 Absolute maximum ratings

This part may be irreparably damaged if taken outside the specified absolute maximum ratings. Operation above the absolute maximum ratings may also cause a decrease in reliability.

The operating junction temperature range is -40 °C to +150 °C. The maximum junction temperature must not be exceeded except when in deployment and within the deploy power stages. Deployment is possible starting with a junction temperature of 150 °C. A power dissipation calculation has to be performed for the final application limiting the available functionality to a subset of it in order to respect to the power dissipation capability.

Pin#	Pin name	Pin function	Min	Мах	Unit
1	CS_RS	Remote SPI interface chip select	-0.3	$\text{VCC+0.3} \leq 6.5$	V
2	SCLK_RS	Remote SPI interface clock	-0.3	$\text{VCC+0.3} \leq 6.5$	V
3	MOSI_RS	Remote SPI interface data in	-0.3	$\text{VCC+0.3} \leq 6.5$	V
4	MISO_RS	Remote SPI interface data out	-0.3	$\text{VCC+0.3} \leq 6.5$	V
5	RESET	Reset output	-0.3	$\text{VCC+0.3} \leq 6.5$	V
6	MISO_G	Global SPI interface data out	-0.3	$\text{VCC+0.3} \leq 6.5$	V
7	MOSI_G	Global SPI interface data in	-0.3	$\text{VCC+0.3} \leq 6.5$	V
8	SCLK_G	Global SPI interface clock	-0.3	$\text{VCC+0.3} \leq 6.5$	V
9	CS_G	Global SPI interface chip select	-0.3	$\text{VCC+0.3} \leq 6.5$	V
10	WDT/TM	Watchdog disable	-0.3	20	V
11	SR4	Squib/pyroswitch 4 low-side pin	-0.3	35	V
12	SF4	Squib/pyroswitch 4 high-side pin	-1.0	40	V
13	SS45	Squib/pyroswitch 4 & 5 deployment supply pin	-0.3	40	V
14	SF5	Squib/pyroswitch 5 high-side pin	-1.0	40	V
15	SR5	Squib/pyroswitch 5 low-side pin	-0.3	35	V
16	SR0	Squib/pyroswitch 0 low-side pin	-0.3	35	V
17	SF0	Squib/pyroswitch 0 high-side pin	-1.0	40	V
18	SS01	Squib/pyroswitch 0 & 1 deployment supply pin	-0.3	40	V
19	SF1	Squib/pyroswitch 1 high-side pin	-1.0	40	V
20	SR1	Squib/pyroswitch 1 low-side pin	-0.3	35	V
21	SR8	Squib/pyroswitch 8 low-side pin	-0.3	35	V
22	SF8	Squib/pyroswitch 8 high-side pin	-1.0	40	V
23	SS89	Squib/pyroswitch 8 & 9 deployment supply pin	-0.3	40	V
24	SF9	Squib/pyroswitch 9 high-side pin	-1.0	40	V
25	SR9	Squib/pyroswitch 9 low-side pin	-0.3	35	V
26	DCS8	DC Sensor interface channel 8	-2	40	V

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Pin#	Pin name	Pin function	Min	Max	Unit
27	DCS7	DC Sensor interface channel 7	-2	40	V
28	DCS6	DC Sensor interface channel 6	-2	40	V
29	DCS5	DC Sensor interface channel 5	-2	40	V
30	DCS4	DC Sensor interface channel 4	-2	40	V
31	DCS3	DC Sensor interface channel 3	-2	40	V
32	DCS2	DC Sensor interface channel 2	-2	40	V
33	DCS1	DC Sensor interface channel 1	-2	40	V
34	DCS0	DC Sensor interface channel 0	-2	40	V
35	RSU0	PSI-5/WSS ch. 0 remote sensor output	-1	40	V
36	RSU1	PSI-5/WSS ch. 1 remote sensor output	-1	40	V
37	RSU2	PSI-5/WSS ch. 2 remote sensor output	-1	40	V
38	RSU3	PSI-5/WSS ch. 3 remote sensor output	-1	40	V
39	GPOD0	GPO driver 0 drain output pin	-1	40	V
40	GPOS0	GPO driver 0 source output pin	-1	40	V
41	GPOS1	GPO driver 1 source output pin	-1	40	V
42	GPOD1	GPO driver 1 drain output pin	-1	40	V
43	GPOD2	GPO driver 2 drain output pin	-1	40	V
44	GPOS2	GPO driver 2 source output pin	-1	40	V
45	COVRACT	External Crossover Switch Driver	-0.3	40	V
46	VCOREMON	External Regulator Monitor	-0.3	$\text{VCC+0.3} \leq 6.5$	V
47	MCUFAULTB	Active Low MCU Fault Monitoring Input	-0.3	$\text{VCC+0.3} \leq 6.5$	V
48	SATSYNC	Initiate Satellite Sensor Sync Pulse	-0.3	$\text{VCC+0.3} \leq 6.5$	V
49	PSINHB	Active Low Passenger Airbag Inhibit Control	-0.3	$\text{VCC+0.3} \leq 6.5$	V
50	GNDSUB1	Substrate ground / Squib/pyroswitch ground	-0.3	0.3	V
51	SRB	Squib/pyroswitch B low-side pin	-0.3	35	V
52	SFB	Squib/pyroswitch B high-side pin	-1.0	40	V
53	SSAB	Squib/pyroswitch A & B deployment supply pin	-0.3	40	V
54	SFA	Squib/pyroswitch A high-side pin	-1.0	40	V
55	SRA	Squib/pyroswitch A low-side pin	-0.3	35	V
56	SR3	Squib/pyroswitch 3 low-side pin	-0.3	35	V
57	SF3	Squib/pyroswitch 3 high-side pin	-1.0	40	V
58	SS23	Squib/pyroswitch 2 & 3 deployment supply pin	-0.3	40	V
59	SF2	Squib/pyroswitch 2 high-side pin	-1.0	40	V
60	SR2	Squib/pyroswitch 2 low-side pin	-0.3	35	V
61	SR7	Squib/pyroswitch 7 low-side pin	-0.3	35	V

Table 1	Absolute	maximum	ratings	(continued)	١
	Absolute	maximum	raunys	Commueu	,



Pin#	Pin name	Pin function	Min	Мах	Unit
62	SF7	Squib/pyroswitch 7 high-side pin	-1.0	40	V
63	SS67	Squib/pyroswitch 6 & 7 deployment supply pin	-0.3	40	V
64	SF6	Squib/pyroswitch 6 high-side pin	-1.0	40	V
65	SR6	Squib/pyroswitch 6 low-side pin	-0.3	35	V
66	GNDA	Analog ground	-0.3	0.3	V
67	SAF_CS0	SPI interface safing sensor chip select 0	-0.3	$\text{VCC+0.3} \leq 6.5$	V
68	SAF_CS1	SPI interface safing sensor chip select 1	-0.3	$\text{VCC+0.3} \leq 6.5$	V
69	SAF_CS2	SPI interface safing sensor chip select 2	-0.3	$\text{VCC+0.3} \leq 6.5$	V
70	SAF_CS3	SPI interface safing sensor chip select 3	-0.3	$\text{VCC+0.3} \leq 6.5$	V
71	WD2_LockOut	WD2 fault output	-0.3	$\text{VCC+0.3} \leq 6.5$	V
72	WS3	Wheel speed output Ch3	-0.3	$\text{VCC+0.3} \leq 6.5$	V
73	WS2	Wheel speed output Ch2	-0.3	$\text{VCC+0.3} \leq 6.5$	V
74	WS1	Wheel speed output Ch1	-0.3	$\text{VCC+0.3} \leq 6.5$	V
75	WS0	Wheel speed output Ch0	-0.3	$\text{VCC+0.3} \leq 6.5$	V
76	VCCSEL	VCC select / VCOREMON disable input	-0.3	40	V
77	ACL	EOL disposal control input	-0.3	40	V
78	WAKEUP	Wake-up control input	-0.3	40	V
79	VBATMON	Battery line voltage monitor	-18 ⁽¹⁾	40	V
80	VSF	Safing regulator supply output	-0.3	40	V
81	VIN	Battery connection	-0.3	40	V
82	VER	Reserve voltage	-0.3	40	V
83	ERBOOST	Energy reserve regulator output	-0.3	40	V
84	ERBSTSW	ER Boost switching output	-0.3	40	V
85	BSTGND	Boost regulators ground	-0.3	0.3	V
86	SYNCBSTSW	SYNC Boost switching output	-0.3	40	V
87	SYNCBOOST	SYNC boost output voltage	-0.3	40	V
88	SATBCKSW	SAT Buck switching output	-0.3	40	V
89	SATGND	SAT Buck regulator ground	-0.3	0.3	V
90	SATBUCK	SAT Buck output voltage	-0.3	40	-
91	VCCBCKSW	VCC Buck switch output	-0.3	40	V
92	VCCGND	VCC Buck Ground	-0.3	0.3	V
93	CVDD	Internal 3.3V regulator output	-0.3	4.6	V
94	GNDD	Digital ground	-0.3	0.3	-
95	VCC	VCC Buck voltage	-0.3	6.5	V
96	ARM1	Arming output 1	-0.3	$\text{VCC+0.3} \leq 6.5$	V

Table 1.	Absolute	maximum	ratings	(continued)
	Absolute	maximum	ratings	(continued)



Pin#	Pin name	Pin function	Min	Мах	Unit
97	ARM2	Arming output 2	-0.3	$\text{VCC+0.3} \leq 6.5$	V
98	ARM3	Arming output 3	-0.3	$\text{VCC+0.3} \leq 6.5$	V
99	ARM4	Arming output 4	-0.3	$\text{VCC+0.3} \leq 6.5$	V
100	GNDSUB2	Substrate ground / Squib/pyroswitch ground	-0.3	0.3	V
-	Exposed pad down	Substrate ground / Squib/pyroswitch ground	-0.3	0.3	V

Table 1. Absolute maximum ratings (continued)

1. VBATMON negative AMR is -18 V or -20 mA.



3 Operative maximum ratings

Within the operating ratings the part operates as specified and without parameter deviations. Once taken beyond the operative ratings and returned back within, the part will recover with no damage or degradation.

Additional supply voltage and temperature conditions are given separately at the beginning of each specification table.

Pin #	Pin name	Pin function	Min	Мах	Unit
1	CS_RS	Remote SPI interface chip select	-0.1	$VCC\text{+}0.1 \leq 5.5$	V
2	SCLK_RS	Remote SPI interface clock	-0.1	$\text{VCC+0.1} \leq 5.5$	V
3	MOSI_RS	Remote SPI interface data in	-0.1	VCC+0.1 ≤ 5.5	V
4	MISO_RS	Remote SPI interface data out	-0.1	VCC+0.1 \leq 5.5	V
5	RESET	Reset output	-0.1	VCC+0.1 \leq 5.5	V
6	MISO_G	Global SPI interface data out	-0.1	VCC+0.1 \leq 5.5	V
7	MOSI_G	Global SPI interface data in	-0.1	VCC+0.1 \leq 5.5	V
8	SCLK_G	Global SPI interface clock	-0.1	VCC+0.1 ≤ 5.5	V
9	CS_G	Global SPI interface chip select	-0.1	VCC+0.1 \leq 5.5	V
10	WDT/TM	Watchdog disable	-0.1	15	V
11	SR4	Squib/pyroswitch 4 low-side pin	-0.1	SS45	V
12	SF4	Squib/pyroswitch 4 high-side pin	-1.0	SS45	V
13	SS45	Squib/pyroswitch 4 & 5 deployment supply pin	-0.1	VER	V
14	SF5	Squib/pyroswitch 5 high-side pin	-1.0	SS45	V
15	SR5	Squib/pyroswitch 5 low-side pin	-0.1	SS45	V
16	SR0	Squib/pyroswitch 0 low-side pin	-0.1	SS01	V
17	SF0	Squib/pyroswitch 0 high-side pin	-1.0	SS01	V
18	SS01	Squib/pyroswitch 0 & 1 deployment supply pin	-0.1	VER	V
19	SF1	Squib/pyroswitch 1 high-side pin	-1.0	SS01	V
20	SR1	Squib/pyroswitch 1 low-side pin	-0.1	SS01	V
21	SR8	Squib/pyroswitch 8 low-side pin	-0.1	SS89	V
22	SF8	Squib/pyroswitch 8 high-side pin	-1.0	SS89	V
23	SS89	Squib/pyroswitch 8 & 9 deployment supply pin	-0.1	VER	V
24	SF9	Squib/pyroswitch 9 high-side pin	-1.0	SS89	V
25	SR9	Squib/pyroswitch 9 low-side pin	-0.1	SS89	V

Table 2.	Operative	maximum	ratings
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Pin #	Pin name	Pin function	Min	Мах	Unit
26	DCS8	DC sensor interface channel 8	-1	18	V
27	DCS7	DC sensor interface channel 7	-1	18	V
28	DCS6	DC sensor interface channel 6	-1	18	V
29	DCS5	DC sensor interface channel 5	-1	18	V
30	DCS4	DC sensor interface channel 4	-1	18	V
31	DCS3	DC sensor interface channel 3	-1	18	V
32	DCS2	DC sensor interface channel 2	-1	18	V
33	DCS1	DC sensor interface channel 1	-1	18	V
34	DCS0	DC Sensor interface channel 0	-1	18	V
35	RSU0	PSI-5/WSS ch. 0 remote sensor output	-1	V _{RSU_SYNC_MAX}	V
36	RSU1	PSI-5/WSS ch. 1 remote sensor output	-1	V _{RSU_SYNC_MAX}	V
37	RSU2	PSI-5/WSS ch. 2 remote sensor output	-1	V _{RSU_SYNC_MAX}	V
38	RSU3	PSI-5/WSS ch. 3 remote sensor output	-1	V _{RSU_SYNC_MAX}	V
39	GPOD0	GPO driver 0 drain output pin	-0.1	40	V
40	GPOS0	GPO driver 0 source output pin	-1	40	V
41	GPOS1	GPO driver 1 source output pin	-1	40	V
42	GPOD1	GPO driver 1 drain output pin	-0.1	40	V
43	GPOD2	GPO driver 2 drain output pin	-0.1	40	V
44	GPOS2	GPO driver 2 source output pin	-1	40	V
45	COVRACT	External crossover switch driver	-0.1	40	V
46	VCOREMON	External regulator monitor	-0.1	VCC+0.1 ≤ 5.5	V
47	MCUFAULTB	Active low MCU fault monitoring input	-0.1	VCC+0.1 ≤ 5.5	V
48	SATSYNC	Initiate satellite sensor sync pulse	-0.1	VCC+0.1 ≤ 5.5	V
49	PSINHB	Active low passenger airbag inhibit control	-0.1	VCC+0.1 ≤ 5.5	V
50	GNDSUB1	Substrate ground / Squib/pyroswitch ground	-0.1	0.1	V
51	SRB	Squib/pyroswitch B low-side pin	-0.1	SSAB	V
52	SFB	Squib/pyroswitch B high-side pin	-1.0	SSAB	V
53	SSAB	Squib/pyroswitch A & B deployment supply pin	-0.1	VER	V
54	SFA	Squib/pyroswitch A high-side pin	-1.0	SSAB	V
55	SRA	Squib/pyroswitch A low-side pin	-0.1	SSAB	V
56	SR3	Squib/pyroswitch 3 low-side pin	-0.1	SS23	V
57	SF3	Squib/pyroswitch 3 high-side pin	-1.0	SS23	V
58	SS23	Squib/pyroswitch 2 & 3 deployment supply pin	-0.1	VER	V

Table 2.	Operative	maximum	ratings	(continued)
	operative	maximum	radings	(continued)



Pin #	Pin name	Pin function	Min	Мах	Unit
59	SF2	Squib/pyroswitch 2 high-side pin	-1.0	SS23	V
60	SR2	Squib/pyroswitch 2 low-side pin	-0.1	SS23	V
61	SR7	Squib/pyroswitch 7 low-side pin	-0.1	SS67	V
62	SF7	Squib/pyroswitch 7 high-side pin	-1.0	SS67	V
63	SS67	Squib/pyroswitch 6 & 7 deployment supply pin	-0.1	VER	V
64	SF6	Squib/pyroswitch 6 high-side pin	-1.0	SS67	V
65	SR6	Squib/pyroswitch 6 low-side pin	-0.1	SS67	V
66	GNDA	Analog ground	-0.1	0.1	V
67	SAF_CS0	SPI interface safing sensor chip select 0	-0.1	VCC+0.1 <= 5.5	V
68	SAF_CS1	SPI interface safing sensor chip select 1	-0.1	VCC+0.1 <= 5.5	V
69	SAF_CS2	SPI interface safing sensor chip select 2	-0.1	VCC+0.1 <= 5.5	V
70	SAF_CS3	SPI interface safing sensor chip select 3	-0.1	VCC+0.1 <= 5.5	V
71	WD2_LockOut	WD2 Fault Output	-0.1	VCC+0.1 <= 5.5	V
72	WS3	Wheel Speed Output Ch3	-0.1	VCC+0.1 <= 5.5	V
73	WS2	Wheel Speed Output Ch2	-0.1	VCC+0.1 <= 5.5	V
74	WS1	Wheel Speed Output Ch1	-0.1	VCC+0.1 <= 5.5	V
75	WS0	Wheel Speed Output Ch0	-0.1	VCC+0.1 <= 5.5	V
76	VCCSEL	VCC select / VCOREMON disable input	-0.1	35	V
77	ACL	EOL disposal control input	-0.1	35	V
78	WAKEUP	Wake-up control input	-0.1	VIN	V
79	VBATMON	Battery line voltage monitor	-1	18	V
80	VSF	Safing regulator supply output	-0.1	27	V
81	VIN	Battery connection	-0.1	35	V
82	VER	Reserve voltage	-0.1	35	V
83	ERBOOST	Energy reserve regulator output	-0.1	35	V
84	ERBSTSW	ER Boost switching output	-0.1	35	V
85	BSTGND	Boost regulators ground	-0.1	0.1	V
86	SYNCBSTSW	SYNC Boost switching output	-0.1	35	V
87	SYNCBOOST	SYNC boost output voltage	-0.1	35	V
88	SATBCKSW	SAT Buck switching output	-0.1	35	V
89	SATGND	SAT Buck regulator ground	-0.1	0.1	V
90	SATBUCK	SAT Buck output voltage	-0.1	10	-
91	VCCBCKSW	VCC Buck switch Output	-0.1	10	V

Table 2.	Operative maximum	ratings	(continued)



Pin #	Pin name	Pin function	Min	Max	Unit					
92	VCCGND	VCC Buck Ground	-0.1	0.1	V					
93	CVDD	Internal 3.3V regulator output	-0.1	3.6	V					
94	GNDD	Digital ground	-0.1	0.1	-					
95	VCC	VCC Buck Voltage	-0.1	5.5	V					
96	ARM1	Arming Output 1	-0.1	VCC+0.1 <= 5.5	V					
97	ARM2	Arming Output 2	-0.1	VCC+0.1 <= 5.5	V					
98	ARM3	Arming Output 3	-0.1	VCC+0.1 <= 5.5	V					
99	ARM4	Arming Output 4	-0.1	VCC+0.1 <= 5.5	V					
100	GNDSUB2	Substrate ground / Squib/pyroswitch ground	-0.1	0.1	V					
-	Exposed Pad Down	Substrate ground / Squib/pyroswitch ground	-0.1	0.1	V					

Table 2. Operative maximum ratings (continued)



4 Pin out

The L9680 pin out is shown below. The IC is housed in a 100 pin package (14 x 14 x 1.0mm) with a 7.6 x 7.6 mm exposed pad down.





22/286



The exposed pad is electrically shorted to the substrate pins GNDSUB1 and GNDSUB2. These three connection nodes are to be kept shorted on the application.

5 Overview and block diagram

The L9680 IC is an application specific standard component air bag system chip. Its main functions include, power management, deployment drivers, remote sensor interfaces (PSI-5 satellite sensors or active wheel speed sensors), diagnostics, deployment arming, hall-effect sensor interface, general purpose output drivers, watchdog timer, microcontroller failsafe input and control and a dedicated passenger airbag disarm signal. A block diagram for this IC is shown in *Figure 2*.







5.1 **Power supply**

- Integrated 1.882 MHz boost regulator, 33 V ± 5% or 23 V ± 5% nominal output
- Integrated 1.882 MHz boost regulator, 12 V/14.75 V nominal output, user selectable via SPI command
- Integrated 1.882 MHz synchronous buck regulator, 7.2 V/9 V ± 4% nominal output, user selectable via SPI command
- Integrated 1.882 MHz synchronous buck regulator, 5 V ± 3% or 3.3 V ± 3% nominal output, user selectable via VCCSEL pin
- Over and under voltage detection and shutdown for all regulators
- Under-voltage lockout to guarantee buck regulator outputs disabled and discharged
- Integrated energy reserve capacitor fixed constant current source (65 mA, nominal) switch for controlled inrush and charge characteristics
- Integrated energy reserve diagnostics, capacitor value and ESR
- Integrated energy reserve crossover switch with current limit and battery input voltage monitoring
- Crossover switch 'active' output signal
- Integrated 25 V/20 V SPI selectable linear regulator for high side safing FET gate supply enabled via SPI or arming logic
- Reset output

5.2 Deployment drivers

- 12 high side deployment drivers, 12 low side deployment drivers
- User programmable deployment options
 - 1.20 A or 1.75 A minimum
 - programmable time in 0.1ms increments
- Capability to deploy a squib/pyroswitch with a minimum current of 1.2 / 1.75 A and the SFx shorted to ground up to 25 V on SSxy
- Independently-controlled high-side and low-side FETs
- Squib/pyroswitch resistance measurement
- Firing current monitor feature
- High and low side FET tests
- Open & shorts diagnostics, including between loop drivers
- Independent fire enable logic, SPI and discrete digital input

5.3 Remote sensor interfaces (4)

- Quad channel receiver, user selectable
 - standard PSI-5 v1.3 compatible with sync pulse or
 - active wheel speed sensors
- High side drivers for active wheel speed sensor mode (with driver protection)
- Current limit with short circuit protection diagnostics
- PSI-5 satellite sensor mode
 - Auto-adjusting current trip points for each satellite channel
 - Even parity, 8 or 10 bit messages, 125k or 189kbps
 - Satellite message error detection
- Active wheel speed sensor mode
 - Standard active dual level sensors, 7ma/14ma
 - Three level sensors with direction and air gap data, 7ma/14ma/28ma
 - PWM encoded two level sensor, 2 edges/tooth
 - PWM encoded two level sensor, 1 edge/tooth
 - Standard active two and three level sensor data decoding available through SPI

5.4 DC sensor interfaces (9)

- Nine integrated switch interfaces with current sense capability
- Compatible with Hall-effect, resistive and switch sensors
- Current limit protected
- System dedicated path to disable the passenger airbag with input from DC sensor interface

5.5 General purpose outputs (3)

- Three configurable high-side or low-side drivers
- ON-OFF mode and PWM 0-100% fine control
- Diagnostics for short circuit protection and open load detection
- Current limit and reverse battery protected

5.6 Arming logic

- User configurable safing algorithms with 16 safing records
- Four digital sensor interfaces through SPI
- Independent user programmable thresholds
- Independent user programmable latch timers
- Four discrete and independent arming logic outputs
- Four discrete and independent internal arming signals
- End-of-life interface



5.7 Other features

- One dedicated 32-bit SPI bus for global configuration and control
- One dedicated 32-bit SPI bus for remote sensor configuration and control
- Microcontroller 'state of health' input and control function
- Integrated watchdog control with 2 independent structures: windowed WD and algorithmic WD
- Temperature sensor
- Independent thermal shutdown protection on the ER boost switch, the SYNC boost switch, the energy reserve crossover switch, the energy reserve charge paths, the remote sensor interfaces and the general purpose outputs
- All diagnostics are digital and are available through SPI communications
- Configurable logic operation, 5 V or 3.3 V



6 Start-up and power control

6.1 **Power supply overview**

The L9680 IC contains a complete power management system able to provide all necessary voltages for a high feature airbag system or cut-off battery system. A general block diagram is shown in *Figure 3*. The power supply block contains the following features:

- Two 3.3 V internal regulators for operating internal logic (CVDD) and analog circuits (VINT3V3). An external CVDD pin is used to provide filtering capacitance to digital section supply rail.
- Energy reserve supply (ERBOOST) achieved through an integrated 1.882 MHz switching boost regulator. The energy reserve capacitor is charged using an internal constant current source controllable through SPI. Besides, a second current source is available to discharge the capacitor. The primary function for the second current source is to diagnose the integrity of the energy reserve capacitor, value and ESR. During system shutdown, the device can enable the discharge current source via SPI command to quickly dissipate the remaining energy stored in the energy reserve capacitor.
- Sync pulse supply (SYNCBOOST) is achieved through an integrated 1.882 MHz switching boost regulator. The SYNCBOOST regulator ensures a minimum voltage is available for operating the satellite sync signal and also provides the input voltage to the remote sensor buck regulator. The sync pulse boost regulator is disabled for battery voltage levels resulting in an output voltage above the set regulation point.
- The integrated current limited ER switch requires no external components. This switch is controlled through the integrated power control state machine and is enabled either once a loss of battery is detected or a shutdown command is received. Under the same conditions also the discrete digital pin COVRACT is activated allowing the control of an external optional cross-over switch.
- Two 1.882MHz synchronous buck regulators for remote sensor supply and VCC. The SATBUCK regulator, remote sensor buck supply, is sourced from the SYNCBOOST regulator and can be selected to be either 7.2 V or 9 V nominal. The VCC regulator is sourced from the SATBUCK regulator and is user selectable through the VCCSEL pin to either 5 V or 3.3 V nominal voltage.
- Battery voltage sense input comparator with hysteresis and wake-up input are the primary control signals for the power supply control state machine.
- Based on own mission profile and ECU total current consumption, the user must evaluate if the activation of fast slope option of each ERBoost, SyncBoost and SatBuck regulator (bit 8/9/10, \$3F SW_REGS_CONF SPI register) is needed to increase the overall efficiency.



DS11615 Rev 3



Figure 3. Power supply block diagram



6.2 Power mode control

Start-up and power down of the L9680 are controlled by the WAKEUP pin, VBATMON pin, VIN pin, device status and the SPI interface. There are four main power modes: power-off, sleep, active and passive mode.

Each power mode is described below and represented in the state flow diagram shown in *Figure 4*. The descriptions include references to conditions and sometimes nominal values. The absolute values for each condition are listed in the electrical specifications section.







6.2.1 POWER OFF mode

During the POWER-OFF Mode all supplies are disabled keeping the system in a quiescent state with very low current draw from battery. As soon as WAKEUP>WU_mon the IC will move to SLEEP Mode.

6.2.2 SLEEP mode

During the Sleep mode the VINT3V3 and CVDD internal regulators are turned on and the IC is ready for full activation of all the other supplies. As soon as VIN voltage is over a minimum threshold, all the other supplies are turned on and the IC enters the ACTIVE mode.

6.2.3 ACTIVE mode

This is the normal operating mode for the system.

All power supplies are enabled and the energy reserve boost converter starts to increase the voltage at ERBOOST. Likewise, the SYNCBOOST boost converter continues to charge and regulate to a nominal 12 V (default level at startup). Once the SYNCBOOST has reached a good value, the SATBUCK regulator starts up. In turn, when SATBUCK has ramped up, VCC regulator is enabled. Once the VCC buck regulator is in regulation, RESET is released allowing the system microcontroller and other components to begin their power-on sequence. Among these, also the ER charge current generator can be enabled by the microcontroller via a dedicated SPI command.

The active mode can be left when either WAKEUP pin or VIN voltage drop down. For the very first 9ms after having entered the active mode, the WAKEUP pin low would immediately cause the IC to switch back to sleep mode. After that time, WAKEUP pin low must be first confirmed by a μ C SPI_SLEEP command prior to cause the system to switch to passive mode. Passive mode is also entered in case of VIN voltage low.

6.2.4 PASSIVE mode

In this state, the reserve capacitor charge current and the ERBOOST boost converter are disabled. When in passive mode the device activates both the COVRACT output pin and the integrated ER switch to allow VIN to be connected to the ER capacitor. In this time, VIN is supposed to be increased up to almost VER level and the system operation relies on energy from the ER capacitor. Two scenarios are possible: high or low battery. If VIN < VINGOOD, the device moved from RUN state in ACTIVE mode to the ER state. Here, the ER capacitor is depleted while supplying all the regulators until the POR on internal regulator occurs. The threshold to decide the ER switch activation is based on VIN, because VIN is the supply voltage rail for ERBOOST regulator. If the device has still a good battery level, it entered the POWERMODE SHUTDOWN thanks to a microcontroller command to switch off. In this case, the VER node will be discharged down to approximately VIN level, which then will be supplied out of the battery line. System will continue to run up to a dedicated SPI command to disable the SATBUCK regulator, which will lead the device to enter the POWEROFF state.

The wake-up pin is filtered to suppress undesired state changes resulting from transients or glitches. Typical conditions are shown in the chart below and summarized by state.





Figure 5. Wake-up input signal behaviour

Condition summary:

- No change of sleep mode state but current consumption may exceed specification for 1. sleep mode.
- 2. The sleep mode current returns to within specified limits.
- 3. Power supply exits sleep mode. Switchers start operating if applicable voltages exceed under voltage lockouts. As T_{wakeup} timeout is not elapsed, a low level at WAKEUP instantaneously sends the system back to sleep.
- 4. Sleep reset is released and the entire system starts operating. An SPI command to enter sleep state would not be executed.
- No change in system status, an SPI command to turn off switchers would be ignored. 5.
- No change in system status, but an SPI command to turn off switchers would be 6. accepted and turn the system off.

With the below table, all the functionalities of the device are shown with respect of the power states. When one function is flagged, the related circuitry cannot be activated on that state.

	Power MODE							
Functions	Power off	Sleep		Active		Passive		
	Power off	Wakeup monitor	Awake	Startup	Run	Power mode shutdown	ER	VINGOOD blanking
Wakeup detector	Х							
Internal regulators	Х	Х						
ERBOOST regulator	Х	Х	Х			Х		
SYNCBOOST regulator	Х	Х	Х					
ER CAP charge current	Х	Х	Х			Х	Х	Х
ER CAP discharge current	Х	Х	Х				Х	Х
ER switch	Х	Х	Х	Х	Х			
COVRACT	Х	Х	Х	Х	Х			Х

Table 3. Functions disabling by state



	Power MODE							
Functions	Power off	Sleep		Active		Passive		
	Power off	Wakeup monitor	Awake	Startup	Run	Power mode shutdown	ER	VINGOOD blanking
SATBUCK regulator	Х	Х	Х					
VCC regulator	Х	Х	Х					
Deployment Drivers	Х	Х	Х					
VSF Safing FET regulator	Х	Х	Х					
Remote Sensor Interfaces	Х	Х	Х					
Watchdog	Х	Х	Х					
Diagnostics	Х	Х	Х					
DC Sensor Interface	Х	Х	Х					
GPO drivers	Х	Х	Х					
Safing Logic	Х	Х	Х					

Table 3. Functions disabling by state (continued)





6.2.5 Power-up and power-down sequences

The behaviour of the IC during normal power-up and power-down is shown in *Figure 6* to *Figure 10*. The following sequences represent just a subset of all possible power-up and power-down scenarios. In *Figure 6* a normal IC power-up controlled by the state of the WAKEUP pin is shown assuming the VCOREMON function activated, while in *Figure 7* assuming the VCOREMON function disabled.

Figure 6. Normal power-up sequence with VCOREMON function disabled







Figure 7. Normal power-up sequence with VCOREMON function enabled





Figure 8. Normal power down sequence through POWERMODE SHUTDOWN state - no ER cap active discharge







Figure 9. Normal power down sequence through Powermode Shutdown state - ER cap active discharge

DS11615 Rev 3




Figure 10. Normal power down sequence through ER state



6.2.6 IC operating states

Different states can be identified while operating the device. These states allow safe and predictable initialization, test, operation and final disposal of the part (scrapping).

As soon as the RESET signal is de-asserted at the beginning of the ACTIVE mode, the microcontroller powers up. At this stage, L9680 is in the Init state: during this state the device must be initialized by the controller. In particular, the watchdog timer window can be programmed during this state.

When the watchdog service begins (upon the first successful watchdog feed), the device switches to Diag state for diagnostics purposes. The remaining configuration of the device is allowed in this state, in particular for safing records and deployment masks. Several tests are also enabled while in this state and all these tests are mutually exclusive to one another. HS and LS switch tests of the squib/pyroswitch drivers can only be processed during this Diag state. Also high side safing FET can only be run during this state. When not in Diag state, any commands for squib/pyroswitch driver switch tests will be ignored. Other checks are also performed: on the arming outputs to check for non-stuck-at conditions on the pins and on the configured firing time configuration through one of the ARMx pin. The SSM remains in this state until commanded to transition into the Safing state or Scrap state via the dedicated SPI commands.

Upon reception of the SAFING_STATE command while in Diag state, the device enters Safing state. This is the primary run-time state for normal operation, and the logic performs the safing function, including monitoring of sensor data and setting of the ARMx signals. The only means of exiting Safing state is by the assertion of the SSM_Reset signal.

The Scrap state is entered upon reception of the SCRAP_STATE command while in Diag state. While in Scrap state, the part allows the main microcontroller to initiate a transition to Arming state, and monitoring of the Remote Sensor SPI interface and the safing logic is disabled. From Scrap state, the device can transition to Arming state only, and the only means of moving back to Init state is through an SSM_Reset.

In order to protect from inadvertent entry into Arming state, and to prevent undesired activation of the safing signals, a handshake mechanism is used to control entry into, and exit from Arming state. This handshake is described further in Section 11.6. While in Arming state, the arming outputs are asserted. Exit from Arming state occurs when the periodic SCRAP_KEY commands cease (timeout), the key value is incorrect, or when SSM_Reset is asserted. Upon exit, the device re-enters Scrap state, except for the case of SSM_Reset, which results in entry into Init state.

The device operating states are shown in Figure 11.





Figure 11. IC operating state diagram

6.3 ERBOOST switching regulator

The L9680 IC uses an advanced energy reserve switching regulator operating at 1.882MHz nominal. The higher switching frequency enables the user to select smaller less expensive inductors and moves the operating frequency to permit easier compliance with system emissions.

The ERBoost switching regulator uses a classical peak current mode control loop to properly regulate the output voltage and includes an over-voltage protection that immediately switch off the PowerMOS to protect the device. The regulator includes also a soft start circuit which apply a ramp on the over current threshold from the 40% of IOC_ERBST value to the maximum one with 16 steps and within 1024 μ s. The soft start is restarted every time the regulator has a transition from the ER_BST_OFF to the ER_BST_ON state.

The energy reserve boost regulator charges the external system tank capacitor through an integrated fixed current source significantly reducing in-rush currents typical of large energy reserve capacitors. The boost circuit provides energy for the reserve capacitor with assumed run time load of less than 20 mA and to the VSF regulator. Once system shutdown is initiated or a loss of battery condition is diagnosed, the boost regulator is by default disabled so that system power can be taken from the energy reserve capacitor. Alternatively, the ER Boost could be kept on even during the ER State by setting the SYS_CFG(KEEP_ER_BOOST_ON) bit.

The energy reserve boost regulator defaults to 23 V at power-on and can be set to 33 V nominal by the user through an SPI command. The boost converter can also be disabled by the user through an SPI command. Enabling, disabling and setting the boost output voltage



is done through the System Control (SYS_CTL) register. Boost converter diagnostics include over voltage and under voltage and the circuit is fully protected against shorts. Boost fault status is available through the SPI in Fault Status Register (FLTSR). The integrated FET featuring the boost switch is protected against short to battery by means of a thermal shutdown circuit. When thermal fault is detected the FET is switched off and latched in this state until the related fault flag ERBST_OT in the FLTSR register is read. In case of loss of BSTGND ground the FET is not turned on. Loss of ground can be detected also when the FET is off thanks to a pull-up current present on the BSTGND pin. The FET will be automatically reactivated as soon as ground connection is restored. Over-voltage protection from load dump and inductive flyback is provided via an active clamp and an ER_Boost disable circuitry, see *Figure 12*.





Normal run time power for the system is provided directly from the battery input, not from the boost. Boost energy is available to the system through the energy reserve crossover switch once battery is lost or a commanded system shutdown is initiated.





Figure 13. ERBOOST regulator state diagram

6.4 Energy reserve capacitor charging and discharging circuits

The energy reserve capacitor connected to VER pin can be charged in an efficient way by means of a current generator. Its capability is 65 mA nominal, so that for example a 10 mF capacitor can be charged in approximately 4 s to 24 V. The current generator is activated or deactivated by SPI command only while in ACTIVE mode. When not in ACTIVE mode, the generator is always switched off in order to decouple ERBOOST node voltage from VER reserve voltage.





L9680 also offers a safe control to discharge the ER capacitor by means of a fixed current generator. This discharge can be controlled via SPI command while not in SLEEP mode. Furthermore, this discharge circuit is mutually exclusive with the ER charging circuit, to avoid inefficient way of controlling the charge on the VER energy reserve capacitor.







6.5 **ER CAP diagnostic**

The L9680 IC contains a full integrated solution to check the connection, value and series resistance of energy reserve capacitor independent from ER Cap leakage current and Boost Voltage level.

6.5.1 ER CAP measurement

The IC contains two current generators used to charge and discharge the energy reserve capacitor connected on ER pin. The simplified block diagram is shown in the figure below.



Figure 16. ER CAP measurement block diagram

To obtain an accurate ER CAP measurement, the VER voltage conversion must be required when both current generators are off, namely no current flows through ER cap permits to avoid ESR error contribution.

DS11615 Rev 3



The user can decide the charge and discharge time based on the ER CAP used in application, in order to maximize the differential voltage and then improve the accuracy.

Anyway, a timeout on ER Discharge current has been implemented to prevent thermal issue, so the discharge time cannot be longer than 350 ms.



Figure 17. ER CAP measurement timing diagram

The following formulas can be used to retrieve the ER CAP value from the voltage and timing measurements.

$$\Delta V_1 + \Delta V_2 = \frac{I_1 + I_{LEAK}}{C} T_1 + \frac{I_2 - I_{LEAK}}{C} T_2$$
$$C = \frac{2 \cdot I \cdot T}{V_{start} + V_{end} - 2 \cdot V_{stop}}$$

T₁ = discharge time

 T_2 = charge time, same as discharge time

$$T_{1} = T_{2} = T$$

$$\Delta V_{1} = V_{start} - V_{stop}$$

$$\Delta V_{2} = V_{end} - V_{stop}$$

$$I_{1} = discharge current$$

$$I_{2} = charge current, same as discharge current$$

$$I_{1} = I_{2} = I$$

I_{LEAK} = leakage current



6.5.2 ER CAP ESR measurement

The IC contains the capability to perform a measurement of the equivalent series resistance of energy reserve capacitor. In this case the discharge current is 10 times higher to create a voltage difference proportional to the ER CAP ESR. The voltage measurement and conversion is automatically executed once the user requires the ESR measurement through the LPDIAGREQ register.



Upon an ESR measurement is requested, the IC executes an internal automatic sequence to take three voltage measurements at the ER node, toggling the ER discharge current source on and off as shown in *Figure 19*. The test lasts for T_{ESR_DIAG}. After this time has elapsed, the results can be retrieved by reading the DIAGCTRL_x registers. The three ER voltage measurements are provided at the same time in DIAGCTRLA, DIAGCTRLB and DIAGCTRLC registers. During the execution of the ESR measurement no other activity on ADC is allowed. The user must ensure no other ADC requests are queued to be executed at the same time of ESR measurement. The ESR diagnostic, once initiated, will continue without interruption even if the device enters in ER State because of a battery loss event.







Figure 19. ER ESR measurement timing diagram

The ER CAP ESR can be calculated according to the following formula:

$$\mathsf{ESR}_{\mathsf{ERCAP}} = \frac{\mathsf{V}_{\mathsf{C}} - \mathsf{V}_{\mathsf{B}}}{\mathsf{G}_{\mathsf{ER}_\mathsf{ESR}} \cdot \mathsf{I}_{\mathsf{ER}_\mathsf{DISCHARGE_HIGH}}} + \mathsf{OFF}_{\mathsf{ER}_\mathsf{ESR}}$$

6.6 ER switch and COVRACT pin

L9680 allows the system to run out of the reserve capacitor energy stored on VER node by means of the charging boost regulator. In this way, an extended operation can take place even in case of battery lost. The ER switch implements a connection from the VER pin to the VIN node, supply input for the SYNCBOOST regulator and for internal power supplies.

The ER switch is automatically activated upon entering the PASSIVE mode. Voltage difference between VIN and VER is monitored in order to prevent VER back-feeding when VIN exceeds VER by $V_{\text{ER}_{SW}_{OV}_{TH}}$. The ER switch is automatically deactivated upon the above mentioned overvoltage detection.

During PASSIVE mode the discrete digital output pin COVRACT is activated to allow for external optional cross-over switch control (except during VINGOOD blanking state, where the COVRACT is deactivated).





Figure 20. ER switch state diagram

6.7 SYNCBOOST boost regulator

The SYNCBOOST boost regulator also operates at 1.882 MHz allowing the user to select smaller less expensive external components. The regulator provides a 12 V/14.75 V nominal for the sync pulse feature used in PSI-5 bussed satellite sensor configuration. The regulator also provides the power for the SATBUCK regulator.

The SyncBoost switching regulator uses a classical peak current mode control loop to properly regulate the output voltage and includes an over-voltage protection that immediately switch off the PowerMOS to protect the device. The regulator includes also a soft start circuit which apply a ramp on the over current threshold from the 40% of $I_{OC\ SYNCBST}$ value to the maximum one with 16 steps and within 1024 $\mu s.$ The soft start is restarted every time the regulator is enabled, namely there is a transition from the SYNCBOOST OFF state to the SYNCBOOST ON state.

In normal operation, the SYNCBOOST regulator operates directly from battery providing a voltage level to operate the sync pulse driver circuit. Should the input voltage be greater than regulation point, the output voltage will track the input voltage less any drops in the external components.

The boost regulator is enabled automatically by the power control state machine, but can be disabled on purpose via SPI command through the SYS CTL(SYNCBST EN) bit. The regulation point is fixed at a nominal 12 V at startup. User may increase the output regulation voltage to 14.75 V nominal by setting the SATV bit via a dedicated SPI command, should an extended voltage range be needed.

Boost converter diagnostics include over voltage and under voltage, reported by the S BST NOK bit in the POWER STATE register, and the circuit is fully protected against shorts. The integrated FET featuring the boost switch is protected against short to battery by means of a thermal shutdown circuit. When thermal fault is detected the FET is switched off and latched in this state until the related fault flag ERBST OT in the FLTSR register is read.



In case of loss of ground the FET is not turned on. Loss of ground can be detected also when the FET is off thanks to a pull-up current present on the BSTGND pin. The FET will be automatically reactivated as soon as ground connection is restored. Over-voltage protection from load dump and inductive flyback is provided via an active clamp and a SYNC_Boost disable circuitry, see *Figure 21*.







Figure 22. SYNCBOOST regulator state diagram



DS11615 Rev 3

6.8 SATBUCK regulator

The SATBUCK regulator provides a nominal 7.2 V regulated output voltage at startup for the remote satellite and wheel speed interface circuitry and the VCC buck regulator. The buck regulator is enabled automatically by the power control state machine. This regulator is protected against short circuits. Should the user need a higher voltage range for the remote sensor interface, a specific SPI command allows the output voltage to be increased at 9 V nominal by setting the SAT_V bit. Fault status is available through SPI in the Fault Status Register (FLTSR). The buck converter operates at 1.882 MHz allowing the user to select smaller less expensive external components. Moreover, the synchronous buck regulator integrates the external recirculation diode.





6.9 VCC buck regulator

The VCC buck regulator also operates at 1.882 MHz and is user selectable to either 3.3 V or 5 V nominal output voltage. The user can select the output voltage through the VCCSEL pin. To select 5 V operation, the user must bias VCCSEL to a level higher than V_{TH2 H VCCSEI} for instance SyncBoost. For 3.3 V operation, the VCCSEL pin must be biased to a level lower than V_{TH2 L VCCSEL}. An internal weak pull down is connected to VCCSEL to ensure the input remains at ground potential in case of open pin. The internal power control state machine will read the VCCSEL input pin and latch the resulting state upon the SATBUCK voltage reaches the good value (SATBUCK_OK = 1). Upon latching the VCCSEL state, the VCC buck regulator cannot be changed by the user.

The VCC regulator has over and under voltage detections and shutdown capability and it is also protected against short circuits. During start-up an internal pull up current is enabled in order to detect a potential VCC pin open fault trough the over voltage detection. This pull up current is disabled once in VCC_ON or VCC_SHUTDOWN states. During normal operation, VCC_ON state, the VCC pin open fault is quickly detected through the Under Voltage Detection Low to prevent any MCU damage.

L9680



An open VCC pin shall lead to an under voltage condition on VCC supply monitor. The SPI related signals (SCLK, MISO, MOSI, CS) or other digital nets shall not power the VCC pin due to back-feeding paths.



Figure 24. VCC regulator state diagram



6.10 VCOREMON external core voltage monitor

The device includes the possibility to monitor the external core voltage of MCU in case an additional external regulator is used to provide the 1.2V rail. The internal power control state machine will read the VCCSEL input pin and latch the resulting state upon the VCCBUCK regulator enters in the VCC_ON state: if VCCSEL is lower than $V_{TH1_L_VCCSEL}$ the VCORE monitor will be enabled, otherwise, if VCCSEL is higher than $V_{TH1_H_VCCSEL}$, the VCORE monitor will be disabled.

In summary:

- VCCSEL < V_{TH1 L VCCSEL} (VCCSEL shorted to ground), to select VCC = 3.3 V and to enable the VCORE monitor
- V_{TH1_H_VCCSEL} < VCCSEL < V_{TH2_L_VCCSEL} (VCCSEL shorted to VCC), to select VCC = 3.3 V and to disable the VCORE monitor.
- VCCSEL > V_{TH2_H_VCCSEL} (VCCSEL shorted to SYNCBOOST), to select VCC = 5 V and to disable the VCORE monitor.

The VCORE monitor is enabled once the VCC regulator is in VCC_ON state, therefore the external MCU core voltage regulator (1.2 V) must reach the regulation within 4ms after the VCC regulator power-up.

Upon latching the VCCSEL state, the VCOREMON activation cannot be changed by the user.

In case of VCCSEL open pin, an internal pull down current would force VCCSEL to ground and then the VCORE monitor will be enabled function.

If the VCORE voltage is low and the VCCSEL pin is higher than $V_{TH1 \ L \ VCCSEL}$, after the 4ms delay from power-up, a latched VCOREMON fault will cause RESET to drive low, even though VCCSEL pin is high enough to satisfy the disabling of VCOREMON function. This occurs only once at power-up, and is then appropriately disabled. For this reason the RESET is released 500 µs (namely the reset_hold_time) after the 4 ms delay from power-up as showed in *Figure 6*.



6.11 VSF regulator and control

The L9680 provides a low current linear regulator that can be used in the system design to bias the external high side safing switch. The regulator output is 20 V nominal (configurable to 25 V via SPI command). VSF is enabled if any of the ARMxINT signal is asserted, as shown in *Figure 25*. The VSF regulator supply input is ERBOOST.



Figure 25. VSF control logic

VSF voltage can be monitored by the user through the internal ADC. Characteristics for this function are shown in the electrical performance tables.

6.12 Oscillators

The device integrates two trimmed oscillators, both of them with spread spectrum capability selectable via the CLK_CNF register.

The main oscillator runs at 16 MHz typ and is used to provide clock to the internal synchronous logic. Moreover, this frequency is divided down by factor 8.5 to generate clocks for the switching regulators (1.882 MHz typ).

The auxiliary oscillator runs at 7.5 MHz typ and is used to monitor the main oscillator. In case the main oscillator frequency was lower than $f_{OSC_LOW_TH}$ threshold or higher than $f_{OSC_HIGH_TH}$ threshold, the condition is detected by the frequency monitor circuit and then latched into the CLKFRERR flag in the FLTSR register and a POR is issued.

6.13 Reset control

The device provides reset logic to safely control system operation in the event of internal ECU failures. Several internal reset signals are generated depending on the type of failure detected. In *Figure 26* the voltage monitoring diagram is shown.





Figure 26. Internal voltage monitors

An active low pin output (RESET pin) is driven from the L9680 to allow resetting of external devices such as the microcontroller, sensors, and other ICs within the ECU.

Three internal reset signals are generated by the device:

• POR

Power On Reset - This reset is asserted when a failure is detected in the internal supplies or bandgap circuits. When active, all other resets are asserted.

WSM_RESET

Watchdog State Machine Reset - This reset is generated when the POR is active or when a failure is detected in the VCC or VCORE supply.

SSM_RESET

System State Machine Reset - This reset is asserted when the POR or the WSM_RESET are active, or when a failure is detected in either Watchdog state machine, or again when the MCUFAULTB pin is active.

The RESET pin is the active-low signal driven on the output pin, and is an inverted form of SSM_RESET.

The cause of the RESET activation is latched and reported into the Fault Status Register FLTSR and cleared upon SPI reading.

The reset generated by the MCUFLT_ERR can be masked by the MCU_FLT_TEST test mode signal. This allows verification of MCUFLT pin operation and, in turn, microcontroller fault conditions without asserting a reset. The MCURST bit is still set whether in test mode or not.

The reset logic shall be controlled as shown in the diagram below:





Figure 27. Reset control logic



7 SPI interfaces

The L9680 system solution device has many user selectable features controlled through serial communications by the integrated microcontroller. The device features two SPI interfaces: one global SPI and one Remote Sensor SPI. The global SPI interface provides general configuration, control and status functions for the device, while the Remote Sensor SPI provides dedicated access to Remote Sensor Data and Status Registers.

7.1 SPI protocol

Each SPI interface (Global and Remote Sensor) use their own dedicated set of 4 I/O pins: CS_G, SCLK_G, MOSI_G and MISO_G for Global SPI; CS_RS, SCLK_RS, MOSI_RS and MISO_RS for Remote Sensor SPI. Both the SPI interfaces use the same protocol described here below (the suffix '_X' used in the SPI pin names below is intended to stand for either '_G' or '_RS' depending on the particular SPI interface considered)

The IC SPI interface is composed by an input shift register, an output shift register and four control signals. MOSI_X is the data input to the input shift register. MISO_X is the data output from the output shift register. SCLK_X is the clock input used to shift data into the input shift register or out from the output one while CS_X is the active low chip select input.

All SPI communications are executed in exact 32 bit increments. The general format of the 32 bit transmission for the SPI interface is shown in *Table 4*.

Data sent to the IC (i.e. MOSI_X) consists of a target read register ID (RID), a target write register ID (WID), write data parity (WPAR) and 16 bits of data (WRITE). WRITE data is the data to be written to the target write register indicated by WID. Data returned from the IC (i.e. MISO_X) consists of a global status word (GSW), read data parity (RPAR) and 20 bits of data (READ). READ data will be the contents of the target read register as indicated by the RID bits. The parity bits WPAR and RPAR cover all the 32 bits of the MOSI and MISO frames, respectively. Odd parity type is used.

	SPI register R/W															
	31 30 29 28 27 26 25 24 23 22 21 20 19 18 17										16					
SPI_MOSI	GID RID[6:0] WID[6:0]											WPAR				
SPI_MISO					G	SW[10):0]					RPAR		REA	D[19:1	6]
	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
SPI_MOSI		WRITE[15:0]														
SPI_MISO	READ[15:0]															

Table 4.SPI MOSI and MISO frames layo

The communications is controlled through CS_X, enabling and disabling communication. When CS_X is at logic high, all SPI communication I/O is tri-stated and no data is accepted. When CS_X is low, data is latched on the rising edge of SCLK_X and data is shifted on the falling edge. The MOSI_X pin receives serial data from the master with MSB first. Likewise for MISO_X, data is read MSB first, LSB last.

The L9680 contains a data validation method through the SCLK_X input to keep transmissions with not exactly 32 bits from being written to the device. The SCLK_X input counts the number of received clocks and should the clock counter exceed or count fewer



than 32 clocks, the received message is discarded and a SPI_FLT bit is flagged in the Global Status Word (GSW). The SPI_FLT bit is also set in case of parity error detected on the MOSI_X frame. Any attempt to access to a register with forbidden access mode (read or write) is not leading to changes to the internal registers but the SPI_FLT bit is not set in this case.

7.2 Global SPI register map

The Global SPI interface consists of several 32-bit registers to allow for configuration, control and status of the IC as well as special manufacturing test modes. The register definition is defined by the read register ID (RID) and the write register ID (WID) as shown in *Table 5*. Global ID bit (GID) is used to extend available register addresses, but it is shared between RID and WID; only RID and WID with the same GID value can be addressed within the same SPI word. The operating states here show in which states the SPI command is processed.

The L9680 checks the validity of the received WID and RID fields in the MOSI_G frame. Should a SPI write command with WID matching a writable register be received in an illegal operating state, the command will be discarded and the ERR_WID bit will be flagged in the next Global Status Word GSW. The ERR_WID flag is not set in case WID is addressing a read/only register. Should a SPI read command be received containing an unused RID address, the command will be discarded and the ERR_RID bit will be flagged in the current GSW.



CID			סור	• / •	۸/۱۳	`		Цот	D/M	Namo	Description		Ор	erating S	State ⁽¹⁾	
GID			RIL	,,,	/ • 1 L	,		пех	FC/ VV	Name Description	Init	Diag	Ssafing	Scrap	Arming	
0	0	0	0	0	0	0	0	\$00	R	FLTSR	Global fault status register					
0	0	0	0	0	0	0	1	\$01	R/W	SYS_CFG	Power supply configuration ⁽²⁾	Х	Х	Х	Х	Х
0	0	0	0	0	0	1	0	\$02	R/W	SYS_CTL	Register for power management	Х	Х	Х	Х	Х
0	0	0	0	0	0	1	1	\$03	W	SPI_SLEEP	Sleep Mode command	Х	Х	Х	Х	х
0	0	0	0	0	1	0	0	\$04	R	SYS_STATE	Read register to report in which state the power control state machine is and also in which operating state the device is					
0	0	0	0	0	1	0	1	\$05	R	POWER_STATE	Power state register (feedback on regulators' status and voltage thresholds)					
0	0	0	0	0	1	1	0	\$06	R/W	DCR_0			Х	Х	Х	Х
0	0	0	0	0	1	1	1	\$07	R/W	DCR_1			Х	Х	Х	Х
0	0	0	0	1	0	0	0	\$08	R/W	DCR_2			Х	Х	Х	Х
0	0	0	0	1	0	0	1	\$09	R/W	DCR_3			Х	Х	Х	Х
0	0	0	0	1	0	1	0	\$0A	R/W	DCR_4			Х	Х	Х	Х
0	0	0	0	1	0	1	1	\$0B	R/W	DCR_5			Х	Х	Х	Х
0	0	0	0	1	1	0	0	\$0C	R/W	DCR_6			Х	Х	Х	Х
0	0	0	0	1	1	0	1	\$0D	R/W	DCR_7			Х	Х	Х	Х
0	0	0	0	1	1	1	0	\$0E	R/W	DCR_8			Х	Х	Х	Х
0	0	0	0	1	1	1	1	\$0F	R/W	DCR_9			Х	Х	Х	Х
0	0	0	1	0	0	0	0	\$10	R/W	DCR_A			Х	х	Х	х
0	0	0	1	0	0	0	1	\$11	R/W	DCR_B			Х	Х	Х	Х
0	0	0	1	0	0	1	0	\$12	R/W	DEPCOM	Deployment command register			Х		Х
0	0	0	1	0	0	1	1	\$13	R	DSR_0						
0	0	0	1	0	1	0	0	\$14	R	DSR_1	Deployment status register					
0	0	0	1	0	1	0	1	\$15	R	DSR_2						

56/286

DS11615 Rev 3

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SPI interfaces

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	CID	RID / WID				Hoy	DAM			Operating State ⁽¹⁾							
	GID				,,,		•		TICA						Ssafing	Scrap	Arming
	0	0	0	1	0	1	1	0	\$16	R	DSR_3						
Ī	0	0	0	1	0	1	1	1	\$17	R	DSR_4						
Ī	0	0	0	1	1	0	0	0	\$18	R	DSR_5						
Ī	0	0	0	1	1	0	0	1	\$19	R	DSR_6						
Ī	0	0	0	1	1	0	1	0	\$1A	R	DSR_7	Deployment status register					
Ī	0	0	0	1	1	0	1	1	\$1B	R	DSR_8						
Ī	0	0	0	1	1	1	0	0	\$1C	R	DSR_9						
Ī	0	0	0	1	1	1	0	1	\$1D	R	DSR_A						
Ī	0	0	0	1	1	1	1	0	\$1E	R	DSR_B						
	0	0	0	1	1	1	1	1	\$1F	R	DCMTS01						
Ī	0	0	1	0	0	0	0	0	\$20	R	DCMTS23						
Ī	0	0	1	0	0	0	0	1	\$21	R	DCMTS45	Deployment current monitor register					
Ī	0	0	1	0	0	0	1	0	\$22	R	DCMTS67						
Ī	0	0	1	0	0	0	1	1	\$23	R	DCMTS89						
Ī	0	0	1	0	0	1	0	0	\$24	R	DCMTSAB						
	0	0	1	0	0	1	0	1	\$25	R/W	SPIDEPEN	Lock/Unlock command			Х		Х
	0	0	1	0	0	1	1	0	\$26	R	LP_GNDLOSS	Loss of ground fault for squib/pyroswitch loops					
	0	0	1	0	0	1	1	1	\$27	R	VERSION_ID	Device version					
	0	0	1	0	1	0	0	0	\$28	R/W	WD_RETRY_CONF	Watchdog Retry Configuration	Х				
	0	0	1	0	1	0	0	1	\$29	W	MCU_FLT_TEST	Microcontroller Fault test	Х	Х	Х	Х	Х
	0	0	1	0	1	0	1	0	\$2A	R/W	WDTCR	Watchdog first level configuration	Х				
	0	0	1	0	1	0	1	1	\$2B	R/W	WD1T	Watchdog first level key transmission	Х	Х	Х	Х	Х
ĺ	0	0	1	0	1	1	0	0	\$2C	R	WD_STATE	Watchdog first and second level state					
	0	0	1	0	1	1	0	1	\$2D	R/W	CLK_CONF	Clock configuration	Х	Х	Х	Х	Х

Table 5.Global SPI register map (continued)

L9680

SPI interfaces

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										Table 5.Gl	obal SPI register map (continued)					
				.	A/1F			Hay	DAA	Nama	Description		Ор	erating S	State ⁽¹⁾	
GID			RII		VVIL	,		пех	K / VV	Name	Description	Init	Diag	Ssafing	Scrap	Arming
0	0	1	0	1	1	1	0	\$2E	R	SCRAP_SEED	Scrap Seed command					
0	0	1	0	1	1	1	1	\$2F	W	SCRAP_KEY	Scrap Key command				Х	Х
0	0	1	1	0	0	0	0	\$30	W	SCRAP_STATE	Scrap State command		Х			
0	0	1	1	0	0	0	1	\$31	W	SAFING_STATE	Safing State command		Х			
0	0	1	1	0	0	1	0	\$32	W	WD2_RECOVER	Watchdog second level recovery command	Х	Х	Х	Х	х
0	0	1	1	0	0	1	1	\$33	R	WD2_SEED	Watchdog second level seed transmission					
0	0	1	1	0	1	0	0	\$34	W	WD2_KEY	Watchdog second level key transmission	Х	Х	Х	Х	Х
0	0	1	1	0	1	0	1	\$35	W	WD_TEST	Watchdog first and second level test	Х	Х	Х	Х	Х
0	0	1	1	0	1	1	0	\$36	R/W	SYSDIAGREQ	Diagnostic command for system safing		Х			
0	0	1	1	0	1	1	1	\$37	R	LPDIAGSTAT	Diagnostic result register for deployment loops					
0	0	1	1	1	0	0	0	\$38	R/W	LPDIAGREQ	Diagnostic configuration command for deployment loops		x	х	х	х
0	0	1	1	1	0	0	1	\$39	R/W	SWCTRL	DC sensor diagnostic configuration		Х	Х	Х	Х
0	0	1	1	1	0	1	0	\$3A	R/W	DIAGCTRL_A	In WID is AtoD converter control register A. In RID is AtoD result A request.		x	х	х	х
0	0	1	1	1	0	1	1	\$3B	R/W	DIAGCTRL_B	In WID is AtoD converter control register B. In RID is AtoD result B request.		х	х	х	х
0	0	1	1	1	1	0	0	\$3C	R/W	DIAGCTRL_C	In WID is AtoD converter control register C. In RID is AtoD result C request.		x	х	x	х
0	0	1	1	1	1	0	1	\$3D	R/W	DIAGCTRL_D	In WID is AtoD converter control register D. In RID is AtoD result D request.		x	х	x	х
0	0	1	1	1	1	1	0	\$3E								
0	0	1	1	1	1	1	1	\$3F	R/W	SW_REGS_CONF	Configuration register for switching regulators		Х	Х	Х	Х
0	1	0	0	0	0	0	0	\$40								
0	1	0	0	0	0	0	1	\$41								
0	1	0	0	0	0	1	0	\$42	R/W	GPOCR	General Purpose Output configuration	Х	Х			

SPI interfaces

L9680

59/:
286

577

									R/W	R/W Name Description –		Ор	erating S	State ⁽¹⁾		
GID			RIL) / V	VIL)		нех	R / W	Name Description	Description	Init	Diag	Ssafing	Scrap	Arming
0	1	0	0	0	0	1	1	\$43	R/W	GPOCTRL0	General Purpose Output 0 control register	Х	Х	Х	Х	Х
0	1	0	0	0	1	0	0	\$44	R/W	GPOCTRL1	General Purpose Output 1 control register	Х	Х	Х	Х	Х
0	1	0	0	0	1	0	1	\$45	R/W	GPOCTRL2	General Purpose Output 2 control register	Х	Х	Х	Х	Х
0	1	0	0	0	1	1	0	\$46	R	GPOFLTSR	General Purpose Output fault status register					
0	1	0	0	0	1	1	1	\$47								
0	1	0	0	1	0	0	0	\$48	R/W	WSS_TEST	WSS testmode request		Х			
0	1	0	0	1	0	0	1	\$49								
0	1	0	0	1	0	1	0	\$4A	R/W	RSCR0	PSI5/WSS configuration register		Х			
0	1	0	0	1	0	1	1	\$4B	R/W	RSCR1			Х			
0	1	0	0	1	1	0	0	\$4C	R/W	RSCR2			Х			
0	1	0	0	1	1	0	1	\$4D	R/W	RSCR3			Х			
0	1	0	0	1	1	1	0	\$4E	R/W	RSCTRL	Remote sensor control register		Х	Х	Х	Х
0	1	0	0	1	1	1	1	\$4F								
0	1	0	1	0	0	0	0	\$50								
0	1	0	1	0	0	0	1	\$51								
0	1	0	1	0	0	1	0	\$52								
0	1	0	1	0	0	1	1	\$53								
0	1	0	1	0	1	0	0	\$54								
0	1	0	1	0	1	0	1	\$55								
0	1	0	1	0	1	1	0	\$56								
0	1	0	1	0	1	1	1	\$57								
0	1	0	1	1	0	0	0	\$58								
0	1	0	1	1	0	0	1	\$59								
0	1	0	1	1	0	1	0	\$5A								
0	1	0	1	1	0	1	1	\$5B								

Table 5.Global SPI register map (continued)

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										Table 5.Glo	bal SPI register map (continued)					
									DAM	Nama	Description		Ор	erating S	tate ⁽¹⁾	
GID			RIL) / N	VID)		нех	R/W	Name	Description	Init	Diag	Ssafing	Scrap	Arming
0	1	0	1	1	1	0	0	\$5C								
0	1	0	1	1	1	0	1	\$5D								
0	1	0	1	1	1	1	0	\$5E								
0	1	0	1	1	1	1	1	\$5F								
0	1	1	0	0	0	0	0	\$60								
0	1	1	0	0	0	0	1	\$61								
0	1	1	0	0	0	1	0	\$62								
0	1	1	0	0	0	1	1	\$63								
0	1	1	0	0	1	0	0	\$64	R/W	RS_AUX_CONF1	WSS Threshold configuration register 1		Х			
0	1	1	0	0	1	0	1	\$65	R/W	RS_AUX_CONF2	WSS Threshold configuration register 2		Х			
0	1	1	0	0	1	1	0	\$66	R/W	SAF_ALGO_CONF	Safing Algorithm configuration register		Х			
0	1	1	0	0	1	1	1	\$67								
0	1	1	0	1	0	0	0	\$68								
0	1	1	0	1	0	0	1	\$69								
0	1	1	0	1	0	1	0	\$6A	R	ARM_STATE	Status of arming signals					
0	1	1	0	1	0	1	1	\$6B								
0	1	1	0	1	1	0	0	\$6C								
0	1	1	0	1	1	0	1	\$6D								
0	1	1	0	1	1	1	0	\$6E	R/W	LOOP_MATRIX_ARM1	Assignment of ARM 1 pin to which LOOPS		Х			
0	1	1	0	1	1	1	1	\$6F	R/W	LOOP_MATRIX_ARM2	Assignment of ARM 2 pin to which LOOPS		Х			
0	1	1	1	0	0	0	0	\$70	R/W	LOOP_MATRIX_ARM3	Assignment of ARM 3 pin to which LOOPS		Х			
0	1	1	1	0	0	0	1	\$71	R/W	LOOP_MATRIX_ARM4	Assignment of ARM 4 pin to which LOOPS		Х			
0	1	1	1	0	0	1	0	\$72								

GID			БІГ					Цах	DAM	Namo	Description		Operating State ⁽¹⁾					
GID			RIL	<i>) 1</i>	VIL	,		пех		Name	Description	Init	Diag	Ssafing	Scrap	Arming		
0	1	1	1	0	0	1	1	\$73	R	AEPSTS_ARM1								
0	1	1	1	0	1	0	0	\$74	R	AEPSTS_ARM2	Arming pulse stretch timer value							
0	1	1	1	0	1	0	1	\$75	R	AEPSTS_ARM3								
0	1	1	1	0	1	1	0	\$76	R	AEPSTS_ARM4	Arming pulse stretch timer value							
0	1	1	1	0	1	1	1	\$77										
0	1	1	1	1	0	0	0	\$78	R/W	PADTHRESH_HI	Deesen ver inkikit Threeholds		Х					
0	1	1	1	1	0	0	1	\$79	R/W	PADTHRESH_LO	Passenger Innibit Thresholds		Х					
0	1	1	1	1	0	1	0	\$7A	R/W	LOOP_MATRIX_PSINH	Assignment of PSINH signal to which LOOPS		Х					
0	1	1	1	1	0	1	1	\$7B										
0	1	1	1	1	1	0	0	\$7C										
0	1	1	1	1	1	0	1	\$7D										
0	1	1	1	1	1	1	0	\$7E										
0	1	1	1	1	1	1	1	\$7F	R/W	SAF_ENABLE	Safing record enable		Х	Х	Х	Х		

Table 5.Global SPI register map (continued)

DS11615 Rev 3

577

61/286

L9680

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	Table 5.Global SPI register map (continued)																
CID			חום		חוע			Hoy	DW	Nama	Description	Operating State ⁽¹⁾					
GID			RID	, v	טוי			пех	FC/ VV	Name	Description	Init	Diag	Ssafing	Scrap	Arming	
1	0	0	0	0	0	0	0	\$80	R/W	SAF_REQ_MASK_1			Х				
1	0	0	0	0	0	0	1	\$81	R/W	SAF_REQ_MASK_2			Х				
1	0	0	0	0	0	1	0	\$82	R/W	SAF_REQ_MASK_3			Х				
1	0	0	0	0	0	1	1	\$83	R/W	SAF_REQ_MASK_4			Х				
1	0	0	0	0	1	0	0	\$84	R/W	SAF_REQ_MASK_5			Х				
1	0	0	0	0	1	0	1	\$85	R/W	SAF_REQ_MASK_6	Safing record request mask		Х				
1	0	0	0	0	1	1	0	\$86	R/W	SAF_REQ_MASK_7			Х				
1	0	0	0	0	1	1	1	\$87	R/W	SAF_REQ_MASK_8	Saling record request mask		Х				
1	0	0	0	1	0	0	0	\$88	R/W	SAF_REQ_MASK_9			Х				
1	0	0	0	1	0	0	1	\$89	R/W	SAF_REQ_MASK_10			Х				
1	0	0	0	1	0	1	0	\$8A	R/W	SAF_REQ_MASK_11			Х				
1	0	0	0	1	0	1	1	\$8B	R/W	SAF_REQ_MASK_12			Х				
1	0	0	0	1	1	0	0	\$8C	R/W	SAF_REQ_MASK_13			Х				
1	0	0	0	1	1	0	1	\$8D	R/W	SAF_REQ_MASK_14_pt1			Х				
1	0	0	0	1	1	1	0	\$8E	R/W	SAF_REQ_MASK_14_pt2			Х				
1	0	0	0	1	1	1	1	\$8F	R/W	SAF_REQ_MASK_15_pt1			Х				
1	0	0	1	0	0	0	0	\$90	R/W	SAF_REQ_MASK_15_pt2	Safing record request mask		Х				
1	0	0	1	0	0	0	1	\$91	R/W	SAF_REQ_MASK_16_pt1			Х				
1	0	0	1	0	0	1	0	\$92	R/W	SAF_REQ_MASK_16_pt2			Х				

L9680

											Table 5.Glob	oal SPI register map (continued)						
K									Have	DAA	Norma	Description	Operating State ⁽¹⁾					
	סונ		I	RIL	, v	VIL	,		нех	R/W	Name	Description	Init	Diag	Ssafing	Scrap	Arming	
	1	0	0	1	0	0	1	1	\$93	R/W	SAF_REQ_TARGET_1			Х				
	1	0	0	1	0	1	0	0	\$94	R/W	SAF_REQ_TARGET_2			Х				
	1	0	0	1	0	1	0	1	\$95	R/W	SAF_REQ_TARGET_3			Х				
	1	0	0	1	0	1	1	0	\$96	R/W	SAF_REQ_TARGET_4			Х				
	1	0	0	1	0	1	1	1	\$97	R/W	SAF_REQ_TARGET_5			Х				
	1	0	0	1	1	0	0	0	\$98	R/W	SAF_REQ_TARGET_6			Х				
	1	0	0	1	1	0	0	1	\$99	R/W	SAF_REQ_TARGET_7			Х				
	1	0	0	1	1	0	1	0	\$9A	R/W	SAF_REQ_TARGET_8			Х				
	1	0	0	1	1	0	1	1	\$9B	R/W	SAF_REQ_TARGET_9			Х				
DS	1	0	0	1	1	1	0	0	\$9C	R/W	SAF_REQ_TARGET_10	Safing record request target		Х				
116	1	0	0	1	1	1	0	1	\$9D	R/W	SAF_REQ_TARGET_11			Х				
15 R	1	0	0	1	1	1	1	0	\$9E	R/W	SAF_REQ_TARGET_12			Х				
lev 3	1	0	0	1	1	1	1	1	\$9F	R/W	SAF_REQ_TARGET_13			Х				
	1	0	1	0	0	0	0	0	\$A0	R/W	SAF_REQ_TARGET_14_pt1			Х				
	1	0	1	0	0	0	0	1	\$A1	R/W	SAF_REQ_TARGET_14_pt2			Х				
	1	0	1	0	0	0	1	0	\$A2	R/W	SAF_REQ_TARGET_15_pt1			Х				
	1	0	1	0	0	0	1	1	\$A3	R/W	SAF_REQ_TARGET_15_pt2			Х				
	1	0	1	0	0	1	0	0	\$A4	R/W	SAF_REQ_TARGET_16_pt1			Х				
	1	0	1	0	0	1	0	1	\$A5	R/W	SAF_REQ_TARGET_16_pt2			Х				
	1	0	1	0	0	1	1	0	\$A6	R/W	SAF_RESP_MASK_1	Safing record response mask		Х				

Table 5 Global SPI register man (continued)

63/286

L9680

SPI interfaces

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	Table 5.Global SPI register map (continued)																
									DAM	Nama	Description	Operating State ⁽¹⁾					
GID			RIL	,,,		,		пех	R/W	Name	Description	Init	Diag	Ssafing	Scrap	Arming	
1	0	1	0	0	1	1	1	\$A7	R/W	SAF_RESP_MASK_2			Х				
1	0	1	0	1	0	0	0	\$A8	R/W	SAF_RESP_MASK_3			Х				
1	0	1	0	1	0	0	1	\$A9	R/W	SAF_RESP_MASK_4			Х				
1	0	1	0	1	0	1	0	\$AA	R/W	SAF_RESP_MASK_5			Х				
1	0	1	0	1	0	1	1	\$AB	R/W	SAF_RESP_MASK_6			Х				
1	0	1	0	1	1	0	0	\$AC	R/W	SAF_RESP_MASK_7	-		Х				
1	0	1	0	1	1	0	1	\$AD	R/W	SAF_RESP_MASK_8			Х				
1	0	1	0	1	1	1	0	\$AE	R/W	SAF_RESP_MASK_9			Х				
1	0	1	0	1	1	1	1	\$AF	R/W	SAF_RESP_MASK_10	Cofing record records mack		Х				
1	0	1	1	0	0	0	0	\$B0	R/W	SAF_RESP_MASK_11			Х				
1	0	1	1	0	0	0	1	\$B1	R/W	SAF_RESP_MASK_12			Х				
1	0	1	1	0	0	1	0	\$B2	R/W	SAF_RESP_MASK_13			Х				
1	0	1	1	0	0	1	1	\$B3	R/W	SAF_RESP_MASK_14_pt1			Х				
1	0	1	1	0	1	0	0	\$B4	R/W	SAF_RESP_MASK_14_pt2			Х				
1	0	1	1	0	1	0	1	\$B5	R/W	SAF_RESP_MASK_15_pt1			Х				
1	0	1	1	0	1	1	0	\$B6	R/W	SAF_RESP_MASK_15_pt2			Х				
1	0	1	1	0	1	1	1	\$B7	R/W	SAF_RESP_MASK_16_pt1			Х				
1	0	1	1	1	0	0	0	\$B8	R/W	SAF_RESP_MASK_16_pt2			Х				
1	0	1	1	1	0	0	1	\$B9	R/W	SAF_RESP_TARGET_1			Х				
1	0	1	1	1	0	1	0	\$BA	R/W	SAF_RESP_TARGET_2			Х				
1	0	1	1	1	0	1	1	\$BB	R/W	SAF_RESP_TARGET_3			Х				
1	0	1	1	1	1	0	0	\$BC	R/W	SAF_RESP_TARGET_4	Safing record response target		Х				
1	0	1	1	1	1	0	1	\$BD	R/W	SAF_RESP_TARGET_5			Х				
1	0	1	1	1	1	1	0	\$BE	R/W	SAF_RESP_TARGET_6			Х				
1	0	1	1	1	1	1	1	\$BF	R/W	SAF_RESP_TARGET_7]		Х				

L9680

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22
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								Have	DAM	Nome	Description		Ор	erating S	state ⁽¹⁾	
GID			RIU) / V	VID)		нех	R/W	Name	Description	Init	Diag	Ssafing	Scrap	Arming
1	1	0	0	0	0	0	0	\$C0	R/W	SAF_RESP_TARGET_8			Х			
1	1	0	0	0	0	0	1	\$C1	R/W	SAF_RESP_TARGET_9			Х			
1	1	0	0	0	0	1	0	\$C2	R/W	SAF_RESP_TARGET_10			Х			
1	1	0	0	0	0	1	1	\$C3	R/W	SAF_RESP_TARGET_11			Х			
1	1	0	0	0	1	0	0	\$C4	R/W	SAF_RESP_TARGET_12			Х			
1	1	0	0	0	1	0	1	\$C5	R/W	SAF_RESP_TARGET_13	Sofing record records torget		Х			
1	1	0	0	0	1	1	0	\$C6	R/W	SAF_RESP_TARGET_14_pt1	Saling record response target		Х			
1	1	0	0	0	1	1	1	\$C7	R/W	SAF_RESP_TARGET_14_pt2			Х			
1	1	0	0	1	0	0	0	\$C8	R/W	SAF_RESP_TARGET_15_pt1			Х			
1	1	0	0	1	0	0	1	\$C9	R/W	SAF_RESP_TARGET_15_pt2			Х			
1	1	0	0	1	0	1	0	\$CA	R/W	SAF_RESP_TARGET_16_pt1			Х			
1	1	0	0	1	0	1	1	\$CB	R/W	SAF_RESP_TARGET_16_pt2			Х			
1	1	0	0	1	1	0	0	\$CC	R/W	SAF_DATA_MASK_1			Х			
1	1	0	0	1	1	0	1	\$CD	R/W	SAF_DATA_MASK_2			Х			
1	1	0	0	1	1	1	0	\$CE	R/W	SAF_DATA_MASK_3			Х			
1	1	0	0	1	1	1	1	\$CF	R/W	SAF_DATA_MASK_4			Х			
1	1	0	1	0	0	0	0	\$D0	R/W	SAF_DATA_MASK_5			Х			
1	1	0	1	0	0	0	1	\$D1	R/W	SAF_DATA_MASK_6			Х			
1	1	0	1	0	0	1	0	\$D2	R/W	SAF_DATA_MASK_7	Safing record data mask		Х			
1	1	0	1	0	0	1	1	\$D3	R/W	SAF_DATA_MASK_8			Х			
1	1	0	1	0	1	0	0	\$D4	R/W	SAF_DATA_MASK_9			Х			
1	1	0	1	0	1	0	1	\$D5	R/W	SAF_DATA_MASK_10			Х			
1	1	0	1	0	1	1	0	\$D6	R/W	SAF_DATA_MASK_11			Х			
1	1	0	1	0	1	1	1	\$D7	R/W	SAF_DATA_MASK_12			Х			
1	1	0	1	1	0	0	0	\$D8	R/W	SAF_DATA_MASK_13			Х			

Table 5. Global SPI register map (continued)

L9680

1 1 1 1 1 1 1	0 0 0 0 0 0	RID 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	/ V 1 1 1 1 1 1	/ID 0 0 1	0 1 1 0	1 0 1 0	Hex \$D9 \$DA \$DB	R/W R/W R/W	Name SAF_DATA_MASK_14_pt1 SAF_DATA_MASK_14_pt2	Description	Init	Op Diag X	erating S Ssafing	tate ⁽¹⁾ Scrap	Arming
1 1 1 1 1 1 1	0 0 0 0 0	1 1 1 1 1	1 1 1 1 1	0 0 0 1	0 1 1 0	1 0 1 0	\$D9 \$DA \$DB	R/W R/W	SAF_DATA_MASK_14_pt1 SAF_DATA_MASK_14_pt2	Description	Init	Diag X	Ssafing	Scrap	Arming
1 1 1 1 1 1 1	0 0 0 0 0	1 1 1 1 1	1 1 1 1 1	0 0 0 1	0 1 1 0	1 0 1 0	\$D9 \$DA \$DB	R/W R/W	SAF_DATA_MASK_14_pt1 SAF_DATA_MASK_14_pt2			X			
1 1 1 1 1 1	0 0 0 0	1 1 1 1	1 1 1 1	0 0 1	1 1 0	1 0 1 1 0 1 0 \$ 1 1 0 1 1 0 1 1 \$ 1 1 0 1 1 0 1 1 \$ 1 1 0 1 1 1 0 0 \$	\$DA \$DB	R/W	SAF_DATA_MASK_14_pt2			~			
1 1 1 1	0 0 0	1 1 1	1 1 1	0 1 1	1	1 0	\$DB	R/W				Х			
1 1 1	0 0 0	1	1 1	1	0	0		1.0.00	SAF_DATA_MASK_15_pt1	Sofing record data mask		Х			
1 1 1	0 0	1	1	1	•		\$DC	R/W	SAF_DATA_MASK_15_pt2			Х			
1	0	4		•	0	1	\$DD	R/W	SAF_DATA_MASK_16_pt1			Х			
1		1	1	1	1	0	\$DE	R/W	SAF_DATA_MASK_16_pt2			Х			
	0	1	1	1	1	1	\$DF	R/W	SAF_THRESHOLD_1			Х			
1	1	0	0	0	0	0	\$E0	R/W	SAF_THRESHOLD_2			Х			
1	1	0	0	0	0	1	\$E1	R/W	SAF_THRESHOLD_3			Х			
1	1	0	0	0	1	0	\$E2	R/W	SAF_THRESHOLD_4			Х			
1	1	0	0	0	1	1	\$E3	R/W	SAF_THRESHOLD_5			Х			
1	1	0	0	1	0	0	\$E4	R/W	SAF_THRESHOLD_6			Х			
1	1	0	0	1	0	1	\$E5	R/W	SAF_THRESHOLD_7			Х			
1	1	0	0	1	1	0	\$E6	R/W	SAF_THRESHOLD_8	Sofing record threshold		Х			
1	1	0	0	1	1	1	\$E7	R/W	SAF_THRESHOLD_9			Х			
1	1	0	1	0	0	0	\$E8	R/W	SAF_THRESHOLD_10			Х			
1	1	0	1	0	0	1	\$E9	R/W	SAF_THRESHOLD_11			Х			
1	1	0	1	0	1	0	\$EA	R/W	SAF_THRESHOLD_12			Х			
1	1	0	1	0	1	1	\$EB	R/W	SAF_THRESHOLD_13			Х			
1	1	0	1	1	0	0	\$EC	R/W	SAF_THRESHOLD_14			Х			
1	1	0	1	1	0	1	\$ED	R/W	SAF_THRESHOLD_15			Х			
1	1	0	1	1	1	0	\$EE	R/W	SAF_THRESHOLD_16			Х			
1	1	0	1	1	1	1	\$EF	R/W	SAF_CONTROL_1			Х			
1	1	1	0	0	0	0	\$F0	R/W	SAF_CONTROL_2	Safing record control		Х			
1	1	1	0 0 0 1 \$F1 R/W SAF_CONTROL_3		SAF_CONTROL_3			Х							
	1 1	1 0 1 1	1 0 1 1 1 0 1 1 1 1 1 1	$\begin{array}{c cccccc} 1 & 0 & 1 & 1 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 0 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 0 & 1 \\ 1 & 1 & 1 & 0 \end{array}$	1 0 1 1 1 1 1 0 0 0 1 1 0 0 0 1 1 0 0 0 1 1 0 0 0 1 1 0 0 1 1 1 0 0 1 1 1 0 0 1 1 1 0 0 1 1 1 0 1 0 1 1 0 1 0 1 1 0 1 0 1 1 0 1 0 1 1 0 1 1 1 1 0 1 1 1 1 0 1 1 1 1 0 1 1 1 1 0 1 1 1 1 0 1 1 1 1 0 1 1 1 1 0 0 0 1 1 0 0 0 1 1 0 0 <td>$\begin{array}{c ccccccccccccccccccccccccccccccccccc$</td> <td>1 0 1 1 1 1 1 1 1 0 0 0 0 0 1 1 0 0 0 0 1 1 1 0 0 0 1 0 1 1 0 0 0 1 1 1 1 0 0 1 0 0 1 1 0 0 1 0 0 1 1 0 0 1 0 0 1 1 0 0 1 1 0 1 1 0 1 1 1 0 1 1 0 1 0 1 1 1 1 0 1 0 1 1 1 1 0 1 0 1 1 1 1 0 1 1 0 1 1 1 0 1 1 0 1 1 1 0 1 1 1 0 1 1 0 1 1 1 1 <t< td=""><td>1 0 1 1 1 1 1 \$ 1 1 0 0 0 0 0 \$</td><td>1 0 1 1 1 1 \$1</td></t<><td>1 0 1 1 1 1 \$DF R/W SAF_THRESHOLD_1 1 1 0 0 0 0 \$E0 R/W SAF_THRESHOLD_2 1 1 0 0 0 1 \$E1 R/W SAF_THRESHOLD_3 1 1 0 0 0 1 \$E2 R/W SAF_THRESHOLD_4 1 1 0 0 1 \$E2 R/W SAF_THRESHOLD_5 1 1 0 0 1 \$E3 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 1 1 \$E5 R/W SAF_THRESHOLD_8 1 1 0 1 1 \$E6 R/W SAF_THRESHOLD_10 1 1 0 1 1 \$E7 R/W SAF_THRESHOLD_11 1 1 0</td><td>1 0 1 1 1 1 \$</td><td>1 0 1 1 1 1 \$\vee box \$\v</td><td>1 0 1 1 1 1 \$</td><td>1 0 1 1 1 1 \$</td><td>1 0 1</td></td>	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	1 0 1 1 1 1 1 1 1 0 0 0 0 0 1 1 0 0 0 0 1 1 1 0 0 0 1 0 1 1 0 0 0 1 1 1 1 0 0 1 0 0 1 1 0 0 1 0 0 1 1 0 0 1 0 0 1 1 0 0 1 1 0 1 1 0 1 1 1 0 1 1 0 1 0 1 1 1 1 0 1 0 1 1 1 1 0 1 0 1 1 1 1 0 1 1 0 1 1 1 0 1 1 0 1 1 1 0 1 1 1 0 1 1 0 1 1 1 1 <t< td=""><td>1 0 1 1 1 1 1 \$ 1 1 0 0 0 0 0 \$</td><td>1 0 1 1 1 1 \$1</td></t<> <td>1 0 1 1 1 1 \$DF R/W SAF_THRESHOLD_1 1 1 0 0 0 0 \$E0 R/W SAF_THRESHOLD_2 1 1 0 0 0 1 \$E1 R/W SAF_THRESHOLD_3 1 1 0 0 0 1 \$E2 R/W SAF_THRESHOLD_4 1 1 0 0 1 \$E2 R/W SAF_THRESHOLD_5 1 1 0 0 1 \$E3 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 1 1 \$E5 R/W SAF_THRESHOLD_8 1 1 0 1 1 \$E6 R/W SAF_THRESHOLD_10 1 1 0 1 1 \$E7 R/W SAF_THRESHOLD_11 1 1 0</td> <td>1 0 1 1 1 1 \$</td> <td>1 0 1 1 1 1 \$\vee box \$\v</td> <td>1 0 1 1 1 1 \$</td> <td>1 0 1 1 1 1 \$</td> <td>1 0 1</td>	1 0 1 1 1 1 1 \$ 1 1 0 0 0 0 0 \$	1 0 1 1 1 1 \$1	1 0 1 1 1 1 \$DF R/W SAF_THRESHOLD_1 1 1 0 0 0 0 \$E0 R/W SAF_THRESHOLD_2 1 1 0 0 0 1 \$E1 R/W SAF_THRESHOLD_3 1 1 0 0 0 1 \$E2 R/W SAF_THRESHOLD_4 1 1 0 0 1 \$E2 R/W SAF_THRESHOLD_5 1 1 0 0 1 \$E3 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 0 1 \$E5 R/W SAF_THRESHOLD_6 1 1 0 1 1 \$E5 R/W SAF_THRESHOLD_8 1 1 0 1 1 \$E6 R/W SAF_THRESHOLD_10 1 1 0 1 1 \$E7 R/W SAF_THRESHOLD_11 1 1 0	1 0 1 1 1 1 \$	1 0 1 1 1 1 \$\vee box \$\v	1 0 1 1 1 1 \$	1 0 1 1 1 1 \$	1 0 1

Table 5.Global SPI register map (continued)

SPI interfaces

L9680

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										Table 5.Glo	bal SPI register map (continued)																								
GID																									Цох	DW	Namo	Description	Operating State ⁽¹⁾						
GID				, , ,	VIL	,		пех		Naille	Description	Init	Diag	Ssafing	Scrap	Arming																			
1	1	1	1	0	0	1	0	\$F2	R/W	SAF_CONTROL_4			Х																						
1	1	1	1	0	0	1	1	\$F3	R/W	SAF_CONTROL_5			Х																						
1	1	1	1	0	1	0	0	\$F4	R/W	SAF_CONTROL_6			Х																						
1	1	1	1	0	1	0	1	\$F5	R/W	SAF_CONTROL_7			Х																						
1	1	1	1	0	1	1	0	\$F6	R/W	SAF_CONTROL_8			Х																						
1	1	1	1	0	1	1	1	\$F7	R/W	SAF_CONTROL_9			Х																						
1	1	1	1	1	0	0	0	\$F8	R/W	SAF_CONTROL_10	Safing record control		Х																						
1	1	1	1	1	0	0	1	\$F9	R/W	SAF_CONTROL_11			Х																						
1	1	1	1	1	0	1	0	\$FA	R/W	SAF_CONTROL_12			Х																						
1	1	1	1	1	0	1	1	\$FB	R/W	SAF_CONTROL_13			Х																						
1	1	1	1	1	1	0	0	\$FC	R/W	SAF_CONTROL_14			Х																						
1	1	1	1	1	1	0	1	\$FD	R/W	SAF_CONTROL_15]		Х																						
1	1	1	1	1	1	1	0	\$FE	R/W	SAF_CONTROL_16]		Х																						
1	1	1	1	1	1	1	1	\$FF	R	SAF_CC	Safing Record Compare Complete																								

1. A check mark indicates in which operating state a WRITE-command is valid.

2. KEEP_ERBOOST_ON, LOW_POWER_MODE, VSF_V and VINGOOD_FILT_SEL bits are writable in all states, the other bits of SYS_CFG are only writable in INIT state.

7.3 Global SPI tables

A summary of all the registers contained within the global SPI map are shown below and are referenced throughout the specification as they apply. The SPI register tables also specify the effect of the internal reset signals assertion on each bit field (the symbol '-' is used to indicate that the register is not affected by the relevant reset signal').

Global SPI global status word

The Global SPI of L9680 contains an 11-bit word that returns global status information. The Global Status Word (GSW) of the Global SPI is the most significant 11 bits of MISO_G data.

MISO_G	GSW	Name	POR	WSM	SSM	Description				
31	10	SPIFLT	0	0	0	 SPI Fault, set if previous SPI frame had wrong parity check or wrong number of bits, cleared upon read 0 No fault 1 Fault 				
30	9	DEPOK	0	0	0 General Deployment Successful Flag, logical OR corresponding CHxDS bits (bit 15) in DSRx Registre 0 All the DSRx-CHDS bits are 0 1 At least one of the DSRx-CHDS bits is 1					
29	8	0	0	0	0	Unused				
28	7	WDT/TM_S	0	0	0	State of WDT/TM pin 0 WDT/TM=0 1 WDT/TM=1				
27	6	ERSTATE000Set when Powermode state machine is in ER state 0 Powermode state machine is not in ER state 1 Powermode state machine is in ER state								
26	5	POWERFLT	0	0	0	Fault present in Power State Register, logical OR between bits from 18 to 9 of POWER_STATE Register 0 All the bits from 18 to 9 in the POWER_STATE Registers are 0s 1 At least one of the bits from 18 to 9 in the POWER_STATE Registers is 1				
25	4	FLT	1	1	Fault present in Fault Status Register (FLTSR), logical C between all bits of FLTSR 0 All the bits in the Fault Status Register (FLTSR) are 1 At least one of the bits in the Fault Status Register (FLTSR) is 1					
24	3	CONVRDY2	0	0	0	ADC Conversion of request C or D has been completed so new results are available 0 No new data available 1 New data available				
23	2	CONVRDY1	0	0	0	ADC Conversion of request A or B has been completed so new results are available 0 No new data available 1 New data available				

 Table 6. Global SPI Global Status Word



MISO_G	GSW	Name	POR	WSM	SSM	Description
22	1	ERR_WID	0	0	0	Write address of previous SPI frame is not permitted in current operating phase 0 No Error 1 Error
21	0	ERR_RID	0	0	0	Read address received in the actual SPI frame is unused so data in the response is don't care 0 No Error 1 Error

 Table 6. Global SPI Global Status Word (continued)



Global SPI read/write register

7.3.1 Fault status register (FLTSR)

[19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
MISO	ERCHARGE_OT	MCUFLT_TEST	ERBST_OT	CLKFRERR	,	WD2 r	D2 retry cnt			WD2_LO	MT_2W	WD2_WDR	WD1_LO	WD1_TM	WD1_WDR	MCURST	WSMRST	SSMRST	VCORE_ERR	POR
ID:			00																	
Туре:			R																	
Read:			0000																	
Write:			-																	
ERCHAF	RGE_	<u>о</u> т	o POR	MSW -	- SSM	ER Set	char <u>c</u> wher) No I Fau	ge ove n over Fault ılt	er ten r-temp	npera o con	ture t	oit dete	cted,	cleare	ed on	SPI	read	or PC	R=1	
MCUFLT_TEST 1 1				1	1	MC (U FAI) MC I MC	ULT ti U FL U FL	est m T TM: T TM:	ode - =0 =1	refle	cts M	CU_F	LT_T	M sig	jnal s	tate			
ERBST_OT 0				-	-	ER Set	Boos wher) No I Fau	t ovei n ovei Fault ilt	r-tem r-tem	perati o con	ure bi dition	t dete	cted,	cleare	ed on	SPI	read	or PC	R=1	
CLF	RR	0	-	-	Inte Set	rnal c wher) No I I Fau	oscilla n osc. =ault It	ator cr error	oss-c	heck cted,	error clear	bit ed or	SPI	read	or SU	IPPL	(_PO	R=1		
WD2_retry_cnt[3:0] \$0 \$0						Value of WD2 retry counter														
OTPCF	RR	0	-	-	OTI Set	P CR wher) No I	C erro n OTF =ault It	or bit Perro	r dete	ected	(teste	ed at i	eleas	se of I	POR)	, clea	ired b	y PO	R=1	
۷	LO	0	0	-	WD	2 loci	kout -	refle	cts W	D2 lo	ockout	t state	e							



				0 WD2 Lockout inactive 1 WD2 Lockout active
WD2_TM	0	0	0	WD2 test mode - reflects WD2TM signal state 0 WD2TM=0 1 WD2TM=1
WD2_WDR	0	0	-	WD2 reset latch - set when WD2RESET or STOPPING states are entered, cleared upon read
				0 WD2RST signal = 0 1 WD2RST signal = 1
WD1_LO	0	0	-	WD1 lockout - reflects WD1 lockout state Set and cleared per Watchdog Timer Flow Diagram
				0 WD1 Lockout inactive 1 WD1 Lockout active
WD1_TM	0	0	0	WD1 test mode - reflects WD1TM signal state
				Set and cleared per Watchdog Timer Flow Diagram
				0 WD1TM=0 1 WD1TM=1
WD1_WDR	0	0	-	WD1 reset latch
				Set and cleared per Watchdog Timer Flow Diagram
				0 WD1_WDR signal = 0 1 WD1_WDR signal = 1
MCURST	0	0	-	MCU reset latch - set when MCUFLT pin goes low, cleared upon read
				0 MCURST signal = 0 1 MCURST signal = 1
WSMRST	1	1	-	Watchdog state machine reset
				Set when WSM reset goes to '1', cleared upon SPI read
				0 WSM reset has not occurred1 WSM reset has occurred
SSMRST	1	1	1	Safing state machine reset
				Set when SSM reset goes to '1', cleared upon SPI read
				 0 SSM reset has not occurred 1 SSM Reset has occurred
VCORE_ERR	0	-	-	VCOREMON pin status - set when VCOREMON pin goes out of range, reset upon read



POR

			0 VCORMON in range (VCORE_UV <vcoremon<vcore_ov) 1 VCOREMON out of range (VCOREMON<vcore_uv, or="" vcoremon="">VCORE_OV)</vcore_uv,></vcoremon<vcore_ov)
1	-	-	Power on Reset
			Set when POR goes to '1', cleared upon SPI read

- 0 POR reset has not occurred
- 1 POR Reset has occurred


L9680

7.3.2 System configuration register (SYS_CFG)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0		
MOSI			-		EN_AUTO_SWITCH_OFF	x	LOW_POWER_MODE	KEEP_ERBST_ON	PSINHSEL	HI_LEV_DIAG_TIME	SU_SYNCPULSE_SHIFT_CONF	SQMEAS		VMEAS		NMEAS		DCS_PAD_V	SAFESEL	VSF_V	VINGOOD_FILT_SEL	WD1_T0_DIS
MISO	0	0	0	0	EN_AUTO_SWITCH_OFF	0	LOW_POWER_MODE	KEEP_ERBST_ON	PSINHSEL	HI_LEV_DIAG_TIME	RSU_SYNCPULSE_SHIFT_CONF	SQMEAS	SQMEAS			DCS_PAD_V	SAFESEL	VSF_V	VINGOOD_FILT_SEL	WD1_TO_DIS		
ID: Type: Read: Write:			01 RW 0100 0002																			
EN_AUTO_S\	o POR	0 WSM	0 SSM	Ena mea (able a asure) Auto 1 Auto	uto s ment o swit o swit	witch comp ch off ch off	off IS pletion f disal f enat	RC c n bled bled	urrent	sour	rce ar	nd DC	CS reę	gulato	or afte	er					
LOW_POWE	ER_MO	DDE	0	-	-	Selo VC(,	ectior CBUC) Higl 1 Low	n of ov CK n curr v curre	ver cu ent le ent le	urrent evel vel	dete	ction fo	or SN	YNCE	OOS	T, SA	TBU	CK ar	nd			
KEEP_ER	BST_	ON	0	0	0	ER (Boos) ER 1 ER	t beh Boos Boos	aviou st is d st stay	r duri isable / enal	ng EF ed bled	R state										
PS	SINHS	SEL	1	1	1	PSINH engine mode select Updated by SSM_RESET or SPI write																



HI_LEV_DIAG_TIME

RSU_SYNCPULSE_

SHIFT_CONF

				0 Internal 1 External
DIAG_TIME	0	0	0	Selection of duration of high level squib/pyroswitch diagnostics
				0 Short time (see high level diag diagram)1 Long time (see high level diag diagram)
NCPULSE_	0	0	0	Selection of sync pulses shift duration
				0 Long time
				1 Short time
SQMEAS	00	00	00	Sample number in DC sensor, squib/pyroswitch measurement and temperature conversions
				Updated by SSM_RESET or SPI write
				00 8 samples
				01 16 samples
				10 4 samples 11 2 sample
VMEAS	00	00	00	Sample number in any other voltage measurement conversions
				Updated by SSM_RESET or SPI write
				00 4 samples

00	4 s	sam	p	es	

- 01 16 samples
- 10 8 samples
- 11 1 sample
- DCS_PAD_V 0 0 Passenger inhibit measurement mode 0
 - 0 Current
 - 1 Voltage
 - SAFESEL 1 1 1 Safing engine mode select Updated by SSM_RESET or SPI write 0 Internal safing engine
 - 1 external safing engine



VSF_V	0	0	0	VSF voltage select
				Updated by SSM_RESET or SPI write
				0 20V 1 25V
VINGOOD_FILT_SEL	0	-	-	Selector of filter time for VINGOOD going low (time is fixed to 3.5 μs for VINGOOD going high)
				0 1 μs 1 3.5 μs
WD1_TO_DIS	0	0	-	Disable of initial 500ms timeout function of WD1 state machine
				Updated by WSM_RESET or SPI write
				0 timeout function is enabled1 timeout function is disabled



7.3.3 System control register (SYS_CTL)

[19	18	17	16	15	14	13	12	11 10	9	8 7	6	5	4	3	2	1	0
MOSI			-		RESTART_SYBST_SEL	PD&VRCM_SEL	KEEP_SYNCBST_ON	VIN_TH_SEL	VBATMON_TH_SEL	ER_BST_V	ER_CUR_EN	ER_BST_EN	SYNCBST_EN	SPI_OFF	x	ERSWITCH_LIM_SEL	SYBST_V	SAT_V
MISO	0	0	0	0	RESTART_SYBST_SEL	PD&VRCM_SEL	KEEP_SYNCBST_ON	VIN_TH_SEL	VBATMON_TH_SEL	ER_BST_V	ER_CUR_EN	ER_BST_EN	VSUP_EN	SPI_OFF	0	ERSWITCH_LIM_SEL	∧_rsbst_v	SAT_V
ID:			02															
Туре:			RW															
Read:			0200															
Write:			0004															
RESTART_S)	/BST_	SEL	o POR	MSW .	- SSM	 Selection of comparator used to restart sync boost in erstate (don't care in case SYS_CTL(KEEP_SYNCBST_ON) bit is high) 0 VIN comparator is used; syncboost is switched off entering erstate and switched on once VIN goes above VIN_fastslope threshold. 1 SYNCBST comparator is used; syncboost is switched off entering erstate and switched on when SYNCBST voltage falls down VSYNCBST_RESTART_TH threshold (this condition requires that SYNCBST voltage has been pulled up above the same threshold previously). 											in and	
PD&VR0	CM_S	SEL	0	0	0	Squ thre	uib/py sholo	roswi I sele	tch pull dov ction	wn cu	irrent level	and V		/ leał	kage i	to GN	ID	
							יד 15 m	iA pu	ll down cur	rent a	and 2 mA		, IVI IE8 1 Ieak	akage age ti	0 GN	D three	resno	4 DIC
							1 5 11	iA pu		ient a	anu z ma v	RCIV	i leak	aye u	GIN		511010	1
KEEP_SYNG	CBST_	ON	1	-	-	SYI	NC B	oost b	oehaviour c	luring	IER state							
						() SYN 1 SYN this	NC Bo NC Bo comr	bost is disa bost stay ei mand is rec	bled on hable ceiveo	entering in d in ER sta d during tha	ER s ate. If at sta	tate boos te the	t is O boos	FF in st is s	ER s witch	tate a ed on	and
VIN_	TH_S	SEL	0	0	0	VIN (com VIN 1 VIN	parat GOO GOO	ors thresho D= VINgoo D= VINgoo	old se od0 od1	lector							



VBATMON_TH_SEL	00	00	00	VBATMON comparators threshold selector
				00 VINGOOD= VINgood0
				01 VINGOOD= VINgood1
				$11 \text{ VINGOOD} = \text{VINgood}_2$ $11 \text{ VINGOOD} = \text{VINgood}_3$
ER_BST_V	0	0	0	ER Boost voltage select
				Updated by SSM_RESET or SPI write
				0 set 23V boost
				1 set 33V boost
ER_CUR_EN	00	00	00	ER charge / discharge control
				00 Current sources off
				01 ER charge enabled
				10 ER discharge enabled
				The Guilden Sources on
ER_BST_EN	1	1	1	Boost enable
				Updated by SSM_RESET or SPI write
				0 ER_BOOST OFF request
				1 ER_BOOST ON request
SYNCBST_EN	1	1	1	Syncboost enable
				Updated by SSM_RESET or SPI write
				0 SYNC_BOOST OFF request
				1 SYNC_BOOST ON request
SPI_OFF	0	0	0	Go to POWER OFF state from POWERMODE SHUTDOWN state
				Updated by SSM_RESET or SPI write while in POWERMODE SHUTDOWN state
				0 no effect
				1 transition to POWER OFF state
ERSWITCH_LIM_SEL	0	-	-	ERswitch current limitation select
				Updated by POR or SPI write
				0 Low current limit
				1 High current limit is no more available
SYBST_V	0	0	0	Sync Boost voltage select
				Updated by SSM_RESET or SPI write
				0 Low - syncboost=12V
				1 High - syncboost=14.75V



L9680

SAT_V 0 0 0 SatBuck and Satellite Interface voltage select Updated by SSM_RESET or SPI write 0 Low - satbuck=7.2V 1 High - satbuck=9V

7.3.4 SPI Sleep command register (SPI_SLEEP)

		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOS	I			-									\$3C	95X							
MISC)	0	0	0	0	-	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:				03																	
Туре:				W																	
Read:				-																	
Write:				0006	5																
	SLEE	EP_MO	DDE	N/A N/A	MSW N/A	N/A	Nor PO	n-latcl WERI w Dia	ned c MOD	omma E_SF	and th	nat all OWN	lows t state	transi e acco	tion ir ording	nto ⊨to th	e Pov	ver C	ontro	l Stat	е

7.3.5 System status register (SYS_STATE)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
MISO	0	0	0	0	0	0	0	0	0		OPER_CTL_STATE		0	0	0	0	0		POWER_CTL_STATE	
ID:			04																	
Туре:			R																	
Read:			0400)																
Write:			-																	
OPER_CTL_	STATE	[2:0]	00 POR	WSM 000	WSS 000 00) Rep Upo (oorts dated 000 =	Opera per F INIT	ating (Power	Contro Up P	ol Sta hase	ate s dia	gram							



				001 = DIAG
				010 = SAFING
				011 = SCRAP
				100 = ARMING
				101 unused
				110 unused
				111 unused
POWER CTL STATE[2:0]	000	-	-	Reports Power Control State
				Updated per Power Control State Flow Diagram
				000 = AWAKE
				001 = STARTUP
				010 = RUN
				011 = ER
				100 = POWER MODE SHUTDOWN
				101 unused
				110 unused
				111 unused



7.3.6 Power state register (POWER_STATE)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI		-			X	x	X	X	x	X	X	X	X	X	X	X	X	_ X	X	X
MISO	WAKEUP	VBBAD	NOT_VBGOOD	VINBAD	NOT_VINGOOD	S_BST_NOK	SATBUCK_NOK	ER_BST_NOK	VCC_UV	VCC_OV	0	ER_BST_ON	ER_CHRG_ON	ER_LCDIS_ON	ER_HCDIS_ON	ER_SW_ON	S_BST_ACT	SATBUCK_ACT	VCC_ACT	VSF_ACT
ID: Type: Read: Write:			05 R 0500 -)																
	WAKE	ÜP	- POR	- WSM	- SSM	WA Set	KEUF and () WA	P pin s cleare KEUF	status ed bas ⊃ pin < ⊃ pin >	ed or < WU > WU	n volta _off _on	age								
	VBB	AD	-	-	-	VB/ Set	ATMC and VB VB	ON ba cleare ATMC ATMC	d pin s ed bas DN < V DN > V	statu: ed or /BBA /BBA	s n volt: D D	age								
NOT_VBGOOD -				-	-	VB/ Set	ATMC and o VB VB	ON go cleare ATMC ATMC	od pin ed bas DN < V DN > V	i stati ed or /BGC /BGC	us n volta)OD)OD	age								
	VINB	AD	-	-	-	VIN Set (bad and () VIN I VIN	pin st cleare I > VII I < VII	atus ed bas NBAD NBAD	ed or	n volt	age								
NOT_V	'INGO	OD	-	-	-	VIN Set (good and d VIN VIN	d pin s cleare I > VII I < VII	status ed bas NGOC NGOC	ed or DD DD	n volti	age								
S_E	ST_N	OK	-	-	-	SYI	NCBC	DOST	bad p	oin sta	atus									



				Set based on voltage, cleared on SPI read
				1 V_SYNCBOOST < SYNCBOOST_OK 0 V_SYNCBOOST > SYNCBOOST_OK
SATBUCK_NOK	-	-	-	SATBUCK bad pin status
				Set based on voltage, cleared on SPI read
				1 V_SATBUCK < SATBUCK_OK 0 V_SATBUCK > SATBUCK_OK
ER_BST_NOK	-	-	-	ERBOOST pin status
				Set and cleared based on voltage
				1 V_ERBOOST < ERBOOST_OK
				0 V_ERBOOST > ERBOOST_OK
VCC_UV	-	-	-	VCC_UV status
				Set based on voltage, cleared on SPI read
				0 VCC > VCC_UV 1 VCC < VCC_UV
VCC_OV	-	-	-	VCC_OV status
				Set based on voltage, cleared on SPI read
				0 VCC < VCC_OV 1 VCC > VCC_OV
ER_BST_ON	0	-	-	ERBOOST_ON state
				Updated according to ER_BOOST Control Behavior diagram
				0 RBOOST_OFF or ERBOOST_OT state or ER_BST_STBY state (boost not running)
				1 ERBOOST_ON state (boost running)
ER_CHRG_ON	0	0	0	ERCHARGE_ON state
				Updated according to ER_CHARGE Power Mode Control diagram
				0 ERCHARGE_ON = 0
				1 ERCHARGE_ON = 1
ER_LCDIS_ON	0	-	-	ER Low Current Discharge State
				Updated according to ER Low current discharge state diagram
				0 ER_LCDIS_OFF 1 ER_LCDIS_ON



ER_HCDIS_ON	0	-	-	ER High Current Discharge State
				Updated according to ER High Current discharge state diagram
				0 ER_HCDIS_OFF
				1 ER_HCDIS_ON
ER_SW_ON	0	_	-	ER_SWITCH State
				Updated according to ER Switch state diagram
				0 FR SWITCH OFF
				1 ER_SWITCH_ON
	0			
S_BST_ACT	0	-	-	SYNCBOOST Active state
				Updated according to SYNCBOOST Power Mode Control state diagram
				0 SYNCBOOST supply in SYNCBOOST_OFF state
				1 SYNCBOOST supply in SYNCBOOST_ON state
SATBUCK_ACT	0	0	0	SATBUCK Active state
				Updated according to SATBUCK Power Mode Control state diagram
				0 SATBUCK supply in SATBUCK_OFF state
				1 SATBUCK supply in SATBUCK_ON state
VCC_ACT	0	-	-	Buck Active state
				Updated according to VCC Power Mode Control state diagram
				0 VCC supply in VCC_OFF or VCC_SHUTDOWN states
				1 VCC supply in VCC_RAMPUP or VCC_ON states
VSF_ACT	0	0	0	VSF Active state
				Updated according to VSF Control Logic diagram
				0 VSF EN = 0



7.3.7 Deployment configuration registers (DCR_x)

Deployment Configuration Channel 0 (DCR_0) Deployment Configuration Channel 1 (DCR_1) Deployment Configuration Channel 2 (DCR_2) Deployment Configuration Channel 3 (DCR_3) Deployment Configuration Channel 5 (DCR_5) Deployment Configuration Channel 6 (DCR_6) Deployment Configuration Channel 7 (DCR_7) Deployment Configuration Channel 8 (DCR_8) Deployment Configuration Channel 9 (DCR_9) Deployment Configuration Channel A (DCR_A) Deployment Configuration Channel B (DCR_B)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-	·	x	x	x	x			Deploy	/_Time	9	<u>.</u>			Den evnire time	Deb_expire_time	х	PD_CURR_CSR
MISO	0	0	0	0	0	0	0	0			Deploy	/_Time	9				Den evnire time	موه_ومها و_ساله	0	PD_CURR_CSR
ID:			06 (E 07 (E 08 (E 09 (E 08 (E 08 (E 00 (I 00 (I 00 (I 00 (I 00 (I 10 (E 11 (E	DCR DCR DCR DCR DCR DCR DCF DCF DCR DCR	(2,0) (2,2) (2,2) (2,3) (2,3) (2,3) (2,3) (2,3) (2,3) (2,3) (3,4) (3,4) (3,5) (3,6)(
Туре:			RW																	
Read:			0600 0700 0800 0900 0A00 0B00 0C00 0D00 0E00 0F00) (D() (D() (D() (D() (D() (D() (D() (D() (D() (D(CR_0 CR_1 CR_2 CR_3 CR_4 CR_5 CR_6 CR_6 CR_7 CR_8 CR_9))))))))														



DS11615 Rev 3

	1000 1100	(DCF (DCF	R_A) R_B)	
Write:	000C 000E 0010 0012 0014 0016 0018 001A 001C 001E 0020 0022	(DC) (DC) (DC) (DC) (DC) (DC) (DC) (DC)	R_0) R_1) R_2) R_3) R_3) R_4) R_5) R_6) R_7) R_9) R_9) R_8) R_8) R_8)	
	20R	NSM	SSM	
Deploy_Time[5:0]	0000 00	0000 00	0000 00	Default deployment time = 0 us (no deployment, 8 us pulse output on ARM1 pin during PULSE TEST)
				Deployment time: actual deployment time (ms) = Deploy_Time*0.064ms (0.064ms/count up to 4.032ms max)
Dep_Current[1:0]	00	00	00	Deployment Current limit select
				Updated by SSM_RESET or SPI write while in DIAG state 00 Unused (no deploy) 01 1.75A min 10 1.2A min 11 Unused (no deploy)
Dep_expire_time[1:0]	00	00	00	Deploy command expiration timer select
				Updated by SSM_RESET or SPI write while in DIAG state 00 500ms 01 250ms 10 125ms 11 0ms
PD_CURR_CSR	0	0	0	Pull down current control for Common SR connection Updated by SSM_RESET or SPI write 0 PD Current OFF only for channel selected for diagnostic measurement, ON for all other channel
				 PD Current OFF for both channels of the channel pair selected for diagnostic measurement, ON for all other channel



L9680

7.3.8 Deployment command (DEPCOM)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		x	х	x	х	CHBDEPREQ	CHADEPREQ	CH9DEPREQ	CH8DEPREQ	CH7DEPREQ	CH6DEPREQ	CH5DEPREQ	CH4DEPREQ	CH3DEPREQ	CH2DEPREQ	CH1DEPREQ	CHODEPREQ
MISO	0	0	0	0	0	0	0	0	CHBDE	CHADE P	CH9DEP	CH8DEP	CH7DEP	CH6DEP	CH5DEP	CH4DEP	CH3DEP	CH2DEP	CH1DEP	CHODEP
ID:			12																	
Туре:			RW																	
Read:			1200																	
Write:	0024																			
CHx[DEPR	EQ	N/A	MSW X/A	WSS N/A	Cha	annel	x Dei	olov F	Reaue	est - n	on-la	tched	char	nel-s	pecifi	c der	olov re	eaues	st
						() No (1 Clea DEF	chang ar and PLOY	ge to d star _EN/	deplo t Expi \BLEI	ymen ratior D stat	t cont time te	trol fo r if in	r cha ARM	nnel : ING (x or SA	FING	state	and	in
	CHxE)EP	0	0	0	Cha Set ANI Clea	annel wher D in D ared o oloy E	x dep SPI_ EP_I on SS xpira	Doloym _DEP ENAE SM_R tion T	ent ex COM BLED ESET	kpirat (CHx state COR x read	ion tir DEPF when ches	mer e REQ= in DI timeo	nable 1) AN EP_D out thr	ID in / ISAB eshol	ARMI LED	NG o state	r SAF OR v	ING : /hen	state
							1 Exp) Exp	iratio iratio	n time n Tim	er ena er dis	ibled ablec	- Dep I - De	loy co ploy o	omma comm	and st nand r	till val no mo	id ore va	alid		



7.3.9 Deployment status registers (DSR_x)

Deployment Status Channel 0 (DSR_0) Deployment Status Channel 1 (DSR_1) Deployment Status Channel 2 (DSR_2) Deployment Status Channel 3 (DSR_3) Deployment Status Channel 5 (DSR_5) Deployment Status Channel 6 (DSR_6) Deployment Status Channel 7 (DSR_7) Deployment Status Channel 8 (DSR_8) Deployment Status Channel 8 (DSR_9) Deployment Status Channel A (DSR_A) Deployment Status Channel B (DSR_B)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
MISO	0	0	0	0	CHxDS	CHxSTAT	0	DCRXERR								DE	EP_CH	x_Exp1	Timer	
ID:			13 (E 14 (E 15 (E 16 (E 17 (E 18 (E 19 (E 18 (E 19 (E 18 (E 10 (I 10 (I 10 (I 10 (I	DSR DSR DSR DSR DSR DSR DSR DSR DSR DSR	_0) _1) _2) _3) _4) _5) _6) _7) _6) _7) _8 _9) _2_8) _2_8) _2_8)															
Туре:			R																	
Read:			1300 1400 1500 1600 1700 1800 1800 1800 1800 1000 1000 1E00) (DS)) (DS)	SR_0 SR_1 SR_2 SR_3 SR_3 SR_4 SR_5 SR_6 SR_6 SR_6 SR_6 SR_6 SR_8 SR_8 SR_8 SR_8))))))))														

Write:



	POR	WSM	SSM	
CHxDS	0	0	0	Channel x deployment successful
				Updated according to Deployment Driver Control Logic
				cleared on SSM_RESET OR when deployment starts on ch x)
				0 Deployment not successful
				1 Deployment successful
CHxSTAT	0	0	0	Channel x deployment status
				Updated according to Deployment Driver Control Logic
				(set when deployment starts on ch x, cleared on SSM_RESET OR when deployment terminates due to deploy timer timeout, LS Over current OR GND Loss)
				0 Deployment not in progress
				1 Deployment in progress
DCRxERR	0	0	0	Deployment configuration register error
				0 Deploy configuration change accepted and stored in memory
				1 Deploy configuration change rejected because deploy is in progress (or DEP_EXPIRE_TIME changed when in DEP_ENABLED state)
DEP_CHx_ExpTimer[5:0]	0000	0000	0000	Channel x Deployment Expiration Timer value 8ms/count
	00	00	00	Updated according to Deployment Driver Control Logic
				(Cleared on SSM_RESET OR when Exp Timer times out OR when SPI_DEPREQx is received while in DEP_ENABLED state AND in ARMING or SAFING states)



7.3.10 Deployment current monitor registers (DCMTSxy)

Deployment Current Monitor Status Channel 0,1 (DDCMTS01) Deployment Current Monitor Status Channel 2,3 (DDCMTS23) Deployment Current Monitor Status Channel 4,5 (DDCMTS45) Deployment Current Monitor Status Channel 6,7 (DDCMTS67) Deployment Current Monitor Status Channel 8,9 (DDCMTS89) Deployment Current Monitor Status Channel A,B (DDCMTSAB)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
MISO	0	0	0	0			Curren	t_Mon	_Timer	_y[7:0]					Curren	it_Mon	_Timer	_x[7:0]		
ID:			1F (C 20 (C 21 (C 22 (C 23 (C 24 (C		ATSO ATS2 ATS4 ATS6 ATS8 ATS8)1) 23) 5) 57) 39) AB)														
Туре:			R																	
Read:			1F00 2000 2100 2202 2300 2400	(DD (DD (DD (DD (DD (DD	CMT CMT CMT CMT CMT CMT	S01 S23 S45 S67 S89 SAB))))													
Write:			-																	
Current_Mon_ ⁻	Timer_y	/[7:0]	00\$	WSM \$00	WSS \$00	Cha DCI Set cha mor	nnel MTSx to de nnel y	y cur y. fault (y. Inci hresh	rent n (clear remer nold o	nonito ed) o nts ea n cha	or time n SSM ach 16	er val M_RE ∂µs w y	ue co SET hile c	rresp or wh leploy	oondir nen a /ment	ng to a new o t curre	SPI c deplo ent e>	omma ymen kceed	and t stari s	s on
Current_Mon_1	Timer_>	(7:0]	\$00	\$00	\$00	Cha DCI Set cha mor	nnel MTSx to de nnel x nitor t	x cur y. fault (k. Inc hresh	rent n (clear remei nold o	nonito ed) o nts ea n cha	n SSN ach 16 innel y	er val M_RE ôµs w y	ue co SET /hile c	orresp or wh leploy	oondir nen a ymen	ng to s new o t curro	SPI c deplo ent ex	omma ymen kceed	and t stari Is	s on



	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-								DE	EPEN_	WR[15	5:0]						
MISO	0	0	0	0							DEF	PEN_S	TATE[15:0]						
ID:			25																	
Туре:			RW																	
Read:			2500)																
Write:			004A	۱																
			POR	WSM	SSM															
DEPEN_	WR[1	5:0]	N/A	N/A	N/A	Nor	n-latcl	hed e	ncod	ed va	lue fo	or LO	CK/l	JNLO	CK c	omma	and			
						ę	\$0FF(CK - e	enter I	DEP_	DISA	BLEI	D stat	e					
						ŝ	\$F00F	= UNI	_OCk	(- ent	er DE	EP_E	NABL	ED s	tate.					
DEPEN_ST	TATE[1	5:0]	\$0FFC	\$0FFC	\$0FF	0Dep	oloy E	nable	ed Sta	ate										
						Upo	lated	acco	rding	to Gl	obal S	SPI D	eploy	/ment	Enal	ole St	ate D	iagra	m	

7.3.11 Deploy enable register (SPIDEPEN)

\$0FF0 In DEP_DISABLED state \$F00F In DEP_ENABLED state

7.3.12 Deployment ground loss register (LP_GNDLOSS)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
MISO	0	0	0	0	0	0	0	0	GNDLOSSB	GNDLOSSA	GNDLOSS9	GNDLOSS8	GNDLOSS7	GNDLOSS6	GNDLOSS5	GNDLOSS4	GNDLOSS3	GNDLOSS2	GNDLOSS1	GNDLOSSO
ID:			26																	
Туре:			R																	
Read:	d: 2600																			
Write:			-																	
GN	IDLOS	SSx	o POR	MSW o	0 SSM	Loo Clea duri resi	p x S ared u ng de stanc) Loss I Loss	quib/µ upon eployr e) s of g s of g	oyros SSM_ nent o rounc	witch _RES or loo I not (I dete	Grou ET o p dia detec	ınd lo r SPI g's (⊦ ted	ss read. IS sw	Set v test,	when LS si	GND w test	loss t, squ	is de ib/pyi	ecteo oswit	ł ch



		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				-		х	Х	х	х	х	Х	Х	Х	х	х	х	х	х	х	х	х
MISO		0	0	0	0	0	0	0	0	0	DE	EVICE	ID	0	0			VE	RSN		
ID:				27																	
Туре:				R																	
Read:				2700)																
Write				_																	
	N WS W SS M																				
				д	Š	S															
	DEV	ICE	ID	-	-	-	lde	ntifica	ation c	of the	devic	е									
							Sta	tic va	lue - I	never	upda	ted									
								001	Low e	nd											
								010	Mediu	m eno	k										
								011 I	High e	end											
	١	/ER	SN	-	-	-	lde	ntifica	ation o	of the	silico	n ver	sion								
							Sta	tic va	lue - I	never	upda	ted									
								0000	00 AA	versi	on										
								0000	01 AB	versi	on										
								0010	00 BA	versi	on										
								0010	01 BB	versi	on										
								0100	00 CA	versi	on										
								0100	01 CE	s versi	on										
								0100	10 CC	versi	on										

7.3.13 Device version register (VERSION_ID)



L	.9	6	8	0
		•	•	•

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-	-			WD	2_ERR	_тн	WD2_	RETR	Y_TH	х	х	х	х	х	WD1	_RETR	Ү_ТН
MISO	0	0	0	0	0	0	WD	2_ERR	_тн	WD2_	RETR	Y_TH	0	0	0	0	0	WD1	_RETR	Ү_ТН
ID:			28																	
Туре:			RW																	
Read:			2800)																
Write:			0050)																
WD2_I	ERR_	TH	NOT 4	WSM 4	- SSM	WD WD	2 erro 2_ST	or cou OP s	inter t tate)	hresł	nold (numl	per of	W2 r	eset	perm	itted	befor	e goin	ig to
WD2_RE	TRY_	TH	4	4	-	WD WD	2 retr 2_Lo	y cou ckout	nter tl and i	nresh ncrer	old (r nent '	numb WD2	er of \ _ERR	N2 ei cnt)	rors	perm	itted	befor	e asse	erting
WD1_RE	TRY_	TH	7	7	-	WD WD	1 retr 1_LC	y cou CKO	nter t UT=1	hresh)	old (ı	numb	er of	WD e	errors	perr	nitted	l befo	re lato	ching

7.3.14 Watchdog retry configuration register (WD_RETRY_CONF)

7.3.15 Microcontroller fault test register (MCU_FLT_TEST)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-								MCU	_FLT_	TEST N	lode						
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			29																	
Туре:			W																	
Read:			-																	
Write:			0052	2																
MCU_FL	.T_TE	ST	\$0FF0 POR	\$0FF0WSM	\$0FF0 SSM	MC pre	U Fa vents \$0FF	ult Tes reset 0 Mas F Do i	st Moo sk MC not ma	de - A UFLT ask M	llows ERI	s the R :LT_E	maski ERR	ng of	the I	MCU	FLT_	ERR	and	



7.3.16 Watchdog timer configuration register (WDTCR)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	WD1_MODE			WD.	TMIN[6	6:0]					WD	TDELT	A[6:0]		
MISO	0	0	0	0	0	WD1_MODE			WD.	TMIN[6	6:0]					WD	TDELT	A[6:0]		
ID: Type: Read: Write:			2A RW 2A00 0054)																
WD	1_MO	DE	o POR	MSW 0	- SSM	WD Upo (01 Mo dated 0 Fas 1 Slo	de by W st WD w WE	/SM_F 01 moo 01 mo	RESE de - r de - i	T or anomin	SPI v al 8µ nal 64	vrite w is time 4µs tin	/hile i er res ner re	n WE olutic esolu	D1_IN on (2r tion (IIT st ns m 16.3r	ate ax va ns ma	lue) ax valı	le)
WDT	MIN[6:0]	\$32	\$32	2 -	WD 400 Upo)1 win)µs in dated	idow i WD1 by W	minim fast r ′SM_F	um va node RESE	alue -) T or :	reso SPI v	olution vrite w	acco /hile i	rding n WE	to W D1_IN	/D1_N	MODE ate	E bit (\$	32 =
WDT	WDTMIN[6:0] \$19 \$19 -)1 wir ordin dated	idow g to V by W	delta \ VD1_N ′SM_F	/alue //ODI RESE	- WE E bit (OTMA (\$19 SPI v	X=Wi = 200 vrite w	DTMI µs in /hile i	N+W WD1 n WE	DTD fast 01_IN	ELTA mode	- res e) ate	olutior	ו



	г		-												1				1	1	
		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOS	I			-		х	Х	х	х	х	Х	х	Х	х	х	х	Х	х	х	WD1C	TL[1:0]
MISC)	0	0	0	0				WD1_T	IMER				0	0	0	0	0	0	WD1C	TL[1:0]
ID:				2B																	
Туре:				RW																	
Read:				2B01																	
Write:				0056	;																
V	VD10	CTL[1	1:0]	8 POR	0 WSM	WSS 00	WE Upo	01 Co dated 00 N 01 C 10 C 11 N	ntrol o by S OP ode 'A ode 'E OP	comm SM_R A' 3'	and ESE	T or S	SPI w	vrite							
V	VD1_	_TIM	ER	\$00	\$00) \$0() WE Cle whi	01 Wii ared le in \	ndow by SS WD1_	timer SM_RI _RUN	value ESET or W	e or by D1_T	y WD EST)1 refr state:	esh, i s	incre	ment	ed ev	very 8	us or	64µs

7.3.17 WD1 timer control register (WD1T)



7.3.18 WD state register (WDSTATE)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	Х	х	х	Х	Х	Х	Х	Х	Х	Х	Х	Х	х	Х
MISO	0	0	0	0	0	WE	01_ER	R_CNT	[3:0]	WD_	STATE	[2:0]	WD2	ERR	_CNT	[3:0]	V	VD2_S	TATE[2:0	0]
ID:			2C																	
Туре:			R																	
Read:			2C0(D																
Write:			-																	
WD1_ERR_	_CNT[3:0]	0000 POR	000 WSM	- 0	Wa Upo	tchdc dated	og 1 e acco	rror co	ounte to Wa	r atchd	og St	ate D	iagra	m					
WD1_ST	ATE[2	2:0]	000	000) -	Wa Upo	tchdc dated 000 001 010 ⁻ 011 100 0	og stat acco NITIA RUN TEST RESE OVEF	te rding NL T RRIDE	to Wa	atchd	og St	ate D	iagra	m					
WD2_ERR_	_CNT[3:0]	0000	000	0 -	Wa Upo	tchdc dated	g 2 e acco	rror co rding	ounte to Wa	r atchd	og St	ate D	iagra	m					
WD2_S	TATE[3:0]	0000	000	0 -	Wa Upo	Updated according to Watchdog State Diagram Watchdog state Updated according to Watchdog State Diagram 0000 INITIAL 0001 OVERRIDE 0010 INITSEED 0011 RUN 0100 TEST 0101 QUAL 0110 LOCK 0111 STOPPING 1000 STOP													



L9680

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		x	х	х	х	x	x	VCCBCK F SEL[1:0	 	SATRCK F SFI 11-0		10.11 P. 11 T. 10.20	01 D0 1_L_0EL[1.0]	AUX_SS_DIS	MAIN_SS_DIS		EKB31_F_3EL[1:U]
MISO	0	0	0	0	0	0	0	0	0	0	VCCBCK F SEL		SATROK F SFI		120 1 100/0	01001_L_0EL	AUX_SS_DIS	MAIN_SS_DIS		EKB01_F_0EL
ID: Type: Read: Write:			2D RW 2D00 005A)																
VCCBCK_F	_SEL[[1:0]	00 POR	MSW -	- SSM	VC Upo	CBuc dated 00 1.8 01 2.1 10 2.0	k swit by P 38 MH 13 MH 00 MH	tching OR or Iz Iz Iz Iz	frequ	uency write	sele	ct							
11 2.00 MHz SATBCK_F_SEL[1:0] 00 SatBuck switching frequency select Updated by POR or SPI write 00 1.88 MHz 01 2.13 MHz 10 2.00 MHz 11 2.00 MHz																				
SYBST_F_SEL[1:0] 00 Sync Boost switching frequency select Updated by POR or SPI write 00 1.88 MHz 01 2.13 MHz 10 2.00 MHz 11 2.00 MHz																				
AUX_SS_DIS 1 Auxiliary oscillator Spread Spectrum disable Updated by POR or SPI write 0 Spread Spectrum enabled 1 Spread Spectrum disabled																				

7.3.19 Clock configuration register (CLK_CONF)



MAIN SS DIS	0	_	_	Main oscillator Spread Spectrum disable
	0	-	-	Main Oscillator Opread Opecti din disable
				Updated by POR or SPI write
				0 Spread Spectrum enabled
				1 Spread Spectrum disabled
ERBST_F_SEL[1:0]	00	-	-	ER Boost switching frequency select
				Updated by POR or SPI write
				00 1.88 MHz
				01 2.13 MHz
				10 2.00 MHz
				11 2.00 MHz

7.3.20 Scrap seed read command register (SCRAP_SEED)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-	_	х	х	х	х	х	х	Х	Х	х	Х	Х	х	х	х	х	х
MISO	0	0	0	0	0	0	0	0	0	0	0	0				SEE	D[7:0]			

ID:		2E			
Туре:		R			
Read:		-			
Write:		2E00			
		N/A	WSM N/A	WSS N/A	
	SEED[7:0]	\$00	\$00	\$00	Random scrap seed value - generated from a free-running 8-bit counter



57

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI		-			х	Х	х	х	х	Х	х	Х				KE	/ [7:0]			
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			2F																	
Туре:			W																	
Read:			-																	
Write:			005E	1																
			N/A N/A	WSM N/A	WSS N/A	A														
	KEY[7:	:0]	\$00	\$00	\$00) KE` fror bits	Y valu n the (0, 2	ue sub seed , 4, 6)	omitte value))	d to t usin	he S(g a si	CRAF imple	P state logica	e mac al inv	hine: ersio	(corr n on	ect v the e	alue i ven-r	s deriv umbe	/ed red

7.3.21 Scrap key write command register (SCRAP_KEY)

7.3.22 Scrap state entry command register (SCRAP_STATE)

	-																			
	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-									\$35	535							
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			30																	
Туре:			W																	
Read:			-																	
Write:			0060)																
			N/A	WSM N/A	WSS N/A	Ą														
						Nor	n-latc	hed S	crap \$	State	entry	com	manc	I						
						Ent	er Sc	rap st	tate fro	om D	IAG s	state								



	-																			
_	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-									\$AC	CAC							
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			31																	
Туре:			W																	
Read:			-																	
Write:			0062	2																
			N/A	MSW N/A	WSS N/A	Ą														

7.3.23 Safing state entry command register (SAFING_STATE)

Non-latched Safing State entry command

Enter safing state from DIAG state and clear arming pulse stretch counter (if received in DIAG or SAFING state)

7.3.24 WD2 recover write command register (WD2_RECOVER)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х				\$	AA			
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			32																	
Type:			W																	

Read:	-
Write:	0064

MOd WSS N/A N/A N/A

Non-latched command to clear WD2_retry counter during WD2 LOCK state



	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	х	х	х	Х	х	х	х	х	х	х	х	х	х	х
MISO	0	0	0	0			WD2	_PRE\	/_KEY[7	7:0]					٧	/D2_S	EED[7	:0]		
ID:			33																	
Туре:			R																	
Read:			-																	
Write:			3300)																
			N∕∀ NOR	MSW X/A	WSS N/A	A														
WD2_PREV	_KEY[7:0]	\$0D	\$0D	\$0E) Pre	vious	WD2	key v	alue	- sto	red k	ey fro	m pre	viou	s con	nparis	son		
WD2_SI	EED[7	7:0]	\$F0	\$F0	\$F() Rai	ndom	WD2	seed	valu	e - ge	enera	ted fro	om a	free-	runni	ng 8-	bit co	unter	

7.3.25 WD2 seed read command register (WD2_SEED)

7.3.26 WD2 key write command register (WD2_KEY)

		r		r r				1				r	1	r	r				1	
	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	Х	х	х	х	х	х	х				KE	/ [7:0]			
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			34																	
Туре:			W																	
Read:			-																	
Write:	0068																			
			N/A	MSW N/A	WSS N/A	Ą														
	KEY[7	7:0]	\$0D	\$0E) \$0E	Pre (co + \$	vious rrect v 01 wł	WD2 value nere ‡	key v is der deno	value ived t tes a	- sto from bit-w	red k WD2 /ise X	ey fro _KEY (OR)	m pre = Wl	eviou: D2_S	s con SEED	nparis ‡ Wl	son D2_P	REV_	KEY



	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-				W	D1_TES	ST = \$3	С					W	D2_TE	ST = \$	SC3		
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
ID:			35																	
Туре:			W																	
Read:			-																	
Write:			006A	•																
			N/A	WSM N/A	WSS N/A	N														
			\$0D	\$0D	\$0E) Noi	n-latc	hed V	VD1 a	nd W	D2 T	est C	omma	ands						
						WD Dia	01_TE gram	EST a	nd WI	D2_T	EST	SPI c	omma	and a	s des	scribe	ed in '	Watcl	ndog \$	State

7.3.27 WD test command register (WD_TEST)



	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х	х	Х	х	х		DSTE	ST[3:0]	
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		DSTE	ST[3:0]	

7.3.28	System	diagnostic	register	(SYSDIAGREQ)
--------	--------	------------	----------	--------------

ID:	36
Туре:	RW
Read:	3600
Write:	006C

POR WSM SSM

DSTEST[3:0] 0000 0000 0000 Diagnostic State Test selection

Updated by SSM_RESET or SPI write while in DIAG state

0000 = all outputs inactive 0001 = ARM 1 pin active 0010 = ARM 2 pin active 0011 = ARM 3 pin active 0100 = ARM 4 pin active 0101 = PSINHB pin inactive (high) 0110 = VSF regulator active 0111 = HS squib/pyroswitch driver FET active 1000 = LS squib/pyroswitch driver FET active 1001 = Output deployment timing pulses on ARM1 (separated by 8 ms) 1010 = HS squib/pyroswitch driver FET active to test full path (FET switched off by the

comparator used in the deployment current timer monitor)

1011 - 1111 = all outputs inactive



7.3.29 Diagnostic result register for deployment loops (LPDIAGSTAT)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI					х	х	х	х	х	х	х	х	х	х	х	х	х	х	х	х
MISO	DIAG_LEVEL	TIP	0	FP	FETON	HS_DRV_OK	HSR_HI	HSR_LO		RES MEAS CHSEL/HIGH LEV DIAG SELECTED			SBL	STG	STB	SQP			LEAK_CHSEL	
ID:			37																	
Туре:	R 3700																			
Read:	R 3700 -																			
Write:	3700 -																			
DIAC	R 3700 - AG_LEVEL 0 0 0 Diagnostic mode selector Not present for low level diagnostic Updated by SSM_RESET or SPI write to LPDIAGREQ 0 low level mode 1 high level mode																			
		TIP	0	0	C) Hię Up	gh lev dateo 0 Hig 1 Hig	vel dia d by S gh lev gh lev	gnost SM_F rel dia rel dia	ic tes RESE gnost gnost	t is ru T or ic tes ic tes	unnin Loop st is n st is r	g s diag lot rur unninę	nosti ining 9	c sta	te ma	achine	9		
		FP	0	0	C	Fa Up	ult pro dated 0 Fa 1 Fa	esent d by S iult no iult pr	befor SM_F t pres esent	e requ RESE sent be befor	ueste T or efore e req	ed dia Loop requ jueste	ignost s diag iested ed dia	ic nosti diag gnos	c sta nosti tic	te ma c	achin	e		
	FET	ON	0	0	C	FE Up LS	T act dated FET	ivatio d by S is act	n durii SM_F ivatec	ng dia RESE I durir	ignos T or I ng DI	stic Loop AG s	s diag tate	nosti	c sta	te ma	achine	e or w	∕hen ⊦	IS or



				0 FET is off during diagn	ostic
				1 FET is on during diagr	nostic
	_	_	_		
HS_DRV_OK	0	0	0	FET Test Status	
				Updated by SSM_RESET o full path test is run test is run	r Loops diagnostic state machine or when driver n
				0 HS squib/pyroswitch d	river full path test did not complete successfully
				1 HS squib/pyroswitch d	river full path test complete successfully
HSR_HI	0	0	0	HSR Diagnostic - HIGH Rar	nge
				Updated by SSM_RESET o squib/pyroswitch resistance	r Loops diagnostic state machine or when test is run
				0 HSR measurement < I	HSR HIGH value
				1 HSR measurement > I	HSR HIGH value
HSR_LO	0	0	0	HSR Diagnostic - Low Rang	
				Updated by SSM_RESET o squib/pyroswitch resistance	r Loops diagnostic state machine or when test is run
				1 HSR measurement< F	ISR LOW value
				0 HSR measurement > I	HSR LOW value
RES_MEAS_CHSEL[3:0]	0000	0000	0000) Channel selected for resistance measurement	HIGH_LEV_DIAG_SELECTED[3:0]
				Updated by SSM_RESET o determined by squib/pyrosw	r Loops diagnostic state machine or as <i>i</i> tch resistance channel selected
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0	r Loops diagnostic state machine or as /itch resistance channel selected 0000 No diagnostic selected
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5 0110 = Ch 6	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK 0110 Squib/pyroswitch resistance measurement
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5 0110 = Ch 6 0111 = Ch 7	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK 0110 Squib/pyroswitch resistance measurement 0111 FET test
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5 0110 = Ch 6 0111 = Ch 7 1000 = Ch 8	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK 0110 Squib/pyroswitch resistance measurement 0111 FET test 1000 - 1111 Unused
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5 0110 = Ch 6 0111 = Ch 7 1000 = Ch 8 1001 = Ch 9	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK 0110 Squib/pyroswitch resistance measurement 0111 FET test 1000 - 1111 Unused
				Updated by SSM_RESET o determined by squib/pyrosw 0000 = Ch 0 0001 = Ch 1 0010 = Ch 2 0011 = Ch 3 0100 = Ch 4 0101 = Ch 5 0110 = Ch 6 0111 = Ch 7 1000 = Ch 8 1001 = Ch 9 1010 = Ch A	r Loops diagnostic state machine or as vitch resistance channel selected 0000 No diagnostic selected 0001 VRCM CHECK 0010 Leakage CHECK 0011 Short Between Loops CHECK 0100 ER cap ESR measure 0101 Squib/pyroswitch resistance range CHECK 0110 Squib/pyroswitch resistance measurement 0111 FET test 1000 - 1111 Unused

0100 - 1111 None Selected



SBL	0	0	0	Short between loop state
				Updated by SSM_RESET or Loops diagnostic state machine
				0 Short between squib/pyroswitch loops is not present
				1 Short between squib/pyroswitch loops is present
STG	0	0	0	Short to Ground Test Status
				Updated by SSM_RESET or Loops diagnostic state machine or as determined by squib/pyroswitch leakage diagnostic
				0 STG not detected
				1 STG detected
STB	0	0	0	Short to Battery Test Status
				Updated by SSM_RESET or Loops diagnostic state machine or as determined by squib/pyroswitch leakage diagnostic
				0 STB not detected
				1 STB detected
SQP	0	0	0	Squib/pyroswitch PIN where leakage test has been performed
				Updated by SSM_RESET or Loops diagnostic state machine or as determined by squib/pyroswitch leakage diagnostic
				0 SRx
				1 SFx
LEAK_CHSEL[3:0]	0000	0000	0000	Channel selected for leakage measurement
				Updated by SSM_RESET or Loops diagnostic state machine or as determined by squib/pyroswitch leakage diagnostic
				0000 = Ch 0
				0001 = Ch 1
				0010 = Ch 2
				0011 = Ch 3
				0100 = Ch 4
				0101 = Ch 5
				0110 = Ch 6
				0111 = Ch 7
				1000 = Ch 8
				1001 = Ch 9
				1010 = Ch A
				1011 = Ch B
				1100 - 1111 None Selected



7.3.30 Loops diagnostic configuration command register for low level diagnostic (LPDIAGREQ)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		DIAG_LEVEL	ISRC_CURR_SEL	PD_CURR		ISRC [1:0]	ISINK				ZES MEAS CHSELI3-01					LEAK_CHSEL[3:0]	
MISO	0	0	0	0	DIAG_LEVEL	ISRC_CURR_SEL	PD_CURR		ISRC [1:0]	ISINK	VPCMI1-01			RES MEAS CHSEL [3:0]E					LEAK_CHSEL[3:0]	
ID: Type: Read: Write:			38 RW 3800 0070																	
DIAG	6_LEV	/EL	o POR	o WSM	0 SSM	 Diagnostic mode selector Updated by SSM_RESET or SPI write 0 low level mode 1 N/A - see description below 														
ISRC_CU	RR_S	SEL	0	0	0	Sel	ectior 0 40r 1 8m	n of IS mA A	SRC c	urren	t valu	e								
PC	D_CU	RR	0	0	0	Pul	l dow dated 0 Re ON 1 Re	n curr by S quest l for a quest	rent co SM_R OFF III othe	ontrol ESE ⁻ only f r cha for al	T or S or ch nnels I char	SPI w anne s nnels	rite Is cor	nect	ed to	VRC	CM or	ISINI	K or IS	SRC,
IS	RC [[^]	1:0]	00	00	00	Hig Upo	h side dated 00 = 0	e curr by S OFF	ent so SM_R	urce ESE	for ch T or S	nanne SPI w	el sele rite	ected	in RI	ΞS_N	IEAS	_CH	SEL[3:	0]

57

				01 = ON 40 mA/ 8 mA current for channel selected in RES_MEAS_CHSEL, OFF on all other channels
				10 = ON bypass current for channel selected in RES_MEAS_CHSEL, OFF ON all other channels
				11 = ON ISRC 40mA or 8mA current for channel selected in RES_MEAS_CHSEL and connect the SRM Differential Amplifier to the other squib/pyroswitch channel of the selected channel pair
ISINK	0	0	0	Low Side current sink control (max 50mA)
				Updated by SSM_RESET or SPI write
				0 All channels OFF
				1 ON for channel selected by RES_MEAS_CHSEL[3:0], OFF on all other channels
VRCM[1:0]	00	00	00	Voltage Regulator Current Monitor control
				Updated by SSM_RESET or SPI write
				00 VRCM not connected
				01 VRCM connected to SFx of channel selected by LEAK_CHSEL[3:0]
				10 VRCM connected to SRx of channel selected by LEAK_CHSEL[3:0] and pull down current of the same channel disabled
				11 VRCM connected to SRx of channel selected by LEAK_CHSEL[3:0] and pull down current of the same channel enabled (ISINK and ISRC must be switched off)
RES_MEAS_CHSEL[3:0]	0000	0000	0000) Squib/pyroswitch Resistance Measurement Channel select - selects the channel and muxes for the resistance test, and the channel for HS driver test (full path fet test) activation
				Updated by SSM_RESET or SPI write
				0000 Channel 0
				0001 Channel 1
				0010 Channel 2
				0011 Channel 3
				0100 Channel 4
				0101 Channel 5
				0110 Channel 6
				0111 Channel 7
				1000 Channel 8
				1001 Channel 9
				1010 Channel A
				1011 Channel B
				0100 - 1111 None Selected



LEAK_CHSEL[3:0] 0000 0000 0000 Squib/pyroswitch Leakage Measurement Channel select - selects the channel and muxes for the leakage test, and the channel for HS/LS FET test activation.

Updated by SSM_RESET or SPI write

- 0000 Channel 0
- 0001 Channel 1
- 0010 Channel 2
- 0011 Channel 3
- 0100 Channel 4
- 0101 Channel 5
- 0110 Channel 6
- 0111 Channel 7
- 1000 Channel 8
- 1001 Channel 9
- 1010 Channel A
- 1011 Channel B
- 0100 1111 None Selected

7.3.31 Loops diagnostic configuration command register for high level diagnostic (LPDIAGREQ)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		DIAG_LEVEL	х	×	×	x	x	х	x		HIGH_LEVEL_DIAG_SEL		SQP			LOOP_DIAG_CHSEL[3:0]	
MISO	0	0	0	0	DIAG_LEVEL	0	0	0	0	0	0	0		HIGH_LEVEL_DIAG_SEL		SQP			-00P_DIAG_CHSEL[3:0]	

ID:	38			
Туре:	RW			
Read:	3800			
Write:	0070			
DIAG_LEVEL	o POR	o WSM	WSS 0 E 0	Diagnostic mode selector) 0 N/A - see description above 1 1 high level mode
HIGH_LEVEL_DIAG_SEL	. 000	000 C	00 S	Selection of high level squib/pyroswitch diagnostic Jpdated by SSM_RESET or SPI write 000 No diagnostic selected 001 VRCM CHECK 010 Leakage CHECK 011 Short Between Loops CHECK 100 ER cap ESR measure 101 Squib/pyroswitch resistance range CHECK 110 Squib/pyroswitch resistance measurement 111 FET test
SQP	0	0	0 S	Squib/pyroswitch pin select for all leakage diagnostic Jpdated by SSM_RESET or SPI write


- 0 SRx
- 1 SFx

LOOP_DIAG_CHSEL[3:0] 0000 0000 0000 Channel select - selects the channel and muxes for all squib/pyroswitch diagnostic.

Updated by SSM_RESET or SPI write

0000 Channel 0 0001 Channel 1 0010 Channel 2 0011 Channel 3 0100 Channel 4 0101 Channel 5 0110 Channel 6 0111 Channel 7 1000 Channel 8 1001 Channel 9 1010 Channel A 1011 Channel B 1100 - 1111 None Selected

7.3.32 DC sensor diagnostic configuration command register (SWCTRL)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		×	x	x	x	×	x	x	TOdHNISd	DCS_PDCURR	NHORN	x	x		СНІ	D[3:0]	
MISO	0	0	0	0	0	0	0	0	0	0	0	PSINHPOL	DCS_PDCURR	SWOEN	0	0		СНІ	D[3:0]	

ID:		39			
Туре:		RW			
Read:		3900			
Write:		0072			
	PSINHPOL	o POR	o WSM	0 SSM	Selector of in range/ out of range for passenger inhibit function 0 if result is inside thresholds the counter is initialized to start value 1 if result is outside thresholds the counter is initialized to start value
DCS	_PDCURR	0	0	0	Disable of all pull down current for DC sensor



				Updated by SSM_RESET or SPI write
				0 OFF for channel under voltage or current measurement, ON for all other channels
				1 OFF for all channels
SWOEN	0	0	0	Switch Output Enable
				Updated by SSM_RESET or SPI write
				0 OFF
				1 ON
CHID[3:0]	0000	0000 (0000	Channel ID - selects DC sensor channel for output activation
				Updated by SSM_RESET or SPI write
				0000 Channel 0
				0001 Channel 1
				0010 Channel 2
				0011 Channel 3
				0100 Channel 4
				0101 Channel 5
				0110 Channel 6
				0111 Channel 7

1000 Channel 8 0100 - 1111 None Selected



7.3.33 ADC request and data registers (DIAGCTRL_x)

ADC A control command (DIAGCTRL_A)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х	х			ADC	CREQ_	_A[6:0]		
MISO	NEWDATA_A	Y A												А	DCRE	S_A[9	0:0]			

ID:	3A
Туре:	RW
Read:	3A00
Write:	0074

ADC B control command (DIAGCTRL_B)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х	х			ADO	CREQ_	_B[6:0]		
MISO	NEWDATA_B	0	0		ADCREQ_B[6:0]									A	DCRE	S_B[9	:0]			

ID:	3B
Туре:	RW
Read:	3B00
Write:	0076

ADC C control command (DIAGCTRL_C)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х	х			ADO	CREQ_	_C[6:0]		
MISO	NEWDATA_C	0	0 0 ADCREQ_C[6:0]											A	DCRE	S_C[9	9:0]			

ID:	3C
Туре:	RW
Read:	3C00
Write:	0078



L9680

ADC D control command (DIAGCTRL_D)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	х	х	х	х	х	х	х	Х			ADO	CREQ_	_D[6:0]		
MISO	NEWDATA_D	0	0			ADC	REQ_	D[6:0]						A	DCRE	S_D[§	9:0]			
ID:			3D																	
Туре:			RW																	
Read:			3D00)																
Write:			007A	۹.																
NEW	/DAT/	A_x	o POR	0 WSM	0 SSM	Nev	w data dated 0 cle 1 cor	a avai by S ared o nvertio	ilable SM_R on rea on finis	from ESE ⁻ d shed	conve T or A	ertior	ı state r	nach	ine					
ADCRE	Q_x[t	5:0]	\$00	\$00) \$0() AD Up	C Rei dated Meas \$00 L \$01 G \$02 F \$03 C \$04 C \$05 C \$05 C \$06 S \$07 Ii \$08 Ii \$08 Ii \$08 C \$07 C \$00	quest by S urema Junuse Formation CSx CSx CSx CSx CSx CSx CSx CSx CSx CSx	selec SM_R ent d Ref ale Ref voltag currer resista pyrosv al BG i al BG i voltag voltag voltag voltag voltag voltag	t com ESE ² ef e nt ance witch refere monit e ge ge ge ge ge ge ge ge ge ge ge	mano T or S ence 1 or vo	d 6PI w istan voltage	ce ge (BG (BGN	GR) J	GCTI	RL_x				



- \$14 Vb voltage of ER ESR measure (valid only for ADCREQ_x field of MISO response when ESR measure results are available)
- \$15 Va voltage of ER ESR measure (valid only for ADCREQ_x field of MISO response when ESR measure results are available)
- \$16 Vc voltage of ER ESR measure (valid only for ADCREQ_x field of MISO response when ESR measure results are available)
- \$20 VBATMON pin voltage
- \$21 VIN pin voltage
- \$22 Internal analog supply voltage (VINT)
- \$23 Internal digital supply voltage (VDD)
- \$24 ERBOOST pin voltage
- \$25 SYNCBOOST pin voltage
- \$26 VER pin voltage
- \$27 SATBUCK voltage
- \$28 VCC voltage
- \$29 WAKEUP pin voltage
- \$2A VSF pin voltage
- \$2B WDTDIS pin voltage
- \$2C GPOD0 pin voltage
- \$2D GPOS0 pin voltage
- \$2E GPOD1 pin voltage
- \$2F GPOS1 pin voltage \$30 GPOD2 pin voltage
- \$31 GPOS2 pin voltage
- \$32 RSU0 pin Voltage
- \$33 RSU1 pin Voltage
- \$34 RSU2 pin Voltage
- \$35 RSU3 pin Voltage
- \$36 SS0 pin voltage
- \$37 SS1 pin voltage
- \$38 SS2 pin voltage
- \$39 SS3 pin voltage
- \$3A SS4 pin voltage
- \$3B SS5 pin voltage
- \$3C SS6 pin voltage
- \$3D SS7 pin voltage
- \$3E SS8 pin voltage
- \$3F SS9 pin voltage \$40 SSA pin voltage
- \$41 SSB pin voltage
- \$46 SF0
 - \$47 SF1
 - \$48 SF2 \$49 SF3
 - \$4A SF4
 - \$4B SF5 \$4C SF6

\$4D SF7



\$4E SF8 \$4F SF9 \$50 SFA \$51 SFB

ADCRES_x[9:0] \$000 \$000 10-bit ADC result value corresponding to ADCREQ_x request Updated by SSM_RESET or ADC state machine

7.3.34 Configuration register for switching regulators (SW_REGS_CONF)

_																				
	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		LOW_ERBST_ILIM_ERON	EN_VCC_GNDLOSS_DET	EN_SAT_GNDLOSS_DET	SATBCK_LS_ON_DELAY	VCCBCK_LS_ON_DELAY	SATBCK_FORCE_F_SLOPE	SYBST_FORCE_F_SLOPE	ERBST_FORCE_F_SLOPE	VICCRCK PH SELLI-01			SAIBUR_PH_SEL[1:U]	10-11 IS HI ISAVS			בתסטו_רח_סברן ויען
MISO	0	0	0	0	LOW_ERBST_ILIM_ERON	EN_VCC_GNDLOSS_DET	EN_SAT_GNDLOSS_DET	SATBCK_LS_ON_DELAY	VCCBCK_LS_ON_DELAY	SATBCK_FORCE_F_SLOPE	SYBST_FORCE_F_SLOPE	ERBST_FORCE_F_SLOPE	VCCRCK PH SEI			DAI BUN_FH_DEL	SVBST DH SEI		строст ри се	בחסטו_רח_טבר
ID: Type: Read: Write:			3F RW 3F00)																
Read: Write: LOW_ERBST_ILIM_ERON			o POR	MSW -	- SSM	ER Upo	Boosi dated 0 ER	t curre by P(Boost	ent lim OR or t curre	itatio SPI v ent lim	n beh write nitatic	navio on is l	r selec NOT r	ction educe	ed if	ER S	Switch	is ac	tivate	d
EN_VCC_GND EN_SAT_GND	LOSS_	DET	0	-	-	Nev Upo Nev Upo	1 ER w VCo dated 0 run 1 run w SA ⁻ dated	Boost C grou by P(time time f grou by P(t curre Und lo DR or groun groun Ind los DR or	ent lin ss de SPL d los d los ss de SPL	nitatio etectio write s dete s dete tectio write	on is i on en ectioi ectioi n ena	reduce able n disa n enal able	ed if E bled bled	ER S	witch	is ac	tivate	d	
							0 run	time	groun	d los	s det	ectio	n disa	bled						

DS11615 Rev 3



				1 run time ground loss detection enabled
SATBCK_LS_ON_DELAY	0	-	-	SATBuck low side activation delay Updated by POR or SPI write
				0 No delay is applied
				1 Delay is applied
VCCBCK_LS_ON_DELAY	0	-	-	SVCCBuck low side activation delay Updated by POR or SPI write
				0 No delay is applied
				1 Delay is applied
SATBCK_FORCE_F_SLOPE	0	-	-	SatBuck fast slope selection Updated by POR or SPI write
				0 Fast slope activation depends on VIN voltage
				1 Fast slope is forced ON
SYBST_FORCE_F_SLOPE	0	-	-	SyncBoost fast slope selection Updated by POR or SPI write
				0 Fast slope activation depends on VIN voltage
				1 Fast slope is forced ON
ERBST_FORCE_F_SLOPE	0	-	-	ER Boost fast slope selection Updated by POR or SPI write
				0 Fast slope activation depends on VIN voltage
				1 Fast slope is forced ON
VCCBCK_PH_SEL[1:0]	11	-	-	VCCBuck phase shifting selection (if switching frequency is different respect to another regulator, the phase shift between them is not guaranteed) Updated by POR or SPI write
				00 0 ns switching ON shift respect to t0
				01 125 ns switching ON shift respect to t0
				10 250 ns switching ON shift respect to t0
				11 375 ns switching ON shift respect to t0
SATBCK_PH_SEL[1:0]	10	-	-	SatBuck phase shifting selection (if switching frequency is different respect to another regulator, the phase shift between them is not guaranteed) Updated by POR or SPI write
				00 0 ns switching ON shift respect to t0
				01 125 ns switching ON shift respect to t0
				10 250 ns switching ON shift respect to t0
				11 375 ns switching ON shift respect to t0



SYBST_PH_SEL[1:0]	01	-	-	SyncBoost phase shifting selection (if switching frequency is different respect to another regulator, the phase shift between them is not guaranteed) Updated by POR or SPI write
				00 0 ns switching ON shift respect to t0
				01 125 ns switching ON shift respect to t0
				10 250 ns switching ON shift respect to t0
				11 375 ns switching ON shift respect to t0
ERBST_PH_SEL[1:0]	00	-	-	ER Boost phase shifting selection (if switching frequency is different respect to another regulator, the phase shift between them is not guaranteed) Updated by POR or SPI write
				00 0 ns switching ON shift respect to t0
				01 125 ns switching ON shift respect to t0
				10 250 ns switching ON shift respect to t0

7.3.35 Global configuration register for GPO driver function (GPOCR)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			_		х	х	х	х	х	х	х	х	х	х	х	х	х	GPO2LS	GP01LS	GPO0LS
MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	GP02LS	GP01LS	GPO0LS
ID:			42																	
Туре:			RW																	
Read:			4200)																
Write:			0084	Ļ																
	GPO;	ĸLS	o POR	o WSM	0 SSM	GP Upo	O driv dated 0 Hig ena 1 Low to e	ver co by S h-side able G v-side nable	nfigur SM_R e Driv GPO a Drive GPO	ation ESE er co s HS r con as L	bit T or S nfigur) figura S)	SPI w ratior ation	rrite n for G for GF	iPOx POx ((ER_	_BOC	OST_0 GT_0	OK is K is r	requii not rec	red to juired



7.3.36 GPOx control register (GPOCTRLx)

Channel 0 (GPOCTRL0) Channel 1 (GPOCTRL1) Channel 2 (GPOCTRL2)

MOSI		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MISO 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	MOSI			-		х	х	х	х	х	х	х	х	х	х		(GPOxF	PWM[5	:0]	
	MISO	0	0	0	0	0	0	0	0	0	0	0	0	0	0		(GPOxF	PWM[5	:0]	

ID:	43 (GPOCTRL0)
	44 (GPOCTRL1)
	45 (GPOCTRL2)

Туре:

 Read:
 4300 (GPOCTRL0) 4400 (GPOCTRL1) 4500 (GPOCTRL2)

 Write:
 0086 (GPOCTRL0)

RW

- 0088 (GPOCTRL1) 008A (GPOCTRL2)
 - POR WSM SSM

GPOxPWM 000000 000000 000000 6 bit value for PWM% with scaling of 1.6% per count

Updated by SSM_RESET or SPI write



7.3.37 GPO fault status register (GPOFLTSR)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	Х	х	х	х	Х	Х	х	х	х	х	Х	х	х	х
MISO	GPO2DISABLE	GP01DISABLE	GPO0DISABLE	0	GPOS_NOT_CONF	GPO2TEMP	GP02LIM	GPO2ONOPN	GPO20FFOPN	GP02SH0RT	GPO1TEMP	GP01LIM	GP010N0PN	GP010FF0PN	GP01SHORT	GPOOTEMP	GPOOLIM	GPOOONOPN	GPO00FFOPN	GPO0SHORT
ID:			46																	
Туре:			R																	
Read:			4600)																
Write:			-																	
CROST			POR	MSW 1	NSS 1	CP	0.2.4	icable	o etate											
GFOZ	JIGAL		I	 0 GPO enable to work 1 GPO disabled due to thermal fault or configuration not received e ERBOOST not OK (only HS mode) 1 1 GPO 1 disable state 											ed or					
GPO1	DISAE	BLE	1	1	1	GP	O 1 d	isable	e state) Worl	,									
							1 GP ERI	0 disa 3005	abled ST not	due t OK (o the only	rmal HS n	fault o node)	or con	ıfigur	ation	not r	eceiv	ed or	
GPO0	DISAE	BLE	1	1	1	GP	O 0 d	isable	e state	;										
			0 GPO enable to work 1 GPO disabled due to thermal fault or configuration not recei ERBOOST not OK (only HS mode)									eceiv	ed or							
GPOS_NO	T_CC	NF	1	1	1	GP	Os co	onfigu	ration	statu	IS									
							0 GP 1 GP	Os co Os no	nfigur ot yet o	ed (a config	ctiva jured	tion is (acti ^s	s perm vation	nitted is de) enied)				
GP	O2TE	MP	0	0	0	GP	O 2T	herma	al Fau	lt										
						Cle	ared	as rep	oorted	l in G	PO-C	Over ⁻	Temp (diagr	am, s	set by	/ dete	ection	circui	t
							0 Fai	ult not	t dete	cted										
							1 Fa	ult def	tected											



GPO2LIM	0	0	0	GPO 2 Current Limit Flag
				Cleared by SSM_RESET or SPI read, set by detection circuit while ON
				0 Fault not detected
				1 Fault detected
GPO2ONOPN	0	0	0	GPO 2 Open Detection
				Cleared by SSM_RESET or SPI read, set by detection circuit while ON
				0 Fault not detected 1 Fault detected
GPO2OFFOPN	0	0	0	GPO 2 Open detection in OFF condition
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected
GPO2SHORT	0	0	0	GPO 2 Short Detection in OFF condition (short to battery in HS mode, short to ground in LS mode)
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected
GPO1TEMP	0	0	0	GPO 1 Thermal Fault
				Cleared as reported in GPO-Over Temp diagram, set by detection circuit
				0 Fault not detected
				1 Fault detected
GPO1LIM	0	0	0	GPO 1 Current Limit Flag
				Cleared by SSM_RESET or SPI read, set by detection circuit while ON
				0 Fault not detected
				1 Fault detected
GPO10NOPN	0	0	0	GPO 1 Open Detection
				Cleared by SSM_RESET or SPI read, set by detection circuit while ON
				0 Fault not detected 1 Fault detected
GPO10FF0PN	0	0	0	GPO 1 Open detection in OFF condition
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected



GPO1SHORT	0	0	0	GPO 1 Short Detection in OFF condition (short to battery in HS mode, short to ground in LS mode)
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected
GPO0TEMP	0	0	0	GPO 0 Thermal Fault
				Cleared as reported in GPO-Over Temp diagram, set by detection circuit
				0 Fault not detected
				1 Fault detected
GPO0LIM	0	0	0	GPO 0 Current Limit Flag
				Cleared by SSM RESET or SPI read, set by detection circuit while ON
				0 Fault not detected
				1 Fault detected
GP000N0PN	0	0	0	GPO 0 Open Detection
			OK	Cleared by SSM_RESET or SPI read, set by detection circuit while ON
				0 Fault not detected
				1 Fault detected
GP000FF0PN	0	0	0	GPO 0 Open detection in OFF condition
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected
GPO0SHORT	0	0	0	GPO 0 Short Detection in OFF condition (short to battery in HS mode, short to ground in LS mode)
				Cleared by SSM_RESET or SPI read, set by detection circuit while OFF
				0 Fault not detected 1 Fault detected



L9680

		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				-		x	х	x	х	х	х	х			WSS	SSEL	[6:0]			х	WSSTP
MISO		0	0	0	0	0	0	0	0	0	0	0			WSS	SSEL	[6:0]			x	WSSTP
ID:				48																	
Туре:				RW																	
Read:				4800)																
Write:				0090)																
				PO	R	WS	N	SSM													
	WSS	SSEL	[6:0]	0000	000	0000	00 0	00000	0 Wh of t	ieel Sj he fou	beed Ir WS	Sens Sx out	or Se tputs	electio to pla	on - co ce a	ode b statio	elow coutp	v uniq out le	uely : vel or	selects 1	one
										1010	011 V	VSS	Test I	Mode	for W	/S3 (Dutpu	ıt			
										1010	101 \	VSS	Test	Mode	for W	/S2 (Dutpu	ut			
										1011	001 V	VSS	Test I	Mode	for W	/S1 (Dutpu	ut			
										all of	110 V 201 \	1922 1991		viode Iode (tor W disab	/50 (Iod	Jutpu	It			
										anou		100 1	ICSL IN	loue	JISAD	leu					
	,	WSS	STP	0		0		0	WS	Sx Out	put T	est V	alue								
										1 Ou 0 Ou	tput f tput f	or se or se	lecteo lecteo	d WS> d WS>	< set ' < set '	high' Iow'					

7.3.38 Wheel speed sensor test request register (WSS_TEST)



7.3.39 **PSI5/WSS** configuration register for channel x (RSCRx)

PSI5/WSS configuration register for channel 0 (RSCR0) PSI5/WSS configuration register for channel 1 (RSCR1 PSI5/WSS configuration register for channel 2 (RSCR2) PSI5/WSS configuration register for channel 3 (RSCR3

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		REDUCED_RANGE	BLOCK_CURR_IN_MSG	PERIOD_MEAS_DISABLE	FIX_THRESH	TSxDIS	BLKT _x SEL		WSFI	LT[3:0]		RSPTEN	AVG/SSDIS			STS[3:0]	
MISO	0	0	0	0	REDUCED_RANGE	BLOCK_CURR_IN_MSG	PERIOD_MEAS_DISABLE	FIX_THRESH	TSxDIS	BLKT _X SEL		WSFI	LT[3:0]		RSPTEN	AVG/SSDIS			STS[3:0]	

ID:	4A (R 4B (R 4C (F 4D (F	SCR SCR SCR SCR	D) 1) 2) 3)	
Туре:	RW			
Read:	4A00 4B00 4C00 4D00	(RSC (RSC (RSC (RSC	CR0) CR1) CR2) CR3)	
Write:	0094 0096 0098 009B	(RSC (RSC (RSC (RSC	R0) R1) R2) R3)	
	POR	WSM	SSM	
PSI5 configured ch	annel			
REDUCED_RANGE	0	0	0	Tracking speed of base and delta current
				0 Fast tracking of lbase if rx_sat_pre_filt is low; Slow tracking otherwise. Fast tracking of Idelta if rx_sat_pre_filt is high; Blocked otherwise.
				 Fast tracking of Ibase if current is less than (Ibase+(Idelta/4)); Slow tracking otherwise.

DS11615 Rev 3

Slow otherwise.

Fast tracking of Idelta if current is higher than (top current -(Idelta/4));



BLOCK_CURR_IN_MSG	0	0	0	Tracking enable of base and delta current during message transmission
				0 Ibase tracking is enabled during blanking and after start bits recognition. Idelta tracking is disabled during blanking and enabled after start bits recognition.
				 Ibase tracking is enabled during blanking and disabled after start bits recognition. Idelta tracking is disabled during blanking and enabled after start bits
				recognition
PERIOD_MEAS_DISABLE	0	0	0	Disabling of start bits period measure to decode following bits
				0 Period is measured
				1 Period is not measured (default is used)
FIX_THRESH	0	0	0	PSI5 selection of fixed or auto adaptive thresholds
				0 auto adaptive threshold
				1 fixed threshold (threshold is latched when this bit is set to high, we recommend to set this bit before enabling of the interface)
TSxDIS	0	0	0	Time Slot Control Disable
				0 Slot control enabled
				1 Slot control disabled
BLKTxSEL	0	0	0	Blanking Time Selection
				0 Blanking time = 5ms
				1 Blanking time = 10ms
WSFILT[3:0]	0010	0010	0010) Wheel speed filter time selection
				189k: 125k:
				(16+x)*Tosc (24+x)*Tosc Tosc=1/16MHz
RSPTEN	0	0	0	Pass Through mode Enable
				0 Off
				1 On
AVG/SSDIS	0	0	0	Current average enable during message transmission
				0 Off (base and delta work as configured with bits 12, 14, 15)
				1 On: base is freezed during data message and during blanking time and delta is averaged during message (fcut of the filter=2500 Hz) while is freezed during blanking time.



STSx[3:0]	0000	0000	0000) Sensor Type Selection
				0000 Synchronous PSI5, parity, 8-bit, 125k (P8P-500/3L) 0001 Synchronous PSI5, parity, 8-bit, 189k (P8P-500/3H) 0010 Synchronous PSI5, parity, 10-bit, 125k (P10P-500/3L) 0011 Synchronous PSI5, parity, 10-bit, 189k (P10P-500/3H) 0100 unused (default automatically selected) 0101 unused (default automatically selected) 0110 unused (default automatically selected) 0111 unused (default automatically selected) 0111 unused (default automatically selected) 1000 NA 1001 NA 1001 NA 1011 NA 1100 unused (default automatically selected) 1101 unused (default automatically selected) 1101 unused (default automatically selected) 1101 unused (default automatically selected)
Wheel speed confic	ured	chann	nel	
REDUCED_RANGE	0	0	0	Tracking speed of base and delta current X NA
BLOCK_CURR_IN_MSG	0	0	0	Tracking enable of base and delta current during message transmission X NA
PERIOD_MEAS_DISABLE	0	0	0	Disabling of start bits period measure to decode following bits X NA
FIX_THRESH	0	0	0	PSI5 selection of fixed or auto adaptive thresholds 0 auto adaptive threshold 1 fixed thresholds (configured through SPI registers)
TSxDIS	0	0	0	Time Slot Control Disable X NA
BLKTxSEL	0	0	0	Blanking Time Selection X NA
WSFILT[3:0]	0010	0010	0010) Wheel speed filter time selection (500ns per bit) 0000 8 us 500ns/bit 1111 15.5μs:

DS11615 Rev 3



RSPTEN	0	Ο	0	Pass Through mode Enable (only for PWM 2-edges sensors)
NOLITEN	0	0	U	
				1 On
AVG/SSDIS	0	0	0	WSx output pulses disabled in case of Standstill condition
	Ū	U	Ū	(valid only for PWM Encoded 2 edges sensors)
				0 WSx enabled during Standstill
				1 WSx disabled during Standstill
STSx[3:0]	0000	0000	0000) Sensor Type Selection
				0000 NA
				0001 NA
				0010 NA
				0011 NA
				0100 unused (default automatically selected)
				0101 unused (default automatically selected)
				0110 unused (default automatically selected)
				0111 unused (default automatically selected)
				1000 Two-Level, Standard
				1001 Three-Level, VDA
				1010 PWM Encoded, 2-Level, 2 edges/tooth
				1011 PWM Encoded, 2-Level, 1 edge/tooth
				1100 unused (default automatically selected)
				1101 unused (default automatically selected)
				1110 unused (default automatically selected)
				1111 unused (default automatically selected)

Write:

7.3.40 Remote sensor control register (RSCTRL)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI		I	-	I	x	x	x	x	x	x	х	x	CH3EN	SYNC3E	CH2EN	SYNC2E	CH1EN	SYNC1E	CHOEN	SYNCOE
MISO	0	0	0	0	0	0	0	0	0	0	0	0	CH3EN	SYNC3E	CH2EN	SYNC2E	CH1EN	SYNC1E	CHOEN	SYNCOE
ID:			4E																	
Туре:			R/W																	
Read:			4E00)																

POR	WSM	SSM	
0	0	0	Channel x Output enable
			Updated by SSM_RESET or SPI write
			0 Off
			1 On
0	0	0	Channel x Sync Pulse Enable
			0 Off
			1 On
	0 POR	o POR o WSM	0 0 0 0 0 0 SSM

009C



7.3.41	WSS Threshold configuration register 1 (RS_AUX_CONF1)
--------	---

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	Х	х	Х	х	х	Х	х			wss_	LOW_	THRE	SH [7:0]	
MISO	0	0	0	0	0	0	0	0	0	0	0	0			wss_	LOW_	THRE	SH [7:0]	
ID:			64																	
Туре:			R/W																	
Read:			6400)																
Write:			00C8	3																
WSS_LOW_T	HRESH	[7:0]	НОЧ \$33	WSM \$33	WS S \$3	3 Lov	v thre	shold	settin	g in o	case	of fixe	ed thre	eshol	d is s	select	ted (9	03,75	μA +/-	9%
						eac	h LSI	B). Lo	w thre	shol	d = (\$	\$36+\	NSS_	LOW	_THI	RESH	H)*93	,75 μ	4)	

7.3.42 WSS Threshold configuration register 2 (RS_AUX_CONF2)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		Х	х	Х	Х	Х	х	х	х			wss_	LOW_	THRE	SH [7:0]	
MISO	0	0	0	0	0	0	0	0	0	0	0	0			wss_	LOW_	THRE	SH [7:0]	
ID:			65																	
Туре:			R/W																	
Read:			6500)																
Write:			00CE	3																
WSS_LOW_TH	HRESH	[7:0]	¥Од \$34	WSM \$34	₩SS \$34	1 Del eac Hig (\$6	ta thr h LSI h thre C+W	eshol B). eshold SS_L(d setti I = OW_T	ng in ⁻ HRE	case SH+ ¹	e of fi	xed th _OFF	resho SET_	old is _THR	sele RESH	cted ()*93, ⁻	(93,75 75 μΑ	5 μA + \)	/-9%



				1					1	1				1		1	1		1		
	1	9	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				-		NO_DATA	x		H					ARMP_TH			SUB_VAL			ADD_VAL	
MISO	()	0	0	0	NO_DATA	0							ARMP_TH			SUB_VAL			ADD_VAL	
ID:				66																	
Туре:				R/W																	
Read:				6600)																
Write:				0000	С																
	NO_	DA	TA	o POR	o WSM	0 SSM	Eve	ent co	ounter	no da	ata se	lect									
							Up	dated	by S	SM_R	ESE	T or S	SPI w	/rite w	hile ir	DIA ו	G sta	ate			
		 Opdated by SSM_RESET or SPT write while in DIAG state Event counter reset to 0 if CC=0 or (ABS value of response > limit determined by LIM_SELx) and LIM_ENx=1 when SPT read of SAF_CC b is performed (end of sample cycle) Event counter decremented by SUB_VAL if CC=0 or (ABS value of response > limit determined by LIM_SELx) and LIM_ENx=1 when) bit				
	 0 Event counter reset to 0 if CC=0 or (ABS value of response > limit determined by LIM_SELx) and LIM_ENx=1 when SPI read of SAF_CC bit is performed (end of sample cycle) 1 Event counter decremented by SUB_VAL if CC=0 or (ABS value of response > limit determined by LIM_SELx) and LIM_ENx=1 when SPI read of SAF_CC bit is performed (end of sample cycle) 															f					
	ARM	N_	ΤН	0011	001	1 001	1 Ne	gative	e ever	nt coui	nter t	hresh	old to	o asse	ert arr	ning					
							Up	dated	by S	SM_R	ESE	T or S	SPI w	/rite w	hile ir	ם DIA	G sta	ate			
								0000	Nega	ative e	event	coun	ter di	isable	d						
	ARM	Ρ_	TH	0011	001	1 001	1 Pos	sitive	event	coun	ter th	resho	old to	asse	rt arm	ing					
							Up	dated	by S	SM_R	ESE	T or S	SPI w	rite w	hile ir	ם DIA	G sta	ate			
								0000	Posit	tive ev	vent o	ount	er dis	sabled							
	SUE	3_∖	/AL	011	011	01 [,]	1 De	creme	ental s	step si	ize of	the e	event	coun	ter						
							Up	dated	by S	SM_R	ESE	T or S	SPI w	rite w	hile ir	DIA ו	G sta	ate			
	ADE)_∖	/AL	001	001	00	1 Inc	reme	ntal st	ep siz	ze of	he e	vent	counte	er						
							Up	dated	by S	SM_R	ESE	T or S	SPI w	/rite w	hile ir	ם DIA	G sta	ate			

7.3.43 Safing algorithm configuration register (SAF_ALGO_CONF)



L9680

7.3.44 Arming signals register (ARM_STATE)

	Γ	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				-		х	Х	Х	х	х	Х	Х	х	х	Х	х	Х	Х	Х	х	Х
MISO		0	0	0	0	0	0	0	0	0	0	PSINHINT	PSINH_EXP_TIME	ACL_PIN_STATE	ACL_VALID	ARMINT_4	$ARMINT_3$	ARMINT2	ARMINT_1	0	0
ID:				6A																	
Туре:				R																	
Read:				6A00)																
Write:				-																	
	ARMINT_x - - State of armint signals Updated per Safing Engine output logic diagram in case of internal safing engine otherwise is the echo of ARMx pins ACL_VALID 0 0 0 Valid ACL detection															g					
,				Ū	0	0	van			whon		BVL	1-2								
								1 Set	t whe	n ACL	_GO	OD=:	3								
ACL_F	PIN_	_STA	ΤE	-	-	-	Ecł	no of <i>i</i>	ACL p	oin											
PSINH_	EXF	P_TII	ME	0	0	0	Sta	te of	PSIN	Н ехрі	iratio	n time	er								
							(0 Ifti	mer is	s 0											
								1 Ifti	mer is	s cour	nting										
	PS	INHI	NT	-	-	-	Sta	te of	PSIN	HINT	signa	I									
							Upo is tł	dated ne ec	per F ho of	PSINH PSINI	outp I pin	ut log inver	jic dia ted	agram	in ca	ise of	f inter	nal e	ngine	other	wise



7.3.45 ARMx assignment registers to specific Loops (LOOP_MATRIX_ARMx)

Assignment of ARM1 to specific loops (LOOP_MATRIX_ARM1) Assignment of ARM2 to specific loops (LOOP_MATRIX_ARM2) Assignment of ARM3 to specific loops (LOOP_MATRIX_ARM3) Assignment of ARM4 to specific loops (LOOP_MATRIX_ARM4)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		x	x	х	х	ARMx_LB	ARMx_LA	ARMx_L9	ARMx_L8	ARMx_L7	ARMx_L6	ARMx_L5	ARMx_L4	ARMx_L3	ARMx_L2	ARMx_L1	ARMx_L0
MISO	0	0	0	0	0	0	0	0	ARMx_LB	ARMx_LA	ARMx_L9	ARMx_L8	ARMx_L7	ARMx_L6	ARMx_L5	ARMx_L4	ARMx_L3	ARMx_L2	ARMx_L1	ARMx_L0

ID:

6E (LOOP_MATRIX_ARM1)
6F (LOOP_MATRIX_ARM2)
70 (LOOP_MATRIX_ARM3)
71 (LOOP_MATRIX_ARM4)

Туре:

Read: 6E00 (LOOP_MATRIX_ARM1) 6F00 (LOOP_MATRIX_ARM2) 7000 (LOOP_MATRIX_ARM3) 7100 (LOOP_MATRIX_ARM4)

RW

Write: 00DC (LOOP_MATRIX_ARM1) 00DE (LOOP_MATRIX_ARM2) 00E0 (LOOP_MATRIX_ARM3) 00E2 (LOOP_MATRIX_ARM4)

POR WSM SSM

ARMx_Ly 0 0 0 Configures ARMx for Loop_y

Updated by SSM_RESET or SPI write while in DIAG state

0 ARMx signal is not associated with Loopy

1 ARMx signal is associated with Loopy



7.3.46 ARMx enable pulse stretch timer status (AEPSTS_ARMx)

ARM1 enable pulse stretch timer status (AEPSTS_ARM1) ARM2 enable pulse stretch timer status (AEPSTS_ARM2) ARM3 enable pulse stretch timer status (AEPSTS_ARM3) ARM4 enable pulse stretch timer status (AEPSTS_ARM4)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	х	х	х	х	х	х	х	х	х	х
MISO	0	0	0	0	0	0	0	0	0	0	Timer Count[9:0]									

ID: 73 (AEPSTS_ARM1) 74 (AEPSTS_ARM2) 75 (AEPSTS_ARM3) 76 (AEPSTS_ARM4)

R

Туре:

Read: 7300 (AEPSTS_ARM1) 7400 (AEPSTS_ARM2) 7500 (AEPSTS_ARM3) 7600 (AEPSTS_ARM4)

Write:

POR WSM SSM

Timer Count \$000 \$000 \$000 10-bit ARMing Enable Pulse Stretcher timer value

Cleared by SSM_RESET

Loaded with initial value based on ARMx bit and DWELL[1:0] of SAF_CONTROL_y while safing is met for record y provided current value is < DWELL[1:0] value

Decremented every 2ms while > 0

Contains remaining pulse stretcher timer value



Write:

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х				P/	ADTHI	RESH_	_HI			
MISO	0	0	0	0	0	0	0	0	0	0				P/	ADTHI	RESH	_HI			
ID:			78																	
Туре:			RW																	
Read:			7800)																

7.3.47 Passenger inhibit upper threshold for DC sensor 0 (PADTHRESH_HI)

POR WSM SSM

00F0

PADTHRESH_HI \$000 \$000 Upper threshold - measurements above this upper value will assert the PSINH signal and deactivate loops identified in the PSINH mask

7.3.48 Passenger inhibit lower threshold for DC sensor 0 (PADTHRESH_LO)

					r	-				-				1	1					·
	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	Х	х	Х	х	х				PA	ADTHF	RESH_	LO			
MISO	0	0	0	0	0	0	0	0	0	0				PA	ADTHF	RESH_	LO			
ID:			79																	
Туре:			RW																	
Read:			7900)																
Write:			00F2	2																
			POR	WSM	SSM															
PADTHR	ESH_	LO	\$3FF	\$3F	F \$3F	FLov	ver th nal ar	resho Id dea	ld - m activat	easu e loo	reme ps ide	nts be entifie	elow t ed in t	his lo he P	wer v SINH	/alue I mas	will a k	ssert	the PS	SINH



19 18 17 16 15 14 13 12 11 10 9 8 7 6 5 3 2 1 0 4 PSINH_L0PSINH_L0 SINH_LBPSINH_LB PSINH_LAPSINH_LA PSINH_L9PSINH_L9 SINH_L8PSINH_L8 PSINH_L7PSINH_L7 PSINH_L5PSINH_L5 PSINH_L4PSINH_L4 PSINH_L3PSINH_L3 SINH_L2PSINH_L2 PSINH_L6PSINH_L6 PSINH_L1PSINH_L1 MOSI Х Х Х Х . MISO 0 0 0 0 0 0 0 0

Assignment of PSINH signal to specific Loop(s) 7.3.49 (LOOP_MATRIX_PSINH)

ID:	7A		
Туре:	RW		
Read:	7A00		
Write:	00F4		
	POR	MSM	SSM

WSI 2 PSINH_Ly 0 0

0 Configures PSINH for Loop_y

0 PSINH signal is not associated with Loopy

1 PSINH signal is associated with Loopy

7.3.50 Safing records enable register (SAF_ENABLE)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		EN_SAF16	EN_SAF15	EN_SAF14	EN_SAF13	EN_SAF12	EN_SAF11	EN_SAF10	EN_SAF9	EN_SAF8	EN_SAF7	EN_SAF6	EN_SAF5	EN_SAF4	EN_SAF3	EN_SAF2	EN_SAF1
MISO	0	0	0	0	EN_SAF16	EN_SAF15	EN_SAF14	EN_SAF13	EN_SAF12	EN_SAF11	EN_SAF10	EN_SAF9	EN_SAF8	EN_SAF7	EN_SAF6	EN_SAF5	EN_SAF4	EN_SAF3	EN_SAF2	EN_SAF1

ID:	7F
Туре:	RW
Read:	7F00
Write:	00FE

	POR	WSM	SSM	
EN_SAFx	0	0	0	Safing Record enable Updated by SSM_RESET or SPI write
				0 Disable

1 Enable



DS11615 Rev 3

7.3.51 Safing records request mask registers (SAF_REQ_MASK_x)

Safing record request mask for record 1 (SAF REQ MASK 1) Safing record request mask for record 2 (SAF_REQ_MASK_2) Safing record request mask for record 3 (SAF_REQ_MASK_3) Safing record request mask for record 4 (SAF REQ MASK 4) Safing record request mask for record 5 (SAF_REQ_MASK_5) Safing record request mask for record 6 (SAF_REQ_MASK_6) Safing record request mask for record 7 (SAF_REQ_MASK_7) Safing record request mask for record 8 (SAF_REQ_MASK_8) Safing record request mask for record 9 (SAF_REQ_MASK_9) Safing record request mask for record 10 (SAF REQ MASK 10) Safing record request mask for record 11 (SAF_REQ_MASK_11) Safing record request mask for record 12 (SAF REQ MASK 12) Safing record request mask for record 13 (SAF_REQ_MASK_13) Safing record request mask for record 14_pt1 (SAF_REQ_MASK_14)_pt1 Safing record request mask for record 14 pt2 (SAF REQ MASK 14) pt2 Safing record request mask for record 15_pt1 (SAF_REQ_MASK_15)_pt1 Safing record request mask for record 15_pt2 (SAF_REQ_MASK_15)_pt2 Safing record request mask for record 16_pt1 (SAF_REQ_MASK_16)_pt1 Safing record request mask for record 16_pt2 (SAF_REQ_MASK_16)_pt2

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-																	
MISO	0	0	0	0		SAF_REQ_MASKx[15:0]														

ID:

80 (SAF_REQ_MASK_1)
81 (SAF_REQ_MASK_2)
82 (SAF_REQ_MASK_3)
83 (SAF_REQ_MASK_4)
84 (SAF_REQ_MASK_5)
85 (SAF_REQ_MASK_6)
86 (SAF_REQ_MASK_7)
87 (SAF_REQ_MASK_8)
88 (SAF_REQ_MASK_9)
89 (SAF_REQ_MASK_10)
8A (SAF_REQ_MASK_11)
8B (SAF_REQ_MASK_12)
8C (SAF_REQ_MASK_13)
8D (SAF_REQ_MASK_14_pt1
8E (SAF_REQ_MASK_14_pt2)
8F (SAF_REQ_MASK_15_pt1)
90 (SAF_REQ_MASK_15_pt2)
91 (SAF_REQ_MASK_16_pt1)
92 (SAF_REQ_MASK_16_pt2)
RW
8000 (SAF_REQ_MASK_1) 8100 (SAF_REQ_MASK_2)

Type: Read:



	8200 (SAF_REQ_MASK_3) 8300 (SAF_REQ_MASK_4) 8400 (SAF_REQ_MASK_5) 8500 (SAF_REQ_MASK_5) 8500 (SAF_REQ_MASK_6) 8600 (SAF_REQ_MASK_7) 8700 (SAF_REQ_MASK_8) 8800 (SAF_REQ_MASK_9) 8900 (SAF_REQ_MASK_10) 8A00 (SAF_REQ_MASK_11) 8B00 (SAF_REQ_MASK_12) 8C00 (SAF_REQ_MASK_13) 8D00 (SAF_REQ_MASK_14_pt1 8E00 (SAF_REQ_MASK_14_pt2) 8F00 (SAF_REQ_MASK_15_pt1) 9000 (SAF_REQ_MASK_15_pt2) 9100 (SAF_REQ_MASK_16_pt1) 9200 (SAF_REQ_MASK_16_pt2)
Write:	8000 (SAF_REQ_MASK_1) 8002 (SAF_REQ_MASK_2) 8004 (SAF_REQ_MASK_2) 8006 (SAF_REQ_MASK_3) 8006 (SAF_REQ_MASK_3) 8008 (SAF_REQ_MASK_4) 8008 (SAF_REQ_MASK_5) 800A (SAF_REQ_MASK_5) 800C (SAF_REQ_MASK_7) 800E (SAF_REQ_MASK_7) 8012 (SAF_REQ_MASK_10) 8014 (SAF_REQ_MASK_10) 8014 (SAF_REQ_MASK_11) 8016 (SAF_REQ_MASK_12) 8018 (SAF_REQ_MASK_13) 801A (SAF_REQ_MASK_14_pt1 801C (SAF_REQ_MASK_14_pt2) 801E (SAF_REQ_MASK_15_pt1) 8020 (SAF_REQ_MASK_15_pt2) 8022 (SAF_REQ_MASK_16_pt2)

POR WSM SSM

SAF_REQ_MASKx[15:0] \$0000\$0000\$afing Request Mask for safing record x - 16-bit request mask that is bitwise ANDed with MOSI data from SPI monitor

Updated by SSM_RESET or SPI write while in DIAG state



7.3.52 Safing records request target registers (SAF_REQ_TARGET_x)

Safing record request mask for record 1 (SAF REQ TARGET 1) Safing record request mask for record 2 (SAF_REQ_TARGET_2) Safing record request mask for record 3 (SAF_REQ_TARGET_ 3) Safing record request mask for record 4 (SAF REQ TARGET 4) Safing record request mask for record 5 (SAF_REQ_TARGET_5) Safing record request mask for record 6 (SAF_REQ_TARGET_6) Safing record request mask for record 7 (SAF_REQ_TARGET_7) Safing record request mask for record 8 (SAF_REQ_TARGET_8) Safing record request mask for record 9 (SAF_REQ_TARGET_9) Safing record request mask for record 10 (SAF REQ TARGET 10) Safing record request mask for record 11 (SAF_REQ_TARGET_11) Safing record request mask for record 12 (SAF REQ TARGET 12) Safing record request mask for record 13 (SAF_REQ_TARGET_13) Safing record request mask for record 14 pt1 (SAF_REQ_TARGET_14) pt1 Safing record request mask for record 14 pt2 (SAF REQ TARGET 14) pt2 Safing record request mask for record 15_pt1 (SAF_REQ_TARGET_15)_pt1 Safing record request mask for record 15 pt2 (SAF_REQ_TARGET_15) pt2 Safing record request mask for record 16_pt1 (SAF_REQ_TARGET_16)_pt1 Safing record request mask for record 16_pt2 (SAF_REQ_TARGET_16)_pt2

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI		-	-			SAF_REQ_TARGET[15:0]														
MISO	0	0	0	0		SAF_REQ_TARGET[15:0]														

	-	
	п	
	ப	-
-	_	2

93 (SAF_REQ_TARGET_1)
94 (SAF_REQ_TARGET_2)
95 (SAF_REQ_TARGET_3)
96 (SAF_REQ_TARGET_4)
97 (SAF_REQ_TARGET_5)
98 (SAF_REQ_TARGET_6)
99 (SAF_REQ_TARGET_7)
9A (SAF_REQ_TARGET_8)
9B (SAF_REQ_TARGET_9)
9C (SAF_REQ_TARGET_10)
9D (SAF_REQ_TARGET_11)
9E (SAF_REQ_TARGET_12)
9F (SAF_REQ_TARGET_13)
A0 (SAF_REQ_TARGET_14_pt1
A1 (SAF_REQ_TARGET_14_pt2)
A2 (SAF_REQ_TARGET_15_pt1)
A3 (SAF_REQ_TARGET_15_pt2)
A4 (SAF_REQ_TARGET_16_pt1)
A5 (SAF_REQ_TARGET_16_pt2)
RW
9300 (SAF_REQ_TARGET_1) 9400 (SAF_REQ_TARGET_2)

Type: Read:



	9500 (SAF_REQ_TARGET_3) 9600 (SAF_REQ_TARGET_4) 9700 (SAF_REQ_TARGET_5) 9800 (SAF_REQ_TARGET_5) 9800 (SAF_REQ_TARGET_6) 9900 (SAF_REQ_TARGET_7) 9A00 (SAF_REQ_TARGET_8) 9B00 (SAF_REQ_TARGET_9) 9C00 (SAF_REQ_TARGET_10) 9D00 (SAF_REQ_TARGET_11) 9E00 (SAF_REQ_TARGET_12) 9F00 (SAF_REQ_TARGET_13) A000 (SAF_REQ_TARGET_14_pt1 A100 (SAF_REQ_TARGET_14_pt2) A200 (SAF_REQ_TARGET_15_pt2) A400 (SAF_REQ_TARGET_15_pt2) A400 (SAF_REQ_TARGET_16_pt2)
Write:	8026 (SAF_REQ_TARGET_1) 8028 (SAF_REQ_TARGET_2) 802A (SAF_REQ_TARGET_3) 802C (SAF_REQ_TARGET_3) 802C (SAF_REQ_TARGET_4) 802E (SAF_REQ_TARGET_5) 8030 (SAF_REQ_TARGET_6) 8032 (SAF_REQ_TARGET_6) 8034 (SAF_REQ_TARGET_8) 8036 (SAF_REQ_TARGET_9) 8038 (SAF_REQ_TARGET_10) 803A (SAF_REQ_TARGET_11) 803C (SAF_REQ_TARGET_12) 803E (SAF_REQ_TARGET_13) 8040 (SAF_REQ_TARGET_14_pt1 8042 (SAF_REQ_TARGET_14_pt1 8042 (SAF_REQ_TARGET_15_pt1) 8246 (SAF_REQ_TARGET_15_pt2) 8048 (SAF_REQ_TARGET_16_pt1) 804A (SAF_REQ_TARGET_16_pt2)

POR WSM SSM

SAF_REQ_TARGET[15:0 \$0000\$0000\$afing Request target for safing record x - 16-bit request target that is

compared to the bit-wise AND result of the SAF_REQ_MASKx and MOSI data from SPI monitor

Updated by SSM_RESET or SPI write while in DIAG state



7.3.53 Safing records response mask registers (SAF_RESP_MASK_x)

Safing record response mask for record 1 (SAF RESP MASK 1) Safing record response mask for record 2 (SAF_RESP_MASK_2) Safing record response mask for record 3 (SAF_RESP_MASK_3) Safing record response mask for record 4 (SAF RESP MASK 4) Safing record response mask for record 5 (SAF_RESP_MASK_5) Safing record response mask for record 6 (SAF RESP MASK 6 Safing record response mask for record 7 (SAF_RESP_MASK_7)) Safing record response mask for record 8 (SAF_RESP_MASK_8) Safing record response mask for record 9 (SAF_RESP_MASK_9) Safing record response mask for record 10 (SAF RESP MASK 10) Safing record response mask for record 11 (SAF_RESP_MASK_11) Safing record response mask for record 12 (SAF_RESP_MASK_12) Safing record response mask for record 13 (SAF_RESP_MASK_13) Safing record response mask for record 14 pt1 (SAF RESP MASK 14 pt1) Safing record response mask for record 14 pt2 (SAF RESP MASK 14 pt2) Safing record response mask for record 15_pt1 (SAF_RESP_MASK_15_pt1) Safing record response mask for record 15_pt2 (SAF_RESP_MASK_14_pt2) Safing record response mask for record 16_pt1 (SAF_RESP_MASK_16_pt1) Safing record response mask for record 16_pt2 (SAF_RESP_MASK_16_pt2)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI		-	-		SAF_RESP_MASKx[15									[15:0]						
MISO	0	0	0	0	SAF_RESP_MASKx[15:0]															

ID:

A6 (SAF RESP MASK 1) A7 (SAF RESP MASK 2 A8 (SAF RESP MASK 3 A9 (SAF RESP MASK 4 AA (SAF RESP MASK 5 AB (SAF RESP MASK 6 AC (SAF RESP MASK 7 AD (SAF_RESP_MASK_8 AE (SAF_RESP_MASK_9 AF (SAF RESP MASK 10 B0 (SAF RESP MASK 11 B1 (SAF RESP MASK 12 B2 (SAF RESP MASK 13) B3 (SAF_RESP_MASK_14_pt1) B4 (SAF_RESP_MASK_14_pt2) B5 (SAF_RESP_MASK_15_pt1) B6 (SAF_RESP_MASK_15_pt2)



	B7 (SAF_RESP_MASK_16_pt1 B8 (SAF_RESP_MASK_16_pt2
Туре:	RW
Read:	
Read:	A600 (SAF_RESP_MASK_1) A700 (SAF_RESP_MASK_2 A800 (SAF_RESP_MASK_3 A900 (SAF_RESP_MASK_3 A900 (SAF_RESP_MASK_4 AA00 (SAF_RESP_MASK_5 AB00 (SAF_RESP_MASK_6 AC00 (SAF_RESP_MASK_6 AC00 (SAF_RESP_MASK_7 AD00 (SAF_RESP_MASK_8 AE00 (SAF_RESP_MASK_9 AF00 (SAF_RESP_MASK_10 B000 (SAF_RESP_MASK_10 B000 (SAF_RESP_MASK_11 B100 (SAF_RESP_MASK_12 B200 (SAF_RESP_MASK_13) B300 (SAF_RESP_MASK_14_pt1) B400 (SAF_RESP_MASK_14_pt2) B500 (SAF_RESP_MASK_15_pt1) B600 (SAF_RESP_MASK_16_pt1 B801 (SAF_RESP_MASK_16_pt1
Write:	804C (SAF_RESP_MASK_1) 804E (SAF_RESP_MASK_2 8050 (SAF_RESP_MASK_3 8052 (SAF_RESP_MASK_4 8054 (SAF_RESP_MASK_5 8056 (SAF_RESP_MASK_5 8056 (SAF_RESP_MASK_6 8058 (SAF_RESP_MASK_7 805A (SAF_RESP_MASK_7 805C (SAF_RESP_MASK_9 805E (SAF_RESP_MASK_10 8060 (SAF_RESP_MASK_11 8062 (SAF_RESP_MASK_12 8064 (SAF_RESP_MASK_13) 8066 (SAF_RESP_MASK_14_pt1) 8068 (SAF_RESP_MASK_15_pt1) 806C (SAF_RESP_MASK_16_pt1 8070 (SAF_RESP_MASK_16_pt2)

POR WSM SSM

SAF_RESP_MASKx[15:0] 0000 0000 0000 Safing Response Mask for safing record x - 16-bit response mask that is bitwise ANDed with MISO data from SPI monitor 16-bit request target that is compared to the bit-wise AND result of the SAF_REQ_MASKx and MOSI data from SPI

Updated by SSM_RESET or SPI write while in DIAG state



DS11615 Rev 3

7.3.54 Safing records response mask registers (SAF_RESP_TARGET_x)

Safing record response target for record 1 (SAF RESP TARGET 1) Safing record response target for record 2 (SAF_RESP_TARGET_2) Safing record response target for record 3 (SAF_RESP_TARGET_3) Safing record response target for record 4 (SAF RESP TARGET 4) Safing record response target for record 5 (SAF_RESP_TARGET_5) Safing record response target for record 6 (SAF_RESP_TARGET_6) Safing record response target for record 7 (SAF_RESP_TARGET_7) Safing record response target for record 8 (SAF_RESP_TARGET_8) Safing record response target for record 9 (SAF_RESP_TARGET_9) Safing record response target for record 10 (SAF RESP TARGET 10) Safing record response target for record 11 (SAF_RESP_TARGET_11) Safing record response target for record 11 (SAF RESP TARGET 12) Safing record response target for record 13 (SAF_RESP_TARGET_13) Safing record response target for record 14_pt1 (SAF_RESP_TARGET_14)_pt1 Safing record response target for record 14 pt2 (SAF RESP TARGET 14) pt2 Safing record response target for record 15_pt1 (SAF_RESP_TARGET_15)_pt1 Safing record response target for record 15 pt2 (SAF_RESP_TARGET_15) pt2 Safing record response target for record 16_pt1 (SAF_RESP_TARGET_16)_pt1 Safing record response target for record 16_pt2 (SAF_RESP_TARGET_16)_pt2

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		SAF_RESP_TARGETx[15:0]										l					
MISO	0	0	0	0	SAF_RESP_TARGETx[15:0]															

-	_	
	n	٠
	υ	

B9 (SAF_RESP_TARGET_1)
BA (SAF_RESP_TARGET_2
BB (SAF_RESP_TARGET_3
BC (SAF_RESP_TARGET_4
BD (SAF_RESP_TARGET_5
BE (SAF_RESP_TARGET_6
BF (SAF_RESP_TARGET_7
C0 (SAF_RESP_TARGET_8
C1 (SAF_RESP_TARGET_9
C2 (SAF_RESP_TARGET_10
C3 (SAF_RESP_TARGET_11
C4 (SAF_RESP_TARGET_12
C5 (SAF_RESP_TARGET_13
C6 (SAF_RESP_TARGET_14_pt1
C7 (SAF_RESP_TARGET_14_pt2
C8 (SAF_RESP_TARGET_15_pt1
C9 (SAF_RESP_TARGET_15_pt2
CA (SAF_RESP_TARGET_16_pt1
CB (SAF_RESP_TARGET_16_pt2



L9680

Type:

RW

Read:	B900 (SAF_RESP_TARGET_1) BA00 (SAF_RESP_TARGET_2 BB00 (SAF_RESP_TARGET_3 BC00 (SAF_RESP_TARGET_3 BC00 (SAF_RESP_TARGET_4 BD00 (SAF_RESP_TARGET_5 BE00 (SAF_RESP_TARGET_6 BF00 (SAF_RESP_TARGET_7 C000 (SAF_RESP_TARGET_7 C000 (SAF_RESP_TARGET_8 C100 (SAF_RESP_TARGET_9 C200 (SAF_RESP_TARGET_10 C300 (SAF_RESP_TARGET_10 C300 (SAF_RESP_TARGET_11 C400 (SAF_RESP_TARGET_12 C500 (SAF_RESP_TARGET_13 C600 (SAF_RESP_TARGET_14_pt1 C700 (SAF_RESP_TARGET_14_pt1 C700 (SAF_RESP_TARGET_15_pt1 C900 (SAF_RESP_TARGET_15_pt2 CA00 (SAF_RESP_TARGET_16_pt1 CB00 (SAF_RESP_TARGET_16_pt2)
Write:	8072 (SAF_RESP_TARGET_1) 8074 (SAF_RESP_TARGET_2 8076 (SAF_RESP_TARGET_3 8078 (SAF_RESP_TARGET_4 807A (SAF_RESP_TARGET_4 807A (SAF_RESP_TARGET_5 807C (SAF_RESP_TARGET_6 807E (SAF_RESP_TARGET_7 8080 (SAF_RESP_TARGET_7 8080 (SAF_RESP_TARGET_8 8082 (SAF_RESP_TARGET_9 8084 (SAF_RESP_TARGET_10 8086 (SAF_RESP_TARGET_11 8088 (SAF_RESP_TARGET_12 808A (SAF_RESP_TARGET_13 808C (SAF_RESP_TARGET_14_pt1 808E (SAF_RESP_TARGET_14_pt1 808E (SAF_RESP_TARGET_14_pt1 8092 (SAF_RESP_TARGET_15_pt2 8094 (SAF_RESP_TARGET_16_pt2)

POR WSM SSM

SAF_RESP_TARGETx[15:0] 0000 0000 0000 Safing Response target for safing record x - 16-bit response target that is compared to the bit-wise AND result of the SAF_RESP_MASKx and MISO data from SPI monitor

Updated by SSM_RESET or SPI write while in DIAG state



DS11615 Rev 3

7.3.55 Safing records data mask registers (SAF_DATA_MASK_x)

Safing record data mask for record 1 (SAF DATA MASK 1) Safing record data mask for record 2 (SAF_DATA_MASK_2) Safing record data mask for record 3 (SAF_DATA_MASK_3) Safing record data mask for record 4 (SAF DATA MASK 4) Safing record data mask for record 5 (SAF_DATA_MASK_5) Safing record data mask for record 6 (SAF_DATA_MASK_6) Safing record data mask for record 7 (SAF_DATA_MASK_7) Safing record data mask for record 8 (SAF_DATA_MASK_8) Safing record data mask for record 9 (SAF_DATA_MASK_9) Safing record data mask for record 10 (SAF DATA MASK 10) Safing record data mask for record 11 (SAF_DATA_MASK_11) Safing record data mask for record 12 (SAF DATA MASK 12) Safing record data mask for record 13 (SAF_DATA_MASK_13) Safing record data mask for record 14 (SAF_DATA_MASK_14_pt1) Safing record data mask for record 14 (SAF DATA MASK 14 pt2) Safing record data mask for record 15 (SAF_DATA_MASK_15_pt1) Safing record data mask for record 15 (SAF_DATA_MASK_ 15 pt2) Safing record data mask for record 16 (SAF DATA MASK 16 pt1) Safing record data mask for record 16 (SAF_DATA_MASK_16_pt2)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI	- SAF_DATA_MASKx[15:0]																			
MISO	0	0	0	0																

ID:

CC (SAF_DATA_MASK_1)
CD (SAF_DATA_MASK_2)
CE (SAF_DATA_MASK_3)
CF (SAF_DATA_MASK_4)
D0 (SAF_DATA_MASK_5)
D1 (SAF_DATA_MASK_6)
D2 (SAF_DATA_MASK_7)
D3 (SAF_DATA_MASK_8)
D4 (SAF_DATA_MASK_9)
D5 (SAF_DATA_MASK_10)
D6 (SAF_DATA_MASK_11)
D7 (SAF_DATA_MASK_12)
D8 (SAF_DATA_MASK_13)
D9 (SAF_DATA_MASK_14_pt1)
DA (SAF_DATA_MASK_14_pt2
DB (SAF_DATA_MASK_15_pt1
DC (SAF_DATA_MASK_15_pt2



	DD (SAF_DATA_MASK_16_pt1) DE (SAF_DATA_MASK_16_pt2)
Туре:	RW
Read:	CC00 (SAF_DATA_MASK_1) CD00 (SAF_DATA_MASK_2) CE00 (SAF_DATA_MASK_3) CF00 (SAF_DATA_MASK_3) CF00 (SAF_DATA_MASK_4) D000 (SAF_DATA_MASK_5) D100 (SAF_DATA_MASK_6) D200 (SAF_DATA_MASK_7) D300 (SAF_DATA_MASK_7) D300 (SAF_DATA_MASK_9) D500 (SAF_DATA_MASK_10) D600 (SAF_DATA_MASK_10) D600 (SAF_DATA_MASK_12) D800 (SAF_DATA_MASK_12) D800 (SAF_DATA_MASK_13) D900 (SAF_DATA_MASK_14_pt1) DA00 (SAF_DATA_MASK_14_pt2) DB00 (SAF_DATA_MASK_15_pt1) DC00 (SAF_DATA_MASK_16_pt1) DE00 (SAF_DATA_MASK_16_pt2)
Write:	8099 (SAF_DATA_MASK_1) 809A (SAF_DATA_MASK_2) 809C (SAF_DATA_MASK_3) 809E (SAF_DATA_MASK_3) 809E (SAF_DATA_MASK_4) 80A0 (SAF_DATA_MASK_5) 80A2 (SAF_DATA_MASK_5) 80A4 (SAF_DATA_MASK_6) 80A4 (SAF_DATA_MASK_7) 80A6 (SAF_DATA_MASK_9) 80AA (SAF_DATA_MASK_9) 80AA (SAF_DATA_MASK_10) 80AC (SAF_DATA_MASK_11) 80AE (SAF_DATA_MASK_12) 80B0 (SAF_DATA_MASK_12) 80B0 (SAF_DATA_MASK_14_pt1) 80B4 (SAF_DATA_MASK_14_pt2) 80B6 (SAF_DATA_MASK_15_pt1) 80B8 (SAF_DATA_MASK_16_pt1) 80BC (SAF_DATA_MASK_16_pt2)

POR WSM SSM

SAF_DATA_MASKx[15:0] 0000 0000 0000 Safing Data Mask for safing record x - 16-bit data mask that is bit-wise ANDed with MISO data from SPI monitor

Updated by SSM_RESET or SPI write while in DIAG state



7.3.56 Safing record threshold registers (SAF_THRESHOLD_x)

Safing record threshold for record 1 (SAF_THRESHOLD_1) Safing record threshold for record 2 (SAF_THRESHOLD_2) Safing record threshold for record 3 (SAF_THRESHOLD_3) Safing record threshold for record 4 (SAF_THRESHOLD_4) Safing record threshold for record 5 (SAF_THRESHOLD_5) Safing record threshold for record 6 (SAF_THRESHOLD_6) Safing record threshold for record 7 (SAF_THRESHOLD_7) Safing record threshold for record 8 (SAF_THRESHOLD_7) Safing record threshold for record 9 (SAF_THRESHOLD_8) Safing record threshold for record 10 (SAF_THRESHOLD_9) Safing record threshold for record 12 (SAF_THRESHOLD_11) Safing record threshold for record 13 (SAF_THRESHOLD_12) Safing record threshold for record 14 (SAF_THRESHOLD_13) Safing record threshold for record 15 (SAF_THRESHOLD_14) Safing record threshold for record 15 (SAF_THRESHOLD_15) Safing record threshold for record 16 (SAF_THRESHOLD_16)

	19	18	17	16	15	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1													0	
MOSI			-							\$	SAF_T	HRES	HOLDx	(15:0]						
MISO	0	0	0	0						ş	SAF_T	HRES	HOLDx	[15:0]						
ID:			DF (SAF		RESH)_1)												
				SAF.	_ I НК _ тир	ESH)_2) _3)												
			E1 (\$ E2 (\$ E3 (\$ E3 (\$ E5 (\$ E5 (\$ E6 (\$ E7 (\$ E8 (\$ E9 (\$ E8 (\$ E9 (\$ E8 (\$ E9 (\$ EB (\$ EB (\$ ED ()	SAF SAF SAF SAF SAF SAF SAF SAF SAF SAF				(_3) (_4) (_5) (_6) (_7) (_7) (_7) (_7) (_7) (_7) (_7) (_7)											
Tuno							IOLL	_10)												
Read:			DF00 E000 E100 E200 E300 E400 E500 E600) (S/) (S/) (S/) (S/) (S/) (S/) (S/	4F_T ↓F_T ↓F_T ↓F_T ↓F_T ↓F_T ↓F_T ↓F_T	HRE HRE HRE HRE HRE HRE	SHO SHO SHO SHO SHO SHO SHO	LD_2 LD_3 LD_4 LD_5 LD_6 LD_7 LD_8	1) 2) 3) 4) 5) 5) 5) 7) 3)											


	E700 (SAF_THRESHOLD_9) E800 (SAF_THRESHOLD_10) E900 (SAF_THRESHOLD_11) EA00 (SAF_THRESHOLD_12) EB00 (SAF_THRESHOLD_13) EC00 (SAF_THRESHOLD_14) ED00 (SAF_THRESHOLD_15) EE00 (SAF_THRESHOLD_16)
Write:	80BE (SAF_THRESHOLD_1) 80C0 (SAF_THRESHOLD_2) 80C2 (SAF_THRESHOLD_3) 80C4 (SAF_THRESHOLD_4) 80C6 (SAF_THRESHOLD_5) 80C8 (SAF_THRESHOLD_5) 80CA (SAF_THRESHOLD_7) 80CC (SAF_THRESHOLD_7) 80CC (SAF_THRESHOLD_8) 80CE (SAF_THRESHOLD_8) 80D0 (SAF_THRESHOLD_10) 80D2 (SAF_THRESHOLD_11) 80D4 (SAF_THRESHOLD_12) 80D6 (SAF_THRESHOLD_13) 80D8 (SAF_THRESHOLD_15) 80DB (SAF_THRESHOLD_15) 80DB (SAF_THRESHOLD_16)

 Y
 Z
 Z

 O
 Z
 Z

 SAF_THRESHOLD_x
 \$FFFF \$FFFF \$FFFF Safing threshold for safing record x - 16-bit threshold used for safing data comparison

Updated by SSM_RESET or SPI write while in DIAG state



7.3.57 Safing control x registers (SAF_CONTROL_x)

Safing control registers for record 1 (SAF CONTROL 1) Safing control registers for record 2 (SAF_CONTROL_2) Safing control registers for record 3 (SAF_CONTROL_3) Safing control registers for record 4 (SAF CONTROL 4) Safing control registers for record 5 (SAF_CONTROL_5) Safing control registers for record 6 (SAF CONTROL 6) Safing control registers for record 7 (SAF_CONTROL_7) Safing control registers for record 8 (SAF_CONTROL_8) Safing control registers for record 9 (SAF_CONTROL_9) Safing control registers for record 10 (SAF_CONTROL_10) Safing control registers for record 11 (SAF_CONTROL_11) Safing control registers for record 12 (SAF CONTROL 12) Safing control registers for record 13 (SAF_CONTROL_13) Safing control registers for record 14 (SAF_CONTROL_14) Safing control registers for record 15 (SAF CONTROL 15) Safing control registers for record 16 (SAF_CONTROL_16)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI					ARMS	SELx	SPIFLDSELX	LIM SELX	LIM Enx	COMBx		טיישייש	ARM4x	ARM3x	ARM2x	ARM1x	(CSx[2:(0]	IFx
MISO	0	0	0 0 ARMSELX				SPIFLDSELX	LIM SELX	LIM Enx	COMBx		שעעברראן ו.טן	ARM4x	ARM3x	ARM2x	ARM1x	(CSx[2:(0]	IFx

ID:

EF (SAF_CONTROL_1)
F0 (SAF_CONTROL_2)
F1 (SAF_CONTROL_3)
F2 (SAF_CONTROL_4)
F3 (SAF_CONTROL_5)
F4 (SAF_CONTROL_6)
F5 (SAF_CONTROL_7
F6 (SAF_CONTROL_8)
F7 (SAF_CONTROL_9)
F8 (SAF_CONTROL_10)
F9 (SAF_CONTROL_11)
FA (SAF_CONTROL_12)
FB (SAF_CONTROL_13)
FC (SAF_CONTROL_14)
FD (SAF_CONTROL_15)
FE (SAF_CONTROL_16)
RW
EF00 (SAF_CONTROL_1)

F100 (SAF_CONTROL_3)

Type:



Writo		F200 (F300 (F400) F500 (F600) F700 (F800) F800 (F800) F000 (F000) F000 (F000) F000 (F000)	(SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_((SAF_())))))))))))))))))))))))))))))))))))	CONT CONT CONT CONT CONT CONT CONT CONT	ROL_4) ROL_5) ROL_6) ROL_7 ROL_8) ROL_9) ROL_10) ROL_11) ROL_12) ROL_13) IROL_14) IROL_15) IROL_16)
write:		80DE 80E0	(SAF_ (SAF_	CON	TROL_1) TROL_2)
		80E2	SAF		
		80E4 80E6	(SAF_ (SAF	CONT	ROL_4) TROL 5)
		80E8	SAF		
		80EA 80EC	(SAF_ (SAF		IROL_7 IROL_8)
		80EE	(SAF_	CONT	
		80F0 (80F2 ((SAF_((SAF_(CONT	ROL_10) ROL_11)
		80F4	(SAF_	CONT	ROL_12)
		80F6	(SAF_		ROL_13)
		80FA	(SAF_(CONT	ROL_14)
		80FC	(SAF_	CONT	IROL_16)
		POR	WSM	SSM	
	ARMSELx	00	00	00	ARMINT select for safing recode x - correlates A Updated by SSM_RESET or SPI write while in DIAG state
					00 ARMP OR ARMN
					01 ARMP
					11 ARMP OR ARMN
S	PIFLDSELx	0	0	0	SPI field select for safing record x - determines which 16-bit field in long SPI magazages (>21 bit) to use for response on MISO of SPI magitar
					In case of messages less than 32 bits this bit is don't care. Updated by
					Updated by SSM_RESET or SPI write while in DIAG state
					0 First 16 bits of SPI MISO frame used for Response Mask and Data Mask bit-wise AND
					1 Last 16 bits of SPI MISO frame used for Response Mask and Data Mask bit-wise AND



LIM SELx	0	0	0	Data range limit select for safing record x - When enabled, determines the range limit used for incoming sensor data Updated by SSM_RESET or SPI write while in DIAG state
				0 8-bit data range limit - incoming data >120d is not recognized as
				1 10-bit data range limit - incoming data > 480d is not recognized as valid data
LIM Enx	0	0	0	Data range limit enable for safing record x Updated by SSM_RESET or SPI write while in DIAG state
				0 Data range limit disabled 1 Data range limit enabled
COMBx	0	0	0	Combine function enable for safing record x Updated by SSM_RESET or SPI write while in DIAG state
				0 Combine function disabled
				1 Combine function enabled For record pairs = x,x+1, the comparison for record x uses data(x) + data(x+1) and the comparison for record x+1 uses data(x) - data(x+1) Record pairs are 1,2; 3,4; 5,6; 7,8; 9,10; 11,12
DWELLx[1:0]	00	00	00	Safing dwell extension time select for safing record x Updated by SSM_RESET or SPI write while in DIAG state
				00 2048 ms 01 256 ms 10 32 ms 11 0 ms
ARM4x	0	0	0	ARM4INT select for safing record x - correlates safing result to ARM4INT Updated by SSM_RESET or SPI write while in DIAG state
				0 Safing record x not assigned to ARM4INT 1 Safing record x assigned to ARM4INT
ARM3x	0	0	0	ARM3INT select for safing record x - correlates safing result to ARM3INT Updated by SSM_RESET or SPI write while in DIAG state
				0 Safing record x not assigned to ARM3INT 1 Safing record x assigned to ARM3INT
ARM2x	0	0	0	ARM2INT select for safing record x - correlates safing result to ARM2INT Updated by SSM_RESET or SPI write while in DIAG state
				0 Safing record x not assigned to ARM2INT 1 Safing record x assigned to ARM2INT
ARM1x	0	0	0	ARM1INT select for safing record x - correlates safing result to ARM1INT Updated by SSM_RESET or SPI write while in DIAG state



				0 Safing record x not assigned to ARM1INT 1 Safing record x assigned to ARM1INT
CSx[2:0]	000	000	000	SPI Monitor CS select for safing record x Updated by SSM_RESET or SPI write while in DIAG state
				000 None selected for record x 001 SAF_CS0 selected for record x 010 SAF_CS1 selected for record x 011 SAF_CS2 selected for record x 100 SAF_CS3 selected for record x 101 CS_RS selected for record x 110 None selected for record x 111 None selected for record x
IFx	0	0	0	 SPI format select for safing record x - selects response protocol for SPI monitor Updated by SSM_RESET or SPI write while in DIAG state 0 Out of frame response for record x 1 In Frame response for record x

7.3.58 Safing record compare complete register (SAF_CC)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	Х	х	х	х	Х	Х	х	х	х	х	Х	х	х	х	х
MISO	0	0	0	0	0CC_16	0CC_15	0CC_14	000_13	0CC_12	0CC_11	000_10	000_9	0CC_8	0CC_7	0000_6	0CC_5	CC_4	cc_3	cc_2	cc_1

ID:	FF
Туре:	R
Read:	FF00
Write:	-

CC_xx 0 0 0 SS WS CC

0 Indicates compare complete status of each of the 16 safing records, and defines the end of the sample cycle for safing

Cleared by SSM_RESET or upon SPI read, set by safing engine when request, response mask and target registers match the incoming SPI frame

0 Compare not completed for record x

1 Compare completed for record x



7.4 Remote sensor SPI register map

The Remote Sensor SPI interface consists of twelve 32-bit read registers (one for each logical channel) to allow for access to decoded sensor data and fault registers. The registers are addressed by the read register ID and the Global ID bit.

The L9680 checks the validity of the received RID field in the MOSI_RS frame. Should a SPI read command be received containing an unused RID address, the command will be discarded and the ERR_RID bit will be flagged in the current GSW.

GID RID / WID						Here	DAM	Nomo	Description	Operating State						
GID			RIL	y / v	טוי			нех	R/W	Name	Description	Init	Diag	Safing	Scrap	Arming
0	1	0	1	0	0	0	0	\$50	R	RSDR0						
0	1	0	1	0	0	0	1	\$51	R	RSDR1						
0	1	0	1	0	0	1	0	\$52	R	RSDR2						
0	1	0	1	0	0	1	1	\$53	R	RSDR3						
0	1	0	1	0	1	0	0	\$54	R	RSDR4	Remote sensor					
0	1	0	1	0	1	0	1	\$55	R	RSDR5	data/status					
0	1	0	1	0	1	1	0	\$56	R	RSDR6	registers					
0	1	0	1	0	1	1	1	\$57	R	RSDR7	(PSI-5 or WSS)					
0	1	0	1	1	0	0	0	\$58	R	RSDR8	,					
0	1	0	1	1	0	0	1	\$59	R	RSDR9						
0	1	0	1	1	0	1	0	\$5A	R	RSDR10						
0	1	0	1	1	0	1	1	\$5B	R	RSDR11						
0	1	0	1	1	1	0	0	\$5C	R	RSTHR0_L	Pomoto					
0	1	0	1	1	1	0	1	\$5D	R	RSTHR1_L	sensor					
0	1	0	1	1	1	1	0	\$5E	R	RSTHR2_L	(PSI-5 or					
0	1	0	1	1	1	1	1	\$5F	R	RSTHR3_L	VVSS)					
0	1	1	0	0	0	0	0	\$60	R	RSTHR0_H	Domoto					
0	1	1	0	0	0	0	1	\$61	R	RSTHR1_H	sensor current					
0	1	1	0	0	0	1	0	\$62	R	RSTHR2_H	2 registers					
0	1	1	0	0	0	1	1	\$63	R	RSTHR3_H	(vvSS only)					
0	1	1	0	1	0	1	0	\$6A	R	ARM_STATE	Arming signals status register					
1	1	1	1	1	1	1	1	\$FF	R	SAF_CC	Safing record compare complete register					

Table 7. Remote sensor SPI register m	ар
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7.5 Remote sensor SPI tables

A summary of all the registers contained within the remote sensor SPI map are shown below and are referenced throughout the specification as they apply. The SPI register tables also specify the effect of the internal reset signals assertion on each bit field (the symbol '-'is used to indicate that the register is not affected by the relevant reset signal').

7.5.1 Remote sensor SPI global status word

The Remote Sensor SPI of L9680 contains an 11-bit word that returns global status information. The Global Status Word (GSW) of the Remote Sensor SPI is the most significant 11 bits of MISO_RS data.

MISO_RS	GSW	Name	POR	WSM	SSM	Description
						SPI Fault, set if previous SPI frame had wrong parity check or wrong number of bits, cleared upon read '
31	10	SPIFLT	0	0	0	0 No fault
						1 Fault
30	9	0	0	0	0	Unused
						Remote Sensor Interface Fault Present, logical OR of the corresponding FLTBIT bits (bit 15) for all faults but NODATA
29	8	RSFLT	0	0	0	0 All the RSDRx-FLTBIT bits are 0
						1 At least one of the RSDRx-FLTBIT bits is 1 and the associated fault code is different from NODATA
28	7	0	0	0	0	Unused
27	6	0	0	0	0	Unused
26	5	0	0	0	0	Unused
25	4	0	0	0	0	Unused
24	3	0	0	0	0	Unused
23	2	0	0	0	0	Unused
22	1	0	0	0	0	Unused
		ERR RI				Read address received in the actual SPI frame is unused so data in the response is don't care
21	0	D	0	0	0	0 No Error
						1 Error

Table 8. GSW - Remote sensor SPI global status word



7.6 Remote sensor SPI read/write registers

7.6.1 Remote sensor data/fault registers (RSDRx @FLT = 0)

PSI5/WSS Remote Sensor 0 Data and Fault Flag Register ch 0, slot 1 / ch 0 (RSDR0) PSI5/WSS Remote Sensor 1 Data and Fault Flag Register ch 1, slot 1 / ch 1 (RSDR1) PSI5/WSS Remote Sensor 2 Data and Fault Flag Register ch 2, slot 1 / ch 2 (RSDR2) PSI5/WSS Remote Sensor 3 Data and Fault Flag Register ch 3, slot 1 / ch 3 (RSDR3) PSI5 configuration register for channel 0, slot 2 (RSDR4) PSI5 configuration register for channel 1, slot 2 (RSDR5) PSI5 configuration register for channel 2, slot 2 (RSDR6) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 1, slot 2 (RSDR7) PSI5 configuration register for channel 1, slot 2 (RSDR7) PSI5 configuration register for channel 1, slot 2 (RSDR8) PSI5 configuration register for channel 1, slot 2 (RSDR7) PSI5 configuration register for channel 1, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 3, slot 2 (RSDR7)

Bit 15 = 0 NO FAULT Condition

50 (RSDR0)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI_RS					x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x
MISO_RS		CRC		0	FLT=0	On/Off		LCID	[3:0]		DATA [9:0]									
MISO_RS		CRC		STDSTL	FLT=0	atch_D0	LCID	0 [1:0]			DATA [11:0]									

ID:

	51 (RSDR1) 52 (RSDR2) 53 (RSDR3) 54 (RSDR4) 55 (RSDR5) 56 (RSDR6) 57 (RSDR7) 58 (RSDR8) 59 (RSDR9) 5A (RSDR10) 58 (RSDR11)
Туре:	R
Read:	5000 (RSDR0) 5100 (RSDR1) 5200 (RSDR2) 5300 (RSDR3) 5400 (RSDR4) 5500 (RSDR5) 5600 (RSDR6)



		5700 5800 5900 5A00 5B00	(RSE (RSE (RSE (RSE (RSE	DR7) DR8) DR9) DR10 DR10)) 0) 1)
Write:		-			
		POR	WSM	SSM	
PSI5 configured	cha	nnel			
CRC[2	:0]	-	-	-	CRC based on bits [16:0]
					Updated based on bits [16:0]
F	LT	1	1	1	Fault Status - Depending on Fault Status, the DATA bits are defined differently
					Cleared when all of the following bits are '0': STG, STB, CURRENT_HI, OPENDET, RSTEMP, INVALID, SLOT_ERROR, NODATA
					Set when any of the following bits are '1': STG, STB, CURRENT_HI, OPENDET, RSTEMP, INVALID, SLOT_ERROR, NODATA
					0 No fault
					1 Fault
On/0	Off	0	0	0	Channel On/Off Status
					Cleared by SSM_RESET or when channel is commanded OFF via SPI RSCTRL or when the STG bit is set or the RSTEMP bit is set
					Set when channel is commanded ON by SPI RSCTRL
					0 Off 1 On
LCID[3	8:0]	-	-	-	Logical Channel ID
					Updated based on SPI read request
					0000 RSU0 SLOT1
					0001 RSU0 SLOT2
					0010 RSU0 SLOT3
					0100 RSU1 SLOT1
					0101 RS01 SL012 0110 RS01 SL013
					1000 RSU2 SLOT3
					1001 RSU2 SLOT2
					1010 RSU2 SLOT3
					1100 RSU3 SLOT1
					1010 RSU3 SLOT2
					1110 RSU3 SLOT3

DATA[9:0] \$000 \$000 10-bit data from Manchester decoder



				Cleared by SSM_RESET or SPI read or when channel is commanded OFF
				updated when a valid PSI5 frame is received
Wheel speed confid	ured c	hanne	el (R	SDR0, RSDR1, RSDR2, RSDR3)
CRCI2·01	_	_	_	CRC based on bits [16:0]
010[2.0]	-	-	-	Undated based on bits [16:0]
STDSTL	0	0	0	Standstill indication (valid only for VDA sensor or PWM 2 edges)
				1 Standstill
				0 Valid Sensor Signal
FLT	1	1	1	Fault Status - Depending on Fault Status, the DATA bits are defined differently
				Cleared when all of the following bits are '0': STG, STB, CURRENT_HI, OPENDET, RSTEMP, INVALID, PULSE OVERFLOW ERROR, NODATA
				Set when any of the following bits are '1': STG, STB, CURRENT_HI, OPENDET, RSTEMP, INVALID, PULSE OVERFLOW ERROR, NODATA
				0 No Fault 1 Fault
Latch_D0	0	0	0	Logical Channel ID
				0 no prior bit0 faults
				1 prior message(s) contained bit0 fault
LCID[1:0]				Logical Channel ID
				00 RSU0
				01 RSU1
				10 RSU2
				11 KSU3
DATA[11:0]	\$000 \$	\$000 \$	6000	12-bit data from wheel speed decoder
				VDA Data Format
				DATA [7:0] Counter bits
				PWW Data Format DATA [8:0] Pulse Data bits



7.6.2 Remote sensor data/fault registers w/o fault (RSDRx @ FLT=1)

PSI5/WSS Remote Sensor 0 Data and Fault Flag Register ch 0, slot 1 / ch 0 (RSDR0) PSI5/WSS Remote Sensor 1 Data and Fault Flag Register ch 1, slot 1 / ch 1 (RSDR1) PSI5/WSS Remote Sensor 2 Data and Fault Flag Register ch 2, slot 1 / ch 2 (RSDR2) PSI5/WSS Remote Sensor 3 Data and Fault Flag Register ch 3, slot 1 / ch 3 (RSDR3) PSI5 configuration register for channel 0, slot 2 (RSDR4) PSI5 configuration register for channel 1, slot 2 (RSDR5) PSI5 configuration register for channel 2, slot 2 (RSDR6) PSI5 configuration register for channel 3, slot 2 (RSDR7) PSI5 configuration register for channel 0, slot 2 (RSDR8) PSI5 configuration register for channel 1, slot 2 (RSDR8) PSI5 configuration register for channel 1, slot 2 (RSDR8) PSI5 configuration register for channel 1, slot 2 (RSDR9) PSI5 configuration register for channel 2, slot 2 (RSDR10) PSI5 configuration register for channel 3, slot 2 (RSDR11)

Bit 15 = 1 FAULTED condition

50 (RSDR0)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOS_RSI			-			х	х	х	Х	х	х	х	Х	х	Х	х	х	х	Х	Х
MISO_RS (PSI5)		CRC		x	FLT=1	On/Off	LCID [3:0]			STG	STB	CURRENT_HI	OPENDET	RSTEMP	INVALID	NODATA	SLOT_ERROR	x	×	
MISO_RS (WSS)		CRC		x	FLT=1	On/Off	LCID	LCID [1:0]			STG	STB	URRENT_HI	OPENDET	RSTEMP	INVALID	NODATA	LOT_ERROR	х	x

ID:

	51 (RSDR1) 52 (RSDR2) 53 (RSDR3) 54 (RSDR4) 55 (RSDR5) 56 (RSDR6) 57 (RSDR7) 58 (RSDR8) 59 (RSDR9) 5A (RSDR10) 58 (RSDR11)
Туре:	R
Read:	5000 (RSDR0) 5100 (RSDR1) 5200 (RSDR2) 5300 (RSDR3) 5400 (RSDR4) 5500 (RSDR5) 5600 (RSDR6)



Write:

-

CRC[2:0]

FLT

On/Off 0 0

5700 5800 5900 5A00 5B00 -	(RSD (RSD (RSD (RSD (RSD)R7))R8))R9))R1()R11	D))
POR	WSM	SSM	
-	-	-	CRC based on bits [16:0]
			Updated based on bits [16:0]
0	0	0	Fault Status
			Cleared when all of the following bits are '0': STG, STB, CURRENT_HI, OPENDET, RSTEMP, NODATA, INVALID, SLOT ERROR, PULSE OVERFLOW ERROR
			Set when any of the following bits are '1': STG, STB, CURRENT_HI, OPENDET, RSTEMP, NODATA, INVALID, SLOT ERROR, PULSE OVERFLOW ERROR
			0 No fault
			1 Fault
0	0	0	Channel On/Off Status
			Cleared by SSM_RESET or when channel is commanded OFE via SPL

Cleared by SSM_RESET or when channel is commanded OFF via SPI RSCTRL or when the STG bit is set or the RSTEMP bit is set

Set when channel is commanded ON by SPI RSCTRL

- 0 Off
- 1 On
- LCID[0:3] 0000 0000 0000 Logical Channel ID

Updated based on SPI read request

0000 RSU0 SLOT1
0001 RSU0 SLOT2
0010 RSU0 SLOT3
0100 RSU1 SLOT1
0101 RSU1 SLOT2 1
0110 RSU1 SLOT3
1000 RSU2 SLOT1
1001 RSU2 SLOT2
1010 RSU2 SLOT3
1100 RSU3 SLOT1
1101 RSU3 SLOT2
1110 RSU3 SLOT3



STG	0	0	0	Short to Ground (in current limit condition) Cleared by SSM_RESET or when channel is commanded OFF via SPI RSCTRL 0 No fault 1 Fault
STB	0	0	0	Short to Battery Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL - not cleared by channel OFF caused by STG or RSTEMP Set when channel voltage exceeds VSUP for a time greater than T _{STBTH} 0 No fault 1 Fault
CURRENT_HI	0	0	0	Current High Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL Set when channel current exceeds ILKGG for a time determined by an up/down counter 0 No fault 1 Fault
OPENDET	0	0	0	Open Sensor Detected Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL Set when channel current exceeds ILKGB for a time determined by an up/down counter 0 No fault 1 Fault
RSTEMP	0	0	0	Over temperature detected Cleared by SSM_RESET or when channel is commanded OFF via SPI RSCTRL Set when over-temp condition is detected 0 No fault 1 Fault
INVALID	0	0	0	Invalid Data



				Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL or if one of the following is set: STG, STB, CURRENT_HI, OPEN_DET, RSTEMP, SLOT ERROR (PSI5), PULSE OVERFLOW ERROR (WSS) or if a new valid data is received.
				Set in PSI5 configuration when two valid start bits are received and a Manchester error (# of bits, bit timing) or parity error is detected Set in WSS configuration when parity error is detected (when this check is feasible). Volid any far VDA connect
				0 No fault 1 Fault
NODATA	1	1	1	No Data in buffer
				Cleared when a valid PSI5/WSS frame is received or if one of the following is set: STG, STB, CURRENT_HI, OPEN_DET, RSTEMP, SLOT ERROR, PULSE OVERFLOW ERROR, INVALID
				Set upon SPI read of RSDRx and none of the following bits are set: STG, STB, CURRENT_HI, OPEN_DET, RSTEMP, SLOT ERROR, PULSE OVERFLOW ERROR, INVALID
				0 No fault 1 Fault
PULSE OVERFLOW ERROR	0	0	0	Pulse duration counter overflow (valid only for PWM 2 edges sensors)
				Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL
				0 No fault 1 Fault
SLOT ERROR	0	0	0	Slot error fault (valid only for PSI5 sensors
				Cleared by SSM_RESET or SPI read or when channel is commanded OFF via SPI RSCTRL or if one of the following is set: STG, STB,
				CURRENT_HI, OPEN_DET, RSTEMP or if a new valid data is received
				Set in case of slot control enabled and frame not completely inside slot or more than one frame inside the slot
				0 No fault 1 Fault



7.6.3 Remote sensor x current registers y (RSTHRx_y)

Remote sensor 0, base current and delta to calculate 1st top current (RSTHR0_L) Remote sensor 1, base current and delta to calculate 1st top current (RSTHR1_L Remote sensor 2, base current and delta to calculate 1st top current (RSTHR2_L Remote sensor 3, base current and delta to calculate 1st top current (RSTHR3 L Remote sensor 0 (only for WSS), delta to calculate 2nd top current (RSTHR0_H) Remote sensor 1 (only for WSS), delta to calculate 2nd top current (RSTHR1_H Remote sensor 2 (only for WSS), delta to calculate 2nd top current (RSTHR2_H Remote sensor 3 (only for WSS), delta to calculate 2nd top current (RSTHR3_H

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			-		х	х	х	х	х	х	x x x x x x x x							х	х	х
MISO_RS				DE	LTA 1S	т тор	[9:0]				BASE CURRENT [9:0]									
MISO_RS	0 0 0 0 0 0 0 0 0 0 0 0 DELTA 2ND TOP [9:0]																			

ID:	5C (F 5D (F 5E (F 5F (F 60 (R 61 (R 62 (R 63 (R	RSTH RSTH RSTH RSTH RSTH RSTH RSTH	R0_I R1_I R2_I R3_I R0_H R1_H R2_H R3_H	L) L) -) -) 1) 1) 1)
Туре:	R			
Read:	5C00 5D00 5E00 5F00 6000 6100 6200 6300) (RS) (RS) (RS (RS (RS (RS (RS (RS	THR THR THR THR THR THR THR THR THR	0_L) 1_L) 2_L) 3_L) 0_H) 1_H) 2_H) 3_H
Write:	-			
BASE CURRENT [9:0]	YOd \$A1	WSM \$A1	WSS \$A1	PSI5/WSS base current measured by internal converter (93.75 μA ±9% each LSB).
DELTA 1ST TOP [19:10]	\$103	\$103	\$103	3 PSI5/WSS delta measured by internal converter respect to base current (93.75 μA ±9% each LSB) to get top current.
				Low threshold = base current+(DELTA_1ST_TOP/2) in case of WSS or PSI5 without current averaged algorithm (bit 4 of RSRCx register equal to 0).
				Low threshold = base current+(DELTA_1ST_TOP) in case of PSI5 with current averaged algorithm (bit 4 of RSRCx register equal to 1).



DELTA 2ND TOP [9:0] \$7 \$103 \$103 WSS delta measured by internal converter respect to base current (93.75 µA ±9% each LSB) to get second top current.

High threshold = ((base current+DELTA_1ST_TOP)+(base current+DELTA_2ND_TOP))/2.

7.6.4 Arming signals register (ARM_STATE)

		19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				-	-	х	Х	х	х	х	Х	х	х	х	х	Х	Х	Х	х	х	х
MISO		0	0	0	0	0	0	0	0	0	0	PSINHINT	PSINH_EXP_TIME	ACL_PIN_STATE	ACL_VALID	$ARMINT_4$	ARMINT_3	ARMINT_2	ARMINT_1	0	0
ID:				6A																	
Туре:		R																			
Read:		6A00																			
Write:				-																	
	AR	:MIN ⁻	Γ_x	- POR	- WSM	- SSM	Sta Upo enç	State of ARMINT signals Updated per Safing Engine output logic diagram in case of internal safing engine otherwise is the echo of ARMx pins													
ŀ	ACL	VA	LID	0	0	0	Vali	id AC 0 Clea 1 Set	L dete ared v wher	ection when / ACL_	ACL_ _GO(_BAD DD=3	=2								
ACL_F	PIN	_STA	ΤE	-	-	-	Ecł	no of <i>i</i>	ACL p	oin											
PSINH_	'SINH_EXP_TIME 0 0 0 State of PSINH expiration timer 0 If timer is 0 1 If timer is counting																				
	PSINHINT State of PSINHINT signal Updated per PSINH output logic diagram in case of internal engine other is the echo of PSINH pin inverted												other	wise							



L9680

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI/ MOSI_RS		-			х	х	х	х	х	х	х	х	х	х	х	х	х	х	х	х
MISO/ MISO_RS	0	0	0	0	CC_16	cc_15	CC_14	CC_13	CC_12	cc_11	cc_10	ော၁	cc_8	cc_7	cc_6	cc_5	CC_4	cc_3	cc_2	cc_1

7.6.5	Safing record	compare	complete	register	(SAF_	CC)
-------	---------------	---------	----------	----------	-------	-----

ID:	FF
Туре:	R
Read:	\$FF01
Write:	\$80FE
	SM SN

SSM

CC_xx 0

0 Indicates compare complete status of each of the 16 safing records, and defines the end of the sample cycle for safing

Cleared by SSM_RESET or upon SPI read, set by safing engine when request, response mask and target registers match the incoming SPI frame

- 0 Compare not completed for record \boldsymbol{x}
- 1 Compare completed for record x



8 Deployment drivers

The squib/pyroswitch deployment block consists of 12 independent high side drivers and 12 independent low side drivers. Squib/pyroswitch deployment logic requires a deploy command received through SPI communications and either an arming condition processed by safing logic or a proper ARMx input pin assessment, depending on whether the internal safing engine is used or not. Both conditions must exist in order for the deployment to occur. Once a deployment is initiated, it can only be terminated by an SSM_RESET event.

L9680 allows all 12 squib/pyroswitch loops to be deployed at the very same time or in other possible timing sequence. Deployment drivers are capable of granting a successful deployment also in case of short to ground on low-side circuit (SRx pins). Firing voltage capability across high side circuit is maximum 25 V. High side and low side drivers account for a maximum series total resistance of 2 Ω . Each loop is granted for a minimum number of deployments of 50, under all normal operating conditions and with a deployment repetition time higher than 10s. Both the High and the Low side FET drivers are equipped with passive gate turn-off circuitries to guarantee the FETs are kept in off state also when the device is unpowered or during power-up/down transients.

8.1 Control logic

A block diagram representing the deployment driver logic is shown below. Deployment driver logic features include:

- Deploy command logic
- Deployment current selection
- Deployment current monitoring and deploy success feedback
- Diagnostic control and feedback







Figure 29. Deployment driver control logic - Enable signal







The high level block diagram for the deployment drivers is shown below:



Figure 31. Deployment driver block

8.1.1 Deployment current selection

Deployment current is programmed for each channel using the Deploy Configuration Register (DCRx) shown in *Section* 7.3.7.

The deploy time selection allows the device to deploy for a time up to 4.032 ms. Careful considerations should be done in order to avoid damage on the squib/pyroswitch driver section for excessive thermal heat. In order to prevent device damage, it is suggested to avoid excessive voltage drop between SSxy and SFxy. In case the 1.75 A deployment current level is selected, the voltage drop across the pins should be limited to maximum 17 V for deployment times longer than 0.7 ms and up to 2 ms and 15 V up to 3.2 ms. In case 1.2 A is selected, the voltage drop should be limited to maximum 22 V for deployment times longer than 2 ms and up to 3.2 ms.

8.1.2 Deploy command expiration timer

Deploy commands are received for all channels using SPI communications. Once a deploy command is received, it will remain valid for a specified time period selected in the *Deployment configuration registers (DCR_x)*. The deploy status and deploy expiration timer can be read through the *Deployment status registers (DSR_x)*. The deploy expiration timer is selectable via 2 bits and the maximum programmable time is 500 ms nominal.



8.1.3 Deployment control flow

Deployment control logic requires the following conditions to be true to successfully operate a deployment:

- POR = 0
- SSM to be either in Safing State or Arming State
- a valid arming condition processed by safing logic or ARMx signals to be set (depending on selection of internal or external safing engine)
- channel-specific deploy command request bits to be set via SPI in the Deploy command Register (DEPCOM)
- a global deployment state has to be active, as described in the following figure.



Figure 32. Global SPI deployment enable state diagram

In case a multiple deployment request would be needed, i.e. deploying the same channel in sequence, a toggle on DEP_DISABLED has to be performed and a new DEPCOM command on the same channel has to be sent.

The SPI DEPCOM command is ignored if the device is in the DEP_DISABLED state and the deploy command is not set. While in DEP_ENABLED state, the following functionalities that could be active are forced to their reset state:

- All squib/pyroswitch and DC sensor diagnostic current or voltage sources
- All squib/pyroswitch, DC sensor and ADC diagnostic MUX settings, state machine, etc.

The SPI_LOCK and SPI_UNLOCK signals are available in the SPIDEPEN command:

High-side and Low-side enablers (ARMx) are assigned to the desired channels by means of the programmable loop matrix. Loop matrix registers are 4, one for each ARMx signals. In each loop matrix register 12 bits are present to associate independently loops with ARMx signals. In case external safing is selected LOOP_MATRIX_ARM4 register is don't care because ARM4 pin is used to arm the low side of all loops without association matrix. Deploy commands in the Deploy Command Register (DEPCOM) are channel specific.

Deployment requires a valid arming condition from safing logic or ARMx signals to be set any time before, during or after the specific sequence of deploy commands is received. It is feasible for a deploy command to be received without a valid arming condition from safing logic or the ARMx being set. In this case, the deploy command will be terminated according



to the *Deploy command expiration timer*. Likewise, a valid arming condition signal can be set without receiving a Deploy Command. In this case, the enabling signals will remain active according to the Arming Enable Pulse Stretch Timer or the ARMx enabling state. The Arming Enable Pulse Stretch Timers is available in the AEPSTS register.

8.1.4 Deployment current monitoring

A current comparator is used to indicate when the output current from the HSD, SFx, exceeds the deployment current threshold, I_{THDEPL}. The timer signal remains active and increments while the current meets the programmed deploy current as set in the Deploy Configuration Register. The deploy current counter value is stored in the Deploy Current Monitor Timer Register XY (DCMTSxy). There is a unique timer register for each channel.

If the deploy current falls below the specified current threshold momentarily and recovers, the deploy current counter will pause during the drop-out and continue once the current exceeds the threshold. The deploy current counter will not be reset by the presence or absence of current in the deployment channel.



Figure 33. Current monitor counter behavior

The deploy current counter is reset to \$0000 as soon as a toggle on DEP_DISABLED is performed and a new DEPCOM command on the same channel is received.

8.1.5 Deployment success

Deploy success flag is set when the deploy timer elapses. This bit (CHxDS) is contained in the Deploy Status Register. Within the Global Status Word register (GSW), a single bit (DEPOK) is also set once any of the 12 deployment channels sets a deploy success flag.

8.2 Energy reserve - deployment voltage

One deployment voltage source pin is used for adjacent channels (e.g. SS23 for channels 2 and 3). These pins are directly connected to the high side drivers for each channel.

8.3 Deployment ground return

L9680 is hosted in a particular frame allowing squib/pyroswitch driver ground feedback to be connected to an internal ground ring. This ring is electrically connected to the package exposed pad and to the GNDSUB1 and GNDSUB2 pins. Connection to these two pins is made by means of a strong metal layer, therefore this connection is sufficient for all





deployments occurring simultaneously, even in case of only one out of the three possible connections being available.

8.4 Deployment driver protections

8.4.1 **Delayed low-side deactivation**

To control voltage spikes at the squib/pyroswitch pins during drivers deactivation at the end of a deployment, the low side driver is switched off after t_{depl ls-dly} delay time with respect to the high side deactivation.

8.4.2 Low-side voltage clamp

The Low side driver is protected against overvoltage at the SRx pins by means of a clamping structure as shown in *Figure 31*. When the Low side driver is turned off, voltage transients at the SRx pin may be caused by squib/pyroswitch inductance. In this case a low side FET drain to gate clamp will reactivate the low side FET allowing for residual inductance current recirculation, thus preventing potential low side FET damage by overvoltage.

8.4.3 Short to battery

The Low side driver is equipped with current limitation and overcurrent protection circuitry. In case of short to battery at the squib/pyroswitch pins, the short circuit current is limited by the Low side driver to I_{LIMSRx} . If this condition lasts for longer than t_{IIM} deglitch filter time then the low and high-side drivers will be switched off and latched in this state until a new deployment is commanded after SPI DEPEN is re-triggered.

8.4.4 Short to ground

The squib/pyroswitch driver is designed to stand a short to ground at the squib/pyroswitch pins during deployment. In particular, the current flowing through the short circuit is limited by the high side driver (deployment current) and the high-side FET is sized to handle the related energy.

In case the short to ground during deployment occurs after an open circuit, a protection against damage is also available. The high side current regulator would have normally reacted to the open circuit by increasing the Vgs of the high side FET. Thanks to a dedicated fast comparator detecting the open condition, the driver is able to discharge the FET gate quickly in order to reduce current overshoot and prevent potential driver damage when the short to ground occurs.

8.4.5 Intermittent open squib/pyroswitch

A dedicated protection is also available in case of intermittent open load during deployment. In this case, if load is restored after an open circuit, due to slow reaction of the high-side current regulation loop, the current through the squib/pyroswitch is limited only to ILIMSBx by the low side driver. If this condition lasts for longer than t_{LIMOS} then the high side is turned off for t_{HSOFFOS} and then reactivated. By this feature, intermittent open squib/pyroswitch and short to battery faults may be distinguished and handled properly by the drivers.



8.5 Diagnostics

The L9680 provides the following diagnostic feedback for all deployment channels:

- High voltage leakage test for oxide isolation check on SFx and SRx
- Leakage to battery and ground on both SFx and SRx pins with or without a squib/pyroswitch
- Short between loops diagnostics
- Squib/pyroswitch resistance measurement with leakage cancellation and selectable range (10/50 Ω)
- High squib/pyroswitch resistance with range from 500 Ω to 2000 Ω
- SSxy, SFx and VER voltage status
- High and Low side FET diagnostics
- High side driver diagnostics
- Loss of ground return diagnostics
- High Side Safing FET diagnostics

The above diagnostic results are processed through a 10 bit Analog to digital algorithmic converter. These tests can be addressed in two different ways, with a high level approach or a low-level one. The main difference between the two approaches is that with the low level approach the user is allowed to precisely control the diagnostic circuitry, also deciding the proper timings involved in the different tests. On the other hand, the high level approach is an automatic way of getting diagnostic results for which an internal state machine is taking care of instructions and timings.

The following is block diagram of the Squib/pyroswitch Diagnostics.





Figure 34. Deployment loop diagnostics

The leakage diagnostic includes short to battery, short to ground and shorts between loops. The test is applied to each SFx and SRx pin so shorts can be detected regardless of the resistance between the squib/pyroswitch pins.

8.5.1 Low level diagnostic approach

In this approach, each of the test steps described in the sections below requires user intervention by issuing the proper SPI command.

High voltage leakage test for oxide isolation check

This test is mandatory to address possible leakages that could not be experienced at low voltages on SFx or SRx pins. The I_{source} current generator (ISRC) is enabled on the chosen SFx pin. To confirm that the SFx pin has then reached a suitable voltage level, a dedicated ADC measurement on the SFx pin can be requested. Once this test is performed, a leakage test on SFx and SRx pins can be issued to double check possible leakages.

Leakage to battery/ground diagnostics

Prior to the real test, the Voltage Regulator Current Monitor block (VRCM) has to be tested and validated. The validation of VRCM goes into verifying both the short to battery and short to ground flags.

The I_{source} current generator (ISRC) is first connected to SFx pin to raise its voltage to SYNCBOOST. Then, the Voltage Regulator Current Monitor block (VRCM) is enabled and



connected to the selected SFx pin. The I_{sink} current limited switch (ISNK) is turned off, as well as the pull-down current generator. If the VRCM block works properly, the short to battery flag would be asserted.

Then, the I_{sink} current limited switch (ISNK) is connected to SRx pin, the Voltage Regulator Current Monitor block (VRCM) is enabled and connected to the selected SRx pin. The I_{source} current generator (ISRC) is turned off, as well as the pull-down current generator. If the VRCM block works properly, the short to ground flag would be asserted.





Once the VRCM block is validated, the real leakage tests can be performed. ISRC and ISNK currents have to be kept switched off. The VRCM shall be connected to the desired pin (either SFx or SRx pins); by doing this, also the pull-down current on the selected SRx pin is automatically deactivated). During the test, if no leakage is present the voltage on the selected or SRx pin will be forced by the VRCM to the VREF level and no current is detected or sourced by the VRCM. If there is leakage to ground or battery, the VRCM will sink or source current trying to maintain VREF. Two current comparators, ISTB and ISTG, will detect the abnormal current flow and the relative flags will be given in the LPDIAGSTAT. These flags are not latched and report the real time status of the relevant comparators in case of low-level leakage diagnostic test. Voltage conversion is not required to have these flags updated. In LPDIAGSTAT register are also reported the channel and the pin (SFx or SRx) under test, respectively with LEAK_CHSEL and SQP bit fields.

The pull-down currents on the other SRx pins are still active. Therefore, the leakage test that would show a leakage to ground may be depending on a real leakage on the pin under test or on a short between loops.



Short between loops diagnostics

In case the previous test has reported a leakage to ground fault, the short between loops diagnostics shall be run. The same procedure is followed as described for normal leakage tests except the fact that in this case all the pull-down current generators have to be deactivated (not only the one for the pin under test), by means of the PD_CURR bit in the Diagnostic Request Register (LPDIAGREQ). If a leakage or ground fault is not present, then the channel under test has a short to another squib/pyroswitch loop.

Fault condition on squib/pyroswitch channel	Channel leakage diagnostics with PD_CURR on (for other channels than the one under test	Channel leakage diagnostics with PD_CURR off (for all channels)		
No shorts	No fault	No fault		
Short to battery	STB fault	STB fault		
Short to ground	STG fault	STG fault		
Short between loops	STG fault	No fault		

Table 9. Short between	loops	diagnostics	decoding
------------------------	-------	-------------	----------

The condition of two open channels, i.e. without squib/pyroswitch resistance connecting SFx to SRx, that have a short between loops on SFx cannot be detected. If only one of the two shorted SFx pins is open, the fault will be indicated on the open channel.

Squib/pyroswitch resistance measurement

During a resistance measurement, a two-step process is performed. At the first step, both ISRC current generator and ISNK current limited switch are enabled and connected to the selected SFx and SRx channel, through ISRC, ISRC_CURR_SEL, ISNK and RES_MEAS_CHSEL bit fields in the Loop Diagnostic Request Register (LPDIAGREQ). The ISRC current can be configured to either 40 mA or 8 mA nominal value through the ISRC_CURR_SEL bit in the LPDIAGREQ register providing the user with two different measurement range options. A differential voltage is created between the SFx and SRx pin based on the ISRC current and squib/pyroswitch resistance between the pins. The SPI interface will provide the first resistance measurement voltage (Vdiff1) based on the amplifying factor of the differential amplifier and a 10 bit internal ADC conversion. The second measurement step (bypass measurement) is performed redirecting ISRC to the selected SRx pin, while keeping ISNK on; this way, the differential amplifier and following ADC will output the offset measurement through SPI (Vdiff2). Microcontroller is then allowed to calculate the mathematical difference between first and second measurements to obtain the real squib/pyroswitch resistance value.

$$V_{diff1} = G_{RSQ} \times \left[I_{SRC_*} \times \left(\frac{R_{LKG_SF} \times R_{SQ}}{R_{LKG_SF} + R_{SQ}} \right) + \frac{R_{SQ}}{R_{LKG_SF} + R_{SQ}} (V_{LKG_SF} - V_{SRx_RM}) \right] +$$

+
$$G_{RSQ} \times V_{off_RSQ}$$

$$V_{diff2} = \frac{G_{RSQ} \times R_{SQ}}{R_{LKG SF} + R_{SQ}} \times (V_{LKG_{SF}} - V_{SRx_{RM}}) + G_{RSQ} \times V_{off_{RSQ}}$$

$$R_{SQ} = \frac{V_{diff1} - V_{diff2}}{G_{RSQ} \times I_{SRC_{*}}} \text{ (assuming } R_{LKG_{SF}} >> R_{SQ})$$



The simplification in the calculation method reported above can result in some amount of error that is already incorporated in the overall tolerance of the squib/pyroswitch resistance measurement reported in the electrical parameters table.

Values of each measurement step can be required addressing the proper ADCREQx code in Section 7.3.33: ADC request and data registers (DIAGCTRL_x).

This calculation is tolerant to leakages and, thanks to a dedicated EMI low-pass filter, also to high frequency noises on squib/pyroswitch lines. Moreover, L9680 features a slew rate control on the ISRC current generator to mitigate emissions.

High squib/pyroswitch resistance diagnostics

With this test, the device is able to understand if the squib/pyroswitch resistance value is below 200 Ω , between 500 Ω and 2000 Ω or beyond 5000 Ω . During a high squib/pyroswitch resistance diagnostics, VRCM and ISNK are enabled and connected respectively to SFx and SRx on the selected channel. VREF voltage level will be output on SFx. Current flowing on SFx will be measured and compared to I_{SRlow} and I_{SRhigh} thresholds to identify if the resistance is above or below RSRlow or RSRhigh levels. The results are reported in the LPDIAGSTAT register. The relative flags (HSR_HI and HSR_LO) are not latched and reflect the current status of the comparators.

High and low side FET diagnostics

This couple of tests can only be run during the diagnostic mode of the power-up sequence *Figure 11*. Tests are performed individually for HS driver or LS driver, with two dedicated commands. Prior to either the HS or LS FET diagnostics being run, the VRCM has to be first enabled. Within the command to enable the VRCM, also the channel onto which the FET test will be run has to be selected with the LEAK_CHSEL bit field. Running the leakage diagnostics with the appropriate delay time prior to either the HS or LS FET diagnostics will precondition the squib/pyroswitch pin to the appropriate voltage level. When the FET diagnostic command is issued with the Diagnostic Register SPI command (SYSDIAGREQ), the VRCM flags will be cleared, the VRCM deglitch filter time is switched from the leakage diagnostic deglitch filter time (TFLT_LKG) to the FET test deglitch filter time (TFLT_LKGB_FT) for both HS and LS and the output of the VRCM deglitch filter is now allowed to disable the appropriate HS or LS squib/pyroswitch driver during FET test.

The device monitors the current through the VRCM. If the FET is working properly, this current will exceed $I_{HS_FET_TH}$ or $I_{LS_FET_TH}$ current threshold, respectively for HS or LS FET test for the deglitch filter time of TFLT_LKGB_FT, and the driver under test is turned off immediately and automatically.

If there is a substantial leakage fault to Vbat or GND present during the FET test, leading this leakage current to exceed the IHS_FET_TH or ILS_FET_TH current threshold, for the deglitch filter time of TFLT_LKGB_FT, then the driver under test is turned off immediately and automatically, and the corresponding VRCM flag, STG or STB, is set.

If the current does not exceed the current threshold, the test will be terminated and the driver is anyway turned off within $T_{FETTIMEOUT}$.



VRC	CM Flags	Posult				
STG	STB	Kesuit				
0	0	FET test fail				
0	1	FET test pass OR Leakage to Vbat				
1	0	FET test disabled due to Leakage to Gd				
1	1	State not possible				

Table 10. HS FET TEST

Table 11. LS FET TEST

VR	CM Flags	Posult			
STG	STB	Nesuit			
0	0	FET test fail			
0	1	FET test disabled due to Leakage to Vbat			
1	0	FET test pass OR Leakage to GND			
1	1	State not possible			

During $T_{FETTIMEOUT}$ period, the bit stating that the FET is enabled will be set (FETON=1) and will be cleared as soon as the FET is switched back off.

For all conditions the current on SFx/SRx pins will not exceed the VRCM current limitation value ($I_{LIM_VRCM_SINK}$ or $I_{LIM_VRCM_SRC}$). There may be higher currents on the squib/pyroswitch lines due to the presence of filter capacitors. During these FET tests, energy available to the squib/pyroswitch is limited to less than E_{FET_TEST} . For high side FET diagnostics, if no faults were indicated in the preceding leakage diagnostics then a normal result would be [STB=1, STG=0]. If the returned result for the high side FET test is not as the previous then either the FET is not functional, a short to ground occurred during the test, or there is a missing SSxy connection for that channel.

For low side FET diagnostics if no faults were indicated in the preceding leakage diagnostics then a normal result would be [STB=0, STG=1]. If the returned result for the low side FET test is not as the previous then either the FET is not functional or a short to battery occurred during the test. In case of ground loss the low-side FET diagnostic would not indicate a FET fault.

The VRCM flags will be given in the LPDIAGSTAT register. The status of the VRCM flags after FET test is latched and can be cleared upon either LPDIAGREQ or SYSDIAGREQ SPI commands.

Finally, after FET test is completed, the VRCM deglitch filter time is switched from the FET test deglitch filter time (TFLT_LKGB_FT) to the leakage diagnostic test deglitch filter time



(TFLT_LKG) for both HS and LS and the output of the VRCM deglitch filter is now not allowed to disable the appropriate HS or LS squib/pyroswitch driver anymore.

High side driver diagnostics

This test is intended to verify the proper functionality of the HS FET driver, but also the external squib/pyroswitch connection and other internal circuitries.

First, the ISNK current has to be activated via the LPDIAGREQ register; the channel onto which the ISNK current is activated has to be selected with the RES_MEAS_CHSEL bit field. Then, the HS FET related to the loop channel as indicated in the RES_MEAS_CHSEL bit field is activated with the dedicated DSTEST code for the HS squib/pyroswitch driver test in the Diagnostic Register SPI command (SYSDIAGREQ). In such condition, the HS driver will control the FET current to a level $I_{LIM}_{HS}_{FET}$ much lower than the usual deployment current. The HS_DRV_OK flag will be set accordingly to the test result in the LPDIAGSTAT register, as soon as the deployment current monitoring comparator will detect that the current through the HS FET exceeds the diagnostic current threshold, 90%*I_{LIM HS FET}.

Loss of ground return diagnostics

This diagnostics is available during a squib/pyroswitch measurement or a high side driver diagnostics. This test is based on the voltage drop across the ground return, if the voltage drop exceeds SG_{xy_OPEN} , ground connection is considered as lost. Should the ground connection on the squib/pyroswitch driver circuit be missing, the bit related to the channel under test by the two above diagnostics will be activated in the LP_GNDLOSS register. The flag is latched after a proper filter time T_{FLT SGOPEN} and cleared upon read.

High side safing FET diagnostics

This test has to be issued during the Diag state of the power-up sequence (*Figure 11*). Safing FET has to be switched on with the proper code in DSTEST bit field of the SYSDIAGREQ. Therefore, when the command is received, the device will activate VSF regulator to supply the external safing FET controller. The user can measure the voltage levels of both the VSF regulator and the SSxy nodes. If the safing FET is properly switched on, the voltage on SSxy will be regulated.

The measurement request is done via Diagnostic Control command (DIAGCTRLx), while results will be reported through ADCRESx bit fields.

Deployment Timer diagnostic

This test allows verifying the correct functionality and duration of the timers used to control the deployment times. This test can be executed only when the IC is in the Diag state by setting the appropriate code in the DSTEST field of the SYSDIAGREQ register. When the test is launched, the IC sequentially triggers the activation of the deployment timers of the various channels (each of them separated by 8ms idle time) and outputs the relevant waveform to the ARM1 output discrete pin. See the sequence detail in *Figure 36*. The μ C can therefore test the deployment times by measuring the duration of the high pulses sent by the IC on the ARM1 pin. The deployment time configuration used during this test is the latest one programmed in the DCRx registers. In case the test is run on a channel with no DCRx deployment time previously configured, a default 8 μ s high pulse is output on ARM for the relevant channel.





Squib/pyroswitch diagnostics with common SRx connected loops

In case of two SRx pins are intentionally connected together, the PD_CURR_CSR bit of the Deployment Configuration register (DCR_x, where x = 0, 2, 4, 6, 8, A) must be used to indicate which loop pairs have the common SRx connection. The purpose of this additional bit is to control the pull-down current on each channel to be consistent with or without the Common SRx connected loops. When the DCR_x(PD_CURR_CSR) bit is set for one loop pair and the Deployment diagnostic is run on that loop pair, the pull-down current is disabled on both channels of the loop pair selected.

For the squib/pyroswitch channel pair with common SRx connection, to understand if the two SFx pins are shorted together, the squib/pyroswitch resistance measurement must be required with the following setting: LPDIAGREQ[12:11]=11. In this way the ISRC current generator is enabled on the channel selected by RES_MEAS_CHSEL[3:0] bits while the Differential Operational Amplifier is connected on the other channel of the squib/pyroswitch resistance measurement results will be close to 0, otherwise it will be half the real squib/pyroswitch resistance.

Loop diagnostics control and results registers

Diagnostic tests and channels for each test are controlled through the Loop Diagnostic Request Register (LPDIAGREQ), diagnostic results are stored in the Loop Diagnostic Status Register (LPDIAGSTAT).



8.5.2 High level diagnostic approach

In this approach, the test steps described in the sections below are coded into a dedicated state machine that helps reducing the user intervention to a minimum.

The high-level diagnostic commands are contained in the LPDIAGREQ, LOOP_DIAG_SEL, and LOOP_DIAG_CHSEL registers. The high-level diagnostic response is available in the LPDIAGSTAT register.

The concept is depicted in the following figures.









Figure 38. High level loop diagnostic flow2



9 Remote sensor interface

The L9680 contains 4 remote sensor interfaces, capable of supporting PSI-5 protocol (synchronous mode, increased voltage, extended range) and active wheel speed sensors. A simplified block diagram of the interface is shown below. The interface supply is given on the SATBUCK pin (refer to *Figure 3: Power supply block diagram*). The circuitry consists of a power interface that mirrors current flowing in the external sensor and transmits this current information to the decoder, which produces a digital value for each remote sensor channel. The voltage at the RSUx pins can be limited by the power interface in case of SATBUCK supply overvoltage to protect the external sensors. Decoded data are then output through the Remote Sensor Data Registers (RSDRx). Received signals can be processed to the corresponding discrete logic output pin WS0-WS3. The power interface also contains error detection circuitry. When a fault is detected, the error code is stored in a global SPI data buffer in the Remote Sensor Data Registers (RSDRx).





Remote sensor configuration can be addressed via the Remote Sensor Configuration Registers (RSCRx). Some of the bit fields in the RSCRx registers are available depending on the chosen configuration, remote sensor rather than wheel speed sensors. In particular, TSxDIS bit allows overriding the time slot control for PSI5 I/F and BLKTxSEL allows selection between 5ms and 10ms for the blanking time applied to the current limitation fault detection each time a channel is activated.

The Remote Sensor Control Register (RSCTRL) allow for interface channels to be switched on and Off and for Sync Pulse control via SPI.

The remote sensor interface reports both data information and fault information in the Remote Sensor Data Register (RSDRx). The device accommodates for a total of 12 data registers. Independent data registers are defined for each remote sensor interface and are formatted differently based on whether the interfaces are programmed for PSI-5 remote sensor functions or active wheel speeds.

In the VDA sensor communication, data bit D0 in the RSDRx register might be used by the sensor as a fault bit. Therefore, this bit is latched as D0_L in order to detect whether a fault has occurred: the eight data bits are updated every speed pulse so intermittent fault conditions could be lost. This bit is cleared-upon-read.

If the device detects an error on the sensor interface, the MSB in RSDRx (FLTBIT) will be set to '1' and the following bits will be used to report the detected errors. Otherwise, the register will contain only data information. Detailed information on data and fault reporting are explained in the following sections.



When a fault condition is detected, the RSFLT bit of the global status word (GSW) is set to 1. Faults other than Short to Ground and Over-temperature will only clear after read, not by the disabling of channel.

Data are cleared upon reading the RSDRx register.

9.1 PSI5 mode

All channels are compliant to the PSI-5 v1.3 specification as described below:

- Two-wire current interface
- Manchester coded digital data transmission
- High data transmission speeds of 125 kbps and 189 kbps
- Variable data word length (8 & 10 bit only)
- 1-bit parity
- Synchronous operating mode with 3 time slots

An example of the data format for one possible PSI-5 protocol configuration is shown below. Data size and the error checking may vary, but the presence of 2 sync start bits (referenced below as sync bits) and 2 T_{Gap} time is consistent regardless.



Figure 40. PSI-5 remote sensor protocol (10-bit, 1-bit parity

9.1.1 Functional description

The Remote Sensor Interface block provides a hardware connection between the microcontroller and up to twelve remote sensors (maximum three per channel). Each channel is independent on the others, and is not influenced by possible fault conditions occurring on other channels, such as short circuits to ground or to vehicle battery. Each channel is supplied by a current limited DC voltage derived from SATBUCK, and monitors the current sunk from its supply in order to extract encoded data. The remote sensor modulates the current draw to transmit Manchester-encoded data back to the receiver. The current level detection threshold for all channels is internally computed by the IC in order to adapt the signal level to the sensors quiescent current.

All channels can be enabled or disabled independently via SPI commands. The operational status of all channels can also be read via SPI command. All channels support individual selective sync-pulse control to allow communication back to the remote sensor via sync-pulse voltage modulation as described in the PSI5 v1.3 specification.



The message bits are encoded using a Manchester format, in which logic values are determined by a current transition in the middle of the bit time. When configured for PIS5 sensors each interface supports Manchester 2 encoding as shown in *Figure 41*. When configured for VDA sensors the protocol supported is Manchester 1.





The sensor input filter time, deglitch filter, (delay until a threshold crossing is detected) can be configured in 15 steps. Filters can be selected individually for each channel, through the Remote Sensor Configuration Register, WSFILT bits

The received message data are stored in input data registers that are read out by the microcontroller via the SPI interface. For PSI5, three data registers per channel are used to store remote sensor messages received during timeslots 1, 2, and 3 respectively. Each register is updated after a certain delay (TWRITE_EN_DELAY) from the end of relative sensor message. All the bits inside the registers itself are simultaneously updated upon reception of the remote sensor message to prevent partial frame data from being sampled via the SPI interface. After the data for a given channel is read via the SPI interface, subsequent requests for data from this channel will result in an error response.

To allow for sampling synchronization of remote sensor data with the software in the microcontroller, the Remote sensor Interface block includes sync-pulse circuitry to signal initiation of sampling in the remote sensor. The sync-pulse is output to the remote sensors in the form of an increased voltage level on the RSUx pins when sampling is to be conducted. The higher voltage level required for the sync-pulse is sourced from the SYNCBOOST boost regulator. Pulse shaping is used to limit the slew rate of the pulses to reduce EMI. Feedback protection is provided to prevent fault conditions on one channel from affecting the others during sync-pulse generation. The microcontroller schedules the activation of the sync pulses to the four channels by providing a periodic signal to the SATSYNC pin. When a rising edge is detected on SATSYNC pin, the Remote sensor Interface block outputs sync pulses on channels RSU0-RSU3 in sequence to reduce the average current inrush to the remote sensors as shown in *Figure 42*. The voltage source in the Remote Sensor Interface block can source and sink current and is used to discharge the bus capacitance at the end of the sync pulse. The pull down device used to sink current is current limited.




Figure 42. Remote sensor synchronization pulses

L9680 supports three time slots in a sync period with associated RSDRx registers. The messages received within one sync period are routed to the corresponding RSDRx register associated to each time slot. A time slot control is performed to check if the incoming messages fall within the valid time slots reported in Table 62 and sketched in Figure 43 If the end of the received message occurs outside a valid time slot, a SLOT ERROR fault will be detected and stored in the related RSDRx register. Slot error assignment is described in Figure 43. For instance, if the end of second message falls before expected valid time window the error slot 1 is asserted and then also the data received with the first message is lost. If two messages end within the same slot, the second message will be assigned to that slot, regardless its validity. The time slot control can be disabled by setting the TSxDIS bit in the RSCRx register.



Figure 43. PSI5 slot timing control



57/

The remote sensor interface is also able to detect faults occurring on the sensor interface. The Remote Sensor Data Register (RSDRx) will report multiple fault flags.

When the number of bits decoded is incorrect (either too many or too few), a bit error is indicated. When any bit error is detected (bit time, too many bits, too few bits), the decoder will revert to the minimum bit time of the selected range and the message is discarded.

Error bit INVALID is an OR-ed combination of the following errors:

- Start bit error outside of selected operating range
- Data length error or stop bit error
- Parity Error of received Remote sensor Message
- Bit time error (a data bit edge is not received inside the expected time window)

All fault bit related to channel error are loaded in the 3 time slot register and the fault has the priority, so the fault overwrite valid data.

9.1.2 Sensor data integrity: LCID and CRC

Each RSDRx data register contains a Logical Channel ID which is a 4/2-bit field for remote sensors used to link the received data to the corresponding logical channel number. Each RSDRx register contains also a CRC bit field computed on the data packet for data integrity check. To satisfy functional safety requirements LCID, DATA and CRC bit fields propagate through the same data path as a single item to the SPI output.

The polynomial calculation implemented for PSI5 data is described as in PSI5 specification $g(x)=1+x+x^3$ with initialization value equal to '111'.

Below are the equations to calculate the CRC in combinatorial way.

CRC[2] = CRCext[0]+D[0]+D[1]+D[3]+D[6]+D[7]+D[8]+D[10]+D[13]+D[14]+D[15]

CRC[1] = CRCext[2]+D[0]+D[1]+D[2]+D[4]+D[7]+D[8]+D[9]+D[11]+D[14]+D[15]+D[16]

CRC[0] = CRCext[1]+CRCext[0]+D[0]+D[2]+D[5]+D[6]+D[7]+D[9]+D[12]+D[13]+D[14]+D[16]

Where D[16:0]= RSDR[16:0] and CRCext[n] are the starting seed values (all '1').

9.1.3 Detailed description

Manchester decoding

The Manchester decoder will support remote sensor communication as per PSI specification rev 1.3 for the modes configurable via the STS bits in the RSCRx registers. The Manchester Decoder checks the duty-cycle and period of the start bits to determine their validity, depending on the configuration of the PERIOD_MEAS_DISABLE bit in the RSCRx registers. The expected time windows for the mid bit transitions of each subsequent bit within the received frame are determined by means of the internal oscillator time base. Glitches shorter than 25% of the minimum bit time duration are rejected.







A Manchester Decoder Error occurs if one or more of the following are true:

- Two valid start bits are detected, and at least one of the expected 13 mid-bit transitions are not detected
- Two valid start bits are detected, and more than 13 mid-bit transitions are detected
- When the number of bits decoded is incorrect (either too many or too few), a bit error is indicated. When any bit error is detected (bit time, too many bits, too few bits), the decoder will revert to the minimum bit time of the selected range and the message is discarded.

The Manchester decoder re-initializes at the start of each timeslot, such that remote sensor frames violating timeslot boundaries will result in the setting of a Manchester Error. All errors are readable through the Sensor Fault Status Register and the RSFLT bit in the Global Status Word Register.

When a valid message is correctly decoded, the 10/8 data bits are stored into the appropriate RSDRx register together with the related LCID. The RSDRx register contains the 10/8 bits data as they are received from the sensor (no data range check/mask is done at this stage). The 8-bit data word is right-justified inside the 10-bit data field in the RSDRx registers.

Current sensor w/ auto-adjust trip current

The current sensor is responsible for translating the current drawn by the sensor into a digital state. Each remote sensor channel has a dedicated current sensor.

The current flowing through the RSU power stage is internally downscaled by a factor 100, sent to a 10 bits A/D converter and digitally processed to extract both the sensor quiescent and delta currents.

The delta current threshold for signal detection can either be fixed or auto-adjusted to the actual calculated sensor delta current, depending on the FIX_THRESH bit setting in the RSCRx registers.

The current trip point is dynamically determined by adding the delta current threshold (fixed/auto-adjusted) to the quiescent current (auto-adjusted). The RSU current is compared against the current trip point to determine the current demodulator digital output. A logic '1' represents the sensor current above the current trip point. The current demodulator output is fed into the Manchester decoder and optionally to the WSx discrete output pins, depending on the configuration of the RSPTEN bit in the RSCRx registers.

Thanks to the quiescent and delta current tracking features the receiver is capable to automatically adapt to different nominal sensor currents and/or to be tolerant to sensor current drifts over lifetime.

Both the sensor quiescent and delta current tracking algorithms can be configured by setting appropriately the REDUCED_RANGE, BLOCK_CURR_IN_MSG and AVG/SSDIS bits in the RSCRx registers.



9.2 Active wheel speed sensor

The remote sensor interface circuit conditions and decodes active wheel speed sensor signals with various pulse widths and output currents. The following sensor types are supported and selected through the Remote Sensor Configuration Register (RSCR)

- Standard active 2-level wheel speed sensors (7/14 mA)
- Three level (7/14/28 mA) VDA compliant sensor with direction and air gap information ('Requirement Specification for Standardized Interface for Wheel Speed Sensor with Additional Information', Version 2.0)
- PWM encoded 2-level sensors with 2 edges per tooth (see data sheet Infineon® IC TLE4942/BOSCH DF11)
- PWM encoded 2-level sensors with 1 edge per tooth (see data sheet Allegro® ATS651LSH/BOSCH DF11)

Received wheel speed frames from all the above sensors are decoded into signals suitable for the microcontroller through the four WSx output pins (WS0-WS3). Specific information is shown in *Figure 45*.

For all sensors, other than the standard active 2- level sensor, additional sensor data (diagnostics, etc...) are decoded and available within the Remote Sensor Data Registers (RSDR0, RSDR1, RSDR3, RSDR4). If standard active 2- level sensor is selected the content of the Remote Sensor Data Registers will be NO DATA fault.

Only for 2-level sensors (STD or PWM encoded) the user may choose to have all sensor data processed through the microcontroller by selecting pass through mode, WSPTEN, within the Remote Sensor Configuration Register (RSCR). In pass through mode, the remote sensor interface simply transforms the incoming sensor current pulses to digital voltage pulses on the WSx pins, no decoding is performed.

The sensor input filter time, deglitch filter (delay until a threshold crossing is detected) can be configured in 15 steps. Filters can be selected individually for each channel, through the Remote Sensor Configuration Register, WSFILT bits.

For PWM encoded sensors with 2 edges per tooth not in pass through mode, the standstill signal can be processed directly to the WSx output pins. This is done in the Remote Sensor Configuration Register, SSEN bit.

Since the decoder has to measure the pulses in order to determine, whether they are standstill pulses or not, the first standstill pulse will always be seen on the WSx output pins and the first not stand-still pulse after a stand-still period will be suppressed.

For 3-levels VDA sensors the device performs parity check on the received data frame. In case a parity error is detected, the INVALID fault bit of the RSDRx register will be set.

Data from the sensor are not latched: last incoming frame overwrites the previous one once validated. Faults coming from diagnostic (i.e. over current, short to ground or battery) are latched until the microcontroller reads them.

Sensor signal decoding is done according to two possible algorithms:

• Auto-adjusting current trip points.

With this option, the IC is able to find sensor DC current value (named IB0) in the range from 2.5 mA to 21 mA (default is 7 mA).

The IC is also able to detect the current value of the data pulse and compute the first threshold (named Ith1): Ith1 = IB0 + Δ Ith1/2 where Δ Ith1 is in the range from 5 mA to 9.3 mA (default is 7 mA).



Besides, in case of VDA selected, the ASIC is also able to recognize the current value of the speed pulse by computing a second threshold (named Ith2): Ith2 = IB0 + Δ Ith1 + Δ Ith2/2 where Δ Ith2 in the range from 10 mA to 18.6 mA (default is 14 mA)

• Fixed current trip points where the thresholds are set via SPI. The default value for first threshold is 9.8 mA and for second threshold is 19.6 mA





186/286



9.2.1 Wheel speed data register formats

When programmed as a wheel speed sensor interface, only four data registers are used (Remote Sensor Data Register RSDR0-RSDR3).

Independent data registers are defined for each wheel speed channel and their contents are determined by sensor type. Three level VDA sensors have eight data bits and. At fast wheel speed not all bits may be transmitted by the sensor: the IC is able both to process normal or either truncated frames by providing together with data, a 4 bit counter to inform the microcontroller about the number of received valid bits.

For PWM encoded sensors, each pulse length is written to the sensor data register with a typical resolution of 5 μ s per bit. In case of pulse width duration equal or higher than $T_{STANDSTILL_TH_L}$ and less or equal than $T_{STANDSTILL_TH_H2}$, the standstill condition will be recognized and bit 15 in the corresponding register will be set.

The register is updated when a PWM falling edge is detected; in case of stuck-at 1 of the PWM signal the register is updated when the counter reaches the overflow value (0x1FF): in this case the standstill bit not set and the counter in overflow will signal a fault to the microcontroller.

9.2.2 Test mode

In order test the input structures of the connected microcontroller, the L9680 features a wheel speed test mode that allows test patterns to be applied on the four wheel speed outputs WS0-WS3. The test mode can be entered via SPI and the test patterns can also be controlled via SPI commands. Test patterns can be composed only of static high or low signals, which can be selected via SPI. For failsafe reasons only one channel at a time can be switched into test mode.

9.3 Remote sensor interface fault protection

9.3.1 Short to ground, current limit

Each output is short circuit protected by an independent current limit. Should the output current level reach or exceed the ILIMTH for a time period greater than TILIMTH or the remote sensor interface the output stage is disabled. An internal up-down counter will count in 25 µs increment up to TILIMTH. The filter time is chosen in order to avoid false current limit detection for in-rush current that may happen at interface switch-on. When the output is turned off due to current limit, the appropriate fault code STG is set in the Remote Sensor Data Register (RSDR). The fault timer latch is cleared when the sensor channel is first disabled and then re-enabled through the Remote Sensor Control Register (RSCTRL). This fault condition does not interfere neither with the normal operation of the IC, nor with the operation of the other channels. When a sensor fault is detected, the RSFLT bit of the GSW is set indicating a fault occurred and can be decoded by addressing the RSDR register.

In order to fulfill the blanking time requirement at channel activation as per PSI-5 specification, a dedicated masking time is applied to the current limitation fault detection each time a channel is activated.



All outputs are independently protected against a short to battery condition. Short to battery protection disconnects the channel from its supply rail to guarantee that no adverse condition occurs within the IC. The short-to-battery detection circuit has input offset voltage (10mV, minimum) to prevent disconnecting of the output under an open circuit condition. A short to battery is detected when the output RSUx pin voltage increases above SATBUCK or SYNCBOOST (depending on operation) supply pin voltage for a T_{STBTH} time. An internal up-counter will count in 1.5 μ s increment up to T_{STBTH}. The counter will be cleared if the short condition. Other channels are not affected in case of short of one output pin. As in the case previously described, the STB fault code can be read from RSDR bits and any fault will set the RSFLT bit of the global status word register (GSW). The STB bit is cleared upon read or upon channel disabled via SPI RSCTRL register.

9.3.3 Cross link

The device provides also the capability of a cross link check between outputs, in order to reveal conditions where two output channels are in short. This functionality is allowed by enabling one output channel, while asking for voltage measurement on any of the other ones.

9.3.4 Leakage to battery, sensor open

The sensor interface offers also open sensor detection. The auto-adjusting counter for remote sensor current sensing will drop to 0 in case the current flowing through RSUx pin is lower than 2.5 mA typ. The OPENDET fault flag is asserted when the fault condition lasts for longer than TRSUOP_FILT deglitch filter time. This fault flag can be read from RSDR bits and any fault will set the RSFLT bit of the global status word register (GSW). The channel in this condition is not shutdown. This fault bit is cleared upon read or upon channel disabled via SPI RSCTRL register.

9.3.5 Leakage to ground

The sensor interface offers as well the detection of a leakage to ground condition, that will possibly raise the sensor current higher than 42 mA/12 mA typ in PSI5/WSS modes respectively. The CURRENT_HI fault flag is asserted when the fault condition lasts for longer than T_{RSUCH_FILT} deglitch filter time. This fault flag can be read from RSDR bits and any fault will set the RSFLT bit of the global status word register (GSW). The channel in this condition is not shutdown. This fault bit is cleared upon read or upon channel disabled via SPI RSCTRL register.

9.3.6 Thermal shutdown

Each output is protected by an independent over-temperature detection circuit should the remote sensor interface thermal protection be triggered the output stage is disabled and a corresponding thermal fault is latched and reported through the RSTEMP flag in the Remote Sensor Data Register (RSDRx). The thermal fault flag is cleared when the sensor channel is first disabled and then re-enabled through the Remote Sensor Configuration Register (RSCRx).





10 Watchdog timers

This device offers a 2-level watchdog control approach. The first control level is given by means of a temporal watchdog (WD1). The WD1 window times are SPI programmable and a couple of specific codes have to be written within this window in order to serve the WD1 control. The second control level is featured by an algorithmic seed/key watchdog (WD2). Unlike the temporal watchdog, the algorithmic watchdog service must be maintained before a timeout occurs, i.e. there is no restriction on refreshing the watchdog too early. Both WD1 and WD2 watchdog functionalities can be tested trough the WD_TEST SPI command.

10.1 Temporal watchdog (WD1)

The temporal watchdog ensures the system software is operating correctly by requiring periodic service from the microcontroller at a programmable rate. This service (watchdog refresh) must occur within a time window, and if serviced too early or too late will enter an error state reported via the FLTSR register (WD1_WDR bit).

The overall WD1 functionality is described in the state diagram reported in Figure 46.



Figure 46. WD1 Temporal watchdog state diagram

Following the description of the WD1 states and signals (most of them reported in related SPI registers)



State/Signal	Description		
WD1 INITIAL	Default state entered from startup. While in this state, no watchdog service is required, and the IC may stay in this state indefinitely. For system safety, all arming signals are disabled during this state to prevent deployment.		
WD1 RUN	Normal run time state where WD1 service is required.		
WD1 TEST	A special state used to test the watchdog function. Normally, this state will only be checked once per power cycle by the software, but there is no inherent restriction in the watchdog logic preventing periodic testing. This state allows testing of the watchdog without setting WD1_LOCKOUT=1, which can only be cleared via WSM reset. Deployment is inhibited when the WD state machine is in this state.		
WD1 RESET	State entered when a WD1_ERROR occurs. This is a timed-duration state that is automatically exited after 1ms.		
WD1 OVERRIDE	A special state used to disable watchdog functionality for development purposes. Other logic within the IC can use this state to emulate the WD1 RUN state without the need to service WD1.		
WSM_RESET	Signal used to reset the WD1 state machine to the WD1 INITIAL state and all signals to their inactive values		
WD1_refresh OK	Signal that is asserted only if the watchdog is refreshed ('A' - 'B' or 'B' - 'A' seq.) within the WD1 time window		
WD1_ERROR	Signal that is asserted if the watchdog refresh fails to occur during the WD1 time window.		
WD1_WDR	Watchdog Reset – latched signal that is activated whenever a watchdog error is qualified. For WD1, this occurs when WD1 service is required, but not received. This signal is SPI-readable.		
WD1_TM	Test Mode – a signal that indicates that WD1 is being tested. This signal is SPI-readable.		
WD1_LOCKOUT	A latched signal activated if an unexpected WD1 error occurs. This signal is permanently latched when set (until WSM_RESET). When set, all arming signals are disabled, preventing deployment. This signal is SPI-readable.		
SPI_WD1_TEST	SPI command used to enter WD1 TEST state from WD1 RUN state, or to enter WD1 OVERRIDE state from INITIAL state if WDT/TM pin voltage is greater than the threshold. This command has no effect in other states.		

Table 12	. Watchdog	timer status	description
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10.1.1 Watchdog timer configuration

The watchdog timer can be configured on two different frequency modes:

- Fast watchdog with maximum range of 2ms and a resolution of 8 μs;
- Slow watchdog with maximum range of 16.3ms and a resolution of 64 μs.

The watchdog window times are SPI programmable. The configuration of watchdog timer frequency and window times can be done by setting the Watchdog Timer Configuration Register (WDTCR) with the appropriate values. However, this configuration is accepted only when the device is in the Init operating state, as shown in *Figure 11*. As soon as the device enters in Diag state, the watchdog control is enabled and the watchdog configuration is fixed and cannot be changed anymore.



10.1.2 Watchdog timer operation

While in the WD1_INITIAL state, watchdog service must begin or a SPI command with WD1_TO_DIS=1 must be received within the first 500 ms. If the WD1 Timeout Disable bit is set, the device can stay in the WD1_INITIAL state indefinitely without watchdog service.

To refresh WD1, the logic must receive a Watchdog Timer Register (WD1T) SPI command containing the expected key value within the WD1 time window (WDTMIN+WDTDELTA). If it is received too early, too late the WD1_ERROR signal will be asserted. The WD1_ERROR will not be asserted in case a SPI command containing the Watchdog Timer Register (WD1T) with an incorrect key value is received at any time relative to the window. This allows the system software to repeatedly transmit the key value until it needs to change to the correct key value. Upon reception of the correct key within the window, the logic will reset the watchdog timer to create a new window.

The timer is cleared upon writing code 'A' and code 'B' (either in 'A' - 'B' or 'B' - 'A' sequences) to the WD1CTL [1:0] bits, in the WD1T register. The watchdog timer value can be read via the WD1T register.



10.2 Algorithmic watchdog (WD2)

The algorithmic watchdog (WD2) is intended to protect higher software layers, and as such requires servicing at a much slower rate and allows for software jitter as compared with WD1. Additionally, WD2 is not implemented as a window watchdog, but is a maximum-time watchdog, where refresh is accepted at any time before the timer expires.

The overall WD2 functionality is described in the following state diagram:





Following the description of the WD2 states and signals (most of them available through SPI registers)

State / Signai	Description		
WD2 INIT	Default state entered from startup or after a SSM reset (if not in WD2 STOP state).		
WD2 OVERRIDE	Special state used to disable WD2 watchdog functionality.		
WD2 INITSEED	State entered when the correct default key is received in INIT state. Here the timer starts to count waiting for the real first key.		
WD2 RUN	Normal run-time state where WD2 service is required.		
WD2 TEST	A special state used to test the watchdog function. Normally, this state will only be checked once per power cycle by the software, but there is no inherent restriction in the watchdog logic preventing periodic testing. This state allows testing of the watchdog without affecting WD2 error (no reset is generated, WD2_LOCKOUT stay low). Only WD2_WDR latch could be set to 1, in this way μ C is able to verify the functionality of the watchdog.		
WD2 QUAL	A state used to qualify a number of WD2_ERROR occurrences before action is taken. The intent is to use this state to permit a retry strategy to account for software jitter.		
WD2 LOCK	A state entered after the allowed retries have been exhausted. This is where action is taken due to WD2 service failure.		
WD2 STOPPING	This is a timed-duration state that is automatically exited after 1ms		
WD2 STOP	A state used to prevent continual recovery of WD2 errors using the WD2_KEY key mechanism to restart watchdog service.		
WD2 RESET	State entered when a WD2_ERROR occurs after having been qualified in the WD2_QUAL state (when all retries are exhausted), or when testing the WD2. This is a timed-duration state that is automatically exited after 1ms.		
WSM_RESET	Watchdog State Machine reset – used to force a transition to the WD2 INIT state and reset all signals to their inactive states		
WD2_RETRY	Counter that tracks the number of retry attempts. It is incremented each time the logic detects a WD2 error while qualifying the error.		
WD2_WDR	Watchdog Reset – latched signal that is activated whenever a watchdog error is qualified. For WD2, this occurs when WD2 service not received after all retry attempts have previously failed. This signal is SPI-readable.		
WD2_TM	Test Mode – a signal that indicates that WD2 is being tested. This signal is SPI-readable.		
WD2_LOCKOUT	A latched signal that is activated on startup, or whenever a WD2 error is fully qualified (all retry attempts have failed). Recovery is still possible after this is set going into WD2 RUN state. This signal drives the WD2_LOCKOUT output pin. This signal is SPI-readable.		
SPI_WD2_TEST	SPI command used to enter WD2_TEST state or to enter WD2 OVERRIDE state from INIT.		
TMR2	Timer to count the maximum time limit to receive the correct key		
SPI_WD2_RECOVER	SPI command used to clear retry counter		
WD2_ERR_CNT	Counter that tracks the number of WD2 error occurred		

Table 13. WD2 states and signals



To refresh WD2, the logic must receive a WD2_KEY command containing the expected key value before the WD2 timer expires. If it is received too late the refresh criteria have not been met. The WD2 error is asserted if the refresh does not occur before the end of the timeout. The WD2 error is not asserted if it receives continuously a WD2_KEY command with the correct key. This allows the system software to repeatedly transmit the correct key value at any rate faster than the required timeout.

Upon reception of the correct key, the logic will generate a new seed value, then calculate a new key using the new seed and reset the watchdog timer to create a new timeout.

When in WD2 INITSEED state, the three steps above are executed anyway. The seed is latched from a free-running counter that starts when WSM is released. The WD2_KEY command is used for transmission of the watchdog key, while WD2_SEED command is used to read the new seed and the previous key.

The SEED is generated by latching the value from a free-running counter. The free-running seed counter runs at a rate of f_{WD2_SEED} as specified in *Table 29*. The key value and seed value are 8-bits in length. The key shall be calculated as follows: (KEY = SEED \ddagger PrevKEY + \$01) where \ddagger denotes a bit-wise XOR operation

10.3 Watchdog reset assertion timer

Upon either a WD1 or a WD2 watchdog reset, the watchdog logic will momentarily assert the RESET pin for time duration $T_{WDT1_RST}/T_{WDT2_RST}$. When the RESET pin has been asserted through the watchdog reset assertion timer, stored faults are maintained and can be read by the microcontroller via SPI following the RESET period.

10.4 Watchdog timer disable input (WDT/TM)

This input pin has a passive and active pull-down and is used to disable the watchdog timer. The state of this pin can be read by SPI through the WDT/TM_S bit in the GSW register. When WDT/TM pin is asserted, the watchdog timer is disabled, the timer is reset to its starting value and no faults are generated.

The WDT/TM input pin must not be biased HIGH (WDT/TM > V_{WDTDIS_TH}) prior to POR in order to have a proper start-up.



11 DC sensor interface

L9680 implements a circuitry able to interface with a variety of positioning sensors. The sensors that can be connected to the device are Hall-effect, resistive or simple switches.

Range of measurements is:

- Resistive sensor: 65 Ω to 3 k Ω
- Hall-effect sensor: 1 mA to 2 0 mA.

Within the above ranges, accuracy of $\pm 15\%$ is granted. A reduced accuracy is given in the range 1 mA to 2 mA. Hall sensor and switch interface block diagram is shown below.



Figure 49. DC sensor interface block diagram

The global SPI contains several bits to control and configure the interface. The SWOEN bit is used to enable the output voltage on DCSx pins. The channel to be activated can be chosen by accordingly setting CHID bits. The interface activation is started and switched off upon user SPI command. Alternatively it could be configured via the SYS_CFG(EN_AUTO_SWITCH_OFF) bit to automatically switch off as soon as the measurement is complete, in case of current or resistance measurements; this would help preventing thermal conditions. The interface would not auto-switched off in case of voltage measurement, instead.



The voltage and current for the selected channel are made available to the main ADC by selecting the proper channel and enabling the measurement process by dedicated DIAGCTRLx commands.

The device offers the capability to actively keep all the DCSx lines discharged by means of a weak pull down. The pull down is active by default on all channels and it is deactivated in either of the following cases:

- 1. when the voltage source is active on the relevant channel
- 2. when a voltage measurement is requested on the relevant channel
- 3. if SPI bit SWCTRL(DCS_PD_CURR) is set (global pull-down disable for all channels)

In case of Hall-effect sensors, a single current measurement is processed. The current load needed for regulating the pin is internally reflected to a reference resistance, whose voltage drop is then measured through the internal ADC converter.

When resistive or switch sensors are used, a more complex measurement is performed. In a first step the current information as above described is provided. Then, also the information on the voltage level achieved on the output pin is provided via ADC. By processing these two values, the micro-controller can understand the resistive value. The DCSx voltage is internally rescaled by a voltage divider into the ADC converter voltage range as shown in Figure 48. Additionally a positive voltage offset is internally applied to the scaled voltage in order to allow voltage measurement capability for DCSx down to -1V.

In order to get accurate resistive information even in case of an external ground voltage shift on the sensor of up to +/-1V, the voltage measurement step actually needs two DCSx voltage measurements. A first voltage measurement has to be done with selection of 6.25V on the output channel and a second one with the regulator switched off. The difference between the two measurements will cancel out the offsets (both external ground shift and internal offset).

The DCSx current and voltage can be retrieved from ADC readings according to the following formulas and related parameters specified in the Electrical Characteristics section.

$$I_{DCSx} = 100 \cdot \frac{I_{REF_DCS}}{2} \cdot DIAGCTRLn(ADCRESn) \quad @DIAGCTRL(ADCREQn = $04)$$
$$V_{DCSx} = RATIO_{VDCSx} \cdot \left(\frac{ADC_{REF_hi}}{2} \cdot DIAGCTRLn(ADCRESn) - V_{OFF_DCSx}\right) - V_{OFF_DCSx} \cdot (RATIO_{VDCSx} - 1) \quad @DIAGCTRLn(ADCREQn) = $03$$

The DCSx sensor resistance can be calculated according to the following formula:

$$R_{sensor_{x}} = \frac{\Delta V_{DCSx}}{I_{DCSx}} = \frac{V_{DCSx}@(SWCTRL(SWOEN)=1 - V_{DCSx}@(SWCTRL(SWOEN)=0)}{I_{DCSx}}$$

@SWCTRL(CHID) = x

The device provides also the capability of a cross link check between outputs, in order to reveal conditions where two output channels are in short. This functionality is allowed by enabling one output channel, while asking for voltage measurement on any of the other ones.



Each output is protected against

- Overload conditions by current limit
- Ground offset between the ECU and the loads of up to ±1 V.
- Loss of ECU battery
- Loss of ground
- Unpowered shorts to battery
- Shorts to ground

11.1 Passenger inhibit interface

L9680 provides a feature to deactivate passenger restraint devices based on a preprogrammed mask. It generates a signal (PSINHINT) based on microcontroller-initiated measurements performed on DC Sensor channel 0. The PSINHINT signal is bitwise AND-ed with the LOOP_MATRIX_PSINH mask register, allowing selective deactivation of squib/pyroswitch loops independent of microcontroller control. This signal is also inverted and output on the PSINHB pin of the IC to activate externally controlled squib/pyroswitch loops.



An upper and lower threshold is preprogrammed via SPI by writing the desired 10-bits values into the PADTHRESH_HI and PADTHRESH_LO registers during the Diag state. These thresholds define the measurement window where the passenger restraints are active. Any measurement outside this window will result in the assertion of the PSINHINT signal (as described below), thereby deactivating the squib/pyroswitch loops identified in the PSINH mask. The PSINH mask is also preprogrammed during the Diag state.



Another control (DCS_PAD_V bit in SYS_CFG register) is preprogrammed to select either a voltage measurement or a current measurement on DCS0 for this purpose.

The automated control of the PSINHINT signal occurs when the microcontroller runs diagnostic testing of the DCS0 interface. A 1 second timer is included to ensure the diagnostic test is run periodically. When the timer expires (down-counts to 0), the PSINHINT signal is asserted. When the measurement of the DCS0 voltage or DCS current (as selected by the DCS_PAD_V bit) is taken, and the value falls within the preprogrammed window, the timer will be reloaded. If the measurement is outside the window, the timer will not be reloaded, and it will continue to count down until it expires, resulting in activation of PSINHINT. For testing purposes, the PSINHINT can be controlled directly via SPI while in DIAG state using the Diag State Test Selection (DSTEST) register.



12 Safing logic

12.1 Safing logic overview

The integrated safing logic uses data from on-board and remote locations by decoding the various SPI communications between the interfaces and the main microcontroller. The safing logic has several programmable features enabling its ability to decode SPI transmissions and can process data from up to 16 sensors. The operating mode involves simple symmetrical data threshold comparisons, with the use of symmetrical or asymmetrical counters. A high level diagram is shown in the figure below. Please note that this top-level diagram is simplified, and references more detailed flowcharts to show a) message decoding, b) valid data limits, c) effects of the 'combine' function, d) comparison to thresholds and arming, and e) the setting of the 'compare complete bit. Four independent arming outputs, ARM1INT, ARM2INT, ARM3INT and ARM4INT, are also mapped internally to any of the integrated squib/pyroswitch drivers.



Figure 51. Top level safing engine flow chart



12.2 SPI sensor data decoding

Sensor data is regularly communicated with the main microcontroller through multiple SPI messages. The L9680 monitors SPI traffic on MISO_RS bus. Since not all communications between sensors and the microcontroller contain data, it is important for the decoder to properly sort the communications and extract only the targeted data. The solution involves defining specific masking functions, contained within independent safing records, programmed by the user. The following figures detail the SPI message decoding methodology and the ensuing comparisons of valid sensor data to the programmed thresholds.









Figure 53. Safing engine – 16-bit Message decoding flow chart





Figure 54. Safing engine - Validate data flow chart















- Request Mask and Request Target to understand what sensor the microcontroller is addressing
- Response Mask and Response Target to identify the sensor response
- Data Mask to extract relevant sensor data from the response.
 - Sensor data is extracted as a bit-wise AND result of the SAF_DATA_MASKx and monitored RS_MISO data. The configuration of the set bits of the DATAMASK must be contiguous for both 16-bit and 32-bit records. The 32-bit records are comprised of Part1 as MSW and Part2 as LSW.
 - The extracted data is then right justified into a 16/32 bit register for 16/32 bit safing records, respectively, prior to further processing steps which assume data is signed should be "using two's complement representation".
- Safing Threshold specific value that sets the comparator limit for successful arming
- Control:
 - IF, In Frame to indicate serial data response is 'in frame'. There are two types of potential serial data responses, 'in frame' and 'out of frame'.
 - CS to align safing record with a specific SPI CS. The device contains 5 SPI CS inputs for the safing function (CS_RS, SAF_CSx)
 - ARM there are four internal arming signals, each active record is assigned or mapped to any arming signal. Several safing records can be mapped to a single arming output. ARMx outputs can be enabled also simultaneously.
 - Dwell Once an arming condition is detected, the safing record remains armed for the specified dwell time.
 - Comb (Combined Data) specific solution for dual axis high-g sensors specifically oriented off-axis.
 - LimEn (Limit Enable) to enable PSI5 out-of-range control.
 - LimSel (Limit Select) to select PSI5 out-of-range thresholds between 8-bit and 10-bit protocol.
 - SPIFLDSEL (SPI Field Select) to determine which 16-bit field in long SPI messages (>31 bit) to use for response on MISO of SPI monitor. Don't care for messages less than 32 bits.

If input packet matches multiple safing records, the safing engine should process all of them and treat them independently.

Safing record can only be evaluated on the first matching input packet. Any further data packet matches are ignored (i.e. once CC is set, record can't be processed until CC is cleared)

The En (Record Enable) bit for any record is programmable as on or off at any time and will enable/disable the record itself upon the following SATSYNC.

All CC bits are available in one register (SAF_CC) for access in one single SPI read. After ARMing is achieved and CC is set, no further messages are considered until CC is cleared via read.

Safing Engine must not process sensor data in any state but Safing state (refer to *Figure 11*).

All safing records are cleared on SSM RESET.



Comb (Combined Data) bit allows combining X and Y for off-axis oriented sensors. In this case, it is typical for such orientations to add or subtract the sensor response to translate the sensor signal to an on-axis response. Only couples of 16-bit long records have this feature (i.e. 1&2, 3&4, 5&6, 7&8, 9&10, 11&12).

Records are added and subtracted and results compare against two thresholds. Safing engine will process data as follows:

- Use record(n) and record(n+1), where n = 1, 3, 5, 7, 9, 11.
- The matching inputs used for math combinations are processed only after both are captured.
- The sum of the two matching inputs will be compared to the threshold of record(n).
- The difference of the two records will be compared to the threshold of record(n+1).
- If the Comb feature was enabled on only one of the two records in a couple, math would be performed only on it as shown in *Figure 56*

Example of Combine Function operation:

Record #	Combine Bit	Data	Resulting value	Record Threshold	ARMSELx Configuration	ARMINTx Result

Table 14. Example of combine function operation

All items in the safing records, except En(Record Enable) bit, can be configured only in Diag state (refer to *Figure 11*). Additionally, the global bit to select internal or external safing engine is set in Init state.

12.3 In-frame and out-of-frame responses

Some sensors will communicate data within the current communication frame while others will send data on the next communication frame. Sometimes this is sensor specific and sometimes this is due to the amount of data to be transmitted. A simplified diagram shows the basic communication differences of in and out of frame responses.

In-frame example:



MOSI	Request n	Unused		
MISO	Status	Response n		
		•	GAPGPS01143	

Figure 58. In-frame example

At least one bit needed to allow for synchronization between clock domains (SPI clock and system clock).

Out-of-frame example:

Figure 59. Out-of-frame example				
MOSI	Request n	Request n+1		
MISO	Request n-1	Response n	GAPGPS01144	

Synchronization between clock domains relies upon inter-frame gap.

12.4 Safing state machine operation

State machine operation is disabled when the safing state machine reset signal is active as described in the power supply diagnostics and controls section of this document. The outputs of the state machine are ARMxREQ. As previously stated, there is a maximum of 16 safing records available to the state machine. Inputs to the safety state machine are programmed safing records and sensor data. The configuration of the state machine is common to all sensors.

12.4.1 Simple threshold comparison operation

In this mode, sensor data received through the sensor SPI interface and validated by the safing record is passed to the safing algorithm. The simple threshold comparison algorithm compares the received data to two thresholds, SAF_TH (positive threshold) and (-SAF_TH) (negative threshold). If the sensor data is greater than SAF_TH or is less than (-SAF_TH) then and event is flagged and the event counter is incremented based on the programmed value of ADD_VAL. If sensor data does not trigger the SAF_TH comparators, the counter is decremented by SUB_VAL. SUB_VAL is programmed by the user and can be same or different than ADD_VAL. This feature allows for an asymmetrical counter function making the system either more or less sensitive to sensor data. Since sensor data can indicate a positive or negative event, the algorithm maintains separate event counters, POS_COUNT and NEG_COUNT. ADD_VAL and SUB_VAL programmed values are the same for both event counters.

On each sensor sample, the event counters, POS_COUNT and NEG_COUNT, are updated based on the SAF_TH comparators. Likewise, each event counter is compared with a corresponding arming threshold. In this case, POS_COUNT value is compared to ARMP_TH and NEG_COUNT to ARMN_TH. ARMP_TH and ARMN_TH are programmable thresholds set by the user. The compared result will set ARMP and ARMN to either '1' or '0' depending on the comparison status. If ARMP_TH or ARMN_TH are set to 0, the arming will be activated immediately entering in safing state.



POS_COUNT and NEG_COUNT are not updated if microcontroller stops reading SAF_CC bits (this must be avoided otherwise ARMING set and reset will not be possible).

By way of the assignment of the ADD_VAL, SUB_VAL, ARMP_TH and ARMN_TH settings, the safing engine can be configured to assert arming for either a simple accumulation of COUNTs in a non-consecutive manner, or it could be set to require some number of consecutive samples.

12.5 Safing engine output logic (ARMxINT)

SPI messages are monitored and mapped to specific safing records. Each safing record is configured with its own threshold, dwell time and the appropriate ARMxINT signal to activate if safing criteria are met.

Any enabled safing record can be programmed to an arming signal. All safing records arming status is logically 'OR'd' to its programmed arming signal. For example, if safing records 1, 2, 4 are programmed to ARMINT1 and the records are enabled, any of the records can set the ARMINT1 signal. Configuration of safing record mapping to ARMXINT signals is specified in the in the SAF_CONTROL_x register (refer to *Table 67*).

While in Diag state, L9680 allows diagnostics of the squib/pyroswitch driver HS and LS FETs, ARM pins, VSF output and firing timers. The ARM and VSF output tests are mutually exclusive.

For safety purposes, the safing logic circuitry is physically separated from the circuitry that contains the deployment logic.





Figure 60. Safing engine arming flow diagram





Figure 61. Safing engine diagnostic logic

A configurable mask for each internal ARMxINT signal is available for all of the integrated deployment loops. The un-masked ARMxINT signal for each loop will enable the respective loop drivers.

Activation of VSF (regulation rail for High Side Safing FET) occurs upon ARMxINT. Actual High Side Safing FET activation still requires microcontroller signal.

L9680 is able to provide arming signals to external deployment loops by means of four discrete output ARMx pins.





Figure 62. ARMx input/output control logic

12.5.1 Arming pulse stretch

Upon a valid command processed by the safing logic, the Dwell bit to stretch the arming time assertion (dwell time) applies to each safing record and is used to help safe the deployment sequence to avoid undesired behaviour.

Once dwell time has started, it will continue, regardless of the En (Record Enable) bit. Dwell will be truncated in case of SSM reset. Dwell values in the safing records are transferred to the ARMx signals. A dedicated counter is designed for each ARMx output pin. If different dwell values are assigned to the same ARMx, the longer value is used. Dwell times can only be extended, not reduced. If the remaining dwell time is less than the new dwell extension setting, the new setting will be loaded into the dwell counter.

Dwell times are user programmable.

The behaviour of the pulse stretch timer is shown below.





Figure 63. Pulse stretch timer example

The Arming Enable Pulse Stretch Timer status is available in the AEPSTS register.

12.6 Additional communication line

The ACL pin is the Additional Communication Line input that provides a means of safely activating the arming outputs (ARMx and VSF) for disposal of restraints devices at the end of vehicle life.

The handshake sequence for activating the Arming outputs is illustrated in Figure 64. The strategy involves generation of a seed value from within the L9680 device using a freerunning 8-bit counter running at f_{SCRAP SEED} rate, where it can be read by the microcontroller. The microcontroller uses it to generate an 8-bit key value. When the seed value is read (SPI SCRAP_SEED command), L9680 also freezes the seed value and computes its own key, which is used for comparison to the key subsequently submitted by the microcontroller. The key value is submitted by the microcontroller using the SCRAP_KEY command, and successful reception of this command with a key value matching the internally calculated key allows the successful completion of the first handshake. After that, in case a second handshake (seed-key) completes successfully and if a valid ACL is detected (as described below) the L9680 transitions from Scrap state to Arming state. To remain in Arming state the microcontroller must periodically refresh L9680 with the SCRAP KEY command containing the correct key value in the data field of the command, and L9680 must also receive the correct ACL signal. This must occur before the scrap timeout timer expires (T_{SCRAP TIMEOUT}). The scrap key is derived from the seed value using a simple logical inversion on the even-numbered bits (0, 2, 4, 6). From a logical standpoint, this is equivalent to a bit-wise XOR of the seed value with 0x55.

While the SSM is in Arming state, the arming outputs are asserted (ARMx=1, VSF on). If the periodic scrap key is incorrect, or not received before the timeout expires, or the ACL is not correctly received, the SSM reverts back to the Scrap state, and the arming outputs are deactivated.



Figure 64. Scrap SEED-KEY state diagram

Figure 65. Scrap ACL state diagram





A specific waveform needs to be present on ACL input in order to instruct L9680 to arm all deployment loops. L9680 is designed to support the Additional Communication Line (ACL) aspect of the ISO-26021 standard, which requires an independent hardwired signal (ACL) to implement the scrapping feature. The disposal signal may come from either the vehicle's service connector, or the systems main microcontroller, depending on the end customer's requirements.

The arming function monitors the disposal PWM input (ACL pin) for a command to arm all loops for vehicle end-of-life. The disposal signal characteristic is shown in *Figure 66*. To remain in Arming state, at least three cycles of the ACL signal must be qualified (in addition to the periodic KEY value being received from the microcontroller). For the device to qualify the periodic ACL signal, the period and duty cycle are checked. Two consecutive cycles of invalid disposal signal are to be received to disqualify the ACL signal.

If the logic detects that the signal is incorrect or missing while in Scrap state, the device will stay in Scrap state; would it happen in Arming state, it will transition to Scrap state immediately.



Figure 66. Disposal PWM signal

The disposal PWM signal cycle time and on time parameters can be found in the electrical parameters tables.

13 General purpose output (GPO) drivers

The L9680 contains three General Purpose Output (GPO) drivers configurable either as high-side or low-side modes. The drivers can be independently controlled in ON-OFF mode or in PWM mode setting the desired duty cycle value through the GPO Control Register (GPOCTRLx).

For low side driver configuration, the GPODx pin is the drain connection of an internal MOSFET and is the current sink for the output driver. The GPOSx pin is the source connection of the internal MOSFET and is externally connected to ground. For high side driver configuration, the GPODx pin will be connected to battery and GPOSx pin will be connected to load's high side.



Figure 67. GPO driver and diagnostic block diagram

The drivers are configured in one of the two modes through the GPO Configuration Register (GPOCR) register. This hardware configuration is only allowed during the Init and Diag states.

When configured as high-side, the drivers need ER Boost voltage to be above the $V_{\text{ERBST}\ OK}$ threshold to be enabled.

The default state of all drivers is off. The drivers can be independently activated via SPI control bits on GPO Control Register (GPOCTRLx). In addition, a set point on the GPOCTRLx will control the output drivers in PWM with a 125Hz frequency. If PWM control is desired, user should set the needed set point in the GPOXPWM bits of the GPOCTRLx while activating the interface. When all bits are set to '0', the GPOX output will be disabled.


PWM control is based on a 125Hz frequency. 6 bits of GPOCTRLx are reserved to this mode, in order to control the drivers with 64 total levels from a 0% to a full 100% duty cycle.

When both GPO channels are used in PWM Mode at the same frequency they are synchronized to provide parallel configuration capability.

PWM control is implemented through a careful slew rate control to mitigate EMC emissions while operating the interface. The driver output structure is designed to stand -1V on its terminals and a +1V reverse voltage across source and drain.

The GPO driver is protected against short circuits and thermal overload conditions. The output driver contains diagnostics available in the GPO Fault Status Register (GPOFLTSR). All faults except for thermal overload will be latched until the GPOFLTSR register is read. Thermal overload faults will remain active after reading the GPOFLTSR register should the temperature remain above the thermal fault condition. For current limit faults, the output driver will operate in a linear mode (ILIM) until a thermal fault condition is detected.



Figure 68. GPO Over temperature logic

The device offers also an open load diagnostics while in ON state. The diagnostics is run comparing the current through the output stage with a reference threshold $I_{OpenLoad}$: should the output current be lower than the threshold, the open detection flag is asserted.

The device is also able to detect a fault condition during the OFF state by means of the Voltage Regulator Current Monitor (VRCM) block. During the OFF state the VRCM block tries to force a voltage $V_{OUT_GPOx_OL}$ (2.5 V) on GPOD pin if LS mode is selected (with a current limitation of $I_{LIM_GPOD_SRC/SINK}$) or on GPOS pin if the HS mode is selected (with a current limitation of $I_{LIM_GPOS_SRC/SINK}$) and, at the same, it compares the current sourced or sunk in order to detect if a fault on GPO pins is present. The diagnostic in OFF state is able to detect the open load in both HS and LS modes, the short to ground fault in LS mode and the short to battery fault in HS mode:

	LS N	MODE	
	GPOxSHORT	GPOxOFFOPN	Interpretation
I _{OFF} > I _{SRC_TH}	1	0	Short to ground
- I _{SINK_TH_LS} < I _{OFF} < I _{SRC_TH}	0	1	Open
I _{OFF} < - I _{SINK_TH_LS}	0	0	Normal

Table 15. Shor	t to	ground	fault	in	LS	mode
----------------	------	--------	-------	----	----	------

	HS N	MODE	
	GPOxSHORT	GPOxOFFOPN	Interpretation
I _{OFF} > I _{SRC_TH}	0	0	Normal
- I _{SINK_TH_HS} < I _{OFF} < I _{SRC_TH}	0	1	Open
IOFF < - ISINK_TH_HS	1	0	Short to battery

Table 16. Short to battery fault in HS mode



14 System voltage diagnostics

L9680 has an integrated dedicated circuitry to provide diagnostic feedback and processing of several inputs. These inputs are addressed with an internal analog multiplexer and made available through the SPI digital interface with the Diagnostic Data commands. In order to avoid saturation of high voltage internal signals, an internal voltage divider is used.



Figure 69. ADC MUX

The diagnostics circuitry is activated by four SPI Diagnostics Control commands (DIAGCTRLx); each of them can address all the available nodes to be monitored, except for what mentioned in *Table 17*.

DIAGCTRLx SPI command bit fields are structured in the following way:

DIAGCTRL_A (ADDRESS HEX 3A)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI				х	х	х	х	х	х	х	х	х			ADCF	REQ_	4[6:0]			
MISO	SO NEWDATA_A 0 0 ADCREQ_A[6:0] ADCRES_A[9:0]																			



DS11615 Rev 3

DIAGCTRL_B (ADDRESS HEX 3B)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI			х	х	х	х	х	х	х	х	х			ADCF	REQ_E	B [6:0]				
MISO	O NEWDATA_B 0 0 ADCREQ_B [6:0] ADCRES_B [9:0]																			

DIAGCTRL_C (ADDRESS HEX 3C)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI					х	х	х	х	х	х	х	х	х			ADCF	REQ_0	C [6:0]		
MISO	NEWDATA_C	0	0		ADCREQ_C [6:0] ADCRES_C [9:0]															

DIAGCTRL_D (ADDRESS HEX 3D)

	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MOSI					х	х	х	х	х	х	х	х	х			ADCF	REQ_D	D [6:0]		
MISO	NEWDATA_D		AI	DCR	EQ_	D [6	:0]						ADC	RES_	D [9:0]]				

ADCREQ[A-D] bit fields, used to address the different measurements offered, are listed in *Table 17* for reference.

L9680 diagnostics is structured to take four automatic conversions at a time. In order to get four measurements, four different SPI commands have to be sent (DIAGCTRL_A, DIAGCTRL_B, DIAGCTRL_C and DIAGCTRL_D), in no particular order.

In case the voltage to be measured is not immediately available, the desired inputs for conversion have to be programmed by SPI in advance, to allow them to attain a stable voltage value. This case applies to the squib/pyroswitch resistance measurement and diagnostics (refer to *Loop diagnostics control and results registers*) and to the DC sensor measurement (refer to *Section 11*).

CONVRDY_0 bit in GSW is equal to (NEWDATA_A or NEWDATA_B), while CONVRDY_1 bit in GSW corresponds to (NEWDATA_C or NEWDATA_D).

Each NEWDATAx flag is asserted when conversion is finished and cleared when result is read out. However result is cleared only when new result for that register is available.

When a new request is received it is queued if other conversions are ongoing. The conversions are executed in the same order as their request arrived. The queue is 4 measures long so it's possible to send all 4 requests at the same time and then wait for the results. If a DIAGCTLRx command is received twice, the second conversion request will overwrite the previous one.

Requests are sent to the L9680 IC via the ADC measurement Registers (ADCREQx) as shown in *Table 17*. All diagnostics results are available on the ADCRESx registers, when addressed by the related ADCREQx register (e.g. data requested by ADCREQA would be written to ADCRESA).



	AD	C Re	eque	est (ADC	REC	Qx)		ADC Results (ADCRESx)
		В	it[6:	0]			Hex	Voltage Measurement Selection	Bit[9:0]
0	0	0	0	0	0	0	\$00	Unused	
0	0	0	0	0	0	1	\$01	ADC ground reference	V _{ADC_GROUND}
0	0	0	0	0	1	0	\$02	ADC Test Pattern 2	V _{ADC_FULLSCALE}
0	0	0	0	0	1	1	\$03	DC Sensor ch. selected, Voltage	DCSV_selected
0	0	0	0	1	0	0	\$04	DC Sensor ch. selected, Current	DCSI_selected
0	0	0	0	1	0	1	\$05	DC Sensor ch. selected, Resistance ⁽¹⁾	DCSV and DCSI selected
0	0	0	0	1	1	0	\$06	Squib/pyroswitch measurement loop selected	Voutx
0	0	0	0	1	1	1	\$07	Internal reference Voltage	VBGR
0	0	0	1	0	0	0	\$08	Internal reference monitor Voltage	VBGM
0	0	0	1	0	0	1	\$09	VCOREMON voltage	VCOREMON
0	0	0	1	0	1	0	\$0A	Temperature Measurement	ТЕМР
0	0	0	1	0	1	1	\$0B	DC Sensor ch 0, Voltage	DCSV_0
0	0	0	1	1	0	0	\$0C	DC Sensor ch 1, Voltage	DCSV_1
0	0	0	1	1	0	1	\$0D	DC Sensor ch 2, Voltage	DCSV_2
0	0	0	1	1	1	0	\$0E	DC Sensor ch 3, Voltage	DCSV_3
0	0	0	1	1	1	1	\$0F	DC Sensor ch 4, Voltage	DCSV_4
0	0	1	0	0	0	0	\$10	DC Sensor ch 5, Voltage	DCSV_5
0	0	1	0	0	0	1	\$11	DC Sensor ch 6, Voltage	DCSV_6
0	0	1	0	0	1	0	\$12	DC Sensor ch 7, Voltage	DCSV_7
0	0	1	0	0	1	1	\$13	DC Sensor ch 8, Voltage	DCSV_8
0	0	1	0	1	0	0	\$14	V _B voltage of ER ESR measure ⁽²⁾	V _B
0	0	1	0	1	0	1	\$15	V _A voltage of ER ESR measure ⁽²⁾	V _A
0	0	1	0	1	1	0	\$16	V _C voltage of ER ESR measure ⁽²⁾	V _C
0	0	1	0	1	1	1	\$17	Unused	
0	0	1	1	0	0	0	\$18	Unused	
0	0	1	1	0	0	1	\$19	Unused	
0	0	1	1	0	1	0	\$1A	Unused	
0	0	1	1	0	1	1	\$1B	Unused	
0	0	1	1	1	0	0	\$1C	Unused	
0	0	1	1	1	0	1	\$1D	Unused	
0	0	1	1	1	1	0	\$1E	Unused	
0	0	1	1	1	1	1	\$1F	Unused	
0	1	0	0	0	0	0	\$20	VBATMON pin voltage	VBATMON

Table 17. Diagnostics control register (DIAGCTRLx)



DS11615 Rev 3

	AD	C Re	eque	est (ADC	REC	ג)		ADC Results (ADCRESx)
		В	it[6:	0]			Hex	voltage Measurement Selection	Bit[9:0]
0	1	0	0	0	0	1	\$21	VIN pin voltage	VIN
0	1	0	0	0	1	0	\$22	Internal analog supply voltage (VINT3V3)	VINT3V3
0	1	0	0	0	1	1	\$23	Internal digital supply voltage (CVDD)	CVDD
0	1	0	0	1	0	0	\$24	ERBOOST pin voltage	ERBOOST
0	1	0	0	1	0	1	\$25	SYNCBOOST pin voltage	SYNCBOOST
0	1	0	0	1	1	0	\$26	VER pin voltage	VER
0	1	0	0	1	1	1	\$27	SATBUCK voltage	SATBUCK
0	1	0	1	0	0	0	\$28	VCC voltage	VCC
0	1	0	1	0	0	1	\$29	WAKEUP pin voltage	WAKEUP
0	1	0	1	0	1	0	\$2A	VSF pin voltage	VSF
0	1	0	1	0	1	1	\$2B	WDTDIS pin voltage	WDTDIS
0	1	0	1	1	0	0	\$2C	GPOD0 pin voltage	GPOD0
0	1	0	1	1	0	1	\$2D	GPOS0 pin voltage	GPOS0
0	1	0	1	1	1	0	\$2E	GPOD1 pin voltage	GPOD1
0	1	0	1	1	1	1	\$2F	GPOS1 pin voltage	GPOS1
0	1	1	0	0	0	0	\$30	GPOD2 pin voltage	GPOD2
0	1	1	0	0	0	1	\$31	GPOS2 pin voltage	GPOS2
0	1	1	0	0	1	0	\$32	RSU0 pin Voltage	RSU0
0	1	1	0	0	1	1	\$33	RSU1 pin Voltage	RSU1
0	1	1	0	1	0	0	\$34	RSU2 pin Voltage	RSU2
0	1	1	0	1	0	1	\$35	RSU3 pin Voltage	RSU3
0	1	1	0	1	1	0	\$36	SS0 pin voltage	SS0
0	1	1	0	1	1	1	\$37	SS1 pin voltage	SS1
0	1	1	1	0	0	0	\$38	SS2 pin voltage	SS2
0	1	1	1	0	0	1	\$39	SS3 pin voltage	SS3
0	1	1	1	0	1	0	\$3A	SS4 pin voltage	SS4
0	1	1	1	0	1	1	\$3B	SS5 pin voltage	SS5
0	1	1	1	1	0	0	\$3C	SS6 pin voltage	SS6
0	1	1	1	1	0	1	\$3D	SS7 pin voltage	SS7
0	1	1	1	1	1	0	\$3E	SS8 pin voltage	SS8
0	1	1	1	1	1	1	\$3F	SS9 pin voltage	SS9
1	0	0	0	0	0	0	\$40	SSA pin voltage	SSA
1	0	0	0	0	0	1	\$41	SSB pin voltage	SSB

Table 17. Diagnostics control register (DIAGCTRLx) (continued)



	AD	C Re	eque	est (ADC	REC	ע (x	Veltere Messerere Oclastice	ADC Results (ADCRESx)
		В	it[6:	0]			Hex	voltage measurement Selection	Bit[9:0]
1	0	0	0	0	1	0	\$42	Unused	-
1	0	0	0	0	1	1	\$43	Unused	-
1	0	0	0	1	0	0	\$44	Unused	-
1	0	0	0	1	0	1	\$45	Unused	-
1	0	0	0	1	1	0	\$46	SF0 pin voltage	SF0
1	0	0	0	1	1	1	\$47	SF1 pin voltage	SF1
1	0	0	1	0	0	0	\$48	SF2 pin voltage	SF2
1	0	0	1	0	0	1	\$49	SF3 pin voltage	SF3
1	0	0	1	0	1	0	\$4A	SF4 pin voltage	SF4
1	0	0	1	0	1	1	\$4B	SF5 pin voltage	SF5
1	0	0	1	1	0	0	\$4C	SF6 pin voltage	SF6
1	0	0	1	1	0	1	\$4D	SF7 pin voltage	SF7
1	0	0	1	1	1	0	\$4E	SF8 pin voltage	SF8
1	1 0 0 1 1 1 1 5						\$4F	SF9 pin voltage	SF9
1	1 0 1 0 0 0 \$5						\$50	SFA pin voltage	SFA
1	1 0 1 0 0 0 1 \$5							SFB pin voltage	SFB

Table 17.	Diagnostics	control regis	ter (DIAGCTRL))	(continued)
	Diagnostios	control regio		·/ ·	(continued)

1. The DC sensor resistance measurement can only be addressed through DIAGCRTL_A command. Results are available through DIAGCTRL_A and DIAGCTRL_B, where ADCRES_A will contain DCSI and ADCRES_B will contain DCSV.

2. Valid only for ADCREQ_x field of MISO response when ESR measure results are available.

Proper scaling is necessary for various measurements. The divider ratios vary by measurement and are summarized by function in the table below.

Table 18	Diagnostics	divider ratios
----------	-------------	----------------

Magauramanta	Divider Ratio						
measurements	15:1	10:1	7:1	4:1	1:1		
VER	Х						
ERBOOST	Х						
VSF	Х						
SSxy	Х						
SFx	Х						
GPODx		Х					
GPOSx		Х					
SYNCBOOST		Х					
VIN		Х					



Massuramants			Divider Ratio					
measurements	15:1	10:1	7:1	4:1	1:1			
VBATMON		Х						
WAKEUP		Х						
SATBUCK			Х					
WDT/TM			Х					
RSUx			Х					
VCC				Х				
CVDD				Х				
VINT				Х				
VCOREMON					Х			
Bandgap (BGR/BGM)					Х			

Table 18. Diagnostics divider ratios (continued)

For measurements other than voltage (current, resistance, temperature etc.) the ranges are specified in the electrical parameters section of the relevant block.

14.1 Analog to digital algorithmic converter

The device hosts an integrated 10 bit Analog to Digital converter, running at a clock frequency of 16 MHz. The ADC output is processed by a D to D converter with the following functions:

- Use of trimming bits to recover additional gain error due to resistor dividers mismatch;
- Digital low-pass filtering;
- Conversion from 12 to 10 bits.

10 bits data are filtered inside the digital section. The number of samples that are filtered vary depending on the chosen conversion. As per Section 7.3.2, the number of used samples in converting DC sensor, squib/pyroswitch or temperature measurements defaults to 8. The number of samples for all other measurements defaults to 4. The sample number can be configured by accessing the SYS_CFG register. After low pass filter, the residual total error is ± 4 LSB. This error figure applies to the case of a ideal reference voltage: the spread of reference voltage causes a proportional error in the conversion output. The reference voltage of the ADC is set to 2.5 V.

The conversion time is comprised of several factors: the number of measurements loaded into the queue, the number of samples taken for any one measurement, and the various settling times. An example of conversion time calculation for a full ADC request queue is reported in *Figure 70*. The timings reported in *Figure 70* are nominal ones, min/max values can be obtained by considering the internal oscillator frequency variation reported in the DC characteristics section.





Figure 70. ADC conversion time



15 Temperature sensor

The L9680 provides an internal analog temperature sensor. The sensor is aimed to have a reference for the average junction temperature on silicon surface. The sensor is placed far away from power dissipating stages and squib/pyroswitch deployment drivers. The output of the temperature sensor is available via SPI through ADC conversion, as shown in *Table 17*. The formula to calculate temperature from ADC reading is the following one:

$$T(^{\circ}C) = 180 - \left\{ \left(\frac{220}{1.652}\right) \cdot \left[\left(\frac{ADC_{REF}}{2} \cdot DIAGCTRLn(ADCRESn)\right) - 0.739 \right] \right\}$$

@ DIAGCTRLn(ADCREQn) = 0A_{hex}

All parametric requirements for this block can be found in specification tables.



16 Applications

The main applications for this IC are two:

- as advanced user configurable airbag IC
- as pyro fuse manager IC

16.1 Application circuit

Figure 71. Application circuit





DS11615 Rev 3

16.2 BOM (Bill Of Materials)

The following table summarizes the suggested BOM for application shown on *Figure 71*.

Component	Min	Тур	Мах	Unit	Requirement	Note
C1	-	100	-	nF	50 V	Input capacitor (unprotected battery)
C2	-	2.2	-	μF	50 V	Input capacitor (protected battery)
C3	-	2.2	15	μF	50 V	ER Boost input capacitor
C4	-	100	-	nF	50 V	ER Boost ceramic output capacitor
C5	-	100	-	μF	50 V	ER Boost electrolytic output capacitor
C6	-	10	-	nF	25 V	VBATMON capacitor
C7	-	100	-	nF	50 V	SYNC Boost input capacitor
C8	-	47	-	μF	35 V	SYNC Boost output capacitor
C9	-	100	-	nF	50 V	SAT Buck input capacitor
C10	-	47	-	μF	35 V	SAT Buck output capacitor
C11	-	100	-	nF	50 V	VCC Buck input capacitor
C12	-	47	-	μF	16 V	VCC Buck output capacitor
C13	2.2	-	4.7	mF	35 V	ER capacitor
C14	-	10	-	nF	25 V	VSF capacitor (near device)
C15	-	10	-	nF	25 V	VSF capacitor (near Safing FET gate)
C16	-	100	-	nF	50 V	Safing FET output capacitor
C17, C18, C19, C20, C21, C22	-	10	-	nF	25 V	SSxy capacitor
C23, C24, C25, C26, C27, C28, C29, C30, C31, C32, C33, C34	-	22	-	nF	25 V	SFx capacitor
C35, C36, C37, C38, C39, C40, C41, C42, C43, C44, C45, C46	-	22	-	nF	25 V	SRx capacitor
C47	-	100	-	nF	50 V	CVDD output capacitor

Table 19. Bill Of Materials



Component	Min	Тур	Max	Unit	Requirement	Note
C48, C49, C50, C51, C52, C53, C54, C55, C56	-	22	-	nF	25 V	DCSx capacitor
C57, C58, C59, C60	-	3.3	-	nF	25 V	RSUx capacitor
C61, C62, C63, C64	-	3.3	-	nF	25 V	WSSx capacitor
D1	-	2	-	Α	-	Reverse battery protection
D2	-	1	-	Α	-	ER Boost diode
D3	-	1	-	Α	-	WAKEUP diode
D4	-	1	-	А	-	SYNC Boost diode
D5	-	12	-	V	-	Safing FET Zener diode
D6, D7, D8, D9, D10, D11	-	1	-	A	-	SSxy diode
L1	-	10	-	μH	1 A	ER Boost inductor
L2	-	4.7	-	μH	1 A	SYNC Boost inductor
L3	-	4.7	-	μH	1 A	SAT Boost inductor
L4	-	4.7	-	μH	1 A	VCC Boost inductor
R1	-	0.43	-	Ω	1 W	Current limit resistor
R2	-	1	-	kΩ	100 mW	VBATMON current limit resistor
R3	-	360	-	Ω	125 mW	Diagnostic resistor
R4	-	1.5	-	kΩ	100 mW	Safing FET passive pull-up resistor
R5	-	1	-	kΩ	100 mW	External Safing FET enable resistor
Q3	-	60	-	А	60 V	External Safing FET (N-channel)
U1	-	-	-	-	PUMD15	External Safing FET enable

Table 19. (continued)Bill Of Materials



17 Electrical characteristics

Every parameter in this chapter is fulfilled down to $\mathsf{VIN}_{\mathsf{GOOD}(\mathsf{max})}.$

No device damage is granted to occur down to VIN_{BAD}(min).

GNDA pin is used as ground reference for the voltage measurements performed within the device, unless otherwise stated.

All table or parameter declared 'Design Info' are not tested during production testing

17.1 Configuration and control

All electrical characteristics are valid for the following conditions unless otherwise noted. -40 $^{\circ}C$ \leq Ta \leq +95 $^{\circ}C.$

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V _{NOV}	Normal Operating Voltage	Design Info Depending on power supply configuration	6	13	18	V
2	V _{JSV}	Jump Start Voltage	Design Info 40°C ≤ Ta ≤ 50°C	18	-	26	V
3	V _{LDV}	Load Dump Voltage	Transient Design Info	26.5	-	40	V
4	WU_mon	WAKEUP Monitor threshold	GNDSUBx as ground reference	-	-	1.5	V
5	WU_off	WAKEUP Off threshold	GNDSUBx as ground reference Vin = 5.5 V and 35 V	2	2.5	3	V
6	WU_on	WAKEUP On threshold	GNDSUBx as ground reference Vin = 5.5 V and 35 V	4	4.5	5	V
7	WU _{RPD}	WAKEUP Pull-down Resistor	GNDSUBx as ground reference	120	300	480	kΩ
8	VB _{GOOD0}		SYS_CTL(VBATMON_TH_SEL)=00 or 11	5.5	5.75	6	V
9	VB _{BAD0}		SYS_CTL(VBATMON_TH_SEL)=00 or 11	5	5.25	5.5	V
10	VB _{GOOD1}	VBATMON Thresholds	SYS_CTL(VBATMON_TH_SEL)=01	6.45	6.7	6.95	V
11	VB _{BAD1}		SYS_CTL(VBATMON_TH_SEL)=01	5.95	6.2	6.45	V
12	VB _{GOOD2}		SYS_CTL(VBATMON_TH_SEL)=10	7.5	7.75	8	V
13	VB _{BAD2}		SYS_CTL(VBATMON_TH_SEL)=10	7	7.25	7.6	V

Table 20. Configuration and control DC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
13b	$\Delta V_{BGOOD2} VB_{BAD2}$	VBATMON delta thresholds	V _{BGOOD2} _VB _{BAD2}	300	-	600	mV
14	I _{LKG_VBATMON_OFF}	VBATMON input	Device OFF	-5	-	5	μA
15	ILKG_VBATMON_ON	leakage	Device ON Design Info	20	24	30	μA
16	R _{PD_VBATMON}	VBATMON pull-down resistance	Device ON VBATMON < 10V Design Info	125	250	375	kΩ
17	I _{LKG_VBATMON_TOT}	VBATMON total input leakage	I _{LKG_VBATMON_ON} + R _{PD_VBATMO} VBATMON = 18V	35	-	180	μA
18	VIN _{GOOD0}		SYS_CTL(VIN_TH_SEL)=0	5	5.25	5.5	V
19	VIN _{BAD0}	VIN Good and VIN Bad Thresholds	SYS_CTL(VIN_TH_SEL)=0	4.5	4.75	5	V
20	VIN _{GOOD1}		SYS_CTL(VIN_TH_SEL)=1	6.05	6.3	6.55	V
21	VIN _{BAD1}		SYS_CTL(VIN_TH_SEL)=1	5.55	5.8	6.05	V
22	VIN _{FASTSLOPE_H}		-	9.3	9.8	10.3	V
23	VIN _{FASTSLOPE_L}	VIN Thresholds used to change Boost regulator transition time	-	9	9.5	10	V
24	VINFASTSLOPE_HYS		-	0.2	0.3	0.4	V
25	VIN _{SYNC_DIS_L}		SYS_CTL(SYBST_V) =0	12.2	-	13.6	V
26	VIN _{SYNC_DIS_H}	VIN SyncBoost Disable	SYS_CTL(SYBST_V) = 1	15	-	16.2	V
27	VIN _{SYNC_DIS_LYS} VIN _{SYNC_DIS_HYS}	Inresnoias	SYS_CTL(SYBST_V) = 0 / 1 Guaranteed by design	5	-	300	mV
28	I _{LKG_VIN_OFF}	VIN input current	Device OFF VIN = 40V	-10	-	10	μA
29	I _{LKG_VIN_ON}		Device ON VIN = 12V	-	-	40	mA
30	C _{VIN}	External VIN capacitor	Design Info	1	-	13 ⁽¹⁾	μF

Table 20. Configuration and control DC specifications (continued)



No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
31	I _{LKG_VER_OFF}		Device OFF VER = 40V	-5	-	50	μA
32	I _{LKG_VER_ON_L}	VER Input Leakage	Device ON ERBOOST > VER ER Charge OFF	50	-	200	μΑ
33	I _{LKG_VER_ON_H}		Device ON ERBOOST < VER ER Charge OFF	100	-	500	μΑ
34	V _{WDTDIS_TH}	WDT/TM threshold	Test go no go	10	12	14	v
35	V _{WDTDIS_HYST}	WDT/TM hysteresis	Design Info	0.2	0.4	0.5	V
36	I _{PD_WDTDIS}	WDT/TM Pull Down Resistance	V _{WDTDIS} ≤ 5V	20	45	70	μA
37	V _{TH1_H_VCCSEL_}		-	1.30	1.55	1.80	v
38	V _{TH1_L_VCCSEL}	VCCSEL Input Voltage Thresholds 1	-	1.05	1.25	1.45	V
39	V _{HYS1_VCCSEL}		-	0.2	-	-	v
40	V _{TH2_H_VCCSEL_}		-	5.9	6.4	6.9	v
41	V _{TH2_L_VCCSEL}	VCCSEL Input Voltage Thresholds 2	-	5.6	6.1	6.6	V
42	V _{HYS2_VCCSEL}		-	0.2	-	-	V
43	IPD_VCCSEL	VCCSEL Pull Down Current	VCCSEL= SATBUCK	20	45	70	μA

Table 20.	Configuration	and control	DC si	pecifications	(continued)
	ooninguruuon		000	scomoutions	(continued)



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
44	I _{TOTLKG_BAT}	Battery Line Total Input Leakage	Room Temp WAKEUP = 0 All following pins at 13V: VBATMON, VIN, ERBSTSW, ERBOOST, SYNCBSTSW, SYNCBOOST Guaranteed by design	-	-	35	μΑ
45	Тյ	Junction Temperature	Design Info	-	-	150	°C

Table 20. Configuration and control DC specifications (continued)

1. Bigger capacitor can be used in case an external switch is used in parallel to the ER-Switch.

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	T _{FLT_VBATMONTH}	VBATMON thresholds deglitch filter time	-	26	30	34	μs
2	T _{FLT_VINGOOD_UP}	VIN Good thresholds deglitch filter time rising edge	-	3	3.5	4	μs
3	T _{FLT_VINGOOD_DO} WN_L	VIN Good thresholds deglitch filter time falling edge	SYS_CFG(VINGOOD_FILT_SEL) = 0	-	1	-	μs
4	T _{FLT_VINGOOD_DO} WN_H	VIN Good thresholds deglitch filter time falling edge	SYS_CFG(VINGOOD_FILT_SEL) = 1	3	3.5	4	μs
6	T _{FLT_VINBAD_DOWN}	VIN Bad thresholds deglitch filter time falling edge	-	3	3.5	4	μs
7	T _{FLT_VINBAD_UP}	VIN Bad thresholds deglitch filter time rising edge	-	26	30	34	μs
8	T _{VINGOOD_BLK}	VIN Good Thresholds blanking time	-	26	30	34	μs
9	T _{FLT_VINSYNCDIS_D} OWN	VIN SyncBoost Disable deglitch filter time falling edge	-	3.3	-	4.2	μs
10	T _{FLT_VINSYNCDIS} _UP	VIN SyncBoost Disable deglitch filter time rising edge	-	9.5	-	11	μs

Table 21. Configuration and control AC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
11	T _{FLT_WAKEUP}	Wakeup deglitch filter time	-	0.95	1.05	1.15	ms
12	T _{LATCH_WAKEUP}	Wakeup latch time	-	9.7	10.8	11.9	ms
13	T _{PWRUP}	Power-up Delay Time – Wake-up to RESET released	-	-	-	10	ms

Table 21. Configuration and control AC specifications (continued)



No	Symbol	Parameter	Conditions / Comments	Min	Тур	Max	Unit
1	GNDA _{OPEN}	GNDA open threshold	GNDSUBx=0	100	200	300	mV
2	GNDD _{OPEN}	GNDD open threshold	GNDSUBx=0	100	200	300	mV
3	BSTGND _{OPEN}	BSTGND open threshold	GNDSUBx=0	100	200	300	mV
4	I _{PU_BSTGND}	BSTGND pull-up current	ER BOOST OFF and SYNC BOOST OFF	130	-	270	μA
5	SATGND _{OPEN}	SATGND open threshold	GNDSUBx=0	100 200 30		300	mV
6	I _{PU_SATGND}	SATGND pull-up current	SATBUCK OFF	80	120	160	μA
7	VCCGND _{OPEN}	VCCGND open threshold	GNDSUBx=0	100	200	300	mV
8	I _{PU_VCCGND}	VCCGND pull-up current	VCC BUCK OFF	80	120	160	μA

Table 22. Open ground detection DC specifications

No	Symbol	Parameter	Condition	Min	Тур	Max	Unit
1	T _{FLT_GNDREFOPEN}	GNDA and GNDD Open Deglitch Filter Time	-	7	11	16	μs
2	T _{FLT_GNDREGOPEN}	BSTGND, SATGND, VCCGND Open Deglitch Filter Time	-	1.9	2.3	2.7	μs

17.2 Internal analog reference

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C ≤ Ta ≤ +95 °C

 $VIN_{BAD0(min)} \le VIN \le 35 V$

Table 24. Internal analog reference	Table 24.	Internal	analog	reference
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N°	Symbol	Parameter	Condition	Min	Тур	Max	Unit
1	V _{BG1}	Bandgap reference	Vin = 5.5 V and 35 V	-1%	1.2	+1%	V
2	V _{BG2}	Bandgap monitor	Vin = 5.5 V and 35 V	-1%	1.2	+1%	V
3	V _{ADC_GROUND}	ADC Ground reference	ADC total error included	90	104	120	mV
4	V _{ADC_FULLSCALE}	ADC Full scale reference	-	-1.5%	2.5	+1.5%	V



17.3 Internal regulators

All electrical characteristics are valid for the following conditions unless otherwise noted. -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V

No	Symbol	Parameter	Condition	Min	Тур	Max	Unit
1	V _{OUT_VINT3V3}	VINT3V3 output voltage	Vin = 5.5 V, 12 V and 35 V	3.14	3.3	3.46	V
2	V _{OV_VINT3V3}	VINT3V3 over voltage	-	3.47	-	3.7	V
3	V _{UV_VINT3V3}	VINT3V3 under voltage	-	2.97	-	3.13	V
4	V _{OUT_CVDD}	CVDD output voltage	Vin = 5.5 V, 12 V and 35 V	3.14	3.3	3.46	V
5	IOUT_CVDD	CVDD current capability	External load is not allowed	-	-	50	mA
6	I _{LIM_CVDD}	CVDD current limit	Vin = 5.5 V and 35 V	80	-	-	mA
7	V _{OV_CVDD}	CVDD over voltage	-	3.47	-	3.7	V
8	V _{UV_CVDD}	CVDD under voltage	-	2.7	-	2.9	V
9	C _{CVDD}	CVDD output capacitance	Design info	60	100	140	nF

Table 25. Internal regulator DC specifications

Table 26	Internal	regulators	AC s	specifications
	. miternai	regulators	NO 3	pecifications

No	Symbol	Parameter	Comment	Min	Тур	Max	Unit
1	T _{FLT_VINT_CVDD_OV}	Internal regulator over voltage deglitch filter time	-	7	11	16	μs
2	T _{FLT_VINT_CVDD_UV}	Internal regulator under voltage deglitch filter time	-	7	11	16	μs



17.4 Watchdog

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V

No	Symbol	Parameter	Condition	Min	Тур	Max	Unit	
1	T	Temporal watchdog timeout	_	-	-	2.00	ms	
I	I	'WDT1_TIMEOUT	Temporal wateridog timeout		-	-	16.3	ms
2	T _{WDT1_RST}	Temporal watchdog reset time	-	0.9	1.0	1.1	ms	

Table 27. Temporal watchdog timer AC specifications (WD1)

Table 28. Algorithmic watchdog timer DC specifications (WD2)

No	Symbol	Parameter	Condition	Min	Тур	Max	Unit
1	V _{OH_WD2LCKOUT}		I _{LOAD} = -0.5 mA	VCC-0.6	-	VCC	V
2	V _{OL_WD2LCKOUT}		I _{LOAD} = 2.0 mA	0	-	0.4	V

Table 29. Algorithmic watchdog timer AC specifications (WD2)

No	Symbol	Parameter	Condition	Min	Тур	Max	Unit
1	T _{WDT2_TIMEOUT}	Algorithmic watchdog timeout	-	45	50	55	ms
2	T _{WDT2_RST}	Algorithmic watchdog reset time	-	0.9	1.0	1.1	ms
3	T _{RISE_WD2LCKOUT}	WD2LockOut rise time	50 pF load, 20%-80%	-	-	1.0	μs
4	T _{FALL_WD2LCKOUT}	WD2LockOut fall time	50 pF load, 20%-80%	-	-	1.0	μs
5	f _{WD2_SEED}	WD2 Seed Counter Rate	-	-	f _{osc} 512	-	MHz



17.5 Oscillators

All electrical characteristics are valid for the following conditions unless otherwise noted: --40 °C \leq Ta \leq +95 °C, VIN_{GOOD0}(max) \leq VIN \leq 35 V.

N #	Symbol	Parameter	Condition	Min	Тур	Мах	Unit
1	f _{osc}	Main oscillator average frequency	-	15.2	16	16.8	MHz
2	f _{MOD_} osc	Main oscillator modulation frequency	SPI_CLK_CNF(MAIN_SS_DIS=0) Design Info	-	f _{osc} 128	-	MHz
3	I _{MOD_} osc	Main oscillator modulation index	SPI_CLK_CNF(MAIN_SS_DIS=0)	2	4	6	%
4	f _{AUX}	Aux oscillator average frequency	-	7.125	7.5	7.875	MHz
5	f _{MOD_AUX}	Aux oscillator modulation frequency	SPI_CLK_CNF(AUX_SS_DIS=0) Design Info	-	f _{osc_AUX} 128	-	MHz
6	I _{MOD_AUX}	Aux oscillator modulation index	SPI_CLK_CNF(AUX_SS_DIS=0)	2	4	6	%
7	f _{OSC_LOW_} TH	Main oscillator low frequency detection threshold	-	<u>128</u> · f _{AUX_MIN}	-	128 68 · f _{AUX_MAX}	MHz
8	fosc_ніgн_ TH	Main oscillator high frequency detection threshold	-	79 32 · f _{AUX_MIN}	-	⁷⁹ / ₃₂ ⋅ f _{AUX_MAX}	MHz

Table 30. Oscillators specifications



17.6 Reset

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, VCCx(min) \leq VCCx \leq VCCx(max), VCC = 3.3 V or 5 V

No	Symbol	Parameter Comment		Min	Тур	Max	Unit
1	V _{OH_RESET}	RESET output voltage	I _{LOAD} = -1.0 mA	VCC-0.4	-	VCC	V
2	V _{OL_RESET}		I _{LOAD} = 2.0 mA	0	-	0.4	V
3	R _{PD_RESET}	RESET pull down resistance	-	65	100	135	kΩ
4	VCORE _{UV}	VCOREMON under voltage threshold	-	1.08	1.11	1.14	V
5	VCORE _{OV}	VCOREMON over voltage threshold	-	1.26	1.29	1.32	۷
6	R _{PD_VCORE}	VCOREMON pull down resistance	-	65	100	135	kΩ
7	VIH_MCUFLT	MCUFAULTB high level input voltage	-	2	-	-	V
8	V _{IL_MCUFLT}	MCUFAULTB Low level Input Voltage	-	-	-	0.8	V
9	I _{PD_MCUFLT}	MCUFAULTB Pull Down Current	MCUFAULTB= VCC	20	45	70	μA

Table 31. Reset	DC	specifications
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Table 32. Reset AC specifications

No	Symbol	Parameter	Comment	Min	Тур	Max	Unit
1	T _{RISE_RESET}	Rise time	50 pE load 20% 80%	-	-	1.00	μs
2	T _{FALL_RESET}	Fall time	50 pr 10au, 2076-0076	-	-	1.00	μs
3	T _{HOLD_RESET}	Reset hold time	-	0.45	0.5	0.55	ms
4	T _{FLT_VCOREOV}	VCOREMON over voltage deglitch filter time	-	27	30	33	μs
5	T _{FLT_VCOREUV}	VCOREMON under voltage deglitch filter time	-	27	30	33	μs
6	T _{FLT_MCUFAULTB}	MCUFAULTB Deglitch filter time	-	9	10	11	μs



17.7 SPI interface

All electrical characteristics are valid for both Global and Remote Sensor SPI and for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, VCCx(min) \leq VCCx \leq VCCx(max), VCC = 3.3 V or 5 V

No	Symbol	Symbol Parameter Comment		Min	Тур	Max	Unit
1	V _{IH_CS_G} V _{IH_CS_RS}	CS_G CS_x High level Input CS_RS Voltage -		2	-	-	V
2	V _{IL_CS_G} V _{IL_CS_RS}	S_G CS_x Low level Input CS_RS Voltage		-	-	0.8	V
3	I _{PU_CS_G} I _{PU_CS_RS}	CS_x Pull Up Current	CS_x = 0V	-70	-45	-20	μA
4	V _{IH_MOSI_G} V _{IH_MOSI_RS}	MOSI_x High level Input Voltage	-	2	-	-	V
5	V _{IL_MOSI_G} V _{IL_MOSI_RS}	MOSI_x Low level Input Voltage	-	-	-	0.8	V
6	I _{PD_MOSI_G} I _{PD_MOSI_RS}	MOSI_x Pull Down Current	MOSI_x = VCC	20	45	70	μA
8	V _{IH_SCLK_G} V _{IH_SCLK_RS}	SCLK_x High level Input Voltage	-	2	-	-	V
9	V _{IL_SCLK_G} V _{IL_SCLK_RS}	LK_G SCLK_x Low level Input _K_RS Voltage		-	-	0.8	V
10	I _{PD_SCLK_G} I _{PD_SCLK_RS}	SCLK_x Pull Down Current	SCLK_x = VCC	20	45	70	μA
12	V _{OH_MISO_G} V _{OH_MISO_RS}	MISO_x High level Output Voltage	I _{LOAD} = -800 μA	VCC -0.5	-	VCC	V
13	V _{OL_MISO_G} V _{OL_MISO_RS}	MISO_x Low level Output Voltage	I _{LOAD} = 2.0 mA	-	-	0.4	V
14	I _{LKG_MISO_G} I _{LKG_MISO_RS}	MISO_x Output Leakage	Tri-state leakage	-10	-	10	μA
15	V _{IH_MISO_RS}	MISO_RS High level Input Voltage	-	2	-	-	V
16	V _{IL_MISO_RS}	MISO_RS Low level Input Voltage	-	-	-	0.8	V

Table 33. Global and remote sensor SPI DC specifications



No	Symbol	Parameter Comments / Conditions		Min	Тур	Max	Unit
1	F _{SCLK}	K SPI transfer frequency -		-	8	8.08	MHz
2	T _{SCLK}	T _{SCLK} SCLK_x period -		123.8	-	-	ns
3	T _{LEAD}	Enable lead time	-	250	-	-	ns
4	T _{LAG}	Enable lag time	-	50	-	-	ns
5	T _{HIGH_SCLK}	SCLK_x high time	-	40	-	-	ns
6	T _{LOW_SCLK}	SCLK_x low time	-	40	-	-	ns
7	T _{SETUP_MOSI}	MOSI_x input setup time	-	20	-	-	ns
8	T _{HOLD_MOSI}	MOSI_x input hold time	-	20	-	-	ns
9	T _{ACC_MISO}	MISO_x access time		5	-	60	ns
10	T _{DIS_MISO}	MISO_x disable time	80 pF load	20	-	100	ns
11	T _{VALID_MISO}	MISO_x output valid time		5	-	30	ns
12	T _{HOLD_MISO}	MISO_x Output Hold Time	80 pF load; Design Info	0	-	-	ns
13	T _{NODATA}	SCLK_x hold time	-	20	-	-	ns
14	T _{FLT_CS}	CS_x noise glitch rejection time	-	50	-	300	ns
15	T _{NODATA}	SPI interframe time	-	400	-	-	ns
16	T _{SETUP_MISO_RS}	MISO_RS Input Setup Time	-	20	-	-	ns
17	T _{HOLD_MISO_RS}	MISO_RS Input Hold Time	-	20	-	-	ns

Table 34. SPI AC specifications

Note: All timing is shown with respect to 10% and 90% of the actual delivered VCC voltage.



Figure 72. SPI timing diagram



17.8 ERBoost regulator

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	N/	Roost output voltage	Across all line and I _{O_BST} load (steady state) SYS_CTL(ER_BST_V)=0	22.6	23.8	25	V
2	VO_ERBST	Boost output voltage	Across all line and I _{O_BST} load (steady state) 1SYS_CTL(ER_BST_V)=1	31.65	33	35	V
3	I _{O_ERBST}	Boost output current	-	0.1	-	70	mA
4	dV _{SR_ac}	Line transient response	All line, load; dt=100us; BST33V = 0/1 Design Info	-8%	-	8%	%
5	$\mathrm{dV}_{\mathrm{LR}_{\mathrm{ac}}}$	Load transient response	All line, load; dt=100us; BST33V = 0/1 Design Info	-8%	-	8%	%
6	R _{DSON_ERBST}	Power switch resistance	-	-	-	1	Ω
7	I _{OC_ERBST}		-	650	-	1350	mA
8	8 I _{OC_ERBST_ERON} C	Over current detection	ER Switch activated AND SW_REGS_CONF(LOW_E RBST_ILIM_ERON) = 1	125	-	600	mA
9	I _{LKG_ERBST_OFF}		ERBOOST=40V Power-off or Sleep Mode	-5	-	+5	μA
10	ILKG_ERBST_ON	ERBOOST input current	Active or Passive Mode ERBoost reg. enabled ERBSTSW > ERBoost > VER ER Charge OFF VSF regulator OFF Any GPO channel not enabled Guarantee by design	60	-	200	μA
11	ILKG_ERBST_ON_wGPO		Active or Passive Mode ERBoost reg. enabled ERBSTSW > ERBoost > VER ER Charge OFF VSF regulator OFF All GPO channel activated	1.5	-	2.4	mA

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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
12		ERBOOST voltage	BST33V = 0	18	20	22	V
13	VERBST_OK	threshold	BST33V = 1	26	28	30	V
14	V	ERBOOST Over Voltage	SYS_CTL(ER_BST_V) = 0	22.6	-	25	V
15	VERBST_OV	threshold	SYS_CTL(ER_BST_V) = 1	31.65	-	35	V
16	V _{ERBST_DIS_TH}	Voltage difference between VIN and ERBOOST to deactivate the ER Boost regulator	VIN – ERBOOST Vin = 5.5 V, 12 V and 35 V	1.6	2.2	2.5	V
17	V _{ERBST_CLAMP_EN_TH}	Voltage difference between ERBSTSW and ERBOOST to activate the ER Boost CLAMP	V _{ERBSTSW} – V _{ERBOOST}	2.7	3.3	3.7	V
18	T _{JSD_ERBST}	Thormal shutdown	-	150	175	190	°C
19	T _{HYS_TSDERBST}		-	5	10	15	°C

Table	35. ERBoo	ost regulator	DC specifications	(continued)
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Table 36. ERBoost regulator AC specifications

No	Symbol Parameter Conditions		Min	Тур	Max	Unit	
1	F _{SW_ERBST}	ERBOOST switching frequency	-	1.8	1.882	2.0	MHz
2	T _{RISE_ERBSTSW_SLOW} T _{FALL_ERBSTSW_SLOW}	ERBSTSW transition time	10% to 90% voltage on ERBSTSW VIN ≥ VIN _{FASTSLOPE_H} = 10.3 V I_{load} = 6 0mA SYS_CTL(ER_BST_V) = 1 Guaranteed by Design	15	-	35	ns
3	T _{RISE_ERBSTSW_FAST} T _{FALL_ERBSTSW_FAST}		10% to 90% voltage on ERBSTSW VIN = VIN _{FASTSLOPE_L} =9 V	5	-	15	ns
4	T _{ON_ERBST}	ERBOOST charge-up time	$C_{ERBOOST} = 2.2 \ \mu F$ Vin =12V, I _{O_ERBST} = 5mA SYS_CTL(ER_BST_V) = 1 Measured from CS_G edge to V _{O_ERBST} (min)	50	-	500	μs
5	T _{FLT_VIN_ERBST_COMP}	Deglitch filter on VIN_ERBoost comparator	-	27	30	33	μs



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
6	T _{FLT_TSD_ERBST}	Thermal shutdown filter time	-	-	-	10	μs
7	T _{SOFTST_ERBST}	ERBOOST Soft-start Time	Design Info. Time from activation of ERBOOST when overcurrent is 40% of I _{OC_ERBST} (I _{OC_ERBST_ERON}) to instant when overcurrent is 100% of I _{OC_ERBST} (I _{OC_ERBST_ERON})	-	-	1075	μs

Table 3	36. ERBoost	regulator AC	specifications	(continued)
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Table 37. ERBOOST Converter external components design info

No	Symbol	Component	Conditions	Min	Тур	Max	Unit
1	L _{ERBST}	Inductance	-	8	10	12	μH
2	ESL _{ERBST}	Inductance resistance	-	-	-	0.1	Ω
3	C _{BLK_ERBST}	Output bulk capacitance to ensure regulator stability	Min cap value including derating factors	1	2.2	-	μF
4	ESR _{CBLK_ERBST}	Bulk capacitor ESR	-		-	50	mΩ
5	V _{FSTR_ERBST}	Steering diode forward voltage	I _F =100 mA	-	-	0.85	V
6	I _{LKGSTR_ERBST}	Steering diode reverse leakage	Ta = 95 °C	-	-	3	mA



17.9 ER CAP current generators and diagnostic

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, 8 V \leq ERBOOST.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	I _{ER_CHARGE}	ER charge current	ERBOOST \ge 8 V ERBOOST - VER \ge 2 V ERBOOST = 24 V and 35 V	60	65	70	mA
2	IER_DISCHARGE_LOW	ER discharge low level current	VER ≥ 6V	60	65	70	mA
3	I _{ER_DISCHARGE_HIGH}	ER discharge high level current	VER ≥ 8V	589	640	691	mA
4	R _{DSON_ERCHARGE}	ER charge power resistance	(V _{ERBOOST} ⁻ V _{VER})/I _{VER} I _{VER} = 10mA	-	-	20	Ω
5	VER _{RANGE}	VER voltage measurement range	-	20	-	35	V
6	VER _{ACC}	VER voltage measurement accuracy	VER _{RANGE}	-8	-	+8	%
7	ERCAP _{RANGE}	Energy reserve capacitor measurement range	Design Info	-	-	10	mF
8	ERCAP _{ACC}	Energy reserve capacitor measurement accuracy	∆VERMIN = 2 V	-7	-	+7	%
9	ERCAP_ESR _{RANGE}	Energy reserve capacitor ESR measurement range	-	200	-	600	mΩ
10	ERCAP_ESR _{ACC}	Energy reserve capacitor ESR measurement accuracy	All errors included except the offset one (OFF _{ER_ESR})	-20		+20	%
11	G _{ER_ESR}	Energy Reserve Capacitor ESR Measurement Gain	-	-13%	3	+13%	V/V
12	OFF _{ER_ESR}	Energy Reserve Capacitor ESR Measurement Offset	Design Info	70	-	160	mΩ
13	T _{JSD_ERBST}	ER charge thermal	-	150	175	190	°C
14	T _{HYS_TSDERBST}	shutdown	-	5	10	15	°C
15	Vver_vbatmon_th	Voltage difference between VER and VBATMON to activate the ER Discharge in passive mode	VER - VBATMON	1.6	2.2	2.5	V

 Table 38. ER CAP current generators and diagnostic DC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	T _{ON_ERCAP}	Energy reserve capacitor charge-up time	C _{VER} ≤ 10mF nominal, BST33V = 0, Design Info	-	-	4	s
2	T _{ESR_DIAG}	ER CAP ESR diagnostic duration	Total duration time from SPI command to ADC results availability	-5%	225	+5%	μs
3	T _{FLT_TSD_ERCHARGE}	Thermal shutdown filter time	-	-	-	10	μs

Table 39. ER CAP current generators and diagnostic AC specifications

17.10 ER switch

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	R _{DSON_ERSW}	Power switch resistance	Vin = 5.5 V and 35 V	0.5	-	3	Ω
2	I _{LIM_ERSW}	ER switch current limit	VER = 17 V @ VIN = 12 V and VER = 35 V @ VIN = 31 V	608	810	980	mA
3	V _{ER_SW_OV_TH}	ER switch Over Voltage threshold	ER switch turned off when VIN > V _{ER} + V _{ER_SW_OV_TH} Vin = 12 V and 35 V	10	-	200	mV
4	T _{JSD_ERSW}	Thormal shutdown	-	150	175	190	°C
5	5 T _{HYS_TSDERSW}		-	5	10	15	°C

Table 40. ER Switch DC specifications

Table 41. ER Switch AC specifications

No	Symbol	Parameter	Conditions	Min		Мах	Unit
1	T _{ON_ERSW}	ER turn-on time (time to reach either R _{DSON_ERSW} or I _{LIM_ERSW})	C _{VIN} = 10 μF	-	-	5	μs
2	T _{FLT_TSD_ERSW}	Thermal shutdown filter time	-	-	-	10	μs
3	T _{BLK_ERSW}	ER switch activation blanking time after thermal shutdown	-	-	1	-	ms



17.11 COVRACT

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V; VIN_{GOOD}(max) \leq VIN \leq 35 V; VCCx(min) \leq VCCx \leq VCCx(max); VCC = 3.3 V or 5 V

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V _{OH_COVRACT}	COVRACT output voltage	I _{LOAD} = -0.5 mA	VCC -0.6	-	VCC	V
2	V _{OL_COVRACT}		I _{LOAD} = 2.0 mA	0	-	0.4	V
3	I _{REV_COVRACT}	Reverse current short high voltage	COVRACT = 40 V VCC = 3.3 V	-	-	1	mA

Table 42. COVINACT DC specifications	، Fable	42. COV	RACT D)C spec	ifications
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Table 43. COV	RACT AC specifications

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	T _{RISE_COVRACT}	Rise time	50 pF load, 20%-80%	-	-	1.00	μs
2	T _{FALL_COVRACT}	Fall time	50 pF load, 20%-80%	I	I	1.00	μs

17.12 SYNCBOOST converter

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq VIN_{SYNC DIS X}(min)

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1		SYNCBOOST output	Across all line and load, steady state SYS_CTL(SYBST) = 0	11.40	12	-	V
2	Vo_syncbst	voltage	Across all line and load (steady state) SYS_CTL(SYBST) = 1	14.00	14.75	-	V
3	IO_SYNCBST_VL_IH		SYS_CTL(SYBST_V) = 0 SYS_CFG(LOW_POWER_M ODE) = 0	20	-	360	mA
4	IO_SYNCBST_VL_IL	SYNCBOOST output current	SYS_CTL(SYBST_V) = 0 SYS_CFG(LOW_POWER_M ODE) = 1	20	-	240	mA
5	IO_SYNCBST_VH_IH		SYS_CTL(SYBST_V) = 1 SYS_CFG(LOW_POWER_M ODE) = 0	20	-	290	mA

Table 44. SYNCBOOST converter DC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
6	IO_SYNCBST_VH_IL	SYNCBOOST output current	SYS_CTL(SYBST_V) = 0 SYS_CFG(LOW_POWER_M ODE) = 1	20	-	190	mA
7	dV _{SR_ac}		All line, load; dt = 100 µs;	-8%	-	8%	%
8	$dV_{LR_{ac}}$	Line transient response	SYS_CTL(SYBST) = 0/1 Design Info	-8%	-	8%	%
9	R _{DSON_SYNCBST}	Power switch resistance	-	-	-	0.5	Ω
10	I _{OC_SYNCBST_HIGH}	Over current detection	SYS_CFG(LOW_POWER_ MODE) = 0	1.6	-	3.2	А
11	I _{OC_SYNCBST_LOW}	of integrated MOS	SYS_CFG(LOW_POWER_ MODE) = 1	1.5	-	2.6	А
12	I _{LKG_SYNCBOOST}	SYNCBOOST leakage	SYNCBOOST=40V Device off	-	-	10	μA
13	I _{LKG_SYNCBSTSW}	SYNCBSTSW leakage	SYNCBSTSW=40V Device off	-	-	20	μA
14	V _{SYNCBST_} OK	SYNCBOOST voltage threshold	-	9	10	11	V
15	V _{SYNCBST_OV}	SYNCBOOST Over Voltage threshold	-	22	23	24	V
16	V _{SYNCBST_DIS_TH}	Voltage difference between VIN and SYNCBOOST to deactivate the SYNC Boost regulator	V _{VIN} -VS _{YNCBOOST} Vin = 5.5 V, 12 V and 35 V	1.6	2.2	2.5	V
17	V _{SYNCBST_CLAMP_EN_TH}	Voltage difference between SYNCBSTSW and SYNCBOOST to activate the SYNC Boost CLAMP	V _{SYNCBSTSW} –V _{SYNCBOOST}	2.7	3.3	3.7	V
18	VVIN_SYNCBST_RESTART_TH	Voltage threshold to	SYS_CTL(RESTART_SYBST _SEL) = 0 Voltage threshold on VIN pin	9	-	10.3	V
19	V _{SYNCBST_RESTART_TH} V _{SYNCBST_RESTART_TH} V _{SYNCBST_RESTART_TH}	SYS_CTL(RESTART_SYBST _SEL) = 1 Voltage threshold on SYNCBOOST pin	19	20	21	V	
20	T _{JSDERSYNCBST}	Thermal shutdown	-	150	175	190	С
21	T _{HYS_TSDSYNCBST}	Thermal shutdown hysteresis	-	5	10	15	°C

Table 44, SYNCBOOST converter DC specifications	(continued)
	(continued)



L	9	6	8	0
_		v	v	v

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	F _{SW_SYNCBST}	SYNCBST switching frequency	-	1.8	1.882	2.0	MHz
2	T _{RISE_SYNCBSTSW_SLOW} T _{FALL_SYNCBSTSW_SLOW}	SYNCBSTSW	10% to 90% voltage on SYNCBSTSW VIN = VIN _{FASTSLOPE_H} Design Info	15	-	30	ns
3	T _{RISE_SYNCBSTSW_FAST} T _{FALL_SYNCBSTSW_FAST}	transition time	10% to 90% voltage on SYNCBSTSW VIN = VIN _{FASTSLOPE_L} Design Info	5	-	20	ns
4	T _{SOFTST_SYNCBST}	SYNCBST Soft- start Time	Design Info. Time from activation of SYNCBOOST when overcurrent is 40 % of ^I OC_SYNCBST_HIGH (I _{OC_SYNCBST_LOW}) to instant when overcurrent is 100% of I _{OC_SYNCBST_HIGH} (I _{OC_SYNCBST_LOW})	-	-	1075	μs
5	T _{FLT_TSD_SYNCBST}	Thermal shutdown filter time	-	-	-	10	μs
6	T _{BLK_SYNCSW}	Sync boost activation blanking time after thermal shutdown	-	-	1	-	ms

Table 46. SYNCBOOST converter external components design info

No	Symbol	Component	Conditions	Min	Тур	Max	Unit
1	L _{SYNCBST}	Inductance	Min 4.7 µH nominal	3.76	-	-	μΗ
2	ESL _{SYNCBST}	Inductance resistance	-	-	-	0.1	Ω
3	C _{BLK_SYNCBST}	Output bulk capacitance	Min 2.2 µF nominal	1.76	-	-	μF
4	ESR _{CBLK_SYNCBST}	Bulk capacitor ESR	-	-	-	50	mΩ
5	V _{FSTR}	Steering diode forward voltage	I _F = 1 A	-	-	0.5	V
6	I _{LKGSTR}	Steering diode reverse leakage	Ta = 95 °C	-	-	3	mA



17.13 SATBUCK converter

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35V, V_{SYNCBST_OK} \leq SYNCBOOST

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V	SATBUCK output	Across all line and load, steady state SAT_V = 0	6.92	7.2	7.48	V
2	VO_SATBCK	VO_SATBCK voltage Across all line and lo steady state SAT_V	Across all line and load, steady state SAT_V = 1	8.64	9	9.36	V
3	I _{O_SATBCK_VH_IH}		SAT_V =0 LOW_POWER_MODE = 0	20	-	450	mA
4	IO_SATBCK_VH_IL	SATBUCK output	SAT_V =0 LOW_POWER_MODE = 1	20	-	300	mA
5	IO_SATBCK_VL_IH	current	SAT_V =1 LOW_POWER_MODE = 0	20	-	390	mA
6	IO_SATBCK_VL_IL	:	SAT_V =1 LOW_POWER_MODE = 1	20	-	240	mA
7	dV _{SR_ac}	Line transient response	All line, load; dt=100 μs; SAT_V = 0/1 Design Info	-4%	-	4%	%
8	$\mathrm{dV}_{\mathrm{LR}_{\mathrm{ac}}}$	Load transient response	All line, load; dt=100 μs; SAT_V = 0/1 Design Info	-4%	-	4%	%
9	R _{DSON_SATBCK_HS}	High side power switch resistance	SyncBoost = 12 V and 35V	-	-	0.6	Ω
10	R _{DSON_SATBCK_LS}	Low side power switch resistance	SyncBoost = 12 V and 35V	-		0.6	Ω
11	I _{OC_HS_SATBCK_HI}	High side over	LOW_POWER_MODE = 0	0.83	1.1	1.37	А
12	I _{OC_HS_SATBCK_LO}	current detection	LOW_POWER_MODE = 1	0.53	0.7	0.9	А
13	IOCP_LS_SATBCK_LO	Low side positive	V _{SATBCKSW} ≥ 0 V _{SYNCBST} < V _{SYNCBST_RESTART_TH}	1	-	100	mA
14	I _{OCP_LS_SATBCK_HI}	detection	V _{SATBCKSW} ≥ 0 FAST SLOPE	100	240	350	mA
15	I _{OCN_LS_SATBCK_HI}	Low side negative	V _{SATBCKSW} = 0 LOW_POWER_MODE = 0	0.94	1.25	1.56	A
16	IOCN_LS_SATBCK_LO	detection	V _{SATBCKSW} = 0 LOW_POWER_MODE = 1	0.64	0.85	1.06	А
17	V _{SATBCK_OK_LOW}	SATBUCK voltage	SYS_CTL(SAT_V) = 0	6.2	6.5	6.8	V
18	V _{SATBCK_OK_HIGH}	threshold	SYS_CTL(SAT_V) = 1	7.7	8.1	8.5	V

Table 47. SATBUCK converter DC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Units
1	F _{SW_SATBCK}	SATBUCK switching frequency	-	1.8	1.882	2.0	MHz
2	T _{RISE_SATBCKSW} _SLOW TFALL_SATBCKSW _SLOW		10% to 90% voltage on SATBCKSW V _{SYNCBST} < V _{SYNCBST_RESTART_TH} Design Info	10	-	25	ns
3	T _{RISE_SATBCKSW} _FAST T _{FALL_SATBCKSW} _FAST	SATBCKSW transition time	10% to 90% voltage on SATBCKSW V _{SYNCBST} > V _{SYNCBST_RESTART_TH} Design Info	5	_	15	
4	T _{SOFTST_SATBCK}	SATBUCK soft start time	From 10% to 90%	0.50	-	2	ms

Table 48. SATBUCK converter AC specifications

Table 49. SATBUCK converter external components design info

No	Symbol	Component	Conditions	Min	Тур	Max	Unit
1	L _{SATBCK}	Inductance	Min 4.7 µH nominal	3.76	-	-	μH
2	ESR _{LSATBCK}	Inductance Resistance	-	-	-	0.25	Ω
3	C _{BLK_SATBCK}	Output Bulk Capacitance	Min 4.7 µH nominal	3	-	30	μF
4	ESR _{CBLK_SATBCK}	Bulk Capacitor ESR	-	-	-	50	mΩ

17.14 VCC regulator

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, V_{SATBCK_OK} \leq SATBUCK V_{UV_VCOREMON} \leq VCOREMON \leq V_{OV_VCOREMON}

No	Symbol	Parameter	Conditions	Min	Тур	Max	Units
1	- Vo_vcc	VCCBUCK Output	Across all line and load, steady state VCCSEL < V _{TH1_L_VCCSEL}	3.20	3.3	3.40	V
2		Voltage	Across all line and load, steady state VCCSEL = > V _{TH1_H_VCCSEL}	4.85	5	5.15	V

Table 50. VCC converter DC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Units
3	I _{O_VCC3V_НI}		VCCSEL < V _{TH1_L_VCCSEL} LOW_POWER_MODE = 0	20	-	420	mA
4	IO_VCC3V_LO	VCCBUCK output current	VCCSEL < V _{TH1_L_VCCSEL} LOW_POWER_MODE = 1	20	-	230	mA
5	I _{O_VCC5V_HI}		VCCSEL > V _{TH1_H_VCCSEL} LOW_POWER_MODE = 0	20	-	270	mA
6	dV_{SR_ac}	Line transient response	All line, load; dt=100 µs; Design Info	-4%	-	4%	%
7	$dV_{LR_{ac}}$	Load transient response	All line, load; dt=100 µs; Design Info	-4%	-	4%	%
8	R _{DSON_VCCBCK_HS}	High side power switch resistance	SATBUCK = 6.92 V and 9.36 V	-	-	0.6	Ω
9	R _{DSON_VCCBCK_LS}	Low side power switch resistance	SATBUCK = 6.92 V and 9.36 V	-	-	0.6	Ω
10	I _{OC_HS_VCCBCK_HI}	High side over current detection	SYS_CFG(LOW_POWER_ MODE) = 0	0.59	0.75	0.9	А
11	IOC_HS_VCCBCK_LO		SYS_CFG(LOW_POWER_ MODE) = 1	0.4	0.56	0.7	А
12	IOCP_LS_VCCBCK	Low side positive over current detection	V _{VCCBCKSW} > 0 SYS_CFG(LOW_POWER_ MODE) = 0 / 1	1	-	100	mA
13	IOCN_LS_VCCBCK_HI	Low side negative over	V _{VCCBCKSW} = 0 LOW_POWER_MODE = 0	0.67	0.9	1.13	А
14	IOCN_LS_VCCBCK_LO	current detection	V _{VCCBCKSW} = 0 LOW_POWER_MODE = 1	0.49	0.65	0.82	А
15	I _{OF_VCC}	Open feedback current on VCC	-	100	150	200	μA
16	VCC _{OV3V}	VCC over voltage	VCCSEL < V _{TH2_L_VCCSEL}	3.43	-	3.6	V
17	VCC _{OV5V}	detection	VCCSEL > V _{TH2_H_VCCSEL}	5.25	-	5.50	V
18	VCC _{UV3V}	VCC under voltage	VCCSEL < V _{TH2_L_VCCSEL}	3.0	-	3.17	V
19	VCC _{UV5V}	detection high	VCCSEL > V _{TH2_H_VCCSEL}	4.5	-	4.75	V
20	VCC _{UVL}	VCC under voltage detection low	-	1.8	2	2.2	V

Table 50. VCC converter DC specifications (continued)


L	9	6	8	0
_	•	9	v	v

No	Symbol	Parameter	Conditions	Min	Тур	Max	Units
1	F _{SW_VCCBCK}	VCCBUCK switching frequency	-	1.8	1.882	2.0	MHz
2	T _{RISE_} VCCBCKSW T _{FALL_} VCCBCKSW	VCCBCKSW transition time	10% to 90% voltage on VCCBCKSW Design Info	8	-	20	ns
3	T _{SOFTST_VCCBCK}	VCCBUCK soft start time	From 10% to 90%	0.5	-	2	ms
4	T _{FLT_VCCOV}	VCC over voltage detection deglitch filter time	-	27	30	33	μs
5	T _{FLT_VCCOV_RAMPUP}	VCC Over voltage detection deglitch filter time during VCC_RAMPUP state	VCC reg in VCC_RAMPUP state	1.5	2	2.5	μs
6	T _{FLT_VCCUV}	VCC under voltage detection deglitch filter time	-	27	30	33	μs
7	T _{FLT_VCCUVL}	VCC under voltage low detection deglitch filter time	-	1.5	2	2.5	μs

 Table 51. VCC converter AC specifications

Table 52. VCC converter external components des	sign info
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No	Symbol	Component	Conditions	Min	Тур	Max	Unit
1	L _{VCCBCK}	Inductance	Min 4.7 µH nominal	3.76	-	-	μH
2	ESR _{LVCCBCK}	Inductance resistance	-	-	-	0.25	Ω
3	C _{BLK_VCCBCK}	Output bulk capacitance	Min 4.7 μF nominal	3	-	30	μF
4	ESR _{CBLK_VCCBCK}	Bulk capacitor ESR	-	-	-	50	mΩ

17.15 VSF regulator

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35V, VSF + 2V \leq ERBOOST

Table 53. VSF	regulator DC	specifications
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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1			All line, load, IO_VSF up to 6mA SYS_CGF(VSF_V)= 0	18	20	22	V
2	VSF	Output voltage	All line, load, IO_VSF up to 6mA Only in case SYS_CTL(ER_BST_V)=1 SYS_CGF(VSF_V) = 1	23	25	27	V
3	I _{LIM_VSF}	Output load current limit	VSF = 0	7	10	13	mA
4	V_{DO_VSF}	Drop-out voltage	V(ERBOOST-VSF)	I	-	2	V
5	C _{VSF}	Output capacitance	Design Info	2.9	-	14	nF



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
6	I _{LKG_VSF_OFF}	VSF input leakage	Device OFF	-5	-	5	μA
7	R _{PD_VSF}	VSF pull-down resistance	Device ON VSF regulator OFF; VSF = 25V	60	125	220	kΩ
8	I _{PD_VSF}	VSF pull-down current	Device ON VSF regulator ON; Design Info	34	40	46	μA
9	I _{PD_VSF_TOT}	VSF total pull-down current	Device ON VSF regulator ON VSF = 25V SYS_CGF(VSF_V)= 1	147	230	462	μΑ

Table 53.	VSF regulator D	C specifications	(continued)
	Vol regulator D	o specifications	(continued)

Table 54. VSF regulator AC specifications

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	T _{ON_VSF}	VSF turn on time	C _{VSF} = 14 nF Measured from VSF_EN=1 to VSF inside regulation limits	-	-	100	μs

17.16 Deployment drivers

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN $_{GOOD0} \leq$ VIN \leq 35V, 6V \leq SSxy \leq 35V, SSxy - SFx \leq 25V.

Table 55.	Deployment	drivers – DC	specifications

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	I _{DEPL_LO}		R = 2 ohms Considering 9mA as not detected leakage with a 1kOhm equivalent resistance from SFx to GND	1.33	1.4	1.6	A
2	I _{DEPL_HI}	Deployment Current	R = 2 ohms, 9V ≤ SSxy Considering 13.5mA as not detected leakage with a 1kOhm equivalent resistance from SFx to GND,	1.94	1.99	2.3	А
3	I _{TH_DEPL}	Deployment Current Counter Threshold	-	I _{DEPL} x 90%	-	-	A
4	I _{OC_SR}	Low side Over Current Detection	-	2.2	3.1	4.0	А
5	I _{LIM_SR}	Low side Current Limitation	-	2.2	3.1	4.0	A



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
6	$\Delta I_{LIM_OC_SR}$	Difference between Current Limitation and OC Threshold	I _{LIM_SR} - I _{OC_SR}	0.1	-	-	mA
7	R _{DSON_HSLS}	Combined High side MOS + Low side MOS On Resistances	Ta = 95°C	-	-	2	Ω
8	I _{REV_SF}	Reverse Current on SFx	Without device malfunction ⁽¹⁾ Not to be tested in series production	-	-	-100	mA
9	I _{LKG_SS_OFF}		Device OFF SSxy ≤ 35 V SFx=SFy=0	-10	-	10	μA
10	I _{LKG_SS_ON_} 1CH		Device ON SSxy ≤ 35 V SFx = 0 SSxy Leakage current of each channel Not Tested	70	100	130	μΑ
11	I _{LKG_SS_ON}	SSxy leakage current	Device ON SSxy $\leq 35 V$ SFx = SFy = 0 Total SSxy leakage current with both x and y channels NOT armed (= 2 * 100 μ A)	140	200	260	μΑ
12	I _{LKG_SS_CH_} ARMED		Device ON SSxy ≤ 35 V SFx = 0 Total SSxy leakage current with only one channel armed (=520 + 100 µA)	450	620	850	μΑ
13	I _{LKG_SS_2CH} _ARMED		Device ON SSxy $\leq 35 V$ SFx = SFy = 0 Total SSxy leakage current with both x and y channels armed (= 2* 520 μ A) Not Tested	884	1040	1196	μΑ

Table 55. Deployment drivers – DC specifications (continued)



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
14	I _{LKG_SF_ON_} 0V		Device ON, SYNCBOOST = SSxy = 35V, SFx = 0V	-5	-	5	μΑ
15	I _{LKG_SF_ON_} 35V		Device ON, SYNCBOOST = SSxy = 35V, SFx = 35V	-5	-	50	μΑ
16	ILKG_SF_OFF _0V	SF Leakage Current	Device OFF SYNCBOOST = open, SSxy = open but all SSxy pins connected, SFx = 0V	-5	-	5	μΑ
17	I _{LKG_SF_OFF} 35V		Device OFF SYNCBOOST = open, SSxy = open but all SSxy pins connected, SFx = 35V	-5	-	50	μΑ
18	I _{LKG_SR_ON}		Device ON, SYNCBOOST = SSxy = 35V, SRx = 0V-35	-	-	50	μΑ
19		SR Leakage Current	DEVICE OFF, SYNCBOOST = open, SSxy = open but all SSxy pins connected, SRx pull down current OFF SRx=0V-20V	-	-	50	μΑ
20	ILKG_SR_OFF		DEVICE OFF, SYNCBOOST = open, SSxy = open but all SSxy pins connected, SRx pull down current OFF SRx=35V	-	-	30	mA
21	V _{SR_CLAMP}	SR voltage clamp	-	35	-	40	V
22	L _{DEPL}	Load Inductance	Maximum load inductance Design Info ⁽²⁾	0	-	56	μH
23	C _{SFx}	Load Canacitance	Maximum capacitance to GND	13	-	455	nF
24	C _{SRx}	C _{SRx} Design Info	13	-	455	nF	



No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
25	C _{SSxy}	SSxy Capacitance	Maximum capacitance to GND connected directly to SSxy pin Design Information	-	-	10	nF
26	R _{SFLx}	Load Impedance	Design Info	-	-	6.5	Ω
27		Wire Length	Squib/pyroswitch Loops containing a clock spring shall be limited to a maximum length of 3m	1	-	10	m
28	R _{Wirex}	Wire Resistance	Design Info	16.8	-	63.4	mΩ/ m
29	L _{Wirex}	Wire Inductance	Design Info	0.6	-	1.8	μΗ/ m
30	R _{CSx}	Clock Spring Resistance	Maximum number of clock springs is 3 for any IC Design Info	0	-	0.7	Ω
31	L _{CSx}	Clock Spring Inductance	Design Info	0	-	42.9	μH
32	k _{L_CS1 –} L_CS2	Clock Spring Coupling	Design Info	0.739	-	0.903	-
33	L _{EMI}	Squib/pyroswitch EMI protection	Design Info	0	-	7.7	μH

Table 55	Denloy	mont dri	vors – F)C sn	ocifications	(continued)
Table 55.	Depioy	ment un	vers – L	JC Sp	ecifications	s (continueu)

1. In case of an unsupplied device and shorted deployment pins (e.g. to battery voltage), the dynamic reverse current through the high side power stage depends on C_{SSxy} .

2. L_{DEPL} could be calculated in the following way:

Non-Clock Spring Loops: $L_{DEPL}(max) = L_{Wire}(10m*2) + L_{EMI} = (3.6uH/m*10m) + 7.7uH = 43.7uH$

 $\begin{array}{l} \textbf{Clock Spring Loops: } L_{Wire}(3m^{*}2) + 2*L_{CSx} + L_{EMI} \text{-} (2*k_{L-CX}*SQRT(L_CS1*L_CS2)) = = (3.6uH/m*3m) + 2*42.9uH + 7.7uH \text{-} (2*0.739*42.9uH) = 40.9uHClock Spring Loops with short to ground \\ L_{DEPL}(max) = L_{Wire}(3m) + L_{CSx} + L_{EMI} = (1.8uH/m*3m) + 42.9uH + 7.7uH = 56uH. \end{array}$





Figure 73. Deployment drivers diagram

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1				-			
2			DCR_x(Dep_Current) =	x(Depl		_x(D	
3	T _{DEPL}	Deployment time	I _{DEPL_LO} ≥1.209A rising to 1.209A falling; T _{DEPL} = DCR_x(Deploy_Time)* T _{DEP_TIME_RES} - TDEL_IDEP	oy_Ti me)* TDEP _TIM E_RE S - 65 -	-	eploy _Tim e)* T _{DEP} _TIME _RES -	ms
4	T _{DEP_TIME_RES}	DCR_x Deploy_Time resolution	-	-	$\frac{1024}{f_{osc}}$	-	μs
5	T _{DEP_CC_RES}	Deployment current counter resolution	-	-	256 f _{osc}	-	μs
6	T _{RISE_IDEPL}	Rise time 10% - 90% of I _{DEPL}	2000 - 25 V	-	-	32	μs
7	T _{DEL_IDEP}	Delay time SPI_CS to 90% I _{DEPL}	$R_{SQ} = 2.2 \text{ ohm},$ C = 22 pE $L = 44 uH$	-	-	65	μs
8	T _{FALL_IDEPL}	Fall time 90% - 10% I _{DEPL}	U – 22 NF L = 44 μΠ	-	-	32	μs
9	T _{DEL_SD_LS}	Low side shutdown delay time (with respect to high-side deactivation)	-	50	-	-	μs

Table 56. Deployment drivers – AC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
10	T _{flt_ilim_ls}	Low side overcurrent to low side deactivation deglitch time in short to battery condition	-	80	100	120	μs
11	T _{FLT_OS_LS}	Low side overcurrent to high side deactivation deglitch time in case of intermittent open to squib/pyroswitch condition	-	-	-	20	μs
12	T _{OFF_OS_HS}	High side OFF time in case of intermittent open to squib/pyroswitch condition	-	4	-	12	μs

Table 56. Deployment drivers – AC specifications

17.17 Deployment driver diagnostic

17.17.1 Squib/pyroswitch resistance measurement

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0}(max) \leq VIN \leq 35 V, 6 V \leq SSxy \leq 35 V, 7 V \leq SYNCBOOST \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	R _{SQ_RANGE_1}	Squib/pyroswitch resistance range 1	LPDIAGREQ(ISRC_CURR_ SEL) = 0	0	-	10.0	Ω
2	R _{SQ_RANGE 2}	Squib/pyroswitch resistance range 2	LPDIAGREQ(ISRC_CURR_ 0 -		-	50.0	Ω
3	G _{RSQ}	Squib/pyroswitch resistance measurement Differential amplifier gain	$V_{OUT_{RSQ}} = G_{RSQ} \times [(V_{SF} - V_{SR})] + V_{off_{RSQ}}$ -2		5.2	+2%	V/V
4	V _{off_RSQ}	Squib/pyroswitch resistance measurement Differential amplifier offset	V _{OUT_RSQ} = G _{RSQ} x [(V _{SF} – V _{SR})] + V _{off_RSQ}	200	-	400	mV
5	I _{SRC_HI_SF} I _{SRC_HI_SR}	Squib/pyroswitch resistance measurement High current source	LPDIAGREQ(ISRC_CURR_ SEL) = 0 LPDIAGREQ(ISRC) = '01' or '10' SyncBoost = 11.5 V and 35 V	-5%	40	+5%	mA
6	I _{SRC_LO_SF} I _{SRC_LO_SR}	Squib/pyroswitch resistance measurement Low current source	LPDIAGREQ(ISRC_CURR_ SEL) = 1 LPDIAGREQ(ISRC) ='01' or '10' SyncBoost = 11.5 V and 35 V	-10%	8	+10%	mA
7	I _{SRC_DELTA}	Squib/pyroswitch Resistance Measurement Delta Current Source	I _{SRC_HI_x} - I _{SRC_LO_x}	-5%	32	+5%	mA

Table 57. Deployment drivers diagnostics - Squib/pyroswitch resistance measurement



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
8	SR _{ISRC}	Squib/pyroswitch resistance measurement current source slew-rate	-	3	7.5	12	mA/µs
9	V _{SRx_RM}	SRx voltage during resistance measurement	LPDIAGREQ(ISRC)="01" or "10" LPDIAGREQ(ISINK)=1	0.4	0.7	1.2	V
10	I _{SINK_HI_SR}	SRx current sink limit high	LPDIAGREQ(ISRC_CURR_ SEL) = 0 LPDIAGREQ(ISINK) = 1	50	75	100	mA
11	I _{SINK_LO_SR}	SRx current sink limit low	LPDIAGREQ(ISRC_CURR_ SEL) = 1 LPDIAGREQ(ISINK) = 1	10	17.5	25	mA
12	I _{PD_SR_L}	SRx current null down	SYS_CTL(PD&VRCM_SEL) = 0	0.7	1	1.3	mA
13	I _{PD_SR_H}		SYS_CTL(PD&VRCM_SEL) = 1	4.5	6	7.5	mA
14	$R_{LKG}SF}$	SFx leakage resistance	Design info	1	-	-	kΩ
15	V_{LKG_SF}	SFx leakage voltage source	Design info	-1	-	18	V
16	R _{SQ_ACC}	Squib/pyroswitch resistance measurement accuracy	After software calculation All errors included R_{SQ} between 1.0 Ω and 10.0 Ω With High Current Source (40 mA)	-8%	-	+8	%
17	-	EMI input low-pass filter	Design Info	50	-	100	kHz

Table 57 Deployment drivers disgnastics	Sauih/nuraaujitah raaja	tonoo mooouromont
Table 57. Deployment unvers diagnostics	- Squib/pyroswitch resis	stance measurement



17.17.2 Squib/pyroswitch leakage test (VRCM)

All electrical characteristics are valid for the following conditions unless otherwise noted: -40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1		Output Voltage on SF or	I _{OUT} = 0 mA	-10%	2.5	+10%	V
2	V _{OUT_VRCM}	SR pins during Leakage test	I _{OUT} = 6.6 mA	1.9	-	2.5	V
3	R _{LKG_GSG_TH}		Leakage detected if R _{LKG_GSG} ≤ 1 kΩ and not detected if R _{LKG_GSG} ≥ 10 kΩ Design Info	1	-	10	kΩ
4a	ILKG_GSQ_TH_L	Detection threshold, leakage to GND	Equivalent to resistance range SYS_CTL(PD&VRCM_SEL) = 0 -25 °C \leq T _j \leq +150 °C guaranteed by design/characterization	-15.5 %	450	+15.5 %	μA
4b			Equivalent to resistance range SYS_CTL(PD&VRCM_SEL) = 0 -40 °C $\leq T_j \leq +150$ °C	-17%	450	+15.5 %	μA
5	I _{LKG_GSQ_TH_H}		SYS_CTL(PD&VRCM_SEL) = 1	-15%	2	15%	mA
6	T _{FLT_LKG}	Leakage to GND deglitch filter time	-	17	20	23	μs
7	R _{LKG_BSQ_TH}		Leakage detected if R _{LKG_GSG} ≤ 1 kΩ and not detected if R _{LKG_GSG} ≥ 10 kΩ Design Info	1	-	10	kΩ
8a	I _{LKG_BSQ_TH}	Detection threshold, leakage to battery	Equivalent to resistance range -25 °C $\leq T_j \leq$ +150 °C guaranteed by design/characterization	-12%	1.8	+15%	mA
8b			-40 °C ≤ T _j ≤ +150 °C	-17%	1.8	+15%	mA
9	T _{FLT_LKG}	Leakage to BAT deglitch filter time	-	17	20	23	μs
10	ILIM_VRCM_SRC	VRCM current limitation	-	-20	-	-10	mA
11	ILIM_VRCM_SINK		-	10	-	20	mA
12	V _{SHIFT}	External ground or battery shift	Design Info	-1	-	+1	V

Table	58	Squib/r	vroswitch	Leakage	Test	
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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
13	$R_{SQ_LOW_TH}$		Design Info	200	-	500	Ω
14a	I _{RSQ_LOW_TH}	Detection threshold for "resistance too low"	Equivalent to resistance range -25 °C \leq T _j \leq +150 °C guaranteed by design/characterization	-12%	6	+12%	mA
14b			-40 °C ≤ T _j ≤ +150 °C	-17%	6	+12%	mA
15	T _{FLT_RLOW}	"Resistance too low" deglitch filter time	-	12	15	18	μs
16	R _{SQ_HIGH}	Detection Threshold for	Design Info	2	-	5	kΩ
17	I _{RSQ_HIGH}	"resistance too high"	Equivalent to resistance range	-17%	700	+17%	μA
18	T _{FLT_RHIGH}	"Resistance too high" deglitch filter time	-	12	15	18	μs
19	T _{delay_STG_sele} ction	Time needed to change the VRCM STG thresholds (450 μ A-to-2 mA or 2 mA- to-450 μ A)	guaranteed by design	-	-	2	μs

Table 58. Squib/pyroswitch Leakage Test (VRCM)

17.17.3 High/low side FET test

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0}(max) \leq VIN \leq 35 V, 6 V \leq SSxy \leq 35 V, 7 V \leq SYNCBOOST \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	I _{HS_FET_TH}	Detection threshold high side FET test	-	-12%	1.8	+12%	mA
2	I _{LS_FET_TH}	Detection threshold	SYS_CTL(PD&VRCM_SEL) = 0	-15.5%	450	+15.5%	μA
3	ILS_FET_TH_HIGH	low side FET test	SYS_CTL(PD&VRCM_SEL) = 1	-15%	2	+15%	mA
4	E _{FET_TEST}	Energy transferred to squib/pyroswitch during HS/LS FET tests	Design Info	-	-	170	μJ
5	T _{DRIVER_DIS}	Driver Disable time	Guarantee by design	-	-	1.5	μs
6	T _{TOT_FETTEST_A} CTIVE	Total FET test activation time in case of no fault condition	Guarantee by design	-	-	4	μs
7	T _{FETTIMEOUT}	HS/LS FET test timeout	-	190	200	210	μs

Table 59. High/low side FET test



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
8	T _{FLT_LKGB_FT}	Deglitch filter time during FET test on I _{HS_FET_TH} / I _{LS_FET_TH} current thresholds	-	0.8	1	1.2	μs
9	I _{LIM_HS_FET}	HS FET current in HS driver diagnostics	Not tested, see item # 1 in errata sheet section	40	50	60	mA
10	SGxy _{OPEN}	Squib/pyroswitch open ground detection	GNDSUBx as ground reference	300	450	600	mV
11	T _{FLT_SGOPEN}	Squib/pyroswitch open ground detection filter time	-	46	50	54	μs

Table 59. High/low side FET test (continued)

17.17.4 Deployment timer test

All electrical characteristics are valid for the following conditions unless otherwise noted:

-40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V.

Table 60. Deploy	ment timer test	t - AC specifications	

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	t _{PULSE_PERIOD}	Deployment timer pulse test period time		7	8	9	ms
2	I _{PULSE_HIGH}	Deployment timer pulse test high time	SYSDIAGREQ(DSTEST)=PULSE	-	DCR_x(Deploy_ Time)* T _{DEP_TIM} E_RES	-	μs

17.18 Remote sensor interface

All electrical characteristics are valid for the following conditions unless otherwise noted:

40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, V_{SATBUCK}(min) \leq VSATBUCK,

 $V_{SYNCBOOST}(min) \leq VSYNCBOOST$

17.18.1 PSI-5 interface

Table (61. PSI-5	satellite	transceiver	- DC	specifications
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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	I _{RSU}	Interface quiescent current	-	-35	-	-4	mA
2	V _{RSU_MAX}	Max. output voltage excluding sync. pulse	(internal regulation, VSATBUCK = VSYNCBOOST)	-	-	11	V



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
3	V _{RSU_SYNC_MAX}	Max. output voltage including sync. pulse	(internal regulation, VSYNCBOOST = VIN) Syncboost = 12 V, 14.75 V, 18 V and 35 V	-	-	16.5	V
4	R _{RSU}	RSU output resistance	From I _{RSU} = -4 mA to -65 mA	3	-	9.5	Ω
5	I _{STB_TH}	Static reverse current into SATBUCK or SYNCBOOST pin (V _{SUPPLY})	V _{RSUx} > V _{SUPPLY} + V _{RSU_STB}	0.0	-	10	mA
6	V _{RSU_STB}	Output short to battery threshold	-	10.0	-	100	mV
7	I _{OCTH_PSI5}	Over current detection threshold	Interface disabled after T _{FLT_OCTH_PSI5}	-120	-	-66	mA
8	I _{LIM_PSI5}	Output current limit	I _{RSUx}	-130	-	-80	mA
9	$\Delta I_{\text{LIM}OC_{PSI5}}$	Difference between current limitation and OC threshold	ABS(I _{LIM_RSU}) - ABS(I _{OCTH_RSU})	10	-	-	mA
10	I _{BO}	Base current	Default value	-15%	-15	+15%	mA
11	I _{LKGG}	Trigger point for fault	To ground; detected by I_B	-50.4	-42	-35	mA
12	I _{LKGB}	current detection	To battery; detected by I_B	-3.5	-	-1	
13	I _{OL}	Output open load detection threshold	V _{RSUx} = open	I _{LKGB} (min)	-	I _{LKGB} (max)	mA
14	DAC _{RES}	DAC resolution	-	-	10	-	Bit
15	I _{LSB}	LSB current	Design Info	-	93.75	-	μA
16	V _{t2}	Sync pulse amplitude	I _{RSU} = 4 - 35 mA Referred to V _{RSUx} voltage before sync pulse Syncboost = 12 V, 14.75 V, 18 V and 35 V	3.8	-	-	V
17	V _{SYNCDROP}	Sync drop-out voltage	V _{SYNCBOOST} - V _{RSUx}	1	-	-	V
18	I _{LIM_SYNC_LS}	Sync pulse current limit (LS driver)	-	50	-	80	mA
19	I _{LIM_SYNC}	Static current limitation for each transceiver output RSUx	During sync pulse generator V _{RSUx=GND}	-240	-	-120	mA
20	C ₁	Capacitor on RSUx Regulator	22 nF nominal Design Info	13	-	-	nF
21	R _{E2}	RSU damping resistance	Design info	-	2.5	-	Ω
22	C ₂	ECU pin capacitance	5 nF nominal Design Information, not tested	4	-	6	nF
23	-	Total number of sensors connected to bus	Design info	1	-	3	-

Table 61, PSI-5 satellite transceiver - DC specifications	(continued)
	(00



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	T _{Bit_125k}	Bit time (125 kbps mode)	At the sensor connector	7.6	8	8.4	μs
2	T _{Bit_189k}	Bit time (189 kbps mode)	At the sensor connector	5	5.3	5.6	μs
3	T _{FLT_OCTH_PSI5}	Over Current Detection deglitch filter time	Normal operation	500	-	600	μs
4	т	Over Current	At interface power on (BLKTxSEL = 0)	4.6	-	5.4	ms
5	BLK_OCTH_PSI5	Blanking Time	At interface power on (BLKTxSEL = 1)	9.4	-	10.8	ms
6	Т _{STBTH}	Reverse Battery Blocking Enable Time	-	12	-	16	μs
7	t ₀	Reference time	@0.5 V on top of V(RSUx) Syncboost = 12 V, 14.75 V, 18 V and 35 V	-	0	-	-
8	t ₁	Start delay time	From t0 to SATSYNC Syncboost = 12 V, 14.75 V, 18 V and 35 V	-3	-	-	μs
9	t ₂	Sync signal sustain start	@ VRSU+3.8 V relative to t ₀ Syncboost = 12 V, 14.75 V, 18 V and 35 V	-	-	7	μs
10	SR _{RISE_RSU}	Sync slope rising slew rate		0.43	-	1.5	V/µs
11	SR _{FALL_RSU}	Sync slope falling slew rate		-1.5	-	-	V/µs
12	t ₃	Sync signal sustain time	Design Info	16	-	-	μs
13	t ₄	Discharge time limit	Design Info	-	-	35	μs
14	T _{BLANK}	Decoder blanking time (decoding disabled)	Design Info	-	-	42	μs
15	T _{SYNC}	Time between two sync pulses	Design Info	400	500	-	μs
16	T _{FLT_PSI5_HF}	PSI5 Deglitch filter time	F = 189 kbaud Configurable by SPI (4bits)	1	-	2	μs
17	T _{FLT_PSI5_LF}	PSI5 Deglitch filter time	F = 125 kbaud Configurable by SPI (4bits)	1.5	-	2.5	μs

Table 62. PSI-5 satellite transceiver - AC specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
18			Related to t0, Sensor Side, P8P-500-3L	44	-	58.6	μs
19		Message start	Related to t0, Sensor Side, P8P-500-3H	44	-	58.6	μs
20	T_ES_1, T_LS_1		Related to t0, Sensor Side, P8P-500-4H	44	-	58.6	μs
21		time, Slot 1	Related to t0, Sensor Side, P10P-500-3L	44	-	58.6	μs
22			Related to t0, Sensor Side, P10P-500-3H	44	-	58.6	μs
23			Related to t0, Sensor Side, P10P-500-4H	44	-	58.6	μs
24			Related to t0, Sensor Side, P8P-500-3L	181.3	-	210.4	μs
25			Related to t0, Sensor Side, P8P-500-3H	181.3	-	210.4	μs
26		Message start	Related to t0, Sensor Side, P8P-500-4H	139.5	-	164.2	μs
27	_ES_2, _LS_2	time, Slot 2	Related to t0, Sensor Side, P10P-500-3L	181.3	-	210.4	μs
28			Related to t0, Sensor Side, P10P-500-3H	181.3	-	210.4	μs
29			Related to t0, Sensor Side, P10P-500-4H	139.5	-	164.2	μs
30		ES_3, T_LS_3 Message start time, Slot 3	Related to t0, Sensor Side, P8P-500-3L	328.9	-	373.5	μs
31			Related to t0, Sensor Side, P8P-500-3H	328.9	-	373.5	μs
32			Related to t0, Sensor Side, P8P-500-4H	245.5	-	281.3	μs
33	_ES_3, _LS_3		Related to t0, Sensor Side, P10P-500-3L	328.9	-	373.5	μs
34			Related to t0, Sensor Side, P10P-500-3H	328.9	-	373.5	μs
35			Related to t0, Sensor Side, P10P-500-4H	245.5	-	281.3	μs
36			Related to t _{0,} Sensor Side, P8P-500-3L	107.2	-	127.6	μs
37			Related to t _{0,} Sensor Side, P8P-500-3H	82	-	99.4	μs
38	Ŧ	Slot 1 End valid	Related to t _{0,} Sensor Side, P8P-500-4H	82	-	99.4	μs
39	^I _s1_end_open	opening time	Related to t _{0,} Sensor Side, P10P-500-3L	121	-	142.8	μs
40			Related to t _{0,} Sensor Side, P10P-500-3H	91	-	109.4	μs
41			Related to t _{0,} Sensor Side, P10P-500-4H	91	-	109.4	μs
42			Related to t0, Sensor Side, P8P-500-3L	151	-	174.6	μs
43	-		Related to t0, Sensor Side, P8P-500-3H	119.8	-	139.9	μs
44		Slot 1 End valid	Related to t0, Sensor Side, P8P-500-4H	119.8	-	139.9	μs
45	I_s1_end_closure	vindow, closure time	Related to t0, Sensor Side, P10P-500-3L	167.8	-	193	μs
46			Related to t0, Sensor Side, P10P-500-3H	131	-	152.5	μs
47	-		Related to t0, Sensor Side, P10P-500-4H	131	-	152.5	μs

 Table 62. PSI-5 satellite transceiver - AC specifications (continued)



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
48			Related to t0, Sensor Side, P8P-500-3L	231.6	-	264.9	μs
49			Related to t0, Sensor Side, P8P-500-3H	206	-	236.7	μs
50	т.	Slot 2 End valid	Related to t0, Sensor Side, P8P-500-4H	168	-	194.9	μs
51	^I _s2_end_open	opening time	Related to t0, Sensor Side, P10P-500-3L	245.4	-	280.1	μs
52			Related to t0, Sensor Side, P10P-500-3H	215.5	-	246.7	μs
53			Related to t0, Sensor Side, P10P-500-4H	177.5	-	205	μs
54			Related to t0, Sensor Side, P8P-500-3L	302.8	-	342.1	μs
55			Related to t0, Sensor Side, P8P-500-3H	271.6	-	308	μs
56	Ŧ	Slot 2 End valid	Related to t0, Sensor Side, P8P-500-4H	225.4	-	256.5	μs
57	^I _s2_end_closure	closure time	Related to t0, Sensor Side, P10P-500-3L	319.6	-	360.5	μs
58			Related to t0, Sensor Side, P10P-500-3H	282.7	-	320	μs
59			Related to t0, Sensor Side, P10P-500-4H	236.5	-	269	μs
60			Related to t0, Sensor Side, P8P-500-3L	365.1	-	412.5	μs
61		T_s3_end_open Slot 3 End valid window, opening time	Related to t0, Sensor Side, P8P-500-3H	339.4	-	384.3	μs
62	т		Related to t0, Sensor Side, P8P-500-4H	263.9	-	300.9	μs
63	^I _s3_end_open		Related to t0, Sensor Side, P10P-500-3L	378.9	-	427.7	μs
64			Related to t0, Sensor Side, P10P-500-3H	348.5	-	394.3	μs
65			Related to t0, Sensor Side, P10P-500-4H	273	-	311	μs
66			Related to t0, Sensor Side, P8P-500-3L	465.9	-	522.7	μs
67			Related to t0, Sensor Side, P8P-500-3H	434.7	-	488	μs
68	-	Slot 3 End valid	Related to t0, Sensor Side, P8P-500-4H	342.5	-	386.1	μs
69	^I _s3_end_closure	closure time	Related to t0, Sensor Side, P10P-500-3L	482.7	-	541.1	μs
70			Related to t0, Sensor Side, P10P-500-3H	445.9	-	500	μs
71			Related to t0, Sensor Side, P10P-500-4H	353.7	-	398.2	μs
72	T _{SYNC_DLY_SHORT}	Sync Pulse Start	SYS_CFG(RSU_SYNCPULSE_SHIFT _CONF)=0 Related to Start of Sync Pulse on ch. N-1	-	$\frac{160}{f_{osc}}$	-	μs
73	T _{SYNC_DLY_LONG}	Delay	SYS_CFG(RSU_SYNCPULSE_SHIFT _CONF)=1 Related to Start of Sync Pulse on ch. N-1	-	$\frac{288}{f_{osc}}$	-	μs
74	T _{FLT_OPEN_RSU}	Open Detection Deglitch Filter Time	-	10	-	15	μs
75	T _{FLT_LKG_RSU}	Leakage Deglitch Filter Time	-	10	-	15	μs

Table 62. PSI-5 satellite transceiver - AC specifications (continued)



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
76	T _{WRITE_EN_DELAY_LF}	Data register	Design Info F = 125 kbaud Calculated from transition of last sensor bit to when data is available in SPI register	-	-	19	μs
77	T _{WRITE_EN_DELAY_HF}	write delay	Design Info F = 189 kbaud Calculated from transition of last sensor bit to when data is available in SPI register	-	-	14	μs

Table 62. PSI-5 satellite transceiver - AC specifications (continued)

17.18.2 WSS interface

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	C ₁	RSU load capacitance	10nF nominal, Design Info	6	-	-	nF
2	V _{RSU_MAX}	RSUx Max output voltage	(internal regulation, VSATBUCK=VSYNCBOOST)	-	-	11	V
3	R _{RSU}	Output resistance	From I _{RSU} =-4mA to -35mA	4	-	12	Ω
4	I _{BO}	Base Current	Auto Adaptive option (default value)	+15%	-7	-15%	mA
5a	I _{TH1}	7mA / 14mA detection	Fixed threshold option -25 °C ≤ T _j ≤ +150 °C guaranteed by design/characterization	+15%	-9.8	-15%	mA
5b			Fixed threshold option -40 °C ≤ T _j ≤ +150 °C	+20%	-9.8	-20%	mA
6	I _{TH2}	14mA / 28mA detection	Fixed threshold option	+15%	-19.6	-15%	mA
7a	I _{THOPEN}	Open sensor detection	RSUx OPEN -25 °C ≤ T _j ≤ +150 °C guaranteed by design/characterization	-4.5	-	-0.2	mA
7b			RSUx OPEN -40 °C ≤ T _j ≤ +150 °C	-5.5	-	0	mA
8	I _{THGND}	Leakage to GND threshold	V _{RSUx} = GND	13.2	15	17.1	mA
9	I _{OCTH_WSS}	Over Current Detection Threshold	output disabled after T _{FLT_OCTH_} WSS	-65	-	-38	mA
10	I _{LIMTH_WSS}	Output Current Limit	-	-65	-	-40	mA
11	ΔI _{LIM_OC_WSS}	Difference between Current Limitation and OC Threshold	I _{LIM_RSU} - I _{OC_RSU}	1	-	-	mA

Table 63.	WSS	sensor	- DC	specifications
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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
12	V _{RSU_STB}	Output Short to Battery Threshold		10	-	100	mV
13	I _{STBTH}	Static reverse current into SATBUCK or SYNCBOOST pin (V_supply)	V _{RSUx} > V_supply + V _{RSUxSTB}	0.0	-	10	mA
14	V _{OH_WS}	WSx Output Voltage	I _{LOAD} = -1mA	VCC- 0.5	-	VCC	V
15	V _{OL_WS}		I _{LOAD} = 1mA	-	-	0.4	V
16	I _{LKG_WS}	WSx Output Leakage	Tri-state leakage	-10	-	10	μA

Table 63. WSS sensor - DC specifications (continued)

Table 64. WSS sensor - AC specifications

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	T _{FLT_WS}	WS Deglitch filter time	Configurable by SPI (4bits)	8	-	15.6	μs
2	-	Latency time	between receiving sensor data @ RSUx pin and reaching threshold high level of WSx pin (trigger point 80% of RSUx modulated current)	-	-	2 + T _{FLT_} ws	μs
3	-	Jitter on Latency time	Design Info	-	-	125	ns
4	T _{FLT_OCTH_WS} S	Over Current Detection Deglitch filter time	-	500	-	600	μs
5	T _{FLT_OPEN_RS} U	Open Detection Deglitch Filter Time	-	10	-	15	μs
6	T _{FLT_LKG_RSU}	Leakage Deglitch Filter Time	-	10	-	15	μs
7	T _{STANDSTILL_T} H_L	Pulse duration to assert	-	1.13	-	-	ms
8	T _{STANDSTILL_T} H_H	standstill bit thresholds	-		-	2.55	ms



17.19 DC sensor interface

All electrical characteristics are valid for the following conditions unless otherwise noted: 40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, 8.5 V \leq SYNCBOOST \leq 35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V _{OUT_DCSREG}	DCS output voltage regulation mode	DCS regulator enabled SyncBoost = 11.5 V and 35 V	-10%	6.25	+10%	V
2	I _{LIM_DCSREG}	DCS current limitation regulation mode	DCS regulator enabled SyncBoost = 11.5 V and 35 V	24	27	30	mA
3	V _{DCS_RANGE1}	DCS voltage measurement range1	First voltage measurement (V _{DCS_MEAS1}) to compensate external ground shift and internal offset	-1	-	1.4	v
4	V _{DCS_ACC1}	DCS voltage measurement accuracy 1	V _{DCS} = V _{DCS_RANGE1} Included ADC error	-15	-	15	%
5	V _{DCS_RANGE2}	DCS voltage measurement range 2	-	1.5	-	10	V
6	V _{DCS_ACC2}	DCS voltage measurement accuracy 2	V _{DCS} = V _{DCS_RANGE2} Included ADC error	-8	-	+8	%
7	IDCS_RANGE1	DCS Current measurement range 1	-	1	-	2	mA
8	I _{DCS_ACC1}	DCS current measurement accuracy 1	I _{DCS} = I _{DCS_RANGE1} Included ADC error	-30	-	+30	%
9	IDCS_RANGE2	DCS current measurement range 2	-	2	-	22	mA
10	I _{DCS_ACC2}	DCS current measurement accuracy 2	I _{DCS} = I _{DCS_RANGE2} Included ADC error	-12	-	+12	%
11	I _{DCS_RANGE3}	DCS current measurement range 3	Regulator in current limitation	-	I _{LIM_D} CSREG	-	mA
12	I _{DCS_ACC3}	DCS Current measurement accuracy 3	V _{DCS} = 0V Included ADC error	-12	-	+12	%
13	R _{DCS_RANGE}	DCS resistance measurement range	Design info	65	-	3000	Ω
14	R _{DCS_ACC}	Accuracy of digital resistance measurement	Performing voltage measurements 1 and 2 After software calculation all errors included	-15	-	15	%
15	I _{PD_DCS}	DCSx current pull down	V _{DCS} = 1.5 V	130	200	260	μA
16	R _{PD_DCS}	DCSx resistance pull down	Device active, DCSx current pull down disabled	90	150	210	kΩ

Table 65. DC Sensor interface specifications



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
17	I _{PD_DCS_TOT}	DCSx total current pull down	$I_{PD_DCS_TOT} = I_{PD_DCS} + R_{PD_DCS}$ $V_{DCS} = 6.5 V$	160	240	330	μA
18	C _{DCS}	Output capacitance	Design Info	10	-	-	nF
19	I _{REF_DCS}	Internal Current Reference for DCS Current Measurement	-	-5%	300	+5%	μA
20	Ratio_VDCS	Divider ratio for DCSx voltage measurement	-	-3%	7.125	+3%	V/V
21	V _{OFF_DCS}	DCSx internal offset during voltage measurement	-	0.35	0.375	0.39	V

Table 65. DC Sensor interface specifications

17.20 Safing engine

All electrical characteristics are valid for the following conditions unless otherwise noted:

40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35 V, VCCx(min) \leq VCCx \leq VCCx(max), VCC = 3.3 V or 5 V.

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	V _{TH_H_ACL}	ACL input voltage	-	2.33	-	2.5	V
2	V _{TH_L_ACL}	thresholds	-	1.58	-	1.71	V
3	V _{HYS_ACI}	ACL hysteresis	-	0.6	0.75	0.9	V
4	R _{PD_ACL}	ACL pull down resistance	V _{ACL} = 3.3V	150	210	270	kΩ
5	V _{OH_ARM}	ARMx output high voltage	I _{LOAD} = -0.5 mA internal safing selected	VCC-0.60	-	VCC	۷
6	V _{OL_ARM}	ARMx output low voltage	I _{LOAD} = 2.0 mA internal safing selected	0	-	0.4	V
7	R _{PD_ARM}	ARMx pull down resistance	-	65	100	135	kΩ
8	V _{IH_ARM}	ARMx high level input voltage	-	2	-	-	V
9	V _{IL_ARM}	ARMx low level input voltage	-	-	-	0.8	V
10	R _{PD_ARMx, x=1,2,3}	ARM1,2,3 pull down resistor	External safing selected	60	100	140	kΩ
11	I _{PU_ARM4}	ARM4 pull up current	ARM4 = 0V external safing selected	-100	-75	-50	μA
12	V _{OH_PSINHB}	PSINHB output high voltage	I _{LOAD} = -0.5 mA Internal safing selected	VCC-0.60	-	VCC	V

Table 66. Arming In	terface – DC	specificatio	ons



No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
13	V _{OL_PSINHB}	PSINHB output low voltage	I _{LOAD} = 2.0 mA Internal safing selected	0	-	0.4	V
14	R _{PD_PSINHB}	PSINHB pull down resistance	-	65	100	135	kΩ
15	V _{IH_PSINHB}	PSINHB high level input voltage	-	2	-	-	V
16	V _{IL_PSINHB}	PSINHB low level input voltage	-	-	-	0.8	V
17	V _{IH_SAF_CSx}	SAF_CSx high level input voltage	-	2	-	-	V
18	V _{IL_SAF_CSx}	SAF_CSx low level input voltage	-	-	-	0.8	
19	I _{PU_SAF_CSx}	SAF_CSx pull up current	SAF_CSx = 0 V to V _{IH_SAF_CSx(min)}	-70	-45	-20	μA

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Table 67. Arming interface – AC specifications

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
1	T _{ARM}	Sensor sampling period	-	475	500	525	μs
2	T _{ACL_HI}	ACL pariad time thresholds	-	213	-	237	ms
3	T _{ACL_LO}	ACE period time timesholds	-	168	-	187	ms
4	T _{ON_ACL_HI}	ACL on-time thresholds	-	154	-	171	ms
5	T _{ON_ACL_LO}		-	114	-	126	ms
6	T _{VALID_ACL}	Scrap validation T _{ACL} and T _{ON_ACL} valid	-	3	-	-	cycles
7	T _{INVALID_ACL}	Scrap invalid T _{ACL} invalid	-	2	-	-	cycles
8	T _{SCRAP_TIMEOUT}	Scrap timeout timer	-	520	550	580	μs
9	f _{SCRAP_SEED}	Scrap seed counter frequency	-	-	$\frac{f_{\rm osc}}{16}$	-	MHz
10			-	-	-	0	ms
11	т	Arming enable pulse stretch	-	30	32	34	ms
12	PULSE_STRECH	time	-	242	-	270	ms
13			-	1934	-	2162	ms
14	T _{RISE_ARM}	ARMx rise time		-	-	1.00	μs
15	T _{FALL_ARM}	ARMx fall time	50 pF load, 20% to 80%	-	-	1.00	μs
16	T _{RISE_PSINHB}	PSINHB rise time	internal safing selected	-	-	1.00	μs
17	T _{FALL_PSINHB}	PSINHB fall time		-	-	1.00	μs

L9680



17.21 General purpose output drivers

All electrical characteristics are valid for the following conditions unless otherwise noted: 40 °C \leq Ta \leq +95 °C, VIN_{GOOD0} \leq VIN \leq 35V, VGPODx + 5V \leq VERBOOST.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V _{SAT_GPO_L}	Output saturation voltage	V _{GPOD} – V _{GPOS} I _{LOAD} = 50 mA ERBOOST = 35 V	-	-	0.5	v
2	V _{SAT_GPO_H}	Output saturation voltage	V _{GPOD} – V _{GPOS} I _{LOAD} = 70 mA	-	-	0.7	V
3	I _{LIM_GPO}	Driver current limit	V _{GPOD} – V _{GPOS} = 1.5 V ERBOOST = 35 V	73	110	160	mA
4	I _{OC_GPO}	Over current detection	ERBOOST = 35 V	73	110	160	mA
5	V _{OUT_GPOD_OL}	GPO diag OFF output voltage on GPOD in low side mode in open load condition	GPOxLS = 1 I _{OUT} = 0 mA	-10%	2.5	+10%	V
6	V _{OUT_GPOS_OL}	GPO diag OFF output voltage on GPOS in high side mode in open load condition	GPOxLS = 0 I _{OUT} = 0 mA	-10%	2.5	+10%	V
7	I _{SRC_TH}	GPO diag OFF state short to ground detection threshold	GPOxLS = 0 / 1	15	27	40	μA
8	I _{SINK_TH_LS}	GPO Diag OFF state short to battery detection threshold low side mode	GPOxLS = 1 GPOS = 0	15	27	46	μA
9	I _{SINK_TH_HS}	GPO Diag OFF state short to battery detection threshold high side mode	GPOxLS = 0	170	220	270	μA
10	I _{LIM_GPOD_SRC}	GPO Diag OFF state	GPOxLS = 1, GPO Driver OFF, GPOD = 0 V, GPOS = 0 V	-90	-70	-50	μA
11	I _{LIM_GPOD_SINK}	current limitation on GPOD	GPOxLS = 1, GPO Driver OFF, GPOD = 18 V, GPOS = 0 V	50	70	90	μA
12	I _{LIM_GPOS_SRC}	GPO Diag OFF state	GPOxLS = 0, GPO Driver OFF, GPOD = 18 V, GPOS = 0 V	-90	-70	-50	μA
13	I _{LIM_GPOS_SINK}	current limitation on GPOS	GPOxLS = 0, GPO driver OFF, GPOD = 18 V,GPOS = 18 V	320	400	480	μA

Table 68	. GPO	interface	DC	specifications
		micriace		specifications



No	Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
14	I _{OL_GPO}	Open load current threshold	GPO driver ON	0.5	1	3	mA
15	I _{DIAG_GPO}	Diagnostic current on load	Voltage measurement in progress through Analog MUX Increased leakage for a short specified time (32µs)	-	-	130	μA
16	I _{LKG_GPOD_OFF}		V _{GPOD} = 18 V V _{GPOS} = 0V ERBOOST = 35 V Power-off or Sleep Mode	-5	-	+5	μΑ
17	I _{LKG_GPOD_ON}	GPOD output leakage current	$V_{GPOD} = 18 V$ $V_{GPOS} = 0 V$ ERBOOST = 35 V GPO Driver OFF Active or Passive Mode with GPO un-configured	-5	-	+5	μΑ
18	ILKG_GPOS_OFF		V _{GPOD} = 18 V V _{GPOS} = 0 V ERBOOST = 35 V Power-off or Sleep Mode	-5	-	+5	μA
19	I _{LKG_GPOS_ON}	GPOS output leakage current	$V_{GPOD} = 18 V$ $V_{GPOS} = 0 V$ ERBOOST = 35 V GPO Driver OFF Active or Passive Mode with GPO un-configured	-5	-	+5	μΑ
20	I _{REV_GPO}	Reverse current	V _{GPOS} = V _{GPOD} + 1 V GPO Driver OFF	-	-	1	mA
21	T _{JSD_GPO}	Thermal shutdown	-	150	175	190	°C
22	T _{HYS_TSD_GPO}		-	5	10	15	°C
23	C _{GPO}	Load capacitor	Design Info	6	-	-	nF

Table 68. GPO interface DC specifications (continued)



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No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	SR _{GPOx}	GPOx output voltage slew rate	30% - 70%; R _{LOAD} = 273 Ω, C _{LOAD} = 100 nF	0.1	0.25	0.4	V/µs
2	T _{FLT_OC}	Over current detection filter time	GPO Driver ON	10	12	14	μs
3	T _{FLT_UC}	Open load detection filter time	GPO Driver ON	8	10	12	μs
4	T _{flt_stb}	Short to battery detection in OFF state deglitch filter time	GPO Driver OFF	8	10	15	μs
5	T _{FLT_STG}	Short to GND detection in OFF state deglitch filter time	GPO Driver OFF	8	10	15	μs
6	T _{MASK_STUP_ON}	Diagnostic mask delay after switch ON	C _{GPOX} = 100 nF typ	136	-	200	μs
7	T _{MASK_STUP_OFF}	Diagnostic mask delay after switch OFF	C _{GPOX} = 100 nF typ	520	-	584	μs
8	T _{FLT_TSD}	Thermal shutdown filter time	-	-	-	10	μs
9	F _{PWM}	GPO PWM frequency	Design Info	-	125		Hz
10	DC _{PWM}	GPO PWM duty cycle	Increment step = 1.6%	0	-	100	%

Table 69	GPO driver interfact	e – AC specifications	
Table 03.		e – Ao specifications	,



## 17.22 Analog to digital converter

All electrical characteristics are valid for the following conditions unless otherwise noted: 40 °C  $\leq$  Ta  $\leq$  +95 °C, VIN_{GOOD0}  $\leq$  VIN  $\leq$  35 V.

No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
1	V _{ADC_RANGE}	ADC input voltage range	-	0.1	-	2.5	V
2	V _{ADC_REF}	ADC reference voltage	-	-1.5%	2.5	+1.5%	V
3	ADC_RES	ADC resolution ⁽¹⁾	Design Info	-	10	-	bit
4	DNL	Differential non linearity error (DNL)	Separation between adjacent levels, measured bit to bit of actual and an ideal output step. No missing codes	-1	-	+1	LSB
5	INL	Integral non linearity error (INL)	Maximum difference between the actual analog value at the transition between 2 adjacent steps and its ideal value	-3	-	+3	LSB
6	E _{QUANT}	Quantization error	Design Info	-0.5	-	0.5	LSB
7	TotErr	Total error	Includes INL, DNL, ADC Reference voltage tolerance and quantization error	-15	-	+15	LSB
8	TotErr_0v1	ADC total error for 0.1 V input voltage	-	-5	-	+5	LSB
9	TotErr_2v4	ADC total error for 2.4 V input voltage	-	-15	-	+15	LSB
10	R _{LSB_1}	Reproducibility:	1x sampling measurements. Guaranteed by design	-6	-	6	LSB
11	R _{LSB_4}	conversion result variation for constant	4x sampling measurements. Guaranteed by design	-3	-	3	LSB
12	R _{LSB_8}	input signal	8x sampling measurements. Guaranteed by design	-2.5	-	2.5	LSB
13	Pre-ADC	Pre-ADC settling time	-	-	4.81	-	μs
14	T_TSC	Single conversion time	-	-	2.25	-	μs
15	IQ	Intra-queue settling time	-	-	3.5	-	μs
16	Post-ADC	Post- ADC settling time	-	-	3.44	-	μs

Table 70. Analog to digital converter



No	Symbol	Parameter	Conditions	Min	Тур	Max	Unit
17	-	ADC conversion time - voltage	4x sampling for each of the 4 conversions in the queue Design Info	-	54.75	-	μs
18	-	ADC conversion time – current and voltage	8x sampling for DCS, temperature and squib/pyroswitch loop resistance measurements + 4x sampling for remaining 2 conversions in the queue Design Info	-	51.25	-	μs

Table 70. Analog to digital converter (continued)

1. LSB = (2.5V / 1024) = 2.44mV



#### Voltage diagnostics (Analog MUX) 17.23

All electrical characteristics are valid for the following conditions unless otherwise noted: 40 °C  $\leq$  Ta  $\leq$  +95 °C, VIN_{GOOD0}  $\leq$  VIN  $\leq$  35V.

No	Symbol	Parameter	Conditions	Min	Тур	Мах	Units
1	Ratio_1		V _{IN_RANGE_1} = 0.1 V to 2.5 V	-	1	-	V/V
2	Ratio_4		V _{INPUT_RANGE_4} = 1 V to 10 V	-3%	4	+3%	V/V
3	Ratio_7	Divider ratios	V _{INPUT_RANGE_7} = 1.5V to 17.5V	-3%	7	+3%	V/V
4	Ratio_10		V _{INPUT_RANGE_10} = 2 V to 25 V	-3%	10	+3%	V/V
5	Ratio_15		V _{INPUT_RANGE_15} = 3 V to 35 V	-3%	15	+3%	V/V
6	Offset	Divider Offset	High impedance	-10	-	10	mV
7	R _{RATIO_4}		Multiplexer input to GNDA	80	-	-	kΩ
8	R _{RATIO_7}	Multiplexer input	Multiplexer input to GNDA	120	-	-	kΩ
9	R _{RATIO_10}	resistance	Multiplexer input to GNDA	160	-	-	kΩ
10	R _{RATIO_15}		Multiplexer input to GNDA	200	-	-	kΩ
11	ILEAK_MUX_ON	Additional multiplexer on-state input leakage current	For all divider ratio expect ratio_1	-	-	60	μA
12	V _{MEAS_ACC}	Voltage measurement accuracy	(±15LSB) plus divider error (±3%)				

Table 71. Voltage diagnostics (Analog MUX)

#### 17.24 **Temperature sensor**

All electrical characteristics are valid for the following conditions unless otherwise noted:

40 °C  $\leq$  Ta  $\leq$  +95 °C, VIN_{GOOD0}  $\leq$  VIN  $\leq$  35 V.

Table 72. Temperature sensor specifications										
Symbol	Parameter	Conditions	Min	Тур	Мах					
T _{MON_RANGE}	Monitoring temperature range	-	-40	-	150					

Table 72 Temperature sensor specifications

							1
	2	T _{MON_ACC}	Monitoring temperature accuracy	-	-15	-	
-							

No

1



Unit

°C

°C

15

## 18 Quality information

### 18.1 OTP memory

The device contains a 128-bits One-Time Programmable memory. This OTP memory is used for the following purposes:

- 1. 86 bits data + 3 bits CRC for critical parameters trimming: bandgaps, oscillators, reference currents, firing currents, DC sensor and RSU interface parameters.
- 2. 18 bits data for other blocks trimming: ADC, ER Cap Measurement
- 3. 20 bits data for die and wafer traceability
- 4. 1 bit for debug purpose

User read/write access to the OTP memory via SPI is only possible during production testing and require activation of a special test mode.

During mission mode, the trimming bits are automatically read from OTP and transferred to the related circuits at each POR cycle. During this operation, actual CRC of the protected trimming data is calculated and checked against the expected CRC stored in the OTP. In case of CRC check failure the OTPCRC_ERR flag is set in the FLTSR register.



# 19 Errata sheet

#### Table 73. Errata sheet

#	Component Revision	Category / Function	Issue Description		
1	L9680CC	Deployment Diagnostic	The high side driver diagnostic, described in section <i>on page</i> 174, doesn't work. As consequence, the I _{LIM_HS_FET} parameter is not tested in production.		
2	L9680CC	WSS Over current detection	The over current threshold doesn't work. The user can use the leakage to ground flag to understand if a fault condition is present. The interface is anyway protected by means of thermal protection.		
3	L9680CC	Safing engine	The safing records associated with CS_RS validate and process data with matching request/response masks even if these are not coming from CS_RS frames but from frames sniffed on SAF_CSx.		
			This may lead to issues when expansion chip is used and CS_RS frames sent on expansion are sniffed by SAF_CSx at SBC side; the SBC fails to check its own CS_RS and therefore all RSUs safing records CC with matching request/response masks of expansion RSUs safing records will be updated upon the processing of the expansion RSU SPI data.		
			Workaround: use two different values for WID SPI bit when addressing CS_RS at SBC (ie WID=1) and expansion (WID=0) side.		



## 20 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK is an ST trademark.

### 20.1 TQFP100 (14x14x1.4 mm exp. pad down) package information



Figure 74. TQFP100 (14x14x1.4 mm exp. pad down) package outline



		Dimensions					
Ref		Millimeters		Inches ⁽¹⁾			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
А	-	-	1.20	-	-	0.0472	
A1	0.05	-	0.15	0.0020	-	0.0059	
A2	0.95	1.00	1.05	0.0374	0.0394	0.0413	
b	0.17	0.22	0.27	0.0067	0.0087	0.0106	
С	0.09	-	0.20	0.0035	-	0.0079	
D	15.80	16.00	16.20	0.6220	0.6299	0.6378	
D1	13.80	14.00	14.20	0.5433	0.5512	0.5591	
D2 ⁽²⁾	5.40	-	8.50	0.2126	-	0.3346	
D3	-	12.00	-	-	0.4724	-	
E	15.80	16.00	16.20	0.622	0.6299	0.6378	
E1	13.80	14.00	14.20	0.5433	0.5512	0.5591	
E2 ⁽²⁾⁾	5.40	-	8.50	0.2126	-	0.3346	
E3	-	12.00	-	-	0.4724	-	
е	-	0.50	-	-	0.0197	-	
L	0.45	0.60	0.75	0.0177	0.0236	0.0295	
L1	-	1.00	-	-	0.0394	-	
k	-	3.50	7.00	-	0.1378	0.2756	
CCC	-	-	0.08	-	-	0.0031	

 Table 74. TQFP100 (14x14x1.4 mm exp. pad down) package mechanical data

1. Values in inches are converted from mm and rounded to 4 decimal digits.

2. The size of exposed pad is variable depending of lead frame design pad size. End user should verify "D2" and "E2" dimensions for each device application.



# 21 Order codes

Table	75.	Device	summary
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Order code	Package	Pacing	
L9680		Tray	
L9680TR		Tape & Reel	



# 22 Revision history

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Date	Revision	Changes
03-May-2016	1	Initial release.



Date Revision Changes		Changes	
23-Oct-2018	2	<ul> <li>Modified in Table 1: Absolute maximum ratings the max. values for all SRx pins name from 40 V to 35 V.</li> <li>Updated:</li> <li>Section 5.2: Deployment drivers on page 24,</li> <li>Section 6.2.5: Power-up and power-down sequences,</li> <li>Section 6.10: VCOREMON external core voltage monitor'</li> <li>Section 9.1.1: Functional description'</li> <li>Table 25: Internal regulator DC specifications on page 236,</li> <li>General conditions in Section 17.5: Oscillators on page 238,</li> <li>Table 31: Reset DC specifications on page 239,</li> <li>Table 34: SPI AC specifications on page 241,</li> <li>Table 34: SPI AC specifications on page 241,</li> <li>Table 38: ER CAP current generators and diagnostic DC specifications on page 245,</li> <li>Table 40: ER Switch DC specifications on page 246,</li> <li>Table 41: SYNCBOOST converter DC specifications,</li> <li>Table 50: VCC converter DC specifications,</li> <li>Table 51: Deployment drivers diagnostics - Squib/pyroswitch resistance measurement on page 259,</li> <li>General conditions in Section 17.17.2: Squib/pyroswitch leakage test (VRCM) on page 261,</li> <li>Table 61: PSI-5 satellite transceiver - AC specifications on page 263,</li> <li>Table 62: PSI-5 satellite transceiver - AC specifications on page 263,</li> <li>Table 63: GPO interface DC specifications on page 270,</li> <li>Table 64: GPO interface DC specifications on page 273,</li> <li>Table 65: DC Sensor interface specifications on page 273,</li> <li>Table 71: Voltage diagnostics (Analog MUX) on page 278.</li> <li>Corrected in Section 7.3.29 "register HIGH_LEV_DIAG_SEL" for "100" from "unused" to "ER cap ESR measure".</li> <li>Updated Section 19: Errata sheet on page 280.</li> </ul>	
09-Sep-2021	3	<ul> <li>Updated Section 19: Errata sheet on page 280.</li> <li>Added: <ul> <li>Section : Applications in cover page;</li> <li>Section 16: Applications;</li> <li>Section 21: Order codes.</li> </ul> </li> <li>Minor text changes in: <ul> <li>Table 55: Deployment drivers – DC specifications;</li> <li>Section 1: Description;</li> <li>Section 6.1: Power supply overview;</li> <li>Section 7.3.27: WD test command register (WD_TEST);</li> <li>Section 12.6: Additional communication line.</li> </ul> </li> <li>Changed "Squib" in "Squib/pyroswitch" throughout the document.</li> </ul>	

Table 76. Document revision history



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